

**DPOJET**  
**Jitter and Eye Diagram Analysis Tools**  
**Online Help**

Copyright © Tektronix. All rights reserved. Licensed software products are owned by Tektronix or its subsidiaries or suppliers, and are protected by national copyright laws and international treaty provisions.

Tektronix products are covered by U.S. and foreign patents, issued and pending. Information in this publication supersedes that in all previously published material. Specifications and price change privileges reserved.

TEKTRONIX and TEK are registered trademarks of Tektronix, Inc.

DPOJET Jitter and Eye Diagram Analysis Tools Online Help Part Number, 076-0114-01

### **Contacting Tektronix**

Tektronix, Inc.  
14200 SW Karl Braun Drive  
P.O. Box 500  
Beaverton, OR 97077  
USA

For product information, sales, service, and technical support:

- In North America, call 1-800-833-9200.
- Worldwide, visit [www.tektronix.com](http://www.tektronix.com) to find contacts in your area.

# Table of Contents

General Safety Summary .....	xi
<b>Introduction to the Application</b>	
Welcome .....	1
Five-Time Free Trial .....	1
Related Documentation .....	2
Conventions .....	3
Technical Support .....	3
Customer Feedback .....	4
<b>Getting Started</b>	
Product Description .....	7
DPOJET Option Levels .....	7
Compatibility .....	8
Requirements and Restrictions .....	9
Supported Probes .....	10
Installing the Application .....	11
About DPOJET .....	11
<b>Operating Basics</b>	
About Basic Operations	
Starting the Application .....	13
Application Interface Menu Controls .....	13
Virtual Keypad .....	14
Tips on DPOJET User Interface .....	15
Basic Oscilloscope Functions	
Application Directories .....	16
File Name Extensions .....	16
Application Menu Shortcuts .....	17
Returning to the Application .....	18
Saving and Recalling Setups	
Saving a Setup .....	18
Recalling a Saved Setup .....	18
Recalling the Default Setup .....	19
Setting Up DPOJET to Take Measurements	
Setting Up the Application for Analysis .....	20
Table of Measurements-Period/Freq .....	20
Table of Measurements-Jitter .....	21
Table of Measurements-Time .....	22

Table of Measurements-Eye .....	23
Table of Measurements-Amplitude .....	24
Table of Measurements-More .....	25
Wizard	
One Touch Jitter.....	25
Serial Data/Jitter Guide	
About Serial Data/Jitter Guide .....	28
Select Measurement .....	29
Configure Measurement	
About Configuring Measurement .....	30
Configure Measurement-Skew .....	30
Configure Measurement-Jitter Summary .....	31
Select Sources .....	32
Configure Autoset Options.....	34
Select Plots .....	34
Jitter And Eye Analysis	
About Jitter And Eye Diagram Analysis Options .....	36
Deskew.....	37
Deskew Summary .....	39
Export Data Snapshot-Statistics.....	40
Export Data Snapshot-Measurement .....	41
Export Measurement Summary .....	44
Data Logging	
Data Logging-Statistics .....	44
Data Logging-Measurement .....	46
Data Logging-Worst Case.....	49
Measurement Summary	
Measurement Configuration Summary-Measurement .....	51
Measurement Summary-Ref Levels .....	52
Measurement Summary-Misc .....	54
Preferences Setup	
About Preferences Setup .....	55
Preferences-General .....	55
Preferences-Measurement.....	56
Preferences-Path Defaults.....	59
Limits .....	60
Taking Measurements	
About Taking a New Measurement .....	62
Selecting a Measurement .....	63
Warning Log Notifiers.....	65
Navigation Panel.....	66
Control Panel.....	66

Sources Setup .....	68
Source Autoset .....	69
Ref Levels .....	71
Autoset Ref Levels .....	76
Configuring Measurements	
About Configuring a Measurement .....	77
Global	
About Global .....	81
Gating .....	81
Qualify .....	82
Configuring Qualify with Logic .....	83
Population .....	84
Configuring Population Limit .....	85
General .....	86
Filters .....	87
Advanced Filter Configuration .....	89
Clock Recovery	
About Clock Recovery .....	92
About Constant Clock Recovery .....	92
Constant Clock - Mean .....	94
Constant Clock - Median .....	95
Constant Clock - Fixed .....	96
Clock Recovery Advanced Setup .....	96
About PLL Clock Recovery Setup .....	98
PLL Standard BW .....	98
PLL Custom BW .....	99
About Explicit Clock Recovery .....	101
Explicit Clock-Edge .....	102
Advanced Explicit Clock-Edge .....	103
Explicit Clock-PLL .....	104
Advanced Explicit Clock-PLL .....	105
Effect of Nominal Clock Offset on Eye Diagrams .....	106
Bit Config for Eye Height Measurements .....	107
Bit Config for Mask Hits Measurements .....	108
Bit Config for Amplitude Measurements .....	109
RJDJ	
About RJ/DJ .....	109
RJ/DJ Analysis of Repeating Pattern .....	110
RJ/DJ Analysis of Arbitrary Pattern .....	111
Edges	
Configuring Edges .....	112
Configuring Edges for Skew Measurements .....	113

Configuring Edges for Differential CrossOver Voltage Measurements .....	114
Configuring Edges for Phase Noise Measurements .....	115
Configuring Edges for N-Period Measurements .....	116
Configuring Edges for Two Source Measurements.....	117
Configuring Edges for CC-Period/Duty Cycle Measurements.....	118
Configuring Edges for DCD Measurement.....	119
Sequencing.....	120
Results as Statistics	
Viewing Statistical Results.....	120
Export Results to Ref Waveform.....	123
Plots	
Results as Plots.....	124
Plot Usage .....	126
Selecting Plots.....	129
Configuring Plots	
About Configuring Plots.....	129
Configuring a Bathtub Plot.....	130
Configuring a Spectrum Plot.....	132
Configuring a Time Trend.....	133
Configuring a Histogram Plot.....	134
Configuring a Transfer Plot .....	135
Configuring a Phase Noise Plot.....	136
Configuring an Eye Diagram Plot for Eye Height.....	137
Configuring an Eye Diagram for Mask Hits .....	138
Viewing Plots	
About Viewing Plots.....	139
Using a Second Monitor to View Plots .....	139
Toolbar Functions in Plot Windows.....	140
Moving and Resizing plots.....	140
Using Zoom in a Plot .....	141
Using Cursors in a Plot.....	142
Exporting Plot Files.....	143
Printing Plots .....	143
Reports	
About Reports .....	143

## Tutorial

Introduction to the Tutorial .....	147
Setting Up the Oscilloscope .....	147
Starting the Application .....	147
Waveform Files .....	147
Recalling a Waveform File .....	148
Taking a Period Measurement .....	148
Taking a TIE Measurement .....	150
Taking an Eye Height and Width Measurement .....	151
Summary Tutorial .....	152
Stopping the Tutorial .....	154
Returning to the Tutorial .....	154

## Parameters

About Parameters .....	155
Measurement Select Parameters .....	155
Autoset Parameters .....	156
Ref Level Menu Parameters .....	157
Preferences Parameters .....	158
Deskew Parameters .....	159
Data Logging Parameters .....	160
Control Panel Parameters .....	160
Configure Measurement Parameters	
Bit Config Parameters .....	161
Edges Parameters .....	161
Clock Recovery Parameters .....	162
RJDJ Analysis Parameters .....	165
Filters Parameters .....	165
General Parameters .....	166
Global Parameters .....	166
Plots	
Histogram Plot Parameters .....	167
Eye Diagram Plot Parameters .....	167
Spectrum Plot Parameters .....	167
Time Trend Plot Parameters .....	168
Phase Noise Plot Parameters .....	168
Bathtub Plot Parameters .....	168
Transfer Function Plot Parameters .....	168

Reports..... 169

## Reference

Progress Bar Status Messages..... 171  
 Error Codes..... 172  
 Measurement Values ..... 174

## Algorithms

About Algorithms ..... 177  
 Period/Freq Measurements  
     Period ..... 177  
     Positive and Negative Width ..... 178  
     Frequency..... 179  
     N-Period ..... 180  
     Positive and Negative Duty Cycle..... 181  
     CC-Period ..... 181  
     Positive and Negative CC Duty ..... 182  
 Jitter Measurements  
     TIE ..... 182  
     RJ ..... 183  
     Dual Dirac Random Jitter ..... 183  
     Jitter Summary ..... 183  
     TJ@BER..... 184  
     DJ..... 184  
     Dual Dirac Deterministic Jitter..... 184  
     Phase Noise..... 185  
     PJ ..... 185  
     DDJ..... 185  
     DCD ..... 186  
 Timing Measurements  
     Rise Time ..... 187  
     Fall Time..... 187  
     Skew..... 188  
     High Time ..... 188  
     Low Time..... 189  
     Setup ..... 189  
     Hold ..... 190  
 Eye  
     Eye Width..... 190  
     Width@BER ..... 190  
     Eye Height..... 191  
     Mask Hits..... 192



Amplitude Measurements	
High .....	193
Low .....	193
Common Mode .....	194
T/nT Ratio .....	194
High-Low .....	196
V-Diff-Xovr .....	196
More Measurements	
DDR Setup and Hold Measurements .....	197
DDR Setup-SE .....	201
DDR Setup-Diff .....	202
DDR Hold-SE .....	203
DDR Hold-Diff .....	204
Jitter Separation	
Jitter Analysis Through RJ/DJ Separation .....	204
RJ/DJ Separation via Spectrum Analysis .....	205
RJ/DJ Separation for Arbitrary Patterns .....	206
Estimation of TJ@BER and Eye Width@BER .....	206
Jitter Estimation Using Dual-Dirac Models .....	207
Results .....	207

## GPIB Commands

About the GPIB Program .....	211
GPIB Reference Materials .....	211
Argument Types .....	212
DPOJET: ADDMeas .....	212
DPOJET: CLEARALLMeas .....	213
DPOJET: STATE .....	213
DPOJET: LASTError? .....	214
DPOJET: MEAS<x> .....	214
DPOJET: MEAS<x>: FILTERs: HIGHPass?	
DPOJET: MEAS<x>: FILTERs: HIGHPass: SPEC .....	222
DPOJET: MEAS<x>: FILTERs: HIGHPass: FREQ .....	222
DPOJET: MEAS<x>: FILTERs: LOWPass?	
DPOJET: MEAS<x>: FILTERs: LOWPass: SPEC .....	223
DPOJET: MEAS<x>: FILTERs: LOWPass: FREQ .....	223
DPOJET: MEAS<x>: RJDJ: BER .....	224
DPOJET: MEAS<x>: CLOCKRecovery: METHod .....	226
DPOJET: MEAS<x>: BITType .....	233
DPOJET: MEAS<x>: MASKfile .....	234
DPOJET: MEAS<x>: MEASRange	
DPOJET: MEAS<x>: MEASRange: STATE .....	235

DPOJET:MEAS<x>:PHASENoise:LOWLimit .....	236
DPOJET:MEAS<x>:PHASENoise:HIGHLimit .....	237
DPOJET:MEAS<x>:LOGging	
DPOJET:MEAS<x>:LOGging:STATistics:SElect .....	238
DPOJET:MEAS<x>:LOGging:MEASurements:SElect .....	238
DPOJET:MEAS<x>:LOGging:WORSTcase:SElect .....	239
DPOJET:GATING .....	240
DPOJET:QUALify	
DPOJET:QUALify:STATE .....	241
DPOJET:POPULATION:STATE .....	242
DPOJET:LIMITRise .....	244
DPOJET:DIRacmodel .....	245
DPOJET:INTERp .....	245
DPOJET:SOURCEAutoset .....	246
DPOJET:REFLevels:AUTOSet .....	246
DPOJET:REFLevels:CH<x>:AUTOSet .....	247
DPOJET:REFLevels:CH<x>:ABSolute .....	248
DPOJET:REFLevels:CH<x>:PERcent .....	251
DPOJET:MEAS<x>:RESULts? .....	254
DPOJET:MEAS<x>:RESULTS:STATus? .....	265
Plots	
DPOJET:ADDPlot .....	266
DPOJET:CLEARALLPlots .....	266
DPOJET:PLOT<x>:TYPE? .....	267
DPOJET:PLOT<x>:SOUrce? .....	267
DPOJET:PLOT<x>:TREND:TYPE .....	268
DPOJET:PLOT<x>:HISTOgram:AUTOset .....	268
DPOJET:PLOT<x>:SPECTrum:VERTical:SCALE .....	272
DPOJET:PLOT<x>:TRANSfer:VERTical:SCALE .....	274
DPOJET:PLOT<x>:PHASEnoise:BASEline .....	276
DPOJET:PLOT<x>:BATHtub:VERTical:SCALE .....	277
DPOJET:PLOT<x>:EYE:HORizontal:RESolution .....	278
Reports	
DPOJET:REPORT .....	280
Logging	
DPOJET:LOGging:SNAPshot .....	285
DPOJET:LIMits	
DPOJET:LIMits:STATE .....	289
DPOJET:LIMits:FILEName .....	289

---

DPOJET:DESKEW .....	290
DPOJET:VERsion?.....	295
DPOJET:NUMMeas? .....	295
DPOJET:HIGHPrefrendering .....	295
DPOJET:UNITType.....	296
DPOJET:SAVE .....	296
DPOJET:EXPORT .....	297

## Index



# General Safety Summary

Review the following safety precautions to avoid injury and prevent damage to this product or any products connected to it.

To avoid potential hazards, use this product only as specified.

*Only qualified personnel should perform service procedures.*

While using this product, you may need to access other parts of a larger system. Read the safety sections of the other component manuals for warnings and cautions related to operating the system.

## To Avoid Fire or Personal Injury

**Use Proper Power Cord.** Use only the power cord specified for this product and certified for the country of use.

**Connect and Disconnect Properly.** Do not connect or disconnect probes or test leads while they are connected to a voltage source.

**Connect and Disconnect Properly.** Connect the probe output to the measurement instrument before connecting the probe to the circuit under test. Connect the probe reference lead to the circuit under test before connecting the probe input. Disconnect the probe input and the probe reference lead from the circuit under test before disconnecting the probe from the measurement instrument.

**Observe All Terminal Ratings.** To avoid fire or shock hazard, observe all ratings and markings on the product. Consult the product manual for further ratings information before making connections to the product.

**Do Not Operate Without Covers.** Do not operate this product with covers or panels removed.

**Do Not Operate With Suspected Failures.** If you suspect that there is damage to this product, have it inspected by qualified service personnel.

**Avoid Exposed Circuitry.** Do not touch exposed connections and components when power is present.

### Terms in this Manual

These terms may appear in this manual:



**WARNING.** *Warning statements identify conditions or practices that could result in injury or loss of life.*

---



**CAUTION.** *Caution statements identify conditions or practices that could result in damage to this product or other property.*

---

## Welcome

DPOJET is a jitter, timing, and eye analysis tool for Tektronix Performance Digital Oscilloscopes (DPO7000 and DSA/DPO70000 series). DPOJET enables you to achieve new levels of productivity, efficiency, and measurement reliability on complex clock, digital, and serial data signals.

Some of the features of DPOJET are:

- Advanced Jitter and Timing Analysis for clocks and data signals, with up to 99 simultaneous measurements on 12 sources.
- Jitter Guide/Serial Data wizard for easy configuration of popular measurement sets.
- One Touch Jitter wizard for quick jitter summaries.
- Accurate jitter decomposition and TJ (BER) estimation using industry-accepted methods.
- Comprehensive measurement statistics.
- Flexible measurement/statistic logging and export capabilities.
- Sophisticated graphical analysis tools such as Histograms, Time Trends, Eye Diagrams, Spectrums, Bathtub Plots and Real-Time Eye® diagrams with transition and non-transition bit separation.
- Tektronix patented Programmable PLL software clock recovery.
- Standards-specific support for clock recovery and jitter separation methods.
- Capture and storage of worst-case waveforms for subsequent analysis.
- Thorough remote programmability using oscilloscope-like syntax.

## Five-Time Free Trial

You can refer to the *Optional Applications Software on a Windows-Based Oscilloscope Installation Manual* for details on free trails which are available for all applications. The manual is available on the Optional Applications Software on Windows-Based Oscilloscopes DVD, in the documents directory.

---

**NOTE.** *Before evaluating an application, first check that your DSA/DPO series oscilloscope firmware version is consistent with the version requirements mentioned in the application's readme file. You can check the firmware version number from the oscilloscope Help drop-down list (About TekScope). To check the application's firmware compatibility, refer to the System Requirements section of the readme.txt file.*

---

If an application is introduced after you receive your oscilloscope, you can download the application as described in the installation manual (Tektronix part number 077-0067-XX) to obtain the free trial. You can download the manuals from [www.tektronix.com/manuals](http://www.tektronix.com/manuals) and [www.tektronix.com/software](http://www.tektronix.com/software).

## Related Documentation

Tektronix manuals are available at: [www.tektronix.com/manuals](http://www.tektronix.com/manuals) and [www.tektronix.com/software](http://www.tektronix.com/software). Use the following table to determine the document that you need:

**Table 1: List of reference documents**

<b>For information on:</b>	<b>Refer to:</b>
■ Operating the Oscilloscope	Oscilloscope user manual. Oscilloscope user online help.
■ Software warranty	<i>Optional Applications Software on Windows-Based Oscilloscopes Installation Manual</i> , which is provided on the Optional Applications Software on Windows-Based Oscilloscopes CD-ROM, in the Documents directory.
■ List of available applications	
■ Compatible oscilloscopes	
■ Relevant software and firmware version numbers	
■ Applying a new option key label	
■ Installing an application	
■ Enabling an application	
■ Downloading updates from the Tektronix Web site	






## Conventions

Online Help uses the following conventions:

- When steps require sequence of selections using the application interface, the “>” delimiter marks each transition between a menu and an option. For example, **Analyze > Wizard > One Touch Jitter**.
- The terms “DPOJET application” and “application” refer to DPOJET.
- The term “oscilloscope” refers to any product on which this application runs.
- The term “DUT” is an abbreviation for Device Under Test.
- The term “select” is a generic term that applies to the methods of choosing an option: with a mouse or with the touch screen.
- User interface screen graphics are taken from a DPO7000 series oscilloscope.

You can find a PDF (portable document format) file for this document in the Documents directory on the *Optional Applications Software on Windows-Based Oscilloscopes DVD*. The DVD booklet only contains information on installing the application from the DVD and on how to apply a new label. You can also find the PDF and the Online Help at **Start > Programs > TekApplications > DPOJET**.

**Table 2: Icon descriptions**

Icon	Meaning
	This icon identifies important information.
	This icon identifies conditions or practices that could result in loss of data.
	This icon identifies additional information that will help you use the application more efficiently.

## Technical Support

Tektronix welcomes your comments about products and services. Contact Tektronix through mail, telephone, or the Web site. Click [Contacting Tektronix](#) for more information.

Tektronix also welcomes your feedback. Click [Customer feedback](#) for suggestions for providing feedback to Tektronix.

## Customer Feedback

Tektronix values your feedback on our products. To help us serve you better, please send us your suggestions, ideas, or other comments you may have regarding the application or oscilloscope.

Direct your feedback via email to

**techsupport@tektronix.com**

Or FAX at (503) 627-5695, and include the following information:

### General Information

- Oscilloscope model number (for example: DPO7000 or DSA/DPO70000 series) and hardware options, if any.
- Software version number.
- Probes used.

### Application-specific Information

- Description of the problem such that technical support can duplicate the problem.
- If possible, save the oscilloscope and application setup files as `.set` and associated `.xml` files.
- If possible, save the waveform on which you are performing the measurement as a `.wfm` file.

Once you have gathered this information, you can contact technical support by phone or through e-mail. In the subject field, please indicate “DPOJET Problem” and attach the `.set`, `.xml` and `.wfm` files to your e-mail. If there is any query related to the actual measurement results, then you can generate a `.mht` report and send it.

The following items are important, but optional:

- Your name
- Your company
- Your mailing address
- Your phone number
- Your FAX number

Enter your suggestion. Please be as specific as possible.

Please indicate if you would like to be contacted by Tektronix regarding your suggestion or comments.

---

**TIP.** To copy the above information to your e-mail text editor, right-click the mouse and click **Copy**. The above information will be copied to the clipboard where you can paste it to any text editor.

---

To include screen shots of the oscilloscope waveform and DPOJET user interface, from your oscilloscope menu bar, click **File > Save As > Screen Capture**. To include screenshots of the DPOJET plots, select the floppy-disk icon from the plots toolbar. In either case, enter a file name in the Save As dialog box, select an image file format (For Example: .bmp or .png or .jpeg), choose a save location and select Save. You can then attach the file(s) to your e-mail (depending on the capabilities of your e-mail editor).



## Product Description

DPOJET is a [jitter](#), [timing](#), and [eye diagram analysis](#) tool for Tektronix Performance Digital Oscilloscopes (DPO7000 and DSA/DPO70000 series). DPOJET enables you to achieve new levels of productivity, efficiency, and measurement reliability on complex clock, digital, and serial data signals.

The application provides the following features:

- One Touch Jitter Summary.
- Measurement Setup Wizard.
- Auto-detection of signal type (clock or data).
- RJ/DJ decomposition on repeating and arbitrary data patterns.
- Spectral plot with peak Hold, Averaging, and Nominal.
- Eye diagrams with transition and non-transition bits separation.
- High and Low Pass measurement filters.
- Selectable PLL and line edge detection and clock recovery methods.
- Automatic reference level autoset for eye diagrams, jitter and timing measurements.

### Timing Analysis

Timing analysis is the measurement of period, setup, hold, skew and other edge-to-edge data timing relationships.

### Eye Diagram Analysis

Eye diagram analysis is the plotting and measurement of eye diagrams and masks.

### Jitter Analysis

Jitter Analysis is the measurement of Time Interval Error (TIE), advanced RJ/DJ decomposition, and other clock to data edge relationships.

## DPOJET Option Levels

The DPOJET application offers two different levels of features, depending on how it is configured. The configurations are determined by the following order codes:

- **DJE** – Jitter and Eye Diagram Analysis Tools - Essentials
- **DJA** – Jitter and Eye Diagram Analysis Tools - Advanced

---

**NOTE.** *The application name “Jitter and Eye Diagram Analysis Tools” is the same for DJE and DJA. However, Help > About DPOJET indicates the configured option level. Save/Recall is be compatible between the option levels. If a setup file saved in DJA is recalled in DJE, only the capabilities available in DJE will be recalled.*

---

### Jitter and Eye Diagram Analysis Tools - Essentials

You can use **Essentials** for basic timing and jitter analysis. Essentials offers:

- Period, Frequency and Time Interval Error analysis.
- Timing parametrics such as rise/fall times, pulse width and duty cycle.
- Many graphical tools such as histograms, time trends, and spectrums.
- Configurable HTML report generation.
- Logging features for recording individual measurements, statistics, or worst-case waveforms.
- Comprehensive remote control using oscilloscope-like GPIB syntax.
- A wizard interface to ease common setup tasks.

### Jitter and Eye Diagram Analysis Tools-Advanced

The **Advanced** configuration offers all the features of Essentials, and adds the following:

- Jitter separation (RJ/DJ analysis).
- Eye measurements.
- Amplitude measurements.
- Measurement filters.
- Eye diagrams, bathtub plots or Mask Hits waveform plots.
- Pass/Fail limits capability.

## Compatibility

For information on oscilloscope compatibility, refer to the *Optional Application Software on Microsoft Windows Based Oscilloscopes Installation Manual*, Tektronix part number 077-0067-XX. The manual is available as a PDF file.

## Requirements and Restrictions

Microsoft .NET Framework version 2.0 or higher, MATLAB runtime is required to install and operate DPOJET on your oscilloscope.

## Supported Probes

The application supports the following probes:

- TAP1500
- TAP2500
- TAP3500
- P5100
- P6015
- P6101A
- P6139A
- P6241
- P6243
- P6245
- P6249
- P6150
- P6158
- P7240
- P7260
- P7330
- P7340A
- P7350
- P7350SMA
- P7360A
- P7380A
- P7380SMA
- P7313A
- P7313SMA
- P7513



## Installing the Application

Refer to the *Optional Applications Software on Windows-Based Oscilloscopes Installation Manual* for the following information:

- Software warranty.
- List of available applications, compatible oscilloscopes, and relevant software and firmware version numbers.
- Applying a new option installation key label.
- Installing an application.
- Enabling an application.
- Downloading updates from the Tektronix Web site.

You can find a PDF (portable document format) file for this document in the Documents directory on the *Optional Applications Software on Windows-Based Oscilloscopes DVD*. The DVD booklet contains information on how to install the application from the DVD and on how to apply a new option installation key label.

## About DPOJET

Click **Help > About DPOJET** to view application details such as the software version number, application name, copyright and US patents.









## Starting the Application


On the oscilloscope menu bar, click **Analyze > Jitter and Eye Analysis > Select** to open the application.

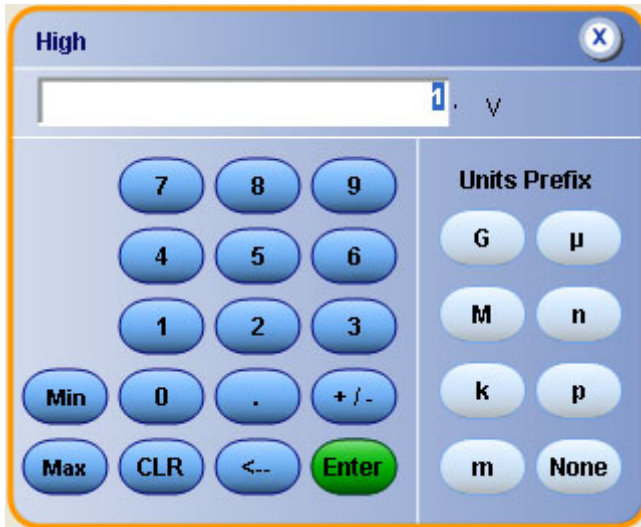
## Application Interface Menu Controls

**Table 3: Application Menu Controls descriptions**

Item	Description
Tab	Shortcut to a menu in the menu bar or a category of menu options; most tabs are short cuts.
Area	Visual frame with a set of related options.
Option button	Button that defines a particular command or task.
Field	Box that you can use to type in text, or to enter a value with the Keypad or a Multipurpose knob.
Check Boxes	Use to select or clear preferences.
Scroll bar	Vertical or horizontal bar at the side or bottom of a display area that can be used for moving around in that area.
Browse	Displays a window where you can look through a list of directories and files.
Command button	Button that initiates an immediate action such as Run command button  in the control panel.
Virtual Keypad icon 	Click to use on-screen keypad to enter alphanumeric values.
MP knob references (a or b)  	Identifiers that show which Multi Purpose Knob (MPK) may be used as an alternate means to control a parameter; turn the knob on the oscilloscope front panel to adjust the corresponding parameter Also, the value can be entered directly on the MPK display component.





## Virtual Keypad

Select the  icon and use the virtual keypad to enter alphanumeric values, such as reference voltage levels.



## Tips on DPOJET User Interface

Here are some tips to help you with the application user interface:

- Use the Serial Data/Jitter Guide to rapidly set up and initiate sets of commonly used measurements. After running the Serial Data/Jitter Guide, you may modify the configuration parameters to meet specific needs.
- Select a measurement to create a measurement and add it to the current measurement table. New measurements initially use the same source as the earlier measurement, or the most recently used source. Click  to change the measurement source or adjust other source parameters such as the reference levels.
- Select any measurement multiple times to create multiple copies. This may be useful if you wish to run the same measurement with different configuration options.
- Use the Single button  to obtain a single set of measurements from a single new waveform acquisition. Pushing the button again before processing has completed will interrupt the processing cycle.
- Use the Run button  to continuously acquire and accumulate measurements. Push the button again to interrupt the current acquisition.
- Use the Recalc button  to perform measurements on the waveform currently displayed on the oscilloscope, that is without performing a new acquisition. This is useful if you wish to modify a configuration parameter and re-run the measurements on the current waveform.

## Application Directories

The installation directory for DPOJET is `C:\Program Files\TekApplications\DPOJET`. During installation, the application sets up directories for various functions such as to save setup files. The file name extension is used to identify the file type.

**Table 4: Application directories**

Default directory	Used for
<code>C:\TekApplications\DPOJET\Images</code>	Exported plot files.
<code>C:\TekApplications\DPOJET\Limits</code>	Pass/fail limits files.
<code>C:\TekApplications\DPOJET\Patterns</code>	Bit patterns.
<code>C:\TekApplications\DPOJET\Logs</code>	Log files. Consists of three subfolders: <ul style="list-style-type: none"> <li>■ <b>Statistics</b> for statistics log files (.csv)</li> <li>■ <b>Measurements</b> for measurement log files (.csv) and</li> <li>■ <b>Waveforms</b> for worst case waveforms (.wfm)</li> </ul>
<code>C:\TekApplications\DPOJET\Masks</code>	Mask files for various serial data standards. For Example - PCIE, FBDIMM, SATA.
<code>C:\TekApplications\DPOJET\Reports</code>	Report files (.mht).
<code>C:\TekApplications\DPOJET</code>	Error log file, <code>DPOJETErrors.log</code> .
<code>C:\TekApplications\DPOJET\Examples</code>	Various tutorial and support files.

## File Name Extensions

**Table 5: File name extensions**

File Extension	Description
.csv	Ascii file containing Comma Separated Values. This file format may be read by any ascii text editor (such as Notepad) or may be imported into spreadsheets such as Excel.
.xml	Ascii file containing measurement setup information, limits or other data in Extensible Markup Language.
.set	Binary file containing oscilloscope setup information in a proprietary format.
.mht	An HTML archive file, compatible with common Windows applications; and contain the full report, including text and graphics.
.wfm	Binary file containing an oscilloscope waveform record in a recallable, proprietary format.

## Application Menu Shortcuts

The DPOJET application provides shortcuts for navigating the user interface. Use **Alt+ A** for the Analyze menu and **Alt+A+J** for Jitter and Eye Analysis.

---

**NOTE.** *Alt+A+J is common for all submenus except the Help menu.*


---

**Table 6: Application shortcuts**

Menu Items	SubMenu	Shortcut
Wizard	One Touch Jitter	Alt +A+J+W+O
	Serial Data/Jitter Guide	Alt +A+J+W+J
Select		Alt +A+J+S
Configure		Alt +A+J+C
Results		Alt +A+J+R
Plots		Alt +A+J+P
Reports		Alt +A+J+O
Export	Data Snapshot	Alt +A+J+E+D
	Measurement Summary	Alt +A+J+E+S
Data Logging		Alt +A+J+L
Preferences		Alt +A+J+F
Limits		Alt +A+J+I
Measurement Summary		Alt +A+J+M
Deskew		Alt +A+J+K
<b>Help</b>		
About DPOJET		Alt +H+J
Help on Jitter and Eye Analysis		Alt +H+T

## Returning to the Application

When you access oscilloscope functions, the DPOJET control windows may be replaced by the oscilloscope control windows or by the oscilloscope graticule. You can access oscilloscope functions in the following ways:

- From the menu bar on the oscilloscope, choose **Analyze > Jitter And Eye Analysis > Select**.
- Alternatively, you can switch between recently used control panels using the forward or backward arrows  on the right corner of the control panel.

## Saving a Setup

The DPOJET application state is automatically saved along with the oscilloscope state. To save the oscilloscope settings and application state, follow these steps:

1. Click **File > Save As > Setup**.
2. In the file browser, select the directory to save the setup file.
3. Select or enter a file name. The application appends \*\_DPOJET.xml to store DPOJET setup, and \*.set to store oscilloscope settings.
4. Click **Save**.

---

**NOTE.** After the oscilloscope application is started, DPOJET needs to be launched at least once before any saved DPOJET configuration can be recalled.

---

## Recalling a Saved Setup

To recall the default application setup and oscilloscope settings, do the following steps:

1. Click **File > Recall**.
2. Select the directory in the file browser from where you can recall the setup file.
3. Select a .set file and click **Recall**.

---

**NOTE.** Only .set files can be selected for recall; any corresponding \_DPOJET.xml file in the same directory will be recalled as well, if DPOJET has been launched at least once since the oscilloscope application was started. If DPOJET has not been launched at least once, the oscilloscope settings will be recalled but the DPOJET configuration will be ignored.

---



## Recalling the Default Setup

To recall the default application and oscilloscope settings, click **File > Recall Default Setup**.

## Setting Up the Application for Analysis

Refer to the following sections for more details on various measurements:

- Period and Frequency measurements
- Jitter measurements
- Time measurements
- Eye measurements
- Amplitude measurements
- More Measurements

## Table of Measurements-Period/Freq

Definitions of the period and frequency-related measurements are given in the following table:

**Table 7: Period/Frequency measurements definitions**

Measurement	Description
Period	For clock signals, the elapsed time between consecutive crossings of the mid reference voltage level in the direction specified; one measurement is recorded per crossing pair. For data signals, the elapsed time between consecutive crossings of the mid reference voltage in opposite directions divided by the estimated number of unit intervals for that pair of crossings; one measurement is recorded per unit interval so N consecutive bits of the same polarity result in N identical period measurements.
Frequency	The inverse of the period for each cycle or unit interval.
CC-Period	The cycle-to-cycle period; the difference in period measurements from one cycle to the next, that is the first difference of the Period measurement.
N-Period	The duration of N periods.
Pos Width	Amount of time the waveform remains above the mid reference voltage level.
Neg Width	Amount of time the waveform remains below the mid reference voltage level.
+Duty Cycle	The ratio of positive width to period, expressed in %.
-Duty Cycle	The ratio of negative width to period, expressed in %.
+CC-Duty	The difference between two consecutive positive widths.
-CC-Duty	The difference between two consecutive negative widths.

## Table of Measurements-Jitter

Definitions of the jitter-related measurements are given in the following table.

---

**NOTE.** *All jitter measurements except TIE are statistical measurements that require sufficient record length so that all deterministic effects can be observed and the random jitter can be modeled.*

---

**Table 8: Jitter measurements definitions**

Measurement	Description
TIE	Time Interval Error is the difference in time between an edge in the source waveform and the corresponding edge in a reference clock or explicitly by another source signal. The reference clock is determined by a clock recovery process.
RJ	Random Jitter is the statistics for all timing errors not exhibiting deterministic behavior, based on the assumption that they follow a Gaussian distribution. Random Jitter is typically characterized by its standard deviation.
RJ- $\delta\delta$	Random Jitter as defined above, but calculated based on a simplified assumption that the histogram of all deterministic jitter can modeled as a pair of equal-magnitude Dirac functions (impulses known as delta-functions).
DJ	Deterministic Jitter is the statistics for all timing errors that follow deterministic behavior. Deterministic Jitter is typically characterized by its peak-to-peak value.
DJ- $\delta\delta$	Deterministic Jitter as defined above, but calculated on the same simplified model as described under RJ- $\delta\delta$ .
PJ	Periodic Jitter is the statistics for that portion of the deterministic jitter which is periodic, but for which the period is not correlated with any data in the waveform.
DDJ	Data-Dependent Jitter is the statistics for that portion of the deterministic jitter directly correlated with the data pattern in the waveform.
DCD	Duty Cycle Distortion is the statistics for that portion of the deterministic jitter directly correlated with signal polarity, that is the difference in the mean timing error on positive edges versus that on negative edges.
TJ@BER	Total Jitter at a specified Bit Error Rate (BER). This combines the Random and Deterministic effects, and predicts a peak-to-peak jitter that will only be exceeded with a probability equal to the BER.

**Table 8: Jitter measurements definitions (cont.)**

Measurement	Description
Jitter Summary	This is not an individual measurement but a convenience function. Pressing this button automatically adds a set of eleven jitter-related measurements with a single action. The measurements are: TIE, RJ, RJ- $\delta\delta$ , DJ, DJ- $\delta\delta$ , PJ, DDJ, DCD, TJ@BER, Width@BER, and Phase Noise.
Phase Noise	The RMS magnitude for all integrated timing jitter falling between two specified frequency limits. This measurement is only applicable for clock signals.

## Table of Measurements-Time

Definitions of the time-related measurements are given in the following table:

**Table 9: Time measurements definitions**

Measurement	Description
Rise Time	Elapsed time between the Low reference level crossing and the High reference level crossing on the rising edge of the waveform.
Fall Time	Elapsed time between the High reference level crossing and the Low reference level crossing on the falling edge of the waveform.
High Time	Amount of time the waveform remains above the high reference voltage level.
Low Time	Amount of time the waveform remains below the low reference voltage level.
Setup	Elapsed time between the designated edge of a data waveform and that of a clock waveform, based on their respective mid reference level crossings.
Hold	Elapsed time between the designated edge of a clock waveform and that of a data waveform, based on their respective mid reference level crossings.
Skew	Time difference between two similar edges on two waveforms assuming that every edge in one waveform has a corresponding edge (either the same or opposite polarity) in the other waveform; edge locations are determined by the mid reference voltage level.

## Table of Measurements-Eye

Definitions of the eye-related measurements are given in the following table:

**Table 10: Eye measurements definitions**

Measurement	Description
Height	The measured clear vertical eye opening at the center of the unit interval. $\text{Height} = \text{High}(\text{min}) - \text{Low}(\text{max})$
Width	Measured clear horizontal eye opening at the middle reference level. $\text{Width} = \text{UI}(\text{mean}) - \text{TIE}(\text{max}) - \text{TIE}(\text{min})$
Width@BER	The horizontal eye opening projected to correspond to a specified Bit Error Rate. This number is obtained by measuring the jitter on the waveform performing RJ/DJ separation analysis, creating a bathtub curve, and reporting the bathtub width at the appropriate error rate. This eye width may not match the observed eye width because it is a statistical measure. The measurement requires a sufficient record length so that all deterministic effects can be observed and the random jitter can be modeled. $\text{Width}(\text{BER}) = \text{UI}(\text{mean}) - \text{TJ}(\text{BER})$
Mask Hits	The number of unit intervals for which mask violations occurred. A mask violation occurs when, during a unit interval, the waveform passes through a segment of the defined mask. Mask hits are separately tallied for Segment 1 (upper), Segment 2 (center-of-eye mask) and Segment 3 (lower), and the total for all three segments is also reported. Thus, as many as three hits can be added to the total count for each unit interval. The population for this measurement gives the total number of unit intervals observed.

## Table of Measurements-Amplitude

Definitions of the amplitude-related measurements are given in the following table:

**Table 11: Amplitude measurements definitions**

Measurement	Description
High	Vertical value in the central portion of the unit interval (UI) for high data bits. The percent of the UI over which the waveform is evaluated is adjustable, as is the method by which a single value is derived from this span. The measurement may optionally be limited to transition or non-transition bits only.
Low	Vertical value in the central portion of the unit interval (UI) for low data bits, with configuration options matching those of the High measurement.
High-Low	Difference between the mean value of the High measurement and the mean value of the Low measurement.
Common Mode	Common-mode voltage for the two sources. $Mean\left(\frac{Source1 + Source2}{2}\right)$
T/nT-Ratio	Ratio of the transition eye-voltage to the nearest subsequent non-transition eye voltage, expressed in decibels.
V-Diff -Xovr	Voltage level at the crossover voltage of a differential signal pair.

## Table of Measurements-More

Measurements in the More category may include timing, jitter, amplitude or eye measurements. Generally, they are measurements that have been modified to support a specific standard or otherwise deviate from the generic measurements. Their definitions are given in the following table:

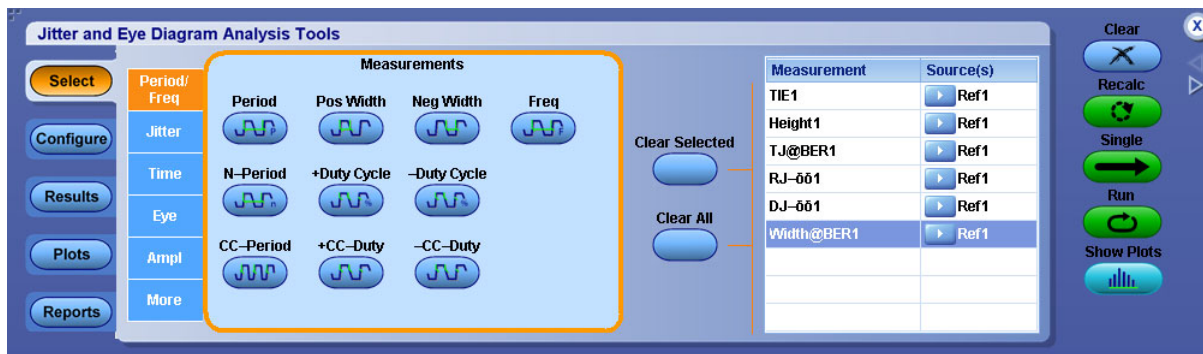
**Table 12: More measurements definitions**

Measurement	Description
DDR Setup-SE	Elapsed time between the designated edge of a data waveform and that of a single-ended DQS waveform, based on their respective DDR-specific reference level crossings.
DDR Setup-Diff	Elapsed time between the designated edge of a data waveform and that of a differential DQS waveform, based on their respective DDR-specific reference level crossings.
DDR Hold-SE	Elapsed time between the designated edge of a single-ended DQS waveform and that of a data waveform, based on their respective DDR-specific reference level crossings.
DDR Hold-Diff	Elapsed time between the designated edge of a differential DQS waveform and that of a data waveform, based on their respective DDR-specific reference level crossings.

## One Touch Jitter

One Touch Jitter is a process for automatically performing complex jitter analysis with a single menu selection. The process selects a waveform source, sets the horizontal and vertical scales, chooses measurements, generates statistical results and creates plot summary (Histogram, Spectrum, Bathtub and Eye Diagram). To run this process, select **Analyze > Jitter and Eye Analysis > Wizard > One Touch Jitter**.

By default, the DPOJET application chooses an appropriate source for the jitter measurements from the available active source(s) (amplitude >50 mV) before generating the jitter summary.



---

**NOTE.** *If the source amplitude is not greater than 50 mV, the application displays a message “Signal amplitude is extremely low for the selected source”.*

---

The following logic is used if none or many sources are active:

- [None of the sources are active](#)
- [Only one source is active](#)
- [Two sources are active](#)
- [Three sources are active](#)
- [Four or more sources are active](#)

### Case 1: None of the sources are active

If none of the sources are active, you are prompted to select any one of the Ch, Ref or Math sources. The selected source is validated to have amplitude  $>50$  mV. When the amplitude of the selected source is  $>50$  mV, then autoselect is performed to increase vertical and horizontal resolution of the signal. The selected source is assigned for all single source jitter measurements. The results and plots are generated for a single sequence.

### Case 2: Only one source is active

The application checks if the active source has amplitude  $>50$  mV. The selected source is assigned for all single jitter measurements. The results and plots are generated for a single sequence.

### Case 3: Two sources are active

The application checks whether the active sources are a differential pair. Creates a Math waveform taking the difference of the other two (Example: Math1=Ref1–Ref2). The lowest numbered Math waveform is considered as the source for all single jitter measurements. The results and plots are generated for a single sequence.

If the active sources are not a differential pair, the application checks if one of the source is a clock with a period that divides the other sources. An explicit clock recovery method derives the clock from the clock source. The application creates explicit-clock measurements TIE, Height, TJ@BER, RJ– $\delta\delta$ , DJ– $\delta\delta$  and Width@BER for the source. The results and plots are generated for a single sequence.

If one of the active sources is not a clock, the application selects a single source from the active sources using the following priority:

- 1<sup>st</sup>- Lowest numbered Math
- 2<sup>nd</sup>- Lowest numbered Channel
- 3<sup>rd</sup>- Lowest numbered Ref

The results and plots are generated for a single sequence.



### Case 4 : Three sources are active

The application checks whether one of the active sources is a Math, which is defined as difference of two sources (Example:  $\text{Math1}=\text{Ref1}-\text{Ref2}$  ). The application selects the Math waveform as the source for all single source jitter measurements. The results and plots are generated for a single sequence.

If one of the active sources is not a Math, the application selects a single source from the active sources using the following priority:

- 1<sup>st</sup>-Lowest numbered Math
- 2<sup>nd</sup>-Lowest numbered Channel
- 3<sup>rd</sup>-Lowest numbered Ref

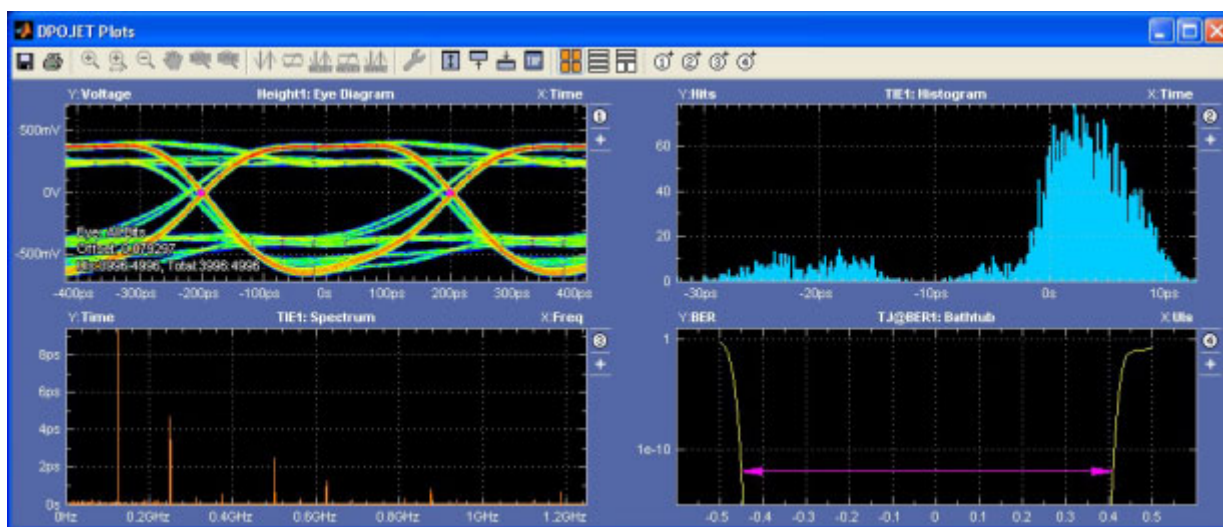
The application creates single source jitter measurements. The results and plots are generated for a single sequence.

### Case 5: Four or more sources are active

If four or more sources are active, the application selects a single source from the active sources using the following priority:

- 1<sup>st</sup>-Lowest numbered Math
- 2<sup>nd</sup>-Lowest numbered Channel
- 3<sup>rd</sup>-Lowest numbered Ref

The application creates single source jitter measurements for the selected source. The results and plots are generated for a single sequence. The following figure shows the summary plot after One Touch Jitter is performed.



## About Serial Data/Jitter Guide

The Serial Data/Jitter Guide allows you to set up, configure and run a measurement without intimate knowledge about the control menus.

Select **Analyze > Jitter and Eye Analysis > Wizard > Serial Data/Jitter Guide** to launch the Serial Data/ Jitter Guide.

The Serial Data/ Jitter Wizard includes the following steps:

- Select Measurement
- Configure Measurement
- Select Source(s)
- Configure Autoset Options
- Select Plots

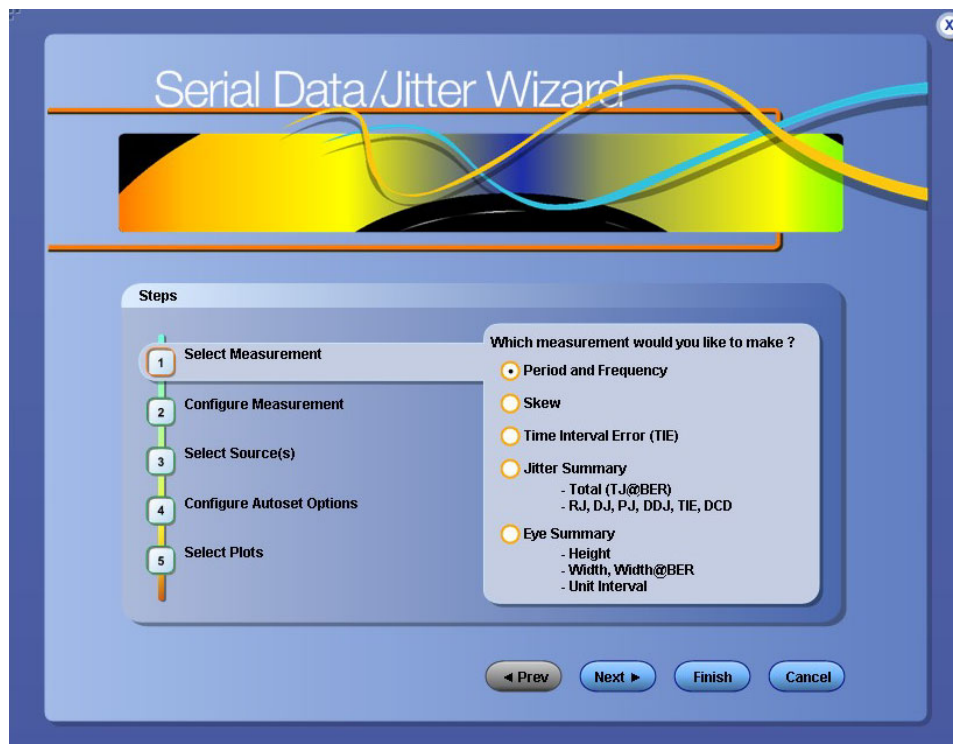
---

**NOTE.** *You can exit the Serial Data/Jitter Wizard without affecting any settings in the DPOJET application by clicking **Cancel** anytime before clicking the **Finish** button.*

---


## Select Measurement

In this step, you can select any of the listed measurements:



- Period and Frequency
- Skew
- Time Interval Error (TIE)
- Jitter Summary includes Total Jitter (TJ@BER), RJ, DJ, PJ, DDJ, TIE, and DCD measurements and plots
- Eye Summary includes Height, Width, Width@BER, and Unit Interval measurements and plots

By default, the Period and Frequency measurement is selected. Click **Next** to accept the measurement

and proceed to Configure Measurement. The transition to next step is represented by  on the left along with selections or default values.

## About Configuring Measurement

By default, the configuration parameters are displayed for Period and Frequency, TIE and Eye measurements. The Configure Measurement option is available only for Skew and Jitter Summary. The selection in the previous step is displayed on the left.

- Configure Skew Measurement
- Configure Jitter Summary Measurement

## Configure Measurement-Skew

If you select Skew in the previous step, you can configure edges by selecting the **From** and **To** edges and set the measurement limits.

Click **Next** to select the measurement sources.



### Related Topics

- Configure Edges for Skew Measurement

## Configure Measurement-Jitter Summary

If you select Jitter Summary measurement in the previous step, you can set the pattern length by selecting Repeating pattern and then entering the pattern length in the text box. If you have a non-repeating waveform pattern or if the pattern length is unknown, select **Arbitrary**.

---

**NOTE.** *The measurements that you select also determine the plot types.*

---

Click **Next** to select the measurement sources.



### Related Topics

- RJ/DJ Analysis Parameters
- RJ/DJ

## Select Sources

In this step, you can select the measurement source(s). The source selection depends on the measurement type. By default, Source1 is displayed automatically for all the measurements depending on the waveform last used. If Ch1/Ref1/Math1 is displayed for Source1, Source2 is Ch2/Ref2/Math2 else Ch1/Math1/Ref1 will be selected as Source2.



The Source2 option is displayed only for two source measurements such as Skew.



Click **Next** to configure autoset.

## Configure Autoset Options

In this step, you can choose to automatically adjust the oscilloscope settings or the reference levels before the measurement. The default of Yes is recommended. By selecting No, you will retain the current oscilloscope settings and/or ref levels.

Click **Next** to select plots.



## Select Plots

In this step, you can select the plots that you want to display. The measurements that you selected earlier also determine which plot types will be available in this step. The following table lists the available plots for measurements:

**Table 13: Measurements and available plots**

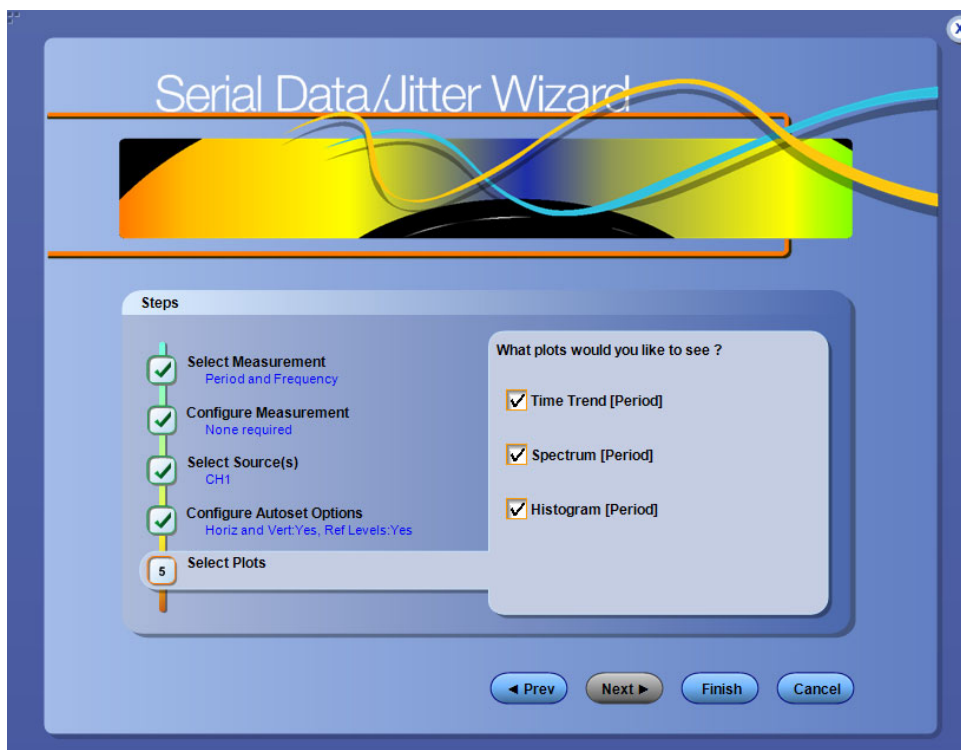
Measurement	Plots
Period and Frequency	Period Trend, Period Spectrum, Period Histogram.
Skew	Skew Trend, Skew Spectrum.
TIE	TIE Trend, TIE Spectrum, TIE Histogram.



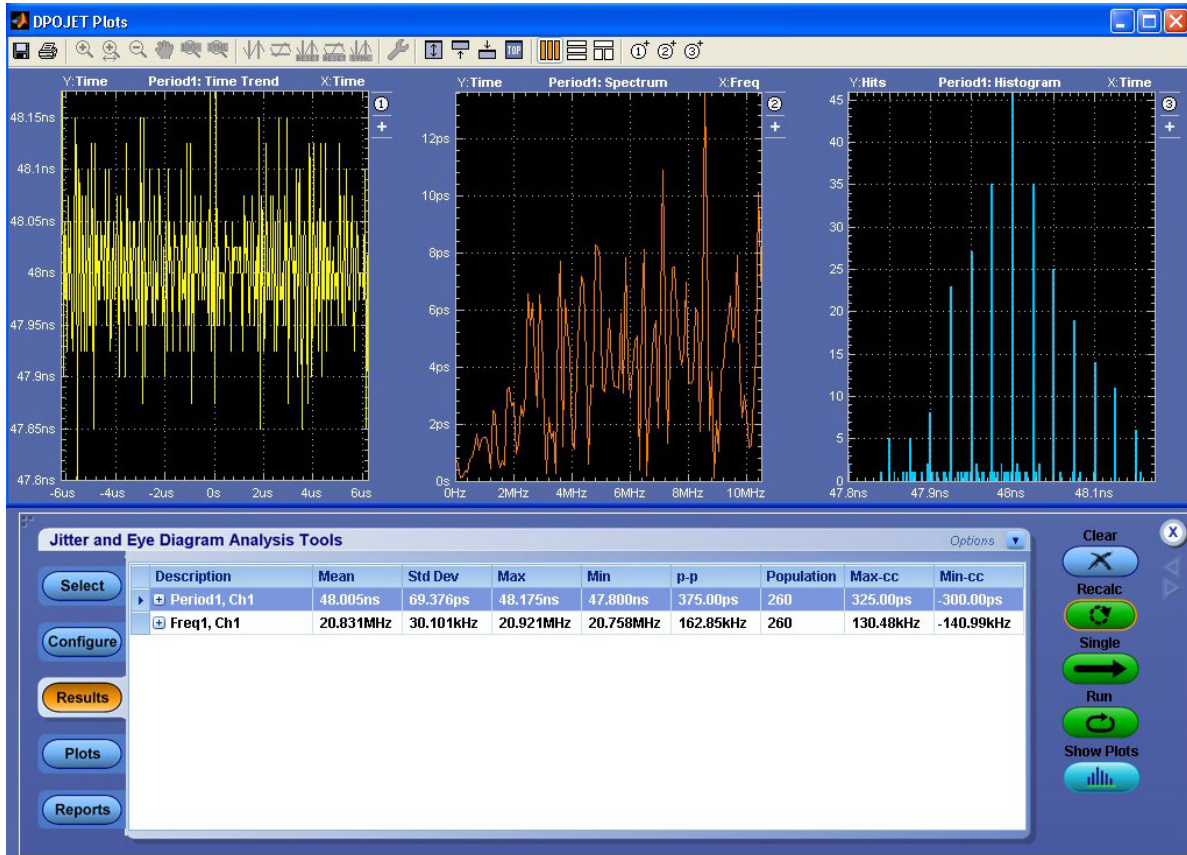
**Table 13: Measurements and available plots (cont.)**

Measurement	Plots
Jitter Summary	TIE Trend, TIE Spectrum, TIE Histogram, and Bathtub Curve.
Eye Summary	Eye Diagram (Transition Bit), Eye Diagram (Non Transition Bit) Unit Interval Histogram, and Eye Width@BER.

In this example, the selections shown are for a Period and Frequency measurement.



Click **Finish** to start the acquisition sequence using the selected settings. The Serial Data/Jitter Guide window closes and the results screen is displayed.



**NOTE.** None of the user specified settings are retained if you click **Cancel** before clicking **Finish**.

## About Jitter And Eye Diagram Analysis Options

Click **Analyze > Jitter And Eye Analysis** to view the following options:

- Export Data Snapshot
- Export Measurement Summary
- Data Logging
- Preferences
- Limits
- Measurement Summary

- Deskew

## Deskew

To ensure accurate results for two-channel measurements and differential signals acquired on two channels, it is important to first deskew the probes and oscilloscope channels before you take measurements of your [DUT](#).

The application includes an automated deskew utility that you can use to deskew any pair of oscilloscope channels.

---

**NOTE.** *To produce the best deskew results, you should connect the probes to the fastest slew rate signals from your DUT.*

---

### Connecting to a Device Under Test (DUT)

You can use any compatible probes or cable interface to connect between your DUT and oscilloscope.



---

**WARNING.** *To avoid electric shock, remove power from the DUT before attaching probes. Do not touch exposed conductors except with the properly rated probe tips. Refer to the probe manual for proper use. Failure to do so may cause injury or death.*

---

Refer to the General Safety Summary in your oscilloscope manual.

### Deskewing on Oscilloscopes with Bandwidth Extension

Some Tektronix oscilloscopes feature software-based bandwidth extension. The bandwidth extension may be enabled on a per-channel basis.

Enabling or disabling bandwidth extension on any channel affects the skew on that channel. Thus, you should deskew probes and channels after you make such configuration changes. Bandwidth Extension provides improved timing accuracy, phase matching, and amplitude accuracy. It also will provide noise reduction. We recommend Bandwidth Extension be used at all times.

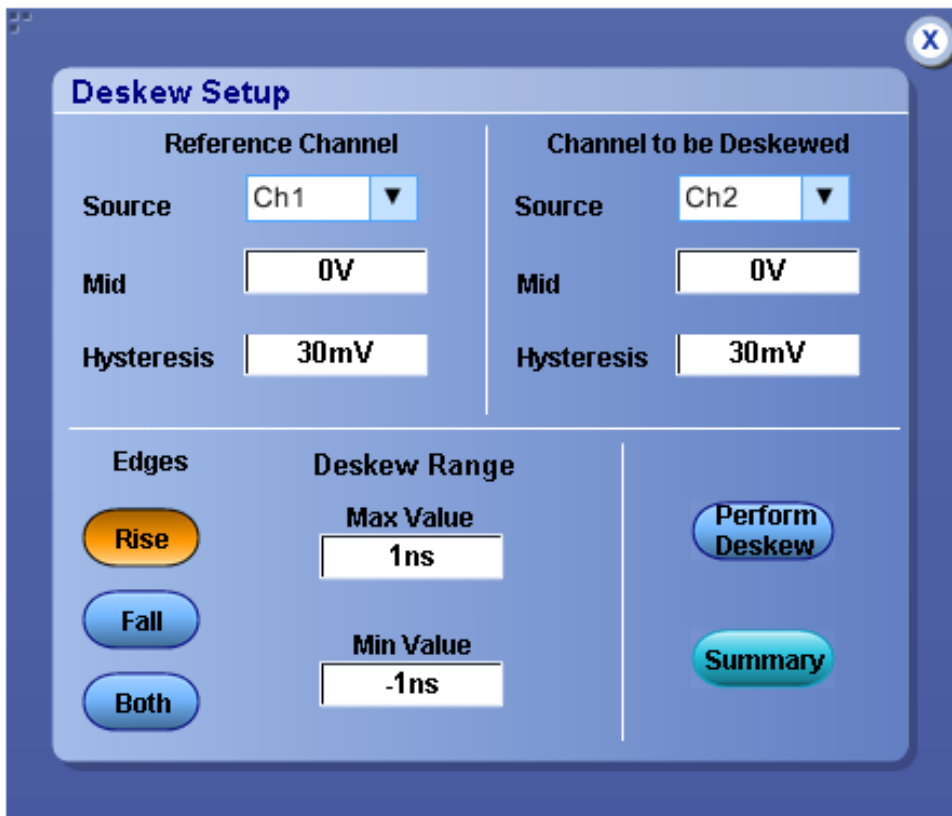
### Steps to Deskew Probes and Channels

To deskew probes and oscilloscope channels, follow these steps:

1. Refer to Connecting to a Device Under Test before starting the procedure.
2. Connect both probes to the fastest signal in your DUT.

Set up the oscilloscope as follows:

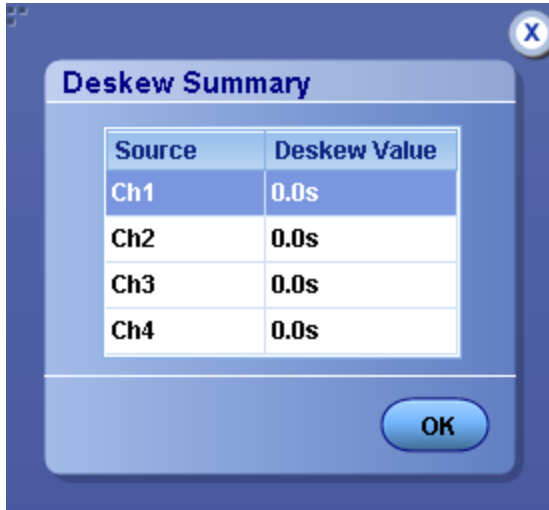
1. Use the Horizontal Scale knob to set the oscilloscope to an acquisition rate so that there is a minimum of two, preferably five, samples per edge or more samples on the deskew edge.
2. Use the Vertical Scale and Position knobs to adjust the signals to fill the display without missing any part of the signals.
3. Set the Record Length so that there are more than 100 edges in the acquisition.
4. Launch the DPOJET application.
5. Click **Analyze > Jitter And Eye Analysis > Deskew**.



6. Set the Reference channel source to Ch1. The source waveform is the reference point used to deskew the remaining channels.
7. Set the Channel to be Deskewed source as Ch2.
8. To start the process, click **Perform Deskew**.
9. Repeat steps 7 and 8 for other Ch waveforms.
10. Select [Summary](#) to view the deskew values.

## Deskew Summary

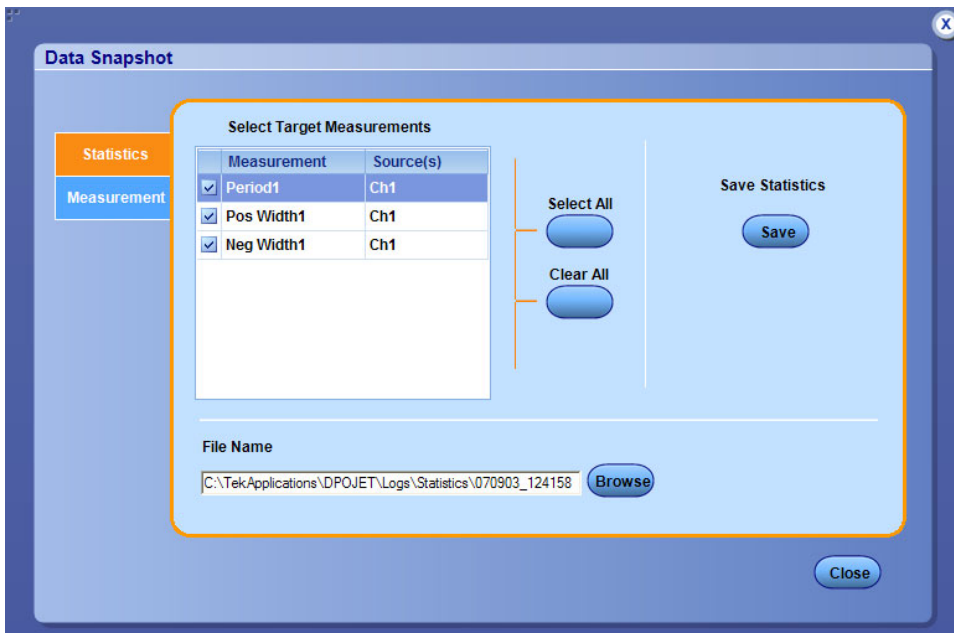
The Deskew Summary dialog lists the channel source and its deskew values.



## Export Data Snapshot-Statistics

You can save a snapshot of the current statistics in .csv format. The default location is C:\TekApplications\DPOJET\Logs\Statistics.

Click **Analyze > Jitter and Eye Analysis > Export > Data Snapshot > Statistics** to view the following:



**Table 14: Data Snapshot- Statistics options**

Item	Description
Select Target Measurements	Displays the measurement list. Click a row to select the measurement. By default, all measurements are selected.
Select All	Selects all the measurements in the list for saving statistics.
Clear All	Deselects all the measurements from the list.
<b>Save Statistics</b>	
Save	Saves the current statistics of selected target measurements to a log file.
<b>File Name</b>	
Browse	Saves the .csv file in the specified directory. The file format is YYMMDD_HHMMSS_Stats.csv. The default directory is C:\TekApplications\DPOJET\Logs.
Close	Accepts the changes and closes the window.

---

**NOTE.** The default location for saving log files can be changed in the Preferences dialog box.

---

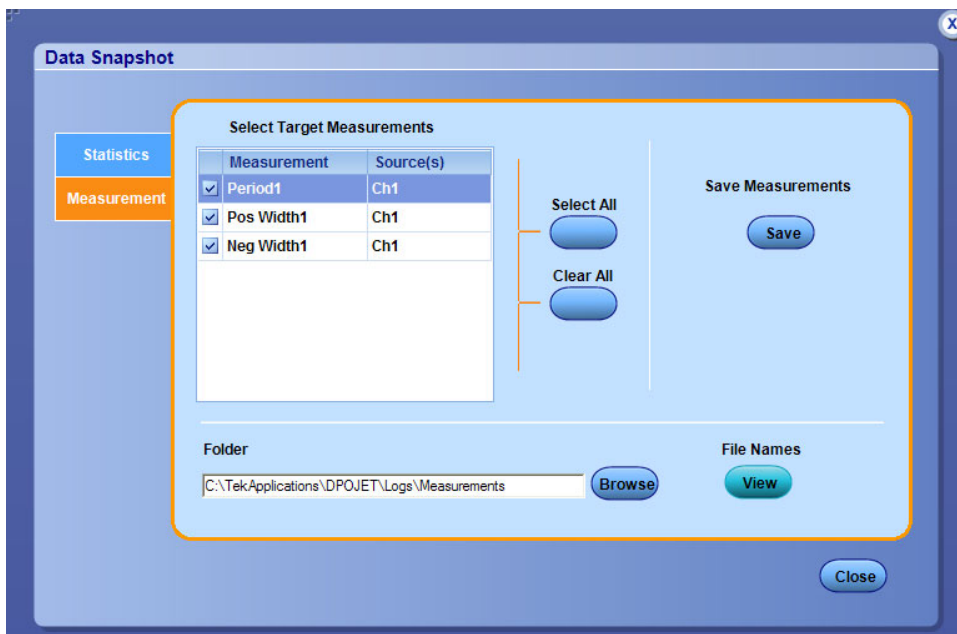
## Related Topics

- Export Data Snapshot-Measurement

# Export Data Snapshot-Measurement

You can save a snapshot of the data points in .csv format. The default location is C:\TekApplications\DPOJET\Logs\Measurements.

Click **Analyze > Jitter and Eye Analysis > Export > Data Snapshot > Measurement** to view the following:



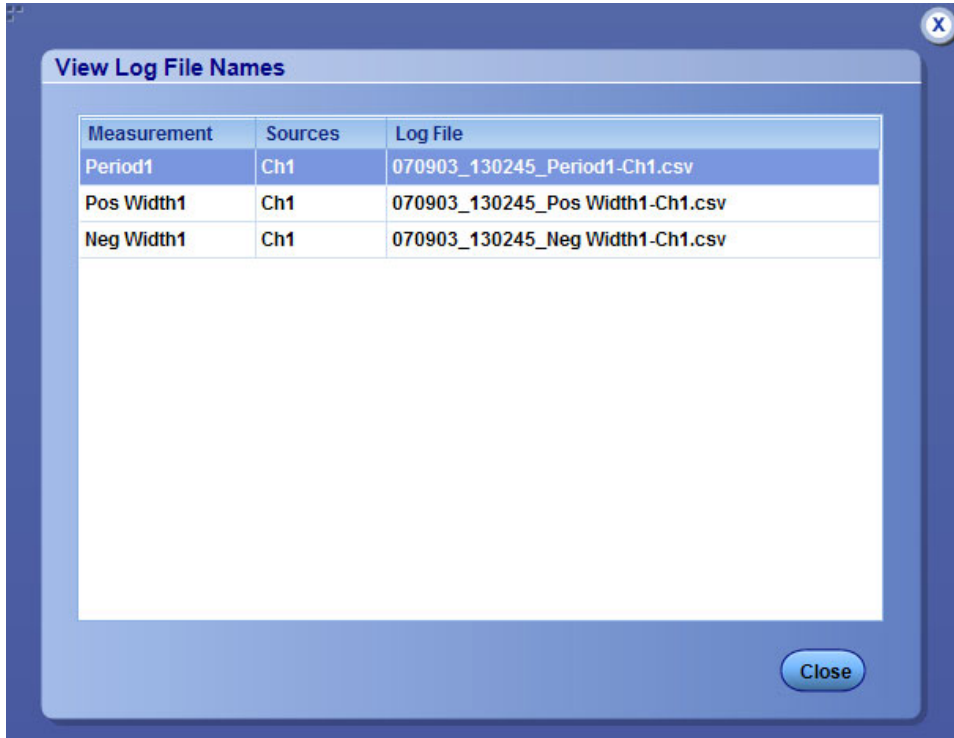
**Table 15: Data Snapshot- Measurement options**

Item	Description
Select Target Measurements	Displays the measurement list. Click a row to select the measurement. By default, all measurements are selected.
Select All	Selects all the measurements in the list for saving statistics.
Clear All	Deselects all the measurements from the list.
<b>Save Measurements</b>	
Save	Saves the data points for current acquisition of selected target measurements in a log file.
<b>Folder</b>	
Browse	Saves the .csv file in the specified directory. The default directory is C:\TekApplications\DPO-JET\Logs\Measurements.
<b>File Names</b>	
View	Displays <a href="#">View Log File Names</a> dialog box which lists the measurements and their source(s) with corresponding log file name in YMMDD_HHMMSS_<Measurement Name>-<SourceName>.csv format.
Close	Accepts the changes and closes the window.

### View Log File Names

The View Log File Names dialog box lists the measurements and their source(s) with corresponding log file name in YMMDD\_HHMMSS\_<Measurement Name>-<SourceName>.csv format. Click **Close** to close the dialog box.



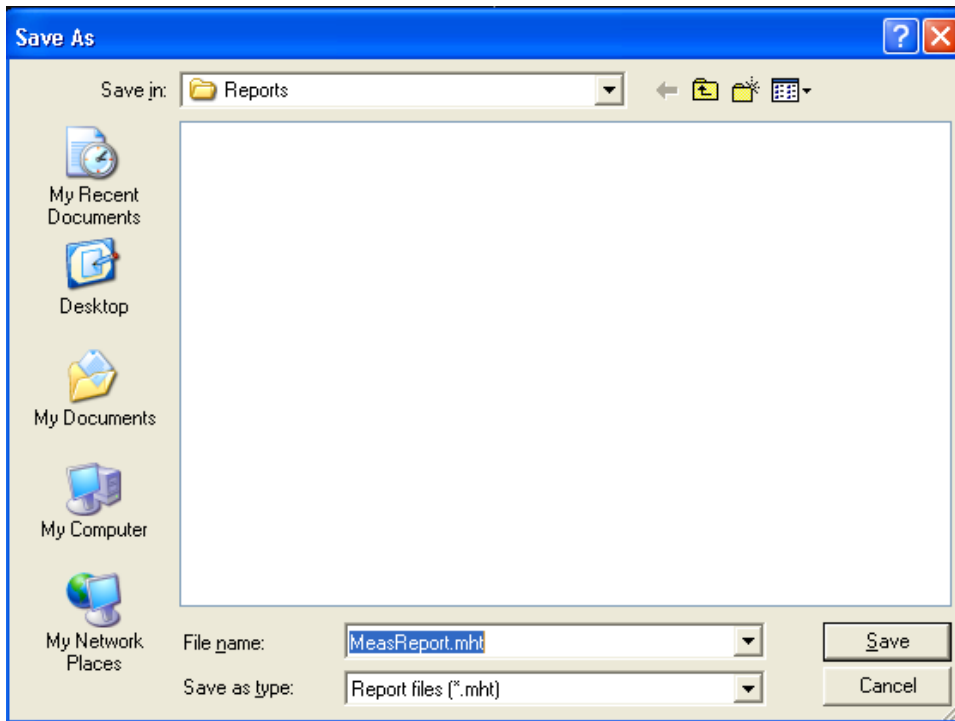


**Related Topics**

- Export Data Snapshot

## Export Measurement Summary

Click **Analyze > Jitter and Eye Analysis > Export > Measurement Summary** to save the generated report in `C:\TekApplications\DPOJET\Reports`. The exported measurement summary contains information only about application setup and configuration.



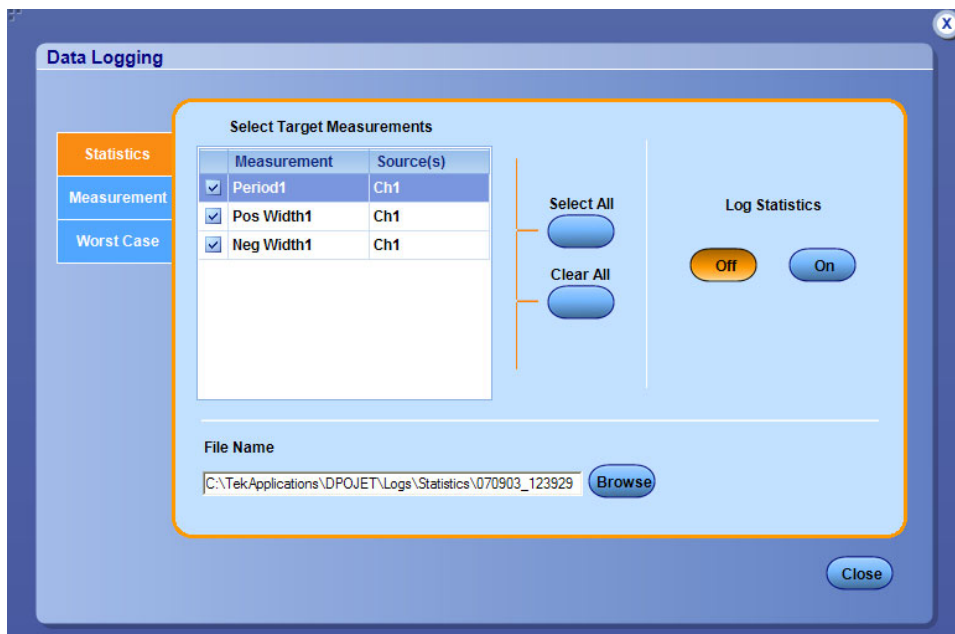
## Data Logging-Statistics

The application can continuously log (save to file) the calculated statistics. You can save the statistics to a “comma separated value” (.csv) file to import into a text editor, a spreadsheet, or an analysis tool.

By default, all measurements are selected. You can select individual measurements by selecting the row in the table on the left.

The steps for logging statistics are:

1. Click **Analyze > Jitter and Eye Analysis > Data Logging > Statistics** to view the Logging Statistics screen.



2. Select the measurements which you want to log in the **Select Target Measurements** table on the left. Click **Select All** to select all the measurements for logging or click **Clear All** to deselect the current measurements list.
3. Click **On/Off** to enable/disable automatic logging statistics for all selected measurements.
4. Click **Browse** to select a directory.

The default directory is C:\TekApplications\DPOJET\Logs\Statistics.

**Table 16: Log-Statistics options**

Item	Description
Select Target Measurements	Displays the measurement list. Select the check box to select the measurement. By default, all measurements are selected.
Select All	Selects all the measurements in the list.
Clear All	Deselects all the measurements in the list.
<b>Log Statistics</b>	
Off	Disables automatic logging for all selected measurements.
On	Enables automatic logging for all selected measurements.
<b>File Name</b>	
Browse	Saves the .csv file in the specified directory. The file format is YYMMDD_HHMMSS_Stats.csv. The default directory is C:\TekApplications\DPOJET\Logs\Statistics.

**NOTE.** Microsoft Excel has a limitation where you cannot increase the number of rows (65,536) or columns (256) beyond the maximum row and column limits. Opening log files in **Wordpad** or another analysis package is recommended. An error message “File not loaded completely” is displayed, if you try to open a log file with data exceeding the aforesaid row and column limits.

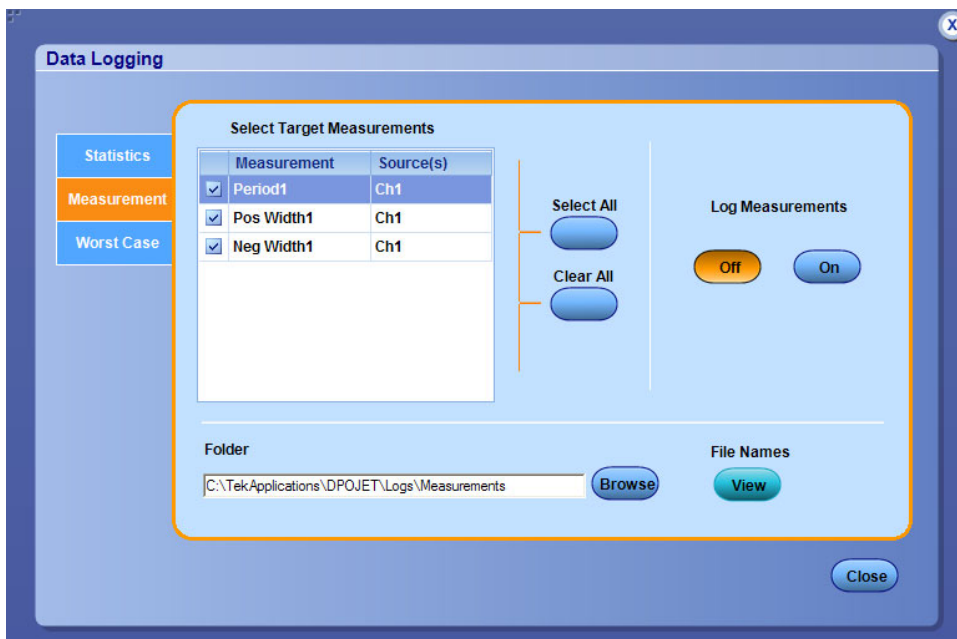
## Related Topics

- Data Logging-Measurement
- Data Logging-Worst Case

## Data Logging-Measurement

You can log the actual individual measurement data values as measurement files.

1. Click **Analyze > Jitter and Eye Analysis > Data Logging > Measurement** to view the Logging screen.



2. Select the measurements that you want to log in the **Select Target Measurements** table on the left. Click **Select All** to select all the measurements for logging or click **Clear All** to deselect the current measurements list.
3. Click **On/Off** to enable/disable logging for all selected measurements.
4. Click **Browse** to select a directory.

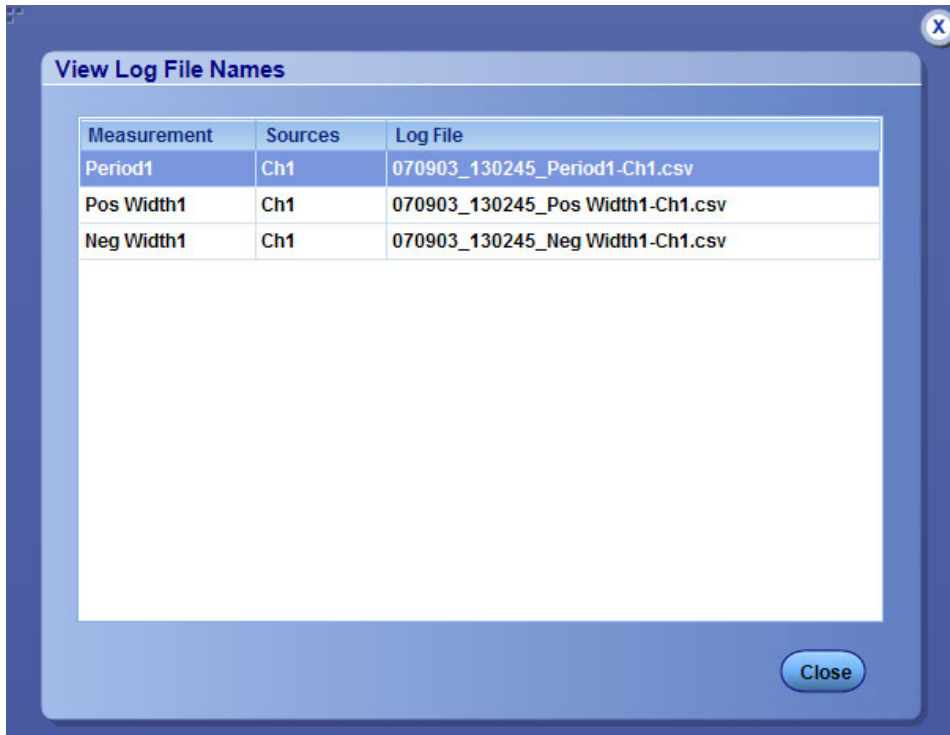
The default directory is C:\TekApplications\DPOJET\Logs\Measurements.

**Table 17: Log-Measurements options**

<b>Item</b>	<b>Description</b>
Select Target Measurements	Displays the measurement list. Select the check box to select the measurement. By default, all measurements are selected.
Select All	Selects all the measurements in the list.
Clear All	Deselects all the measurements from the list.
<b>Log Measurements</b>	
Off	Disables automatic logging for all selected measurements.
On	Enables automatic logging for all selected measurements.
<b>Folder</b>	
Browse	Saves the .csv file in the specified directory. The default directory is C:\TekApplications\DPO-JET\Logs\Measurements.
<b>File Names</b>	
View	Displays <a href="#">View Log File Names</a> dialog box which lists the selected measurements with source(s) and their corresponding log file names in YYMMDD_HHMMSS_<MeasurementName>-<SourceName>.csv format.

### View Log File Names

The View Log File Names dialog box lists the selected measurements with source(s) and their corresponding log file names in YYMMDD\_HHMMSS\_<MeasurementName>-<SourceName>.csv format. Click **Close** to close the dialog box.

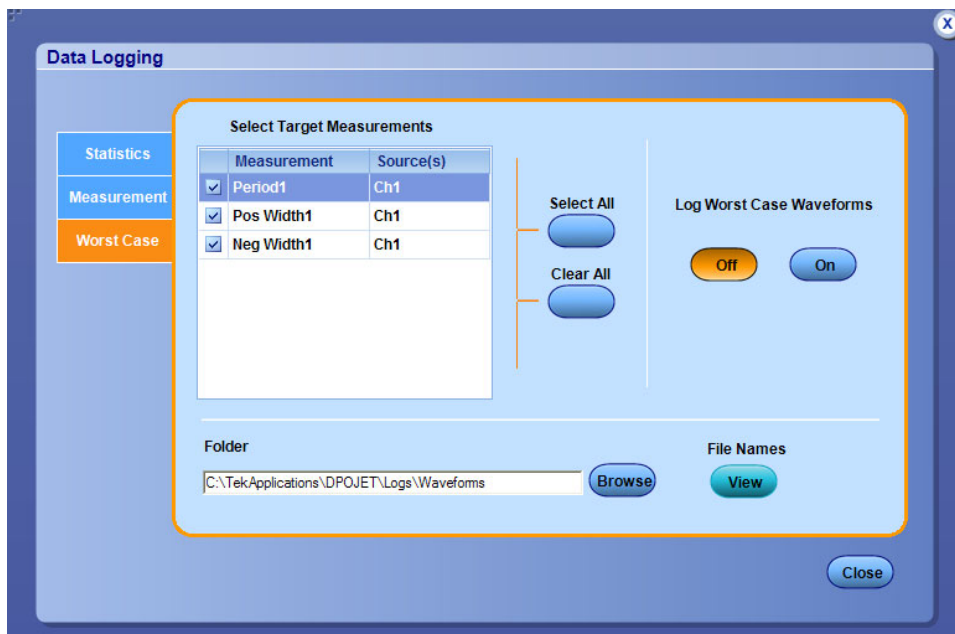


### Related Topics

- Data Logging-Statistics
- Data Logging-Worst Case

## Data Logging-Worst Case

1. Click **Analyze > Jitter and Eye Analysis > Data Logging > Worst Case** to view the Worst Case Logging screen.



2. Select the measurements which you want to log in the **Select Target Measurements** table on the left. Click **Select All** to select all the measurements for logging or click **Clear All** to deselect the current measurements list.
3. Click **On/Off** to enable/disable worst case logging for all selected measurements.
4. Click **Browse** to select a directory.

The default directory is C:\TekApplications\DPOJET\Logs\waveforms.

**Table 18: Log-Worst Case options**

Item	Description
Select Target Measurements	Displays the measurement list. Select the check box to select the measurement. By default, all measurements are selected.
Select All	Selects all the measurements in the list.
Clear All	Deselects all the measurements in the list.
<b>Log Worst Case Waveforms</b>	
Off	Disables the application to save worst case waveforms for all selected measurements.
On	Enables the application to save worst case waveforms for all selected measurements.

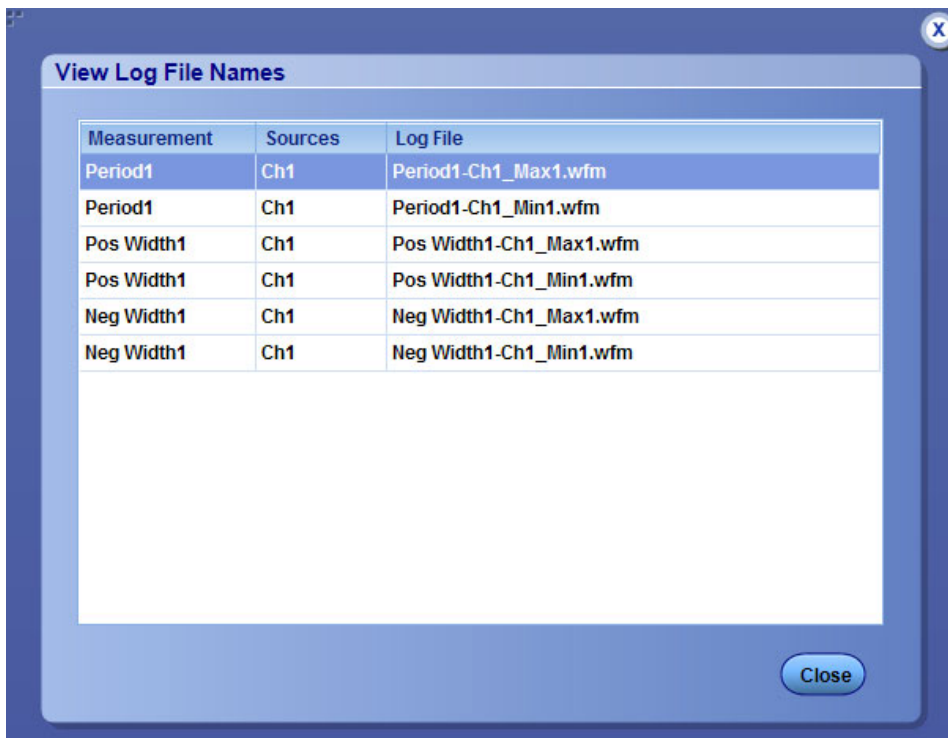
**Table 18: Log-Worst Case options (cont.)**

Item	Description
<b>Folder</b>	
Browse	Saves the .csv file in the specified directory. The default directory is C:\TekApplications\DPO-JET\Logs\waveforms.
<b>File Names</b>	
View	Displays <a href="#">View Log File Names</a> dialog box which lists the selected measurements with source(s) and their corresponding log file names in YYYYMMDD_HHMMSS_<MeasurementName>-<Source(s)>_Max<Source Number>.wfm and <MeasurementName>-<Source(s)>_Min<Source Number>.wfm † format.

† For example, if the selected measurement is Skew1 with Ref1 and Ref3 as sources, then the file names will be Skew1-Ref1,Ref3\_Max1.wfm, Skew1-Ref1,Ref3\_Min1.wfm, Skew1-Ref1,Ref3\_Max2.wfm, and Skew1-Ref1,Ref3\_Min2.wfm.

### View Log File Names

The View Log File Names dialog box lists the selected measurements with source(s) and their corresponding log file names in YYYYMMDD\_HHMMSS\_<MeasurementName>-<Source(s)>\_Max<Source Number>.wfm and <MeasurementName>-<Source(s)>\_Min<source Number>.wfm format. Click **Close** to close the dialog box.



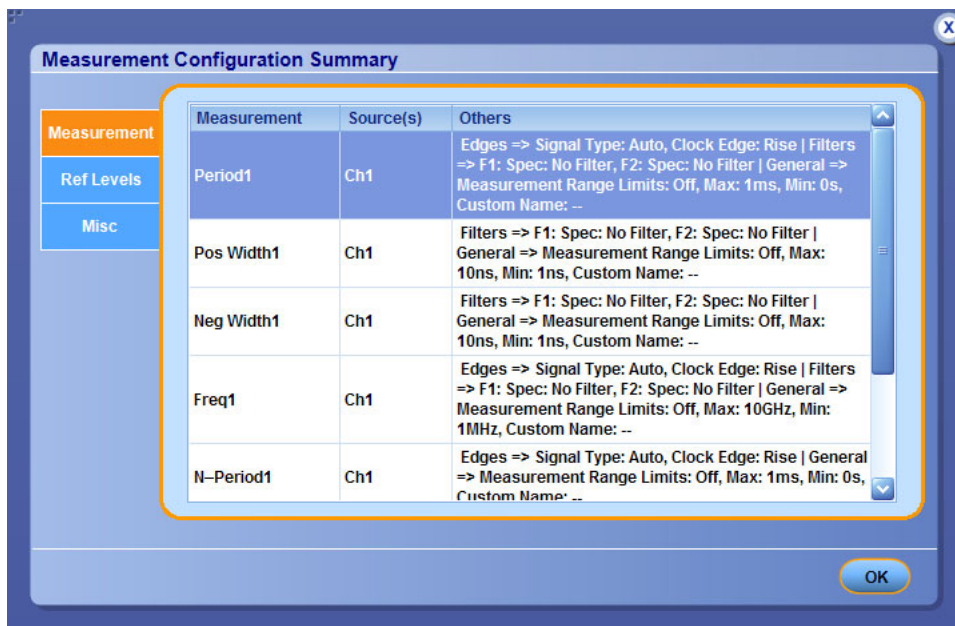


**Related Topics**

- Data Logging-Statistics
- Data Logging-Measurement

## Measurement Configuration Summary-Measurement

Click **Analyze > Jitter and Eye Analysis > Measurement Configuration Summary > Measurement** to view measurement, source and the configuration parameters of each measurement.



**Table 19: Measurement configuration information**

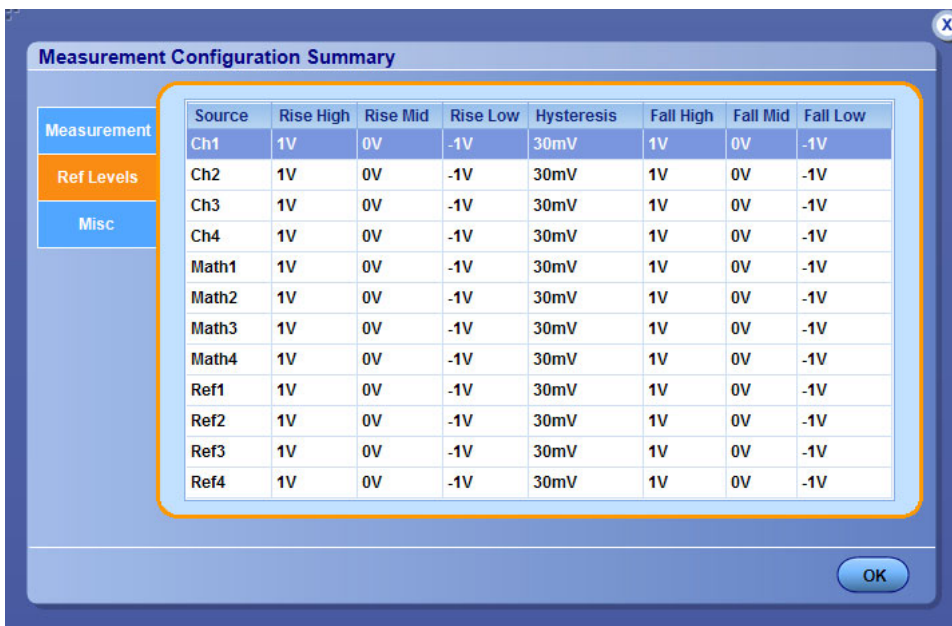
Item	Description
Measurement	Displays the measurement name.
Source	Displays the selected source.
Others	Displays the other configuration information related to the selected measurement.
OK	Closes the window.

**Related Topics**

- Measurement Summary-Ref Levels
- Measurement Summary-Misc

## Measurement Summary-Ref Levels

Click **Analyze > Jitter and Eye Analysis > Measurement Configuration Summary > Ref Levels** to view the ref level tab. This tab provides information about ref level configuration per source. Displays the reference voltage levels for the high, mid, and low thresholds for the rising edge and for the falling edge of each active source, and the hysteresis.



**Table 20: Ref Level configuration information**

Item	Description
Source	Displays the selected source.
Rise High	Displays the high threshold level for the rising edge of the source.
Rise Mid	Displays the middle threshold level for the rising edge of the source.
Rise Low	Displays the low threshold level for the rising edge of the source.

**Table 20: Ref Level configuration information (cont.)**

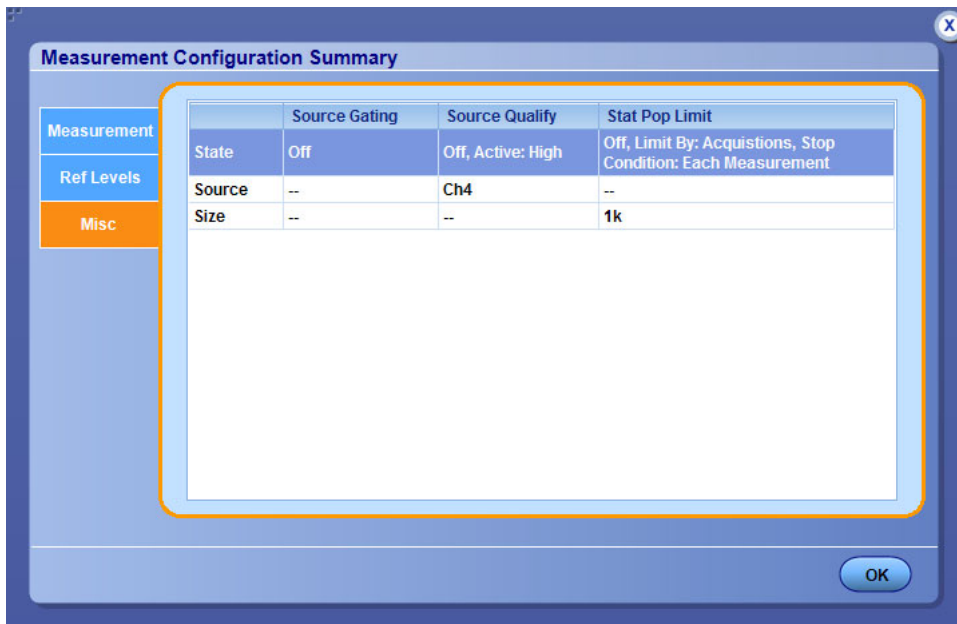
<b>Item</b>	<b>Description</b>
Hysteresis	Displays the threshold margin to the reference level which the voltage must cross to be recognized as changing; the margin is the relative reference level plus or minus half the hysteresis; use to filter out spurious events.
Fall High	Displays the high threshold level for the falling edge of the source.
Fall Mid	Displays the middle threshold level for the falling edge of the source.
Fall Low	Displays the low threshold level for the falling edge of the source.
OK	Closes the window.

**Related Topics**

- Measurement Configuration Summary-Measurement
- Measurement Summary-Misc

## Measurement Summary-Misc

Click **Analyze > Jitter and Eye Analysis > Measurement Configuration Summary > Misc** tab to view various configuration parameters. The Miscellaneous tab shows whether the Gating, Qualify, and Stat Pop Limit functions are enabled; if enabled, it also shows the source for qualification, the size for population, and various other configuration choices.



**Table 21: Miscellaneous configuration information**

Item	Description
State	Displays On when Gating, Qualify and Population are enabled and Off when they are disabled.
Source	Displays the selected source for qualify.
Size	Specifies the maximum population which can be obtained for each active measurement.
OK	Closes the window.

### Related Topics

- Measurement Configuration Summary-Measurement
- Measurement Summary-Ref Levels

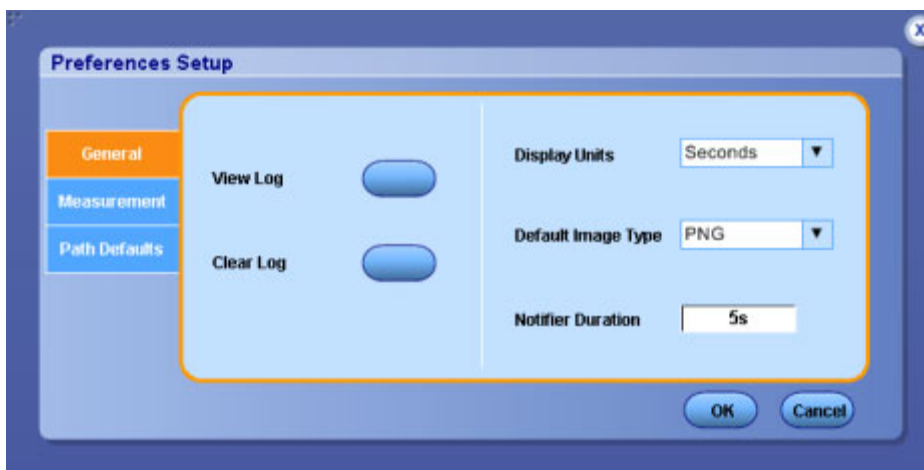
## About Preferences Setup

The application provides Preferences Setup, where you can set options. These options remain unchanged until you reset them. Click **Analyze > Jitter and Eye Analysis > Preferences** to view the Preferences screen. To use the application more efficiently, you can set the options in the following tabs:

- Preferences-General
- Preferences-Measurement
- Preferences-Path Defaults

## Preferences-General

Click **Analyze > Jitter and Eye Analysis > Preferences > General** to view the following:



**Table 22: Preferences-General options**

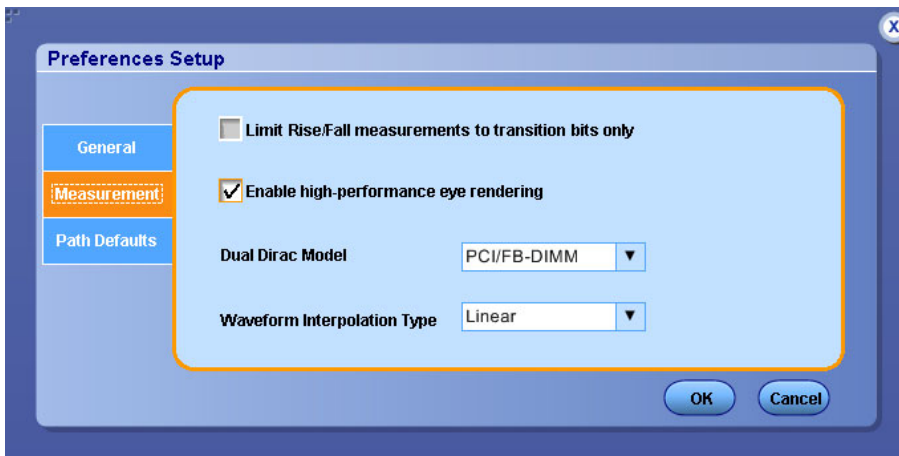
Item	Description
View Log	Displays the error/warning log file in a notepad window when the button is pushed.
Clear Log	Clears the error/warning log file when the button is pushed.
Display Units	Selects the display units for time measurements, between seconds or Unit Intervals.
Default Image Type	Selects the default image format (JPEG, PNG or BMP) that will be used by those functions that save images.
Notifier Duration	Determines how long the Warning notifier will remain on the screen before disappearing. (The notifier may also be dismissed manually).
Cancel	Discards all changes and closes the Preferences window.
OK	Accepts all changes and closes Preferences window.

**Related Topics**

- Preferences-Measurement
- Preferences-Path Defaults

## Preferences-Measurement

Click **Analyze > Jitter and Eye Analysis > Preferences > Measurement** to view the following:



The Measurement tab allows you to limit Rise and Fall measurements to transition bits only, or allow these measurements for all bits. Here, the transition bits refer to edge transitions for which the preceding transition was only one unit interval away. This may be important for signals with pre-emphasis, since the transition following a string of two or more like bits has an intentionally low swing that you may not want to measure.

You can enable or disable high-performance eye rendering from this tab. This provides a trade-off between greater fidelity or greater rendering speed. You can also select the Dual Dirac model and the waveform interpolation type.

**Table 23: Preferences-Measurement options**

Item	Description
Limit Rise/Fall measurements to transition bits only	When selected, determines whether Rise Time and Fall Time measurements are performed on all bit or only on transition bits.
Enable high-performance eye rendering	When enabled, determines whether eye diagrams are optimized for speed or fidelity. When disabled, all unit intervals (UI) in the waveform(s) are included in the rendered eye. This gives the highest fidelity eye rendering, but can take considerable amount of time for long records. When this option is checked, a statistically representative subset of the UI is rendered, so that eye diagrams for long waveforms can be displayed in a shorter time. The rules for high-performance rendering are as follows: 1) If the waveform contains 15,000 or fewer UI, all the UIs in the waveform are rendered. 2) If the waveform includes more than 15,000 UI, it is subdivided into segments of 2000 UI each. The entire waveform is scanned to find the specific UI, that are the worst-case violators for six different points around the eye. For each of these worst case violators, the entire segment of 2000 UI in which it lies is rendered. Depending on whether multiple worst-case violators lie in the same segment or not, as few as 2000 UI but typically from 8000 to 12,000 UI will be rendered in the final eye.
Dual Dirac Model	When selected, determines which parameter-extraction method is used when RJ/DJ separation is done under the Dual-Dirac model. This affects results for the RJ- $\delta\delta$ and DJ- $\delta\delta$ measurements only. When Fibre Channel is selected, RJ and DJ parameters are extracted according to guidelines given in ANSI/INCITS Technical Report TR-35-2004 "Methodologies for Jitter and Signal Quality Specification". RJ and DJ values are selected that cause an exact match between the bathtub curves from the dual-dirac and the full analytical models at two prescribed BER levels. When PCI/FB-DIMM is selected, RJ and DJ parameters are determined using the methodology defined in the PCI-Express Gen 2 and Fully-Buffered DIMM specifications. In this technique, the bathtub curves are plotted on a Q-scale that linearizes the tails of the bathtub, and the RJ and DJ values are derived from where the asymptotes to the curves intersect the BER=0 line.

**Table 23: Preferences-Measurement options (cont.)**

<b>Item</b>	<b>Description</b>
Waveform Interpolation Type	Select the type of interpolation that is used between sample points, to determine the exact time when a waveform crosses a reference voltage level. Linear interpolation is faster but introduces distortion that raises the jitter noise floor slightly. Sin(x)/x Interpolation, also known as Sinc Interpolation, approaches theoretically perfect waveform reconstruction but is computationally expensive.
Cancel	Discards the changes and closes the window.
OK	Accepts the changes and closes the window.

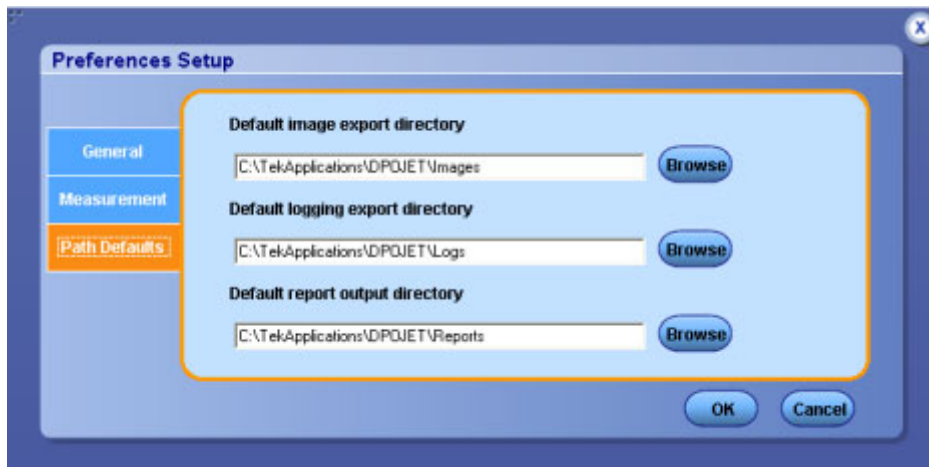
**Related Topics**

- Preferences-General
- Preferences-Path Defaults



## Preferences-Path Defaults

Click **Analyze > Jitter and Eye Analysis > Preferences > Path Defaults** to view the following:



The Path Defaults allows you to set the path for images, reports and log files. Click **Browse** to modify the default directory path.

**Table 24: Preferences-Path Defaults options**

Item	Description
Default image export directory	Selects the directory to which images will be saved, unless overridden at the time of the export.
Default logging export directory	Selects the directory to which logs will be saved, unless overridden at the time of the export.
Default report export directory	Selects the directory to which reports will be saved, unless overridden at the time of the export.
Cancel	Discards the changes and closes the window.
OK	Accepts the changes and closes the window.

### Related Topics

- Preferences-General
- Preferences-Measurement

## Limits

Limits file allows you to determine Pass or Fail status for tests. Each serial data application provides limits file that includes combinations of all measurements and statistical characteristics, and an appropriate range of values for each combination.

The application does not provide any limits file. You can create one by specifying limits for any of the result parameters such as Mean, Std Dev, Max, Min, peak-to-peak, population, MaxPosDelta and MinPosDelta. For each of these result parameters, you can specify Upper Limit (UL), Lower Limit (LL), or Both. The measurement names in the limits file must be entered as mentioned in

[Setting Up the Application for Analysis.](#)

---

**NOTE.** *The limits file supports only absolute values.*

---

To include Pass/Fail status in the result statistics, you can create a limits file using an XML editor or any other editor in the following format. If the file is created in any other editor such as notepad, it should be saved in Unicode format.

```
<?xml version="1.0" encoding="utf-16" ?>
<Main>
<Measurement>
<NAME>Period</NAME>
<STATS>
<STATS_NAME>Mean</STATS_NAME>
<LIMIT>UL</LIMIT>
<UL>1</UL>
<LL>0</LL>
</STATS>
<STATS>
<STATS_NAME>StdDev</STATS_NAME>
<LIMIT>LL</LIMIT>
<UL>1121</UL>
<LL>0121</LL>
</STATS>
<STATS>
<STATS_NAME>Max</STATS_NAME>
```

```
<LIMIT>BOTH</LIMIT>
<UL>1</UL>
<LL>0</LL>
</STATS>
<STATS>
<STATS_NAME>Min</STATS_NAME>
<LIMIT>UL</LIMIT>
<UL>0</UL>
<LL>1</LL>
</STATS>
<STATS>
<STATS_NAME>PeakToPeak</STATS_NAME>
<LIMIT>UL</LIMIT>
<UL>1</UL>
<LL>1</LL>
</STATS>
<STATS>
<STATS_NAME>MaxPosDelta</STATS_NAME>
<LIMIT>UL</LIMIT>
<UL>1121</UL>
<LL>1121</LL>
</STATS>
<STATS>
<STATS_NAME>MinNegDelta</STATS_NAME>
<LIMIT>UL</LIMIT>
<UL>0</UL>
<LL>0</LL>
</STATS>
<STATS>
<STATS_NAME>Population</STATS_NAME>
<LIMIT>UL</LIMIT>
```

```
<UL>0</UL>
<LL>0</LL>
</STATS>
</Measurement>
</Main>
```

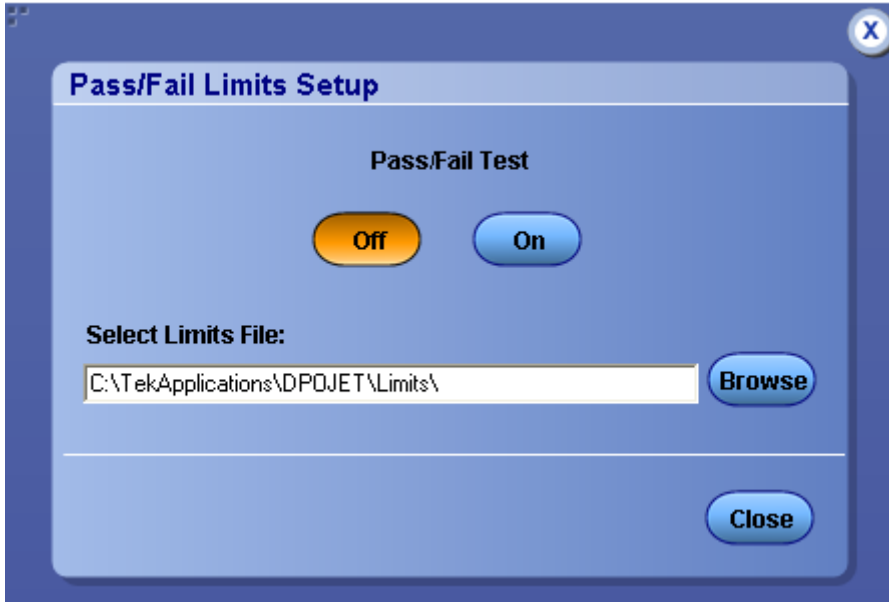


Table 25: Limits options

Item	Description
<b>Pass/Fail Test</b>	
Off/On	Enables (On) or Disables (Off) the display of limit information in results. Select On to choose a limits file for the selected measurement.
<b>Select Limits File</b>	
Browse	To select an existing limits file or locate the directory.
Close	Accepts the changes and closes the window.

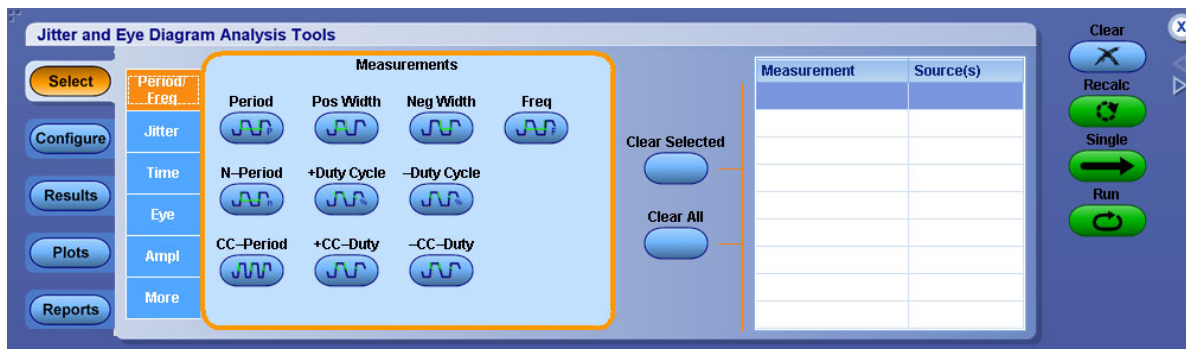
## About Taking a New Measurement

If you want to change the trigger settings or localize the measurements, you should do so before you take any measurements.

**NOTE.** When you run any measurement, Sampling mode in the oscilloscope should be set to “Real Time”. You need to do this setting in the oscilloscope to take DPOJET measurements.

## Selecting a Measurement

To take a measurement, click **Analyze > Jitter And Eye Analysis > Select**.



The application provides you different methods to set up the application:

- [Wizard](#)
- [Measurement Setup sequence](#)

The measurement categories are Period/Freq, Jitter, Time, Eye, Amplitude, and More as shown in the following table:

**Table 26: Measurement selections**

Category	Measurements			
Period/Freq	Period	Pos Width	Neg Width	Freq
	N-Period	+Duty Cycle	-Duty Cycle	
	CC-Period	+CC-Duty	-CC-Duty	
Jitter	TIE	RJ	RJ- $\delta\delta$	Jitter Summary
	TJ@BER	DJ	DJ- $\delta\delta$	Phase Noise
	PJ	DDJ	DCD	
Time	Rise Time	Fall Time	Skew *	
	High Time	Low Time		
	Setup *	Hold *		
Eye	Width	Width@BER		
	Height			
	Mask Hits			

**Table 26: Measurement selections (cont.)**

Category	Measurements	
Ampl	High	Common Mode
	Low	T/nT-Ratio
	High-Low	V-Diff -Xovr *
More	DDR Setup-SE *	DDR Hold-Diff*
	DDR Setup-Diff*	
	DDR Hold-SE*	

\* Two Source Measurements

### Wizard

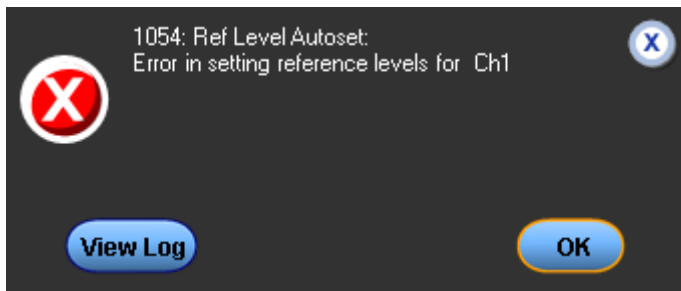
The Serial Data/ Jitter Guide allows you to set up, configure, and run the selected set of measurements without requiring any knowledge of the control menus. However, it does not provide access to many of the advanced features.

### Measurement Setup Sequence

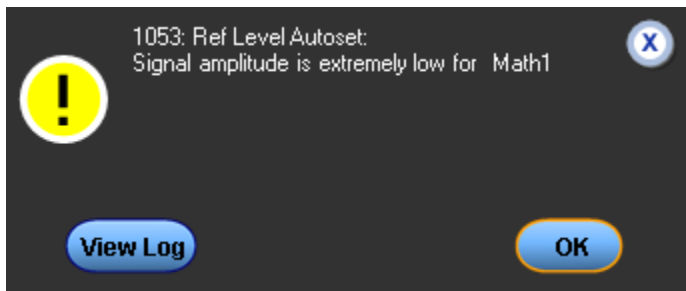
The Measurement Setup Sequence buttons in the left navigation panel shows the logical order you would follow to set up the application if you do not use the Wizard.

## Warning Log Notifiers

Warning Log Notifiers display error messages or warnings. Warnings (⚠) or Error (✖) messages are also shown in the results tab. You can click **View Log** to view the error log information in a text editor. Click **OK** to discard the displayed error message.



You can set the duration for which the warning notification should appear on the screen in the [Preferences](#) dialog box or click **OK** to discard the warning information.



---

**NOTE.** The error or warning log is saved as *DPOJETErrors.log* in *C:\TekApplications\DPOJET* subfolder.

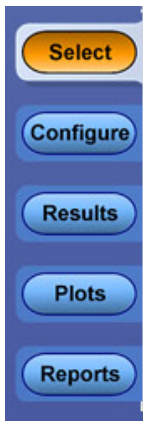
---

## Navigation Panel

The Navigation Panel appears on the left of the application window. It consists of the following tabs: Select, Configure, Results, Plots and Reports.

**Table 27: Navigation panel functions**

Tab	Description
Select	Displays the various measurements available for selection. By default, this tab is highlighted. You can click any measurement categorized with Period/Freq, Jitter, Time, Eye and Amplitude tabs.
Configure	Displays the configuration for the selected measurement.
Results	Displays the result for the selected measurement.
Plots	Displays the result as a two-dimensional plot for additional measurement analysis. You can select and configure plots for selected measurements.
Reports	Displays the configuration for generating reports in .mht format. Allows you to select results, plots and details.



## Control Panel

The Control Panel appears on the right of the application window. Using this panel, you can start or stop the sequence of processes for the application and the oscilloscope to acquire information from the waveform. The controls are Clear, Recalc, Single and Run. The following table describes each of these controls:





**Table 28: Control panel selections**


Item	Description
Clear	Clears the current result display and resets any statistical results and autoselected ref levels.
Recalc	Runs the selected measurements on the current acquisition.
Single	Initiates a new acquisition and runs the selected measurements.
Run	Initiates a new acquisition and runs the selected measurements repeatedly until Stop is clicked. Used only for live sources.
Show Plots	Displays the plot summary window when clicked. This button appears in the control panel only when a plot is selected.

The control panel with Show Plots is as shown:



## Sources Setup

The application takes measurements from waveforms specified as input sources. You can select an oscilloscope channel input (live), a reference or a math waveform as the source. You can configure sources using any of the following options:

- Click  icon in the table which lists the selected measurements.
- Double-click anywhere on row in the table which lists the selected measurements.

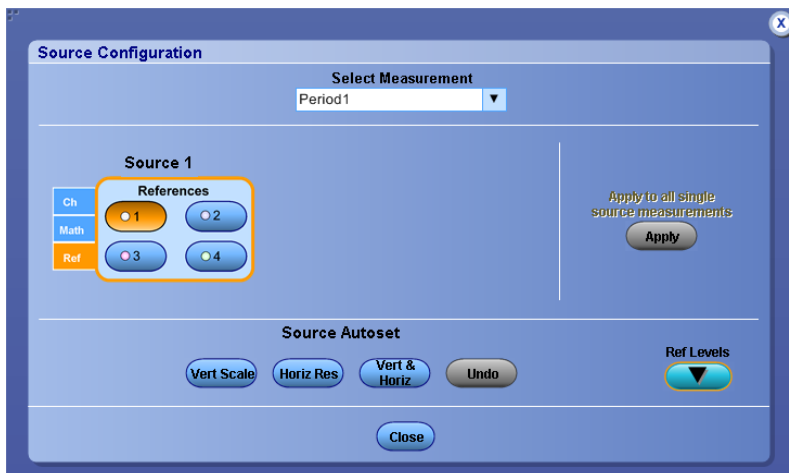
The source selections depend on the selected measurement. For differential input sources, you need to use only math waveforms.

---

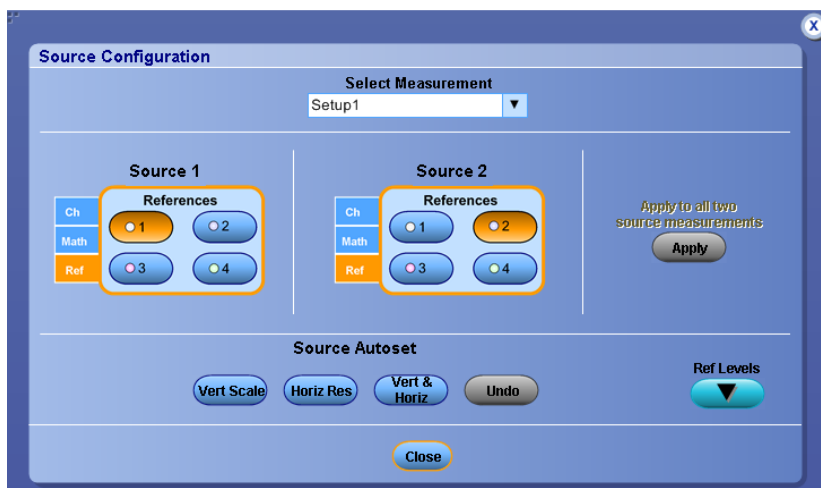
**NOTE.** *Setup, Hold, V-Diff-Xovr, Common Mode and Skew are two source measurements. The Source2 option is displayed only for two source measurements.*

---

When more than one single source measurement is selected, **Apply to all single source measurements** option is enabled in the source configuration screen.



When more than one two source measurement is selected, **Apply to all two source measurements** option is enabled in the source configuration screen.



## Related Topics

- Source Autoset
- Ref Levels

## Source Autoset

The Source Autoset allows you to automatically adjust the oscilloscope's vertical and/or horizontal settings for live sources (Ch1-Ch4) to improve measurement accuracy.

The Vertical Scale option automatically checks the peak-to-peak level of live sources. The vertical scale and offset of all signals with a peak-to-peak value less than six divisions are adjusted so the peak-to-peak will be eight divisions. If the maximum or minimum value of a signal is “clipped”, the vertical scale and offset are adjusted so that the peak-to-peak value will be eight divisions.

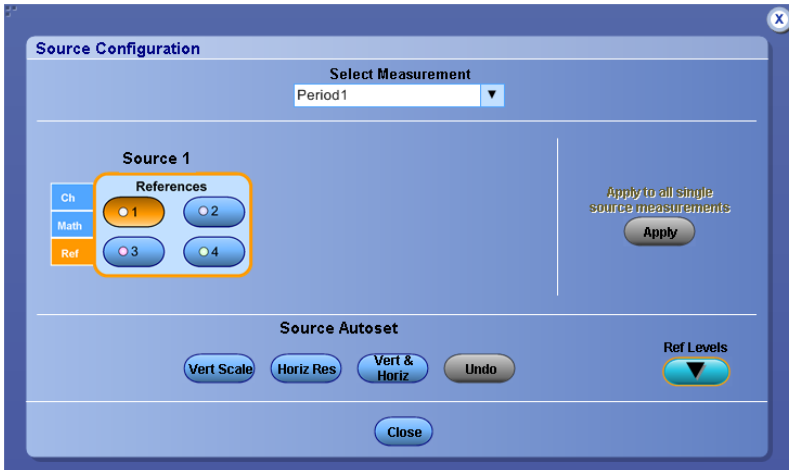
The Horizontal Resolution option automatically checks the number of samples/edge on the rising and falling transitions (Rise Time/Resolution and Fall Time/Resolution) of all live channels. The oscilloscope horizontal resolution is set to the largest value that does not cause the samples/edge of the fastest edge to fall below the specified target. The target is five samples per edge. The Horizontal Resolution sets the acquisition sampling mode to Real Time for signals with very high edge speeds. The default record length is 500 k points.

To automatically define both the vertical and horizontal settings for all channel sources, select the Vert and Horiz button. The Vert and Horiz option also applies an oscilloscope autoset on each channel before performing the vertical scale and horizontal resolution autoset.


Follow these steps to automatically define the vertical or horizontal settings for active sources:

1. Ensure that any channel waveform that you want to autoset is visible on the oscilloscope.

2. For Vert & Horiz and Horizontal resolution, the edge resolution is configured for five samples per edge or more for better edge timing and measurement accuracy.
3. Select one of the following options:
  - Vert & Horiz to autoset both vertical and horizontal setting.
  - Vert Scale button to autoset oscilloscope vertical settings only.
  - Horiz Res to autoset oscilloscope horizontal settings only.
  - Undo to return the oscilloscope to its state before autoset.

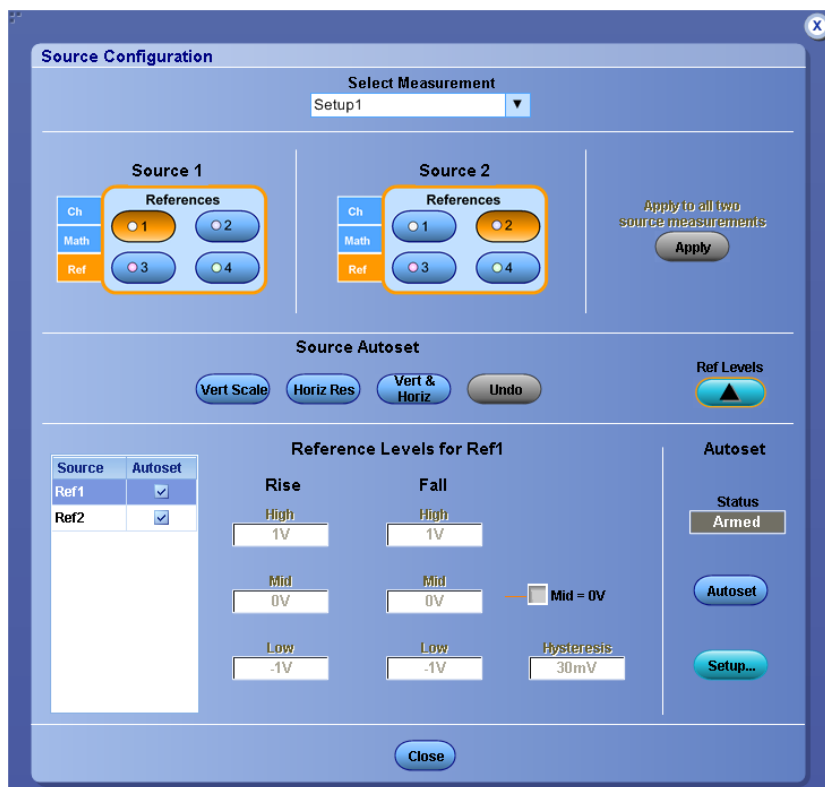


**Table 29: Autoset configuration options**

Item	Description
Vertical Scale	If a channel waveform does not exceed six vertical divisions, decreases the scale so that the waveform occupies about eight divisions.
Horiz Res	Sets the horizontal resolution so that the number of samples on the fastest transition (edge) exceeds a specified target.
Vert & Horiz	Performs a sequence: Oscilloscope Autoset, Vertical scale and Horizontal resolution.
Undo	Returns to the settings present before an Autoset was performed; disabled after measurements are taken until you perform another source autoset.
Ref Levels Setup 	Click Ref Levels Setup in the Source Configuration screen to hide/unhide the Ref Levels Setup.

## Ref Levels

Timing measurements are based on state transition times. By definition, edges occur when a waveform crosses specified reference voltage levels. Reference voltage levels must be set so that the application can identify state transitions on a waveform. By default, the application automatically chooses reference voltage levels when necessary.

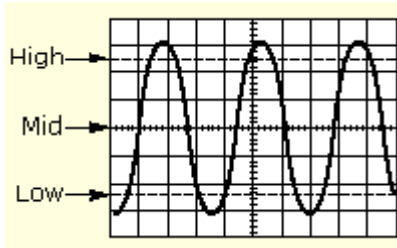


The DPOJET application uses three basic reference levels: High, Mid and Low. In addition, a hysteresis value defines a voltage band that prevents a noisy waveform from producing spurious edges. The reference levels and hysteresis are independently set for each source waveform, and are specified separately for rising versus falling transitions. There are two ways to set the reference voltage levels: [automatic](#) and [manual](#).

### High, Mid, and Low Reference Voltage Levels

The application uses three reference voltage levels: High, Mid, and Low.

- For most measurements, the application only uses the Mid reference voltage level. The Mid reference level defines when the waveform state transition occurs at a given threshold.
- For Rise Time and Fall Time measurements, the High and Low reference voltage levels define when the waveform is fully high or fully low.



### Rising Versus Falling Thresholds

You can specify thresholds for each of the reference voltage levels: High, Mid, and Low. The application uses the thresholds to determine the following events:

- A Low/Mid/High rising event, which occurs when the waveform passes through the corresponding Rise threshold in the positive direction.
- A Low/Mid/High falling event, which occurs when the waveform passes through the corresponding Fall threshold in the negative direction.

For a given logical reference level (such as Low, Mid, or High), rising and falling events alternate as time progresses.

---

**NOTE.** In many cases, the rising and falling thresholds for a given reference voltage level are set to the same value. In those cases, a hysteresis value helps prevent spurious edges produced by small amounts of noise in a waveform.

---

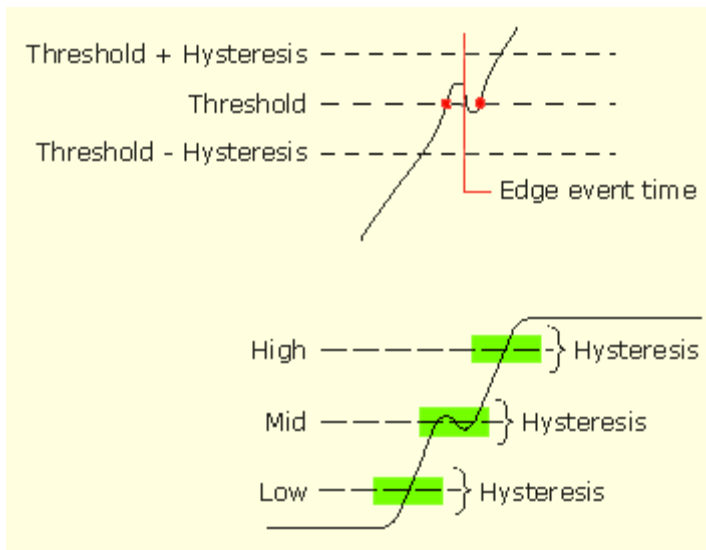
### Using the Hysteresis Option

The hysteresis option can prevent small amounts of noise in a waveform from producing multiple threshold crossings. You can use a hysteresis when the rising and falling thresholds for a given reference voltage level are set to the same value.

The reference voltage level  $\pm$  the hysteresis value defines a voltage range that must be fully crossed by the waveform for an edge event to occur. If the decision threshold is crossed more than once before the waveform exits the hysteresis band, the mean value of the first and last crossing are used as the edge event time.

For example, if the waveform rises through the Threshold – Hysteresis, then rises through the Threshold, then falls through the Threshold, then rises through both the Threshold and the Threshold + Hysteresis, a single edge event occurs at the mean value of the two rising crossings.

### Example of Hysteresis on a Noisy Waveform



### Automatic Versus Manual Reference Voltage Levels

Each measurement source may be configured to automatically choose voltage reference levels (default), or to lock the reference voltages to levels of your choosing.

In the Ref Levels Setup panel, a table at the left edge contains all of the currently active measurement sources. An Autoset check box appears beside each source. To enable or disable Autoset for a given source, choose the source in the left column and select the corresponding check box to toggle its state.

For more details, refer to [Understanding When Ref Level Autoset will Occur](#) and [Understanding How Ref Level Autoset Chooses Voltages](#).

**Table 30: Configure sources ref levels autoset configuration**

Item	Description
Autoset*	Calculates and displays the reference voltage levels for all sources where the autoset option is set according to the Autoset Ref Level Setup.
Setup	Specifies the Base-Top method and relative percent to be used for all reference voltage levels when autoset occurs.
Status	Specifies Armed/Disarmed status indicating whether the ref level voltages will be recalculated/retained for a measurement.

\* If you do not perform Autoset using Autoset button, the application updates the reference levels (if required) when you select Single or Run to take measurements.

## Understanding When Ref Level Autosest will Occur

When Autosest is enabled for a given source, the individual reference levels are displayed but you may not manually adjust them. Instead, the reference levels are automatically recalculated whenever one of the following events occur:

- A measurement sequence is initiated for the first time after a source has become active.
- A measurement sequence is initiated for the first time after all results have been cleared.
- The Autosest button at the right edge of the panel is pressed.

The Autosest button is provided as a convenience, but it is never required. Autosest will always be run (if enabled) before an uninitialized source is used for a measurement.

An **Armed** indicator appears in the upper right corner of the panel whenever a new source has been added or deleted or measurement results have been cleared. This lets you know that the reference levels will be recalculated the next time either the Single or the Run button is selected.

If **DisArmed** indicator appears, the displayed reference levels will be retained if a measurement sequence is performed with no further configuration changes. Of course, you can cause the reference levels to be recalculated at any time by selecting the Autosest button.

## Understanding How Ref Level Autosest Chooses Voltages

Once triggered, the Reference Level Autosest function uses the following logic to determine actual voltage levels.


For each applicable source, the Top (high logic level) and Base (low logic level) are first determined. Then, the High, Mid and Low levels are calculated as percentages of the Top-Base difference. For example, if the Top and Base are 2.8 volts and 0.4 volts respectively and the High percentage level is 90%, this threshold would be calculated as:

$$HighThres = Base + High\ Percent (Top - Base) = 0.4 + 0.9 (2.8 - 0.4) = 2.56$$

Click **Setup** to select a method used to calculate the Top and Base of the waveform and also the percentages used for the High, Mid and Low thresholds for each source. The [Autosest Ref Levels](#) appears.

## Manually Adjusting the Reference Voltage Levels

Whether or not you use the application to automatically calculate the initial reference voltage levels, you may need to manually change the values. To set the reference levels manually, follow these steps:

1. Click  icon in the table which lists the selected measurements to view the source configuration screen.
2. Select the desired source from the Source list.

---

**NOTE.** You cannot select inactive sources.

---

3. Clear the Autosest option for the sources you wish to set manually.



4. Select the reference levels or hysteresis options and manually adjust the values. The values will not change when you select Autoset or take measurements.

---

**NOTE.** *A source will become inactive if all measurements on that source are removed. If a new measurement is then added on that source, the source once again becomes active, and defaults to Autoset. If you clear all measurement on a source that was set to Manual, you must reselect the Manual state (if desired) when the source is again added.*

---

**Table 31: Configure sources ref levels configuration**

Item	Description
Autoset*	Calculates and displays the reference voltage levels for all sources where the autoset option is set according to the Autoset Ref Level Setup.
Setup	Specifies the Base-Top method and relative percent to be used for all reference voltage levels when autoset occurs.
Ref Levels Setup (one level per source) †	
Rise High	Sets the high threshold level for the rising edge of the source.
Rise Mid	Sets the middle threshold level for the rising edge of the source.
Rise Low	Sets the low threshold level for the rising edge of the source.
Fall High	Sets the high threshold level for the falling edge of the source.
Fall Mid	Sets the middle threshold level for the falling edge of the source.
Fall Low	Sets the low threshold level for the falling edge of the source.
Hysteresis	Sets the threshold margin to the reference level which the voltage must cross to be recognized as changing; the margin is the relative reference level plus or minus half the hysteresis; use to filter out spurious events.
Close	Accepts the changes and closes the window.
Status	Specifies Armed/Disarmed status indicating whether the ref level voltages will be recalculated/retained for a measurement.

\* If you do not update ref levels by clicking Autoset, the application updates the reference levels (if required) when you select the Single or Run to take measurements.

† Default setting are 90% (High), 50% (Mid), 10% (Low), and 3% (Hysteresis).

## Autoset Ref Levels

Click **Setup** in the Ref Level Setup screen to select a method used for calculating Top and Base of the waveform and also the percentages used for the High, Mid and Low thresholds for each source. The Autoset Ref Levels screen appears.

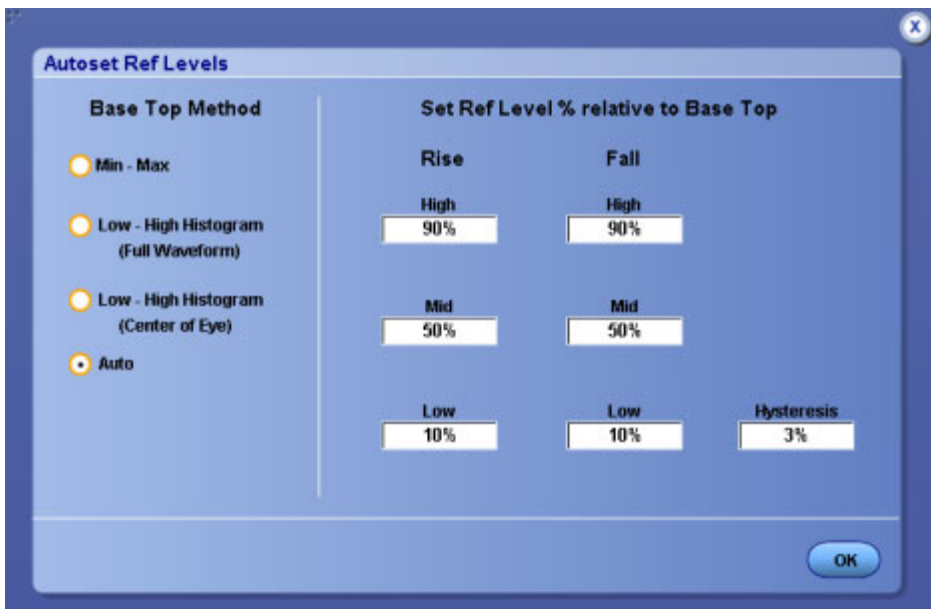


Table 32: Autoset ref level configuration

Item	Description
<b>Base Top Method</b>	
Min-Max	Uses the minimum and maximum values in the waveform to determine the base and top amplitude. Useful on a waveform with low noise and free from excessive overshoot.
Low-High Histogram (Full Waveform)	Uses a histogram approach to determine the base top amplitude. Creates a histogram of the amplitudes of the entire waveform; the histogram should have a peak at the nominal high level, and another peak at the nominal low level.
Low-High Histogram (Center of Eye)	Uses a histogram approach to determine the base top amplitude. Creates a histogram of the amplitudes in the center of each bit (unit interval) while ignoring the waveform during bit transitions. The histogram should have a peak at the nominal high level and another peak at the nominal low level.
Auto	Automatically determines the best Base Top method to use.
<b>Set Ref Level % Relative to Base Top*</b>	

**Table 32: Autoset ref level configuration (cont.)**

Item	Description
Rise High	Sets the high threshold level for the rising edge of the source.
Rise Mid	Sets the middle threshold level for the rising edge of the source.
Rise Low	Sets the low threshold level for the rising edge of the source.
Fall High	Sets the high threshold level for the falling edge of the source.
Fall Mid	Sets the middle threshold level for the falling edge of the source.
Fall Low	Sets the low threshold level for the falling edge of the source.
Hysteresis	Sets the threshold margin to the reference level which the voltage must cross to be recognized as changing; the margin is the relative reference level plus or minus half the hysteresis; use to filter out spurious events.
OK	Accepts the changes and closes the window.

\* Default setting are 90%(High), 50% (Mid), 10% (Low), and 3% (Hysteresis).

## About Configuring a Measurement

You can configure the measurements listed under the following categories:

- Period/Freq
- Jitter
- Time
- Eye
- Amplitude
- More

---

**NOTE.** *Configure tabs are displayed only when you select a measurement.*

---

The following tables lists the configure tabs displayed for each measurement.

**Table 33: Period/Freq measurements**

UI Name	Measurements	Edges	Bit Config	Clock Recovery	RJDJ	Filters	General	Global
Period	Clock Period	✓				✓	✓	✓
	Data Period					✓	✓	✓
Freq	Clock Frequency	✓				✓	✓	✓
	Data Frequency					✓	✓	✓
Pos Width	Pos Width					✓	✓	✓
Neg Width	Neg Width					✓	✓	✓
N-Period	N-Period	✓					✓	✓
+Duty Cycle	+Duty Cycle	✓				✓	✓	✓
-Duty Cycle	-Duty Cycle	✓				✓	✓	✓
CC-Period	CC-Period	✓				✓	✓	✓
+CC-Duty	+CC-Duty					✓	✓	✓
-CC-Duty	-CC-Duty					✓	✓	✓

**Table 34: Jitter measurements**

UI Name	Measurements	Bit Config	Edges	Clock Recovery	RJDJ	Filters	General	Global
TIE	Clock TIE		✓	✓		✓	✓	✓
	Data TIE			✓		✓	✓	✓
TJ@BER	Clock TJ		✓	✓	✓	✓	✓	✓
	Data TJ			✓	✓	✓	✓	✓
DCD	Clock DCD		✓	✓	✓	✓	✓	✓
	Data DCD			✓	✓	✓	✓	✓

**Table 34: Jitter measurements (cont.)**

UI Name	Measurements	Bit Config	Edges	Clock Recovery	RJDJ	Filters	General	Global
RJ	Clock RJ		✓	✓	✓	✓	✓	✓
	Data RJ			✓	✓	✓	✓	✓
DJ	Clock DJ		✓	✓	✓	✓	✓	✓
	Data DJ			✓	✓	✓	✓	✓
DDJ	DDJ		✓	✓	✓	✓	✓	✓
RJ-δδ	Clock RJ-δδ		✓	✓	✓	✓	✓	✓
	Data RJ-δδ			✓	✓	✓	✓	✓
DJ-δδ	Clock DJ-δδ		✓	✓	✓	✓	✓	✓
	Data DJ-δδ			✓	✓	✓	✓	✓
PJ	Clock PJ		✓	✓	✓	✓	✓	✓
	Data PJ			✓	✓	✓	✓	✓
Jitter Summary <sup>1</sup>								
Phase Noise			✓			✓	✓	✓

<sup>1</sup> Jitter Summary is not an individual measurement but a convenience function. Pressing this button automatically adds a set of eleven jitter-related measurements with a single action. The measurements are: TIE, RJ, RJ-δδ, DJ, DJ-δδ, PJ, DDJ, DCD, TJ@BER, Width@BER, and Phase Noise.

**Table 35: Timing measurements**

Measurements	Bit Config	Edges	Clock Recovery	RJDJ	Filters	General	Global
Rise Time			✓		✓	✓	✓
Fall Time			✓		✓	✓	✓
Skew		✓			✓	✓	✓
High Time					✓	✓	✓
Low Time					✓	✓	✓
Setup		✓			✓	✓	✓
Hold		✓			✓	✓	✓

**Table 36: Eye measurements**

Measurements	Bit Config	Edges	Clock Recovery	RJDJ	Filters	General	Global
Width			✓			✓	✓
Width@BER		✓	✓	✓	✓	✓	✓
Height	✓		✓			✓	✓
Mask Hits	✓		✓			✓	✓

**Table 37: Amplitude measurements**

Measurements	Bit Config	Edges	Clock Recovery	RJDJ	Filters	General	Global
High	✓		✓		✓	✓	✓
Common Mode					✓	✓	✓
Low	✓		✓		✓	✓	✓
T/nT Ratio			✓		✓	✓	✓
High-Low	✓		✓		✓	✓	✓
V-Diff-Xovr		✓			✓	✓	✓

**Table 38: More measurements**

Measurements	Bit Config	Edges	Clock Recovery	RJDJ	Filters	General	Global
DDR Setup-SE		✓			✓	✓	✓
DDR Setup-Diff		✓			✓	✓	✓
DDR Hold-SE		✓			✓	✓	✓
DDR Hold-Diff		✓			✓	✓	✓

**Related Topics**

- Bit Config
- Edges
- Clock Recovery
- RJDJ
- Filters
- General

- Global

## About Global

This configuration tab is common for all measurements. You can limit the waveform data analysis by Gating, Qualifying and Populating the waveform data.



## Gating

Gating allows you to focus the analysis on a specific area of the waveform bounded by a gated region, which is a way to filter unnecessary information.

You can set up a gated region in one of the following ways:

- Zoom
- Cursors



**Table 39: Global-Gating options**

Item	Description
Off	No gating occurs; application takes measurements over the entire waveform.
Zoom	Zooms the specified region of the source waveform to take measurements within the selected area. The region of waveform within the zoom is analyzed.
Cursors	Gates the waveform with Vertical cursors. The region of waveform within the cursors is analyzed.

## Qualify

Qualifiers allows you to limit the application to more narrowly defined conditions before taking measurements. All sources for the measurements and Qualify input must have the same Horizontal Sample Rate, Record Length, and Position to ensure that measurements function properly. For measurements which require clock recovery such as TIE or eye measurements, only the first qualified region will be measured even if multiple qualified regions are present. For all other measurements, the entire waveform is processed.



**Table 40: Global-Qualify options**

Item	Description
Off	Disables the application from using the defined conditions while taking measurements.
On	Enables the application to use the defined conditions while taking measurements.
Configure	Displays the <a href="#">Qualify with Logic</a> dialog box.



## Configuring Qualify with Logic

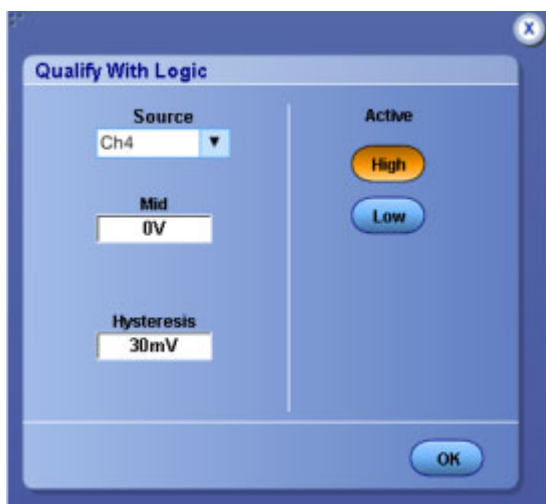


Table 41: Qualify-Configure options

Item	Description
Source *	Selects a waveform to qualify the signal or clock source used for the measurement. The input source waveforms or files are Ch, Ref, Math and Search.
Mid	Shows the vertical reference level of the qualifier waveform. †
Hysteresis	Shows the amount of hysteresis applied to the vertical reference level of the qualifier waveform. Hysteresis prevents small amounts of noise in a waveform from producing multiple threshold crossings.
<b>Active</b>	
High †	Enables measurements in regions † where the qualifier waveform exceeds the mid reference level.
Low †	Enables measurements in regions † where the qualifier waveform falls below the mid reference level.
OK	Accepts the changes and closes the window.

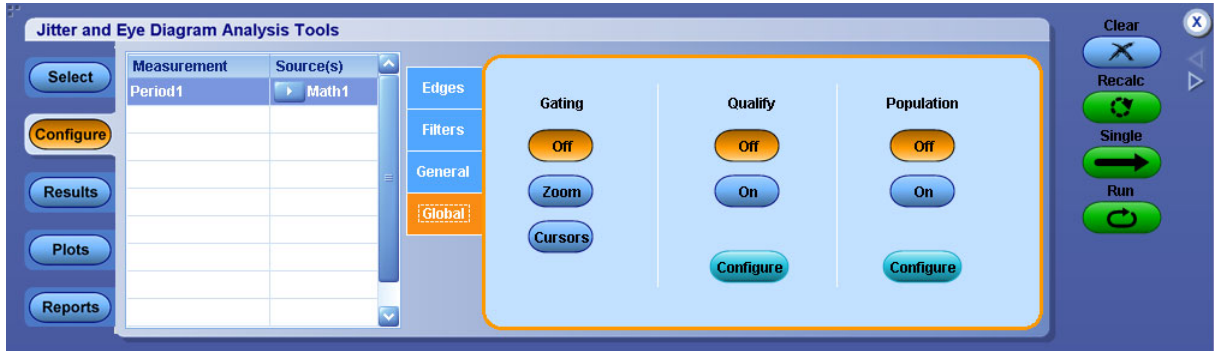
\* Measurement and Qualify sources must have the same Horizontal Sample Rate, Record Length, and Position to ensure that measurements function properly.

† For measurements that require clock recovery, only the first qualified region will be measured even if multiple qualified regions are present.

‡ The default behavior for all reference levels is to automatically adjust based on the signal amplitude after a "Clear" operation, unless you disable the autoset checkbox in the source configuration panel. Whether you use the Qualify with Logic dialog box to adjust the levels or not, be aware that the levels may change if automatic adjustment is still enabled. For more information, refer to [Automatic Versus Manual Reference Voltage Levels](#).

# Population

The Population control allows you to limit the amount of waveform data that is analyzed. This is often done in industry standards to make sure that there is consistency between measurement techniques.



**Table 42: Global-Population options**

Item	Description
Off	Disables the application from using a Population limit while taking measurements.
On	Enables the application to use a Population limit while taking measurements.
Configure	Displays the <a href="#">Population Limit</a> dialog box wherein you can set a limit on a maximum population to obtain, for selected measurements.

## Configuring Population Limit

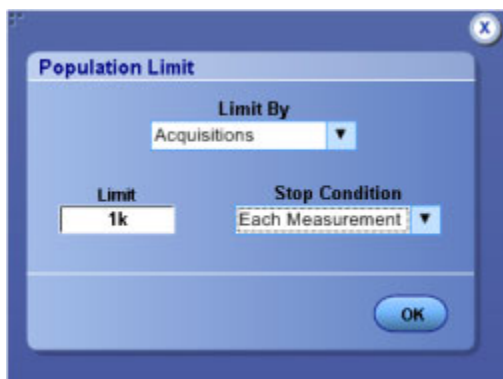


Table 43: Population-Configure options

Item	Description
<b>Limit By</b>	
Population	The limit determines the population of measurement observations that will be accumulated. Some measurements may accumulate observations more quickly than others.
Acquisitions	The limit determines the number of acquisition cycles that will be performed.
<b>Stop Conditions</b>	
Each Measurement	Each measurement stops accumulating as soon as it reaches the specified limit. Sequencing does not stop until all measurements have reached the limit, at which time every measurement will have exactly the limit.
Last Measurement	Sequencing continues and all measurements continue accumulating until the last (slowest accumulating) measurement reaches the limit, at which time they all stop. When sequencing stops, all measurements except one may have higher population than the limit.
Limit	Specifies the number of acquisitions or measurements the application takes before sequencing stops.
OK	Accepts the changes and closes the window.

## General

This configuration tab allows you to customize the measurement name and qualify the measurement within a selected result range. The General tab looks the same for all the measurements but is not common. The values are different for different measurements. You can set the custom name per measurement here.

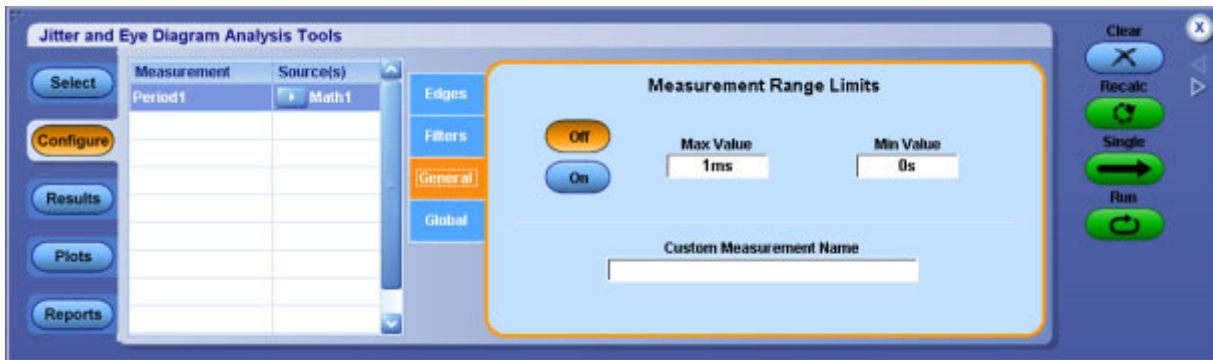


Table 44: General options

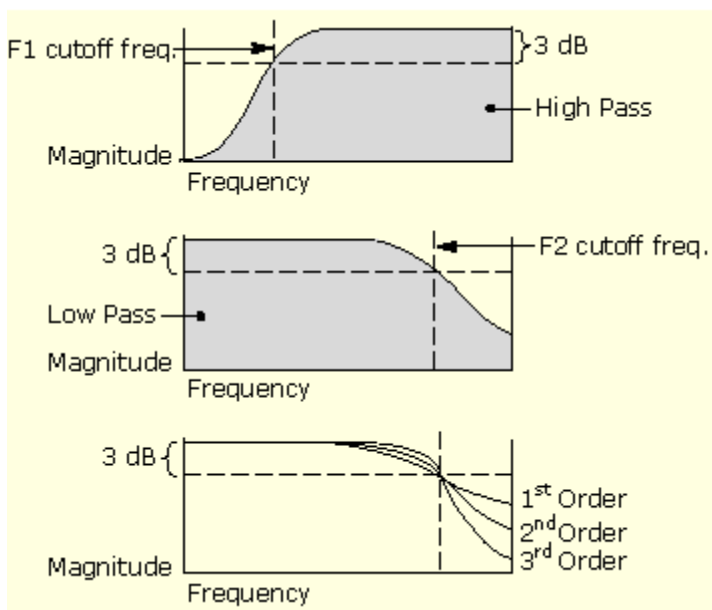
Item	Description
Off	Disables the application from using the specified measurement limits.
On	Enables the application to use the specified measurement limits.
Max or Min value	Specify the maximum and minimum range of valid measurement values measurements. The default values for the Measurement Range Limits options vary by measurement.
Custom Measurement Name	Option to modify the measurement name. Allows adding a user-specified name to any measurement. This is useful for aligning DPOJET measurements with a user measurement list or standard.

**NOTE.** If a max value smaller than the min value is entered, it is accepted and the min value is also silently reduced to the same value. Likewise, if a min value larger than the max is entered, both are set to that value.

## Filters

This configuration tab allows you to modify the measurement data by applying a High Pass filter to block out low frequency band components or a Low Pass filter to block out high frequency band components. For Example: Selecting a 1 MHz high pass filter can reduce the effect of SSC on results.

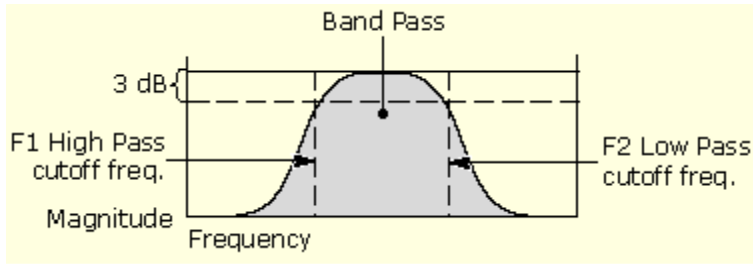
For some measurements (Period, Frequency, TIE, +Duty Cycle, -Duty Cycle, +CC Duty, - CC Duty, CC-Period, Positive Width, Negative Width, N-Period, Rise Time, Fall Time, Low Time, High Time, Common ModeV, High-Low, High, Low and T/nT Ratio), the measurements versus time waveform (time trend) that is derived from the original oscilloscope waveform can be filtered before it is passed to the statistics and plotting subsystems.



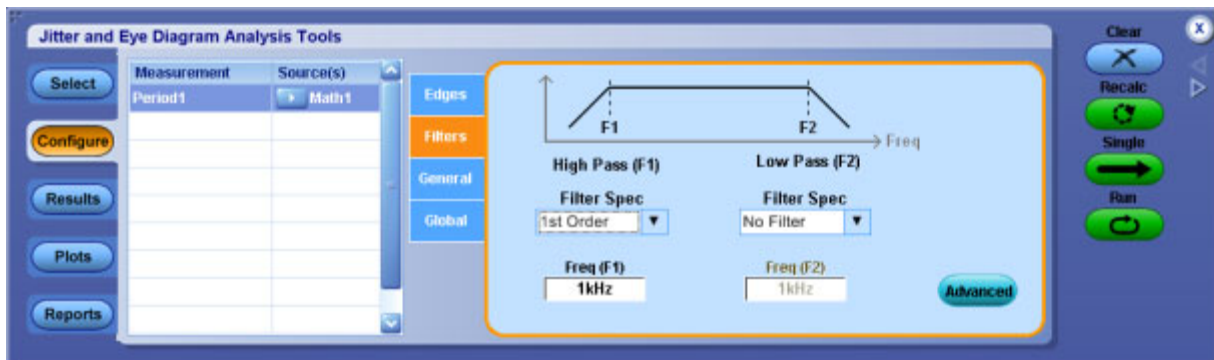
### Band Pass Filtering

You can create a band pass filter by enabling both the High Pass and the Low Pass filters on a measurement. The cut-off frequency for the Low Pass filter must be greater than or equal to the cut-off frequency for the High Pass filter.

You should be aware that setting the cut-off frequencies close to each other may effectively filter out all of the measurement data, or all but a small amount of timing noise. This diagram shows the spectrum of the measurement data passed to the statistics and plotting subsystems when you use both the High Pass and the Low Pass filters.



High Pass filters attenuate low frequencies, and filter out DC values entirely. When a high pass filter is added to a period or frequency measurement, the mean value of the filtered measurement goes to zero. This can be seen by creating a Time Trend plot of a high-pass-filtered period or frequency measurement. Although this is the correct theoretical behavior for the filtered measurement, it is not very useful if the Results panel reports that the mean period or frequency is zero. For this reason, the mean values that appear in the results panels for Period and Frequency measurements are the values before the filter.



**Table 45: Filter options**

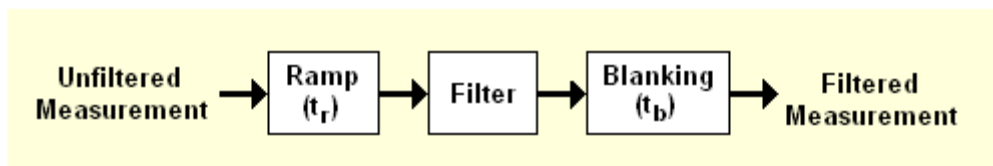
Item	Description
<b>High Pass</b>	
Filter Spec	When enabled, blocks the low frequency band and passes only the high frequency band of the waveform; defined as 1 <sup>st</sup> order, 2 <sup>nd</sup> order, 3 <sup>rd</sup> order Butterworth and No filter, being the default.
Freq (F1)*	High Pass filter cut off frequency at which the filter magnitude falls by 3 dB.
<b>Low Pass</b>	
Filter Spec	When enabled, blocks the high frequency band and passes only the low frequency band of the waveform; defined as 1 <sup>st</sup> order, 2 <sup>nd</sup> order, 3 <sup>rd</sup> order Butterworth, and No filter, being the default.
Freq (F2)*	Low Pass filter cut off frequency at which the filter magnitude falls by 3 dB.
<b>Advanced</b>	Displays the <a href="#">Advanced Filter Configuration</a> dialog box.

\* Includes a 3 dB cut-off frequency.

## Advanced Filter Configuration

The measurement filters are implemented using infinite impulse response (IIR) designs. As with any causal filter, a transient may occur at the filter’s output in response to the arrival of the input signal. It is usually desirable to exclude this transient from the measurement results.

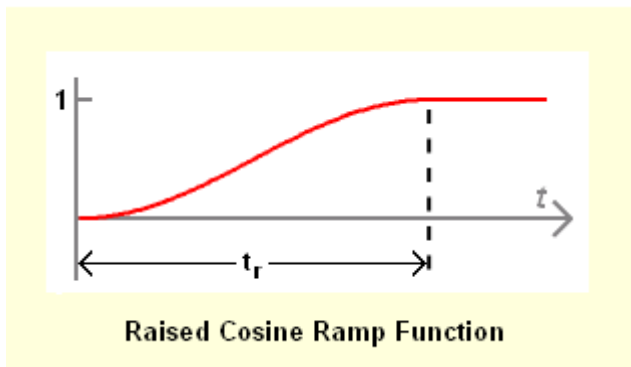
In the DPOJET application, the filter transient is managed in two ways. First, the input to the filter is gently “ramped up” from zero to its full value over some ramp time  $t_r$ . Second, the output of the ramp is “blanked” over some duration  $t_b$ , so that the remaining effects of any transient are omitted from measurement results, statistics and plots. The sequence of operations is depicted here:



The ramp function has a raised-cosine profile and is defined in the time domain as:

$$\frac{1}{2} \left[ 1 - \cos\left(\pi * \frac{t}{t_r}\right) \right] \quad 0 < t \leq t_r$$

$$1 \quad t > t_r$$



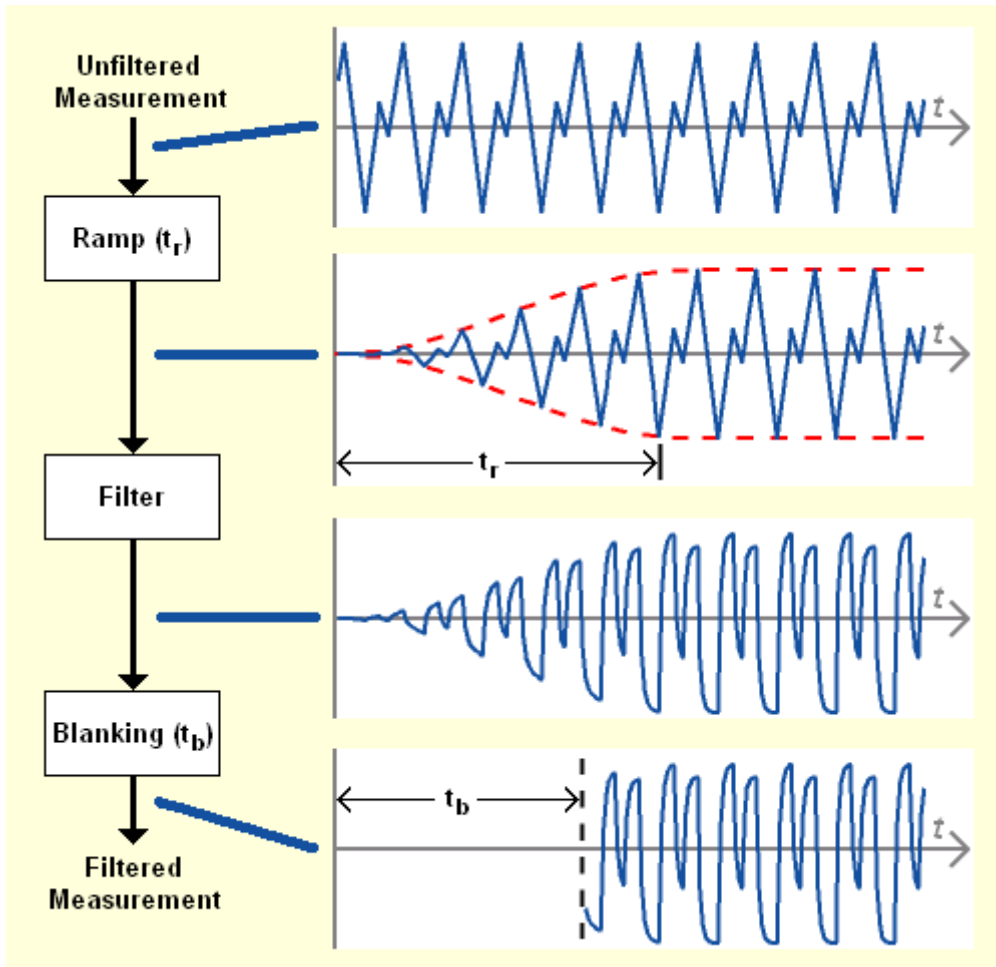
You may adjust the ramp time  $t_r$  by means of the Advanced control panel. If you wish to turn off the ramp function, set the ramp time to 0.

Similarly, you may adjust the blanking duration  $t_b$  by means of the Advanced control panel. Setting the blanking duration to 0 will allow you to see the entire filtered measurement, including any transients.

Both, the ramp time  $t_r$  and the blanking duration  $t_b$ , are set relative to the reciprocal of the lowest filter frequency  $F_c$ . By default, both of these parameters are set to  $1/F_c$ . Since they are normalized to the filter frequency, they will automatically adjust if you change the filter cut-off frequency.

The complete set of signal processing options, together with representative waveforms that suggest how the options affect the measurement vector, are shown here:





**Advanced Filter Configuration**

**To avoid a filter start-up transient:**

- \* Multiply by a smoothing Ramp, and/or
- \* Blank out a part of the filter output.

**To disable the ramp or the blanking effects,**  
set the corresponding time to zero.

Filter Frequency, F =

Ramp Time  / F =

Blanking Time  / F =

**Table 46: Advanced filter configuration options**

Item	Description
Ramp Time	Duration of the raised-cosine smoothing function applied to the measurement vector before the vector is filtered.
Blanking Time	Duration of the filter's output that is suppressed. The blanked portion of the output is not included in the measurement statistics, or in any plots.
OK	Accepts changes and closes.

## About Clock Recovery

Clock recovery refers to the process of establishing a reference clock, the edges of which can be used as a basis for timing comparisons. The Clock Recovery configuration tab allows you to select one of the following clock recovery methods:

- Constant Clock - Mean
- Constant Clock - Median
- Constant Clock - Fixed
- Phase Locked Loop Standard BandWidth
- Phase Locked Loop Custom BandWidth
- Explicit Clock - Edge
- Explicit Clock - PLL

The first four methods derive the reference clock from the same channel upon which the measurement is defined. This is the conventional method of clock recovery for serial data communications, where no separate clock is available. The last two methods (Explicit Clock) derive the reference clock from a channel other than the one upon which the measurement is defined.

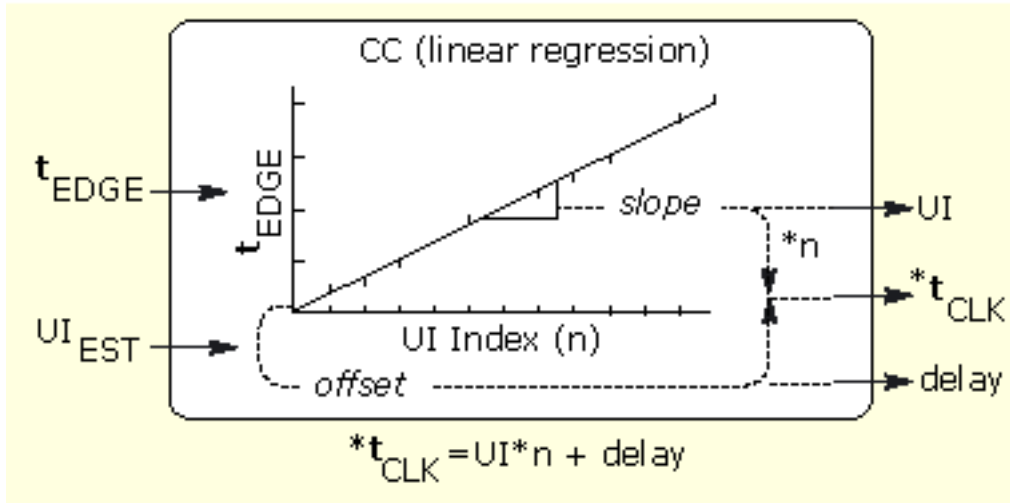
## About Constant Clock Recovery

In Constant Clock Recovery, the clock is assumed to be of the form  $A \cdot \sin(2\pi f t + \Phi)$ , where the frequency ( $f$ ) and phase ( $\Phi$ ) are treated as unknown constants. Once a source waveform has been acquired and the edges extracted, one or both of these constants are determined using linear regression, so that the recovered clock minimizes the mean squared sum of the Time Interval Error (TIE) for that waveform.

If **Constant Clock - Mean** is selected as the clock recovery method, both the frequency and the phase are chosen to minimize the mean squared error.

If **Constant Clock - Fixed** is selected as the clock recovery method, the precise frequency specified is used but the phase is chosen so that the median error between the recovered and measured edges is zero.

If **Constant Clock - Median** is selected as the clock recovery method, the phase is chosen so that the median error between the recovered and measured edges is zero.



## Constant Clock - Mean

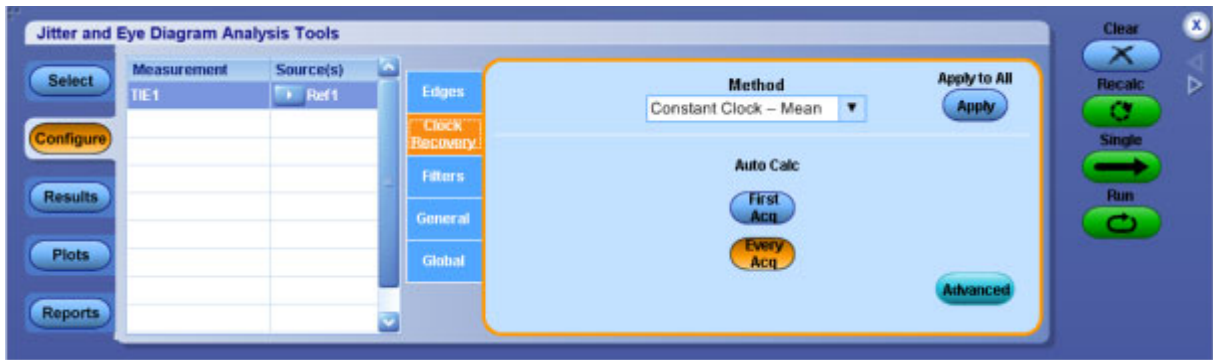
This method provides the following options that control how the clock recovery is performed:

- Auto Calc First Acq
- Auto Calc Every Acq

Selecting Autocalc First Acq will allow the clock-recovery algorithm to choose a new best-fit clock frequency and phase only on the first acquisition. Subsequent acquisitions will choose a best fit on clock phase but retain the clock frequency found on the first acquisition.

Selecting Autocalc Every Acq will allow the clock-recovery algorithm to choose a new best-fit clock frequency and phase for each new oscilloscope acquisition.

Clearing the measurement results by choosing Clear on the sequencing panel will reset the clock recovery so that both frequency and phase are optimized on the subsequent acquisition.



**Table 47: Constant Clock - Mean options**

Item	Description
Auto Calc First Acq	Calculates the best fit of the initial acquisition or the first acquisition after clearing results, and then uses the value until you clear the results.
Auto Calc Every Acq	Calculates the best fit for each acquisition (default).
<b>Apply to All</b>	
Apply	Applies the current clock recovery configuration to all selected measurement(s) PLL-Standard clock recovery options that have Clock Recovery as configuration tab.
<b>Advanced</b>	Displays the <a href="#">Clock Recovery Advanced Setup</a> dialog box.

## Constant Clock - Median

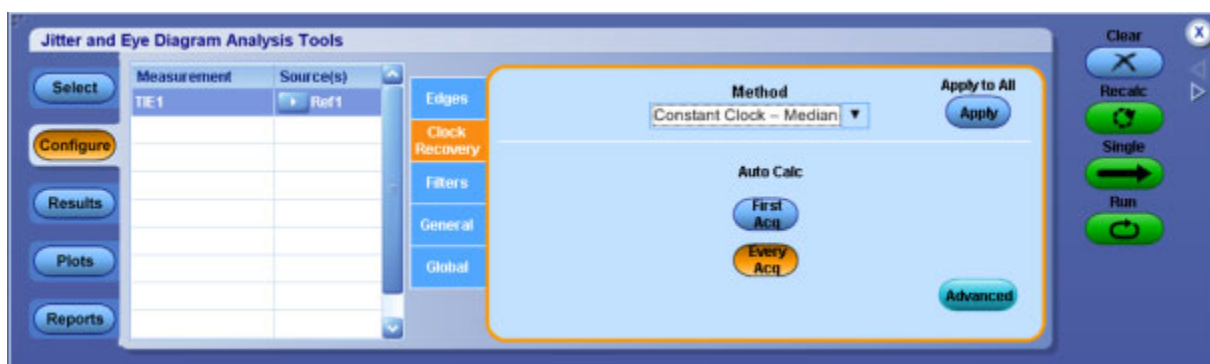
This method provides the following options that control how the clock recovery is performed:

- Auto Calc First Acq
- Auto Calc Every Acq

Selecting Autocalc First Acq will allow the clock-recovery algorithm to choose a new best-fit clock frequency and phase only on the first acquisition. Subsequent acquisitions will choose a best fit on clock phase but retain the clock frequency found on the first acquisition.

Selecting Autocalc Every Acq will allow the clock-recovery algorithm to choose a new best-fit clock frequency and phase for each new oscilloscope acquisition.

Clearing the measurement results by choosing Clear on the sequencing panel will reset the clock recovery so that both frequency and phase are optimized on the subsequent acquisition.

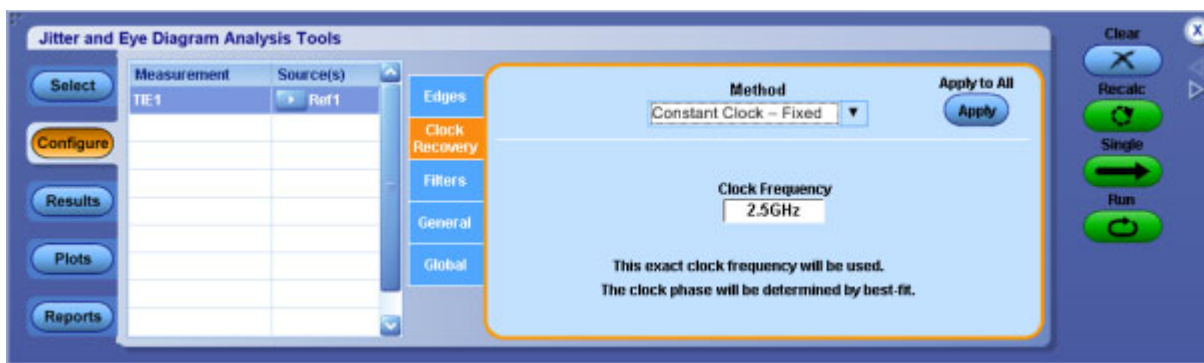


**Table 48: Constant Clock - Median options**

Item	Description
Auto Calc First Acq	Calculates the best fit of the initial acquisition or the first acquisition after clearing results, and then uses the value until you clear the results.
Auto Calc Every Acq	Calculates the best fit for each acquisition (default).
<b>Apply to All</b>	
Apply	Applies the current clock recovery configuration to all selected measurement(s) that have Clock Recovery as configuration tab.
<b>Advanced</b>	Displays the <a href="#">Clock Recovery Advanced Setup</a> dialog box.

## Constant Clock - Fixed

This method provides a single option that controls how the clock recovery is performed: the Clock Frequency. With Fixed Constant Clock recovery, no attempt is made to derive information about the actual data rate from the signal under test. Instead, the precise frequency that you specify will be used. (However, the clock phase will be chosen so that the median difference between the recovered and measured edges is zero.)




---

**NOTE.** Click *Apply to All* to apply the clock recovery configuration to all selected measurement(s) that have Clock Recovery as configuration tab.

---

## Clock Recovery Advanced Setup

The Advanced Clock Recovery methods are used when unusually high noise defeats normal clock recovery methods. Under most normal operating conditions, these methods are not required nor recommended. Nominal Data Rate and Known Data Pattern are the two advanced clock recovery methods.

In Nominal Data Rate, you can provide the nominal data rate to the clock recovery algorithm. Normally, the application analyzes your data and determines the nominal data rate automatically. Using Nominal provides a starting point or hint to the clock recovery algorithm from which it analyzes data.

In Known Data Pattern, the pattern is specified by using an ASCII text file containing the characters 1 and 0. The file may contain other characters, spaces and tabs for formatting purposes, but they will be ignored. Several files for commonly used patterns are included with the application, and you may use these as examples if you wish to create your own pattern files. Click **Browse** to modify the default location for pattern files.

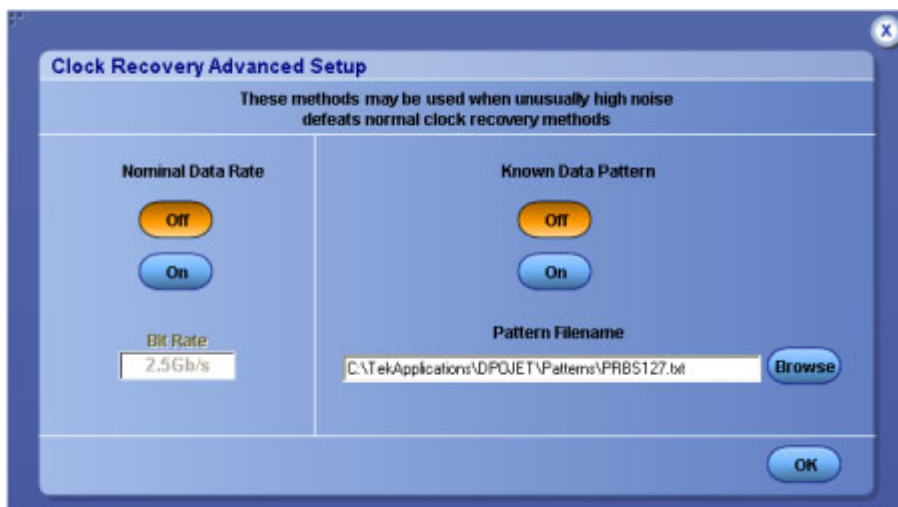


Table 49: Advanced clock recovery options

Item	Description
<b>Nominal Data Rate</b>	
Off, On	Enables (On) or disables (Off) the advanced clock recovery through data rate guidance.
Bit Rate	Defines the nominal data rate in bits per second (b/s). Use the pop-up keypad to set the data rate.
<b>Known Data Pattern</b>	
Off , On	Enables (On) or disables (Off) advanced clock recovery through a known data pattern.
<b>Pattern File Name</b>	
Browse	Selects a file to use for the data pattern.
OK	Accepts changes and closes.

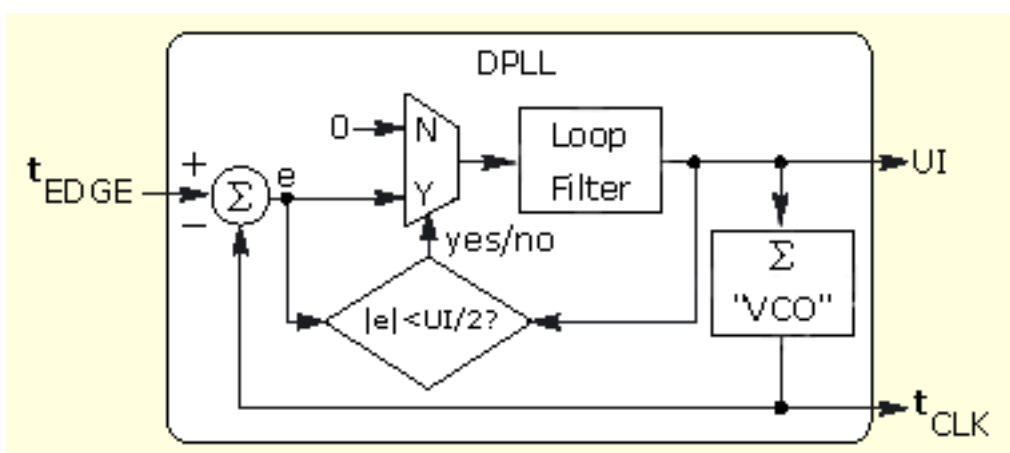
## About PLL Clock Recovery Setup

When PLL-based clock recovery is selected, the application simulates the behavior of the hardware Phase Locked Loop clock recovery circuit. This is a feedback loop in which the Voltage-Controlled Oscillator (VCO) is used to track or follow slow variations in the bit rate of the input waveform. Such loops are frequently used to recover the clock in communication links that do not transmit the clock as a separate signal. The PLL parameters in the application may be adjusted to simulate with the behavior of a receiver in such a link, within certain guidelines.

---

**NOTE.** *The effective transfer function of a PLL loop is not equal to the PLL Loop BW setting. The Transfer function depends on the factors such as damping, transition density and type.*

---



## PLL Standard BW

The PLL control area provides control over the phase-locked loop used for clock recovery. You can choose the loop bandwidth and the loop order, and if a Type II loop is chosen, you can specify the damping factor.

To set the loop bandwidth automatically, based on a serial standard, select PLL: Standard BW as the clock recovery method. From the Standard: b/s list box, select the standard that matches your data link. For example, choose “PCI-E: 2.5” to test a 2.5 Gbit/second PCI-Express link. In this case, the PLL bandwidth will be set to 1.5 MHz, which is 1/1667 of the baud rate as specified in PCI-Express standard.

You can use the PLL Model list box to choose between Type I and Type II loop. A Type I loop has a transfer function that approaches zero frequency with a slope of 1/s and a Type II loop approaches zero frequency with a 1/s<sup>2</sup> slope (In much of the PLL literature, these terms are used interchangeably with First-Order and Second-Order loops. For a thorough discussion of loop type versus order, see Frequency Synthesis by Phase Lock, by William Egan).



**NOTE.** Although it is possible to configure a Type II PLL with a bandwidth up to 1/10 of the baud rate, such a loop will have poor dynamic performance. This is because Type II loops have less phase margin than Type I loops. A preferred alternative to using a Type II PLL with a bandwidth close to its baud rate is to use a 2<sup>nd</sup> order high-pass measurement filter to emulate the effects of the PLL.

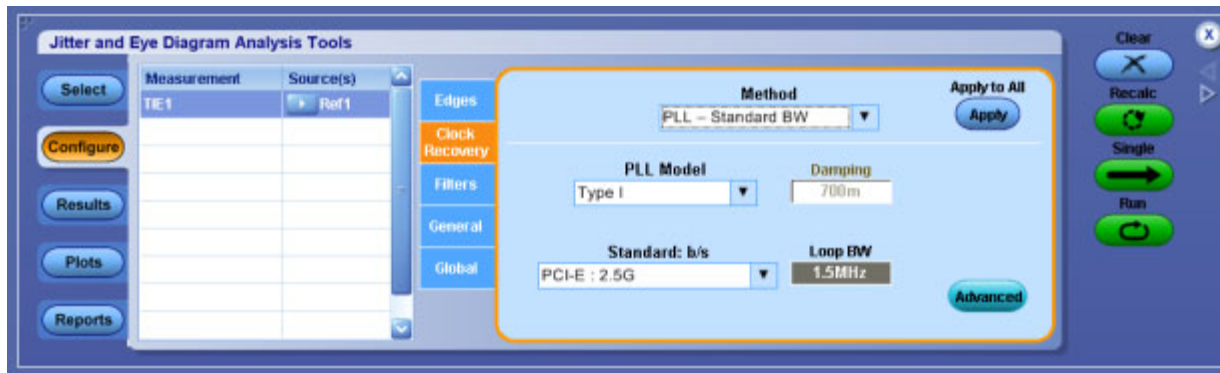


Table 50: PLL-Standard clock recovery options

Item	Description
PLL Model	Selects between a Type I or Type II phase-locked loop.
Damping	Use the keypad to specify the damping ratio of the PLL. It is enabled only for Type II phase-locked loop.
Loop BW	Displays the bandwidth that has been selected based on the current standard.
Standard: b/s	Implicitly sets the loop bandwidth of the clock recovery PLL, based on selection of the industry standard and data rate in bits/second.
<b>Apply to All</b>	
Apply	Applies the current clock recovery configuration to all selected measurement(s) that have clock recovery as configuration tab.
<b>Advanced</b>	Displays the Clock Recovery Advanced Setup. For more details, refer to the <a href="#">Clock Recovery Advanced Setup</a> .

## PLL Custom BW

The PLL control area provides control over the phase-locked loop used for clock recovery. You can choose the loop bandwidth and the loop order, and if a Type II loop is chosen, you can specify the damping factor.

To manually control the loop bandwidth, select PLL: Custom BW as the clock recovery method and use the User BW control to select the 3 dB bandwidth of the loop, in Hz.

You can use the PLL Model list box to choose between a Type I and Type II loop. A Type I loop has a transfer function that approaches zero frequency with a slope of 1/s and a Type II loop approaches zero frequency with a 1/s<sup>2</sup> slope. (In much of the PLL literature, these terms are used interchangeably with First-Order and Second-Order loops. For a thorough discussion of loop type versus order, see Frequency Synthesis by Phase Lock, by William Egan).

**NOTE.** Although it is possible to configure a Type II PLL with a bandwidth up to 1/10 of the baud rate, such a loop will have poor dynamic performance. This is because Type II loops have less phase margin than Type I loops. A preferred alternative to using a Type II PLL with a high bandwidth is to use a 2<sup>nd</sup> order high-pass measurement filter to emulate the effects of the PLL.

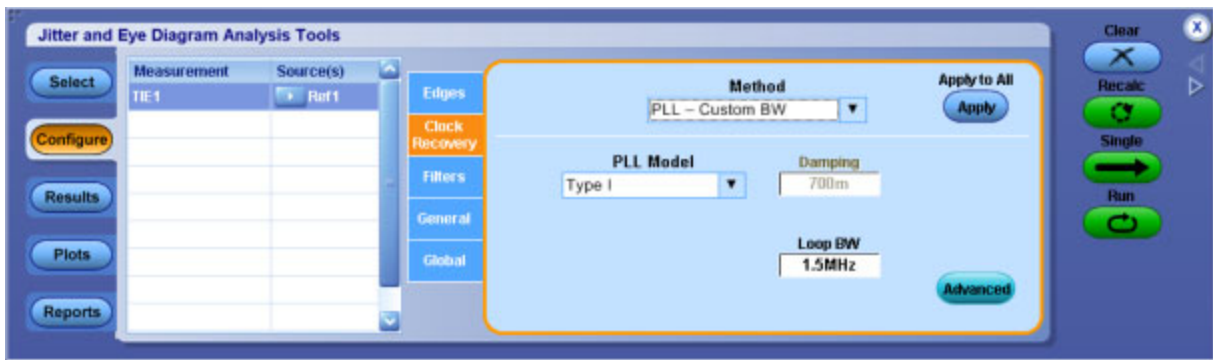


Table 51: PLL-Custom clock recovery options

Item	Description
PLL Model	Selects between Type I or Type II phase-locked loop.
Damping	Use the keypad to specify the damping ratio of the PLL. It is enabled only for Type II phase-locked loop.
Loop BW	Explicitly sets the loop bandwidth of the clock recovery PLL.
<b>Apply to All</b>	
Apply	Applies the current clock recovery configuration to all selected measurement(s) that have Clock Recovery as configuration tab.
<b>Advanced</b>	Displays the Clock Recovery Advanced Setup. For more details, refer to the <a href="#">Clock Recovery Advanced Setup</a> .

## About Explicit Clock Recovery

In Explicit Clock Recovery, the reference clock is not derived from the measurement's target source at all, but is instead taken from a separately-identified source. Since the source used for the measurement now differs from the source used to derive the reference clock, selecting this type of clock recovery converts the measurement from a single-source measurement to a dual-source measurement. The reference clock source is always shown on the right when the two sources appear in a measurement table. Changing the clock-recovery method back to a non-explicit clock method will change the measurement back to a single-source measurement.

## Explicit Clock-Edge

Select Explicit Clock-Edge method if you want to use the edges found in the selected clock source (possibly multiplied up by an integral number). If the Clock Multiplier is set to 1 (the default), only these edges will be used. If the Clock Multiplier is set to a number N other than 1, linear interpolation will be used between each pair of actual edges to create N-1 additional reference edges. The interpolated edge times, combined with the actual edges, give a total of N reference edge times per actual edge.

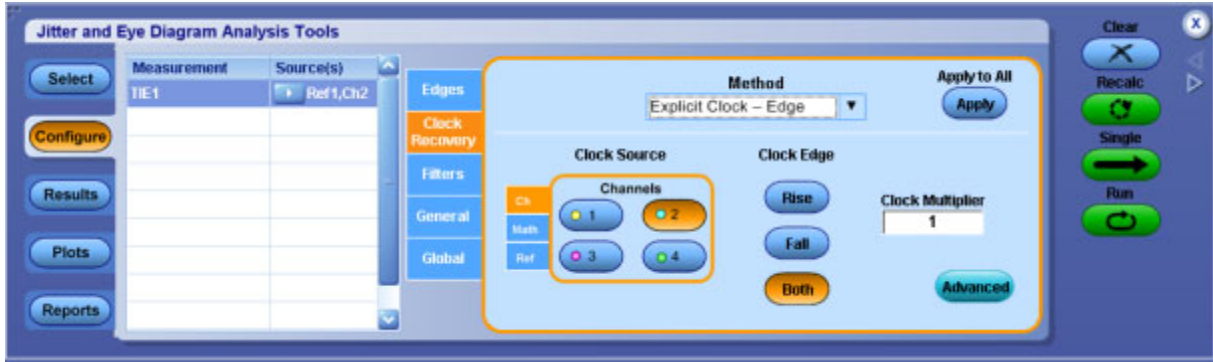


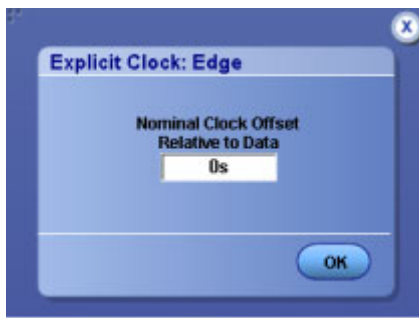
Table 52: Explicit-Clock edge options

Item	Description
Clock Source	Select Ch1 to Ch4, Ref1 to Ref4, or Math1 to Math4 as reference source for clock recovery.
Clock Edge	Specify whether the rising, falling or both edges of selected source should be considered.
Clock Multiplier	Specify the number of edges to be used.
<b>Apply to All</b>	
Apply	Applies the current clock recovery configuration to all selected measurement(s) that have Clock Recovery as configuration tab.
<b>Advanced</b>	Displays the <a href="#">Advanced Explicit Clock-Edge</a> dialog wherein you can adjust the timing relation between reference clock source and data source.

## Advanced Explicit Clock-Edge

To compare the reference clock times to the edge times from the data source, some assumptions must be made about how they align. The default assumption is that each data source edge is associated with the reference clock edge to which it is nearest in time. This assumption may not be optimum, for example if the probes for the reference clock and data signal have different cable lengths.

To change the way the reference clock edges and data edges are associated, you can control the Nominal clock Offset Relative to Data. The (positive or negative) time delay you specify will be used to shift the reference clock edges before the measurement software associates each data edge with the closest clock edge.



### Related Topics

- Effect of Nominal Clock Offset on Eye Diagrams

## Explicit Clock-PLL

Select Explicit Clock-PLL as the clock recovery method if you want to feed the edges from the selected clock source through a PLL rather than using them directly. The actual edges from the clock source will be used to drive a software PLL model, and the edge times coming out of the PLL will be used as the reference edges for the target measurement. If the Clock Multiplier is set to a number N other than 1, the output of the PLL will have N edges per actual edge.

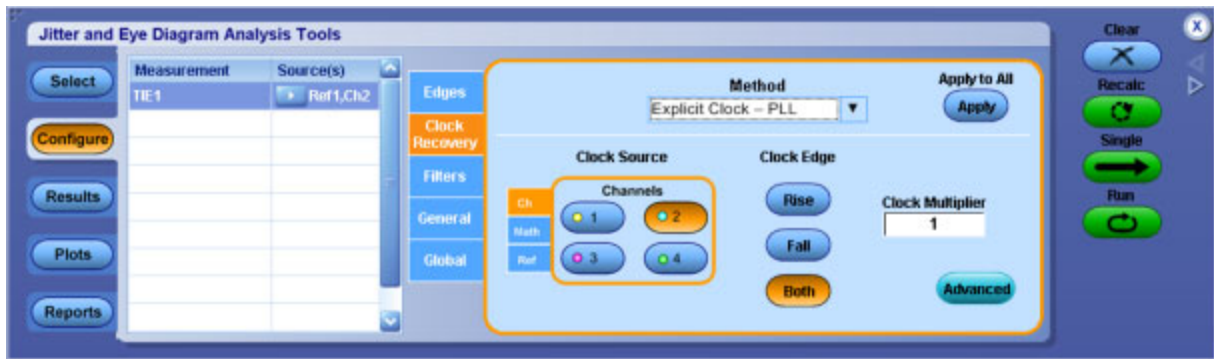


Table 53: Explicit-Clock PLL options

Item	Description
Clock Source	Select Ch1 to Ch4, Ref1 to Ref4 or Math1 to Math4 as reference source for clock recovery.
Clock Edge	Specify whether the rising, falling or both edges of selected source should be considered.
Clock Multiplier	Specify the number of edges to be used.
<b>Apply to All</b>	
Apply	Applies the current clock recovery configuration to all selected measurement(s) that have Clock Recovery as configuration tab.
<b>Advanced</b>	Displays the <a href="#">Advanced Explicit Clock-PLL</a> dialog wherein you can adjust the timing relation between reference clock source and data source.

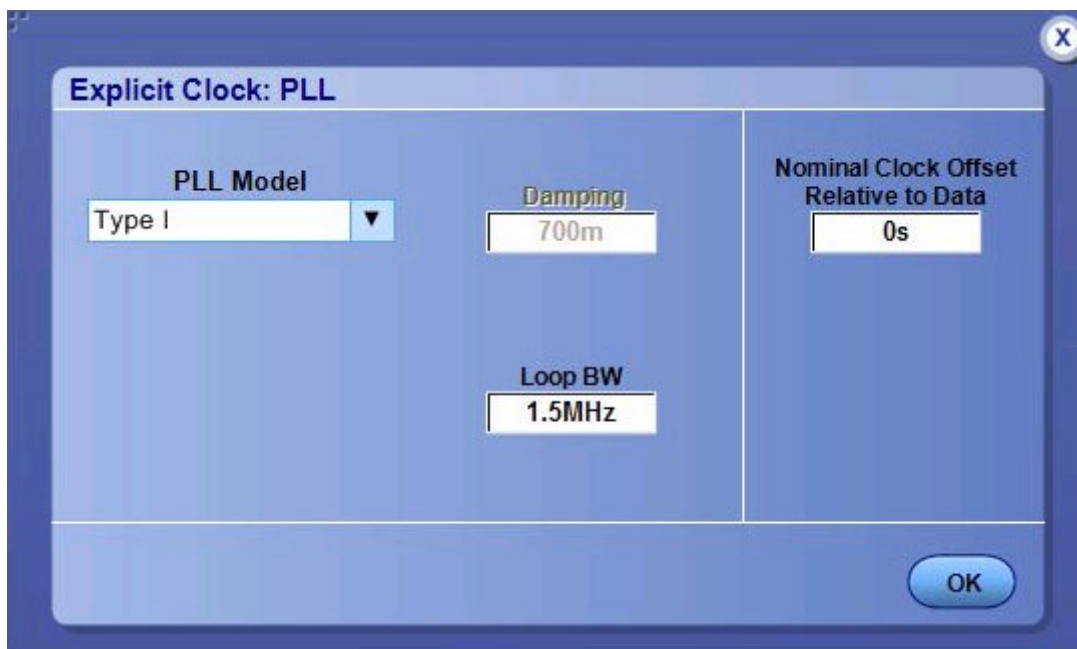
## Advanced Explicit Clock-PLL

In the Advanced Explicit Clock- PLL, you can specify the PLL type, bandwidth, damping factor and nominal clock offset relative to data. Damping numeric input is enabled only for Type II phase-locked loop.

### Nominal Clock Offset Relative to Data

To compare the reference clock times to the edge times from the data source, some assumptions must be made about how they align. The default assumption is that each data source edge is associated with the reference clock edge to which it is nearest in time. This assumption may not be optimum, for example if the probes for the reference clock and data signal have different cable lengths.

To change the way the reference clock edges and data edges are associated, you can control the Nominal clock Offset Relative to Data. The (positive or negative) time delay you specify will be used to shift the reference clock edges before the measurement software associates each data edge with the closest clock edge.



### Related Topics

- Effect of Nominal Clock Offset on Eye Diagrams

## Effect of Nominal Clock Offset on Eye Diagrams

When Explicit Clock Recovery is used, the Nominal Clock Offset, if nonzero, is also applied as a correction to the horizontal axis in any associated eye diagram plot.

Normally the eye diagram is rendered with a width of two unit intervals, with reference clock edges occurring between 25% and 75% across the width of the plot. If the reference clock is derived from the data signal, this places the open part of the eye in the center of the diagram.

Consider the case of Explicit Clock Recovery, when the reference clock is explicitly supplied rather than being derived from the data signal. If the data signal has a nominal offset relative to the clock but the eye diagram still anchors the reference clock to the 25% and 75% points on the horizontal axis, the data eye will be shifted by an amount equal to the nominal offset. To prevent this shift, any offset entered as the Nominal Clock Offset Relative to Data is applied to the data before it is rendered.

A convenient way to set up an eye diagram in such cases is to first perform an Explicit-Clock TIE measurement on the data signal with the Nominal Clock Offset set to zero. When the measurement completes, note the mean value of the TIE measurement. Next, enter this mean TIE as the Nominal Clock Offset Relative to Data. If the TIE measurement is now repeated, it should result in a mean TIE near zero, and an eye diagram that has the open portion of the eye centered horizontally.



## Bit Config for Eye Height Measurements

This configuration tab allows you to select which waveform bit types (Transition bits, Non-Transition or All bits) are included when measuring Eye Height.

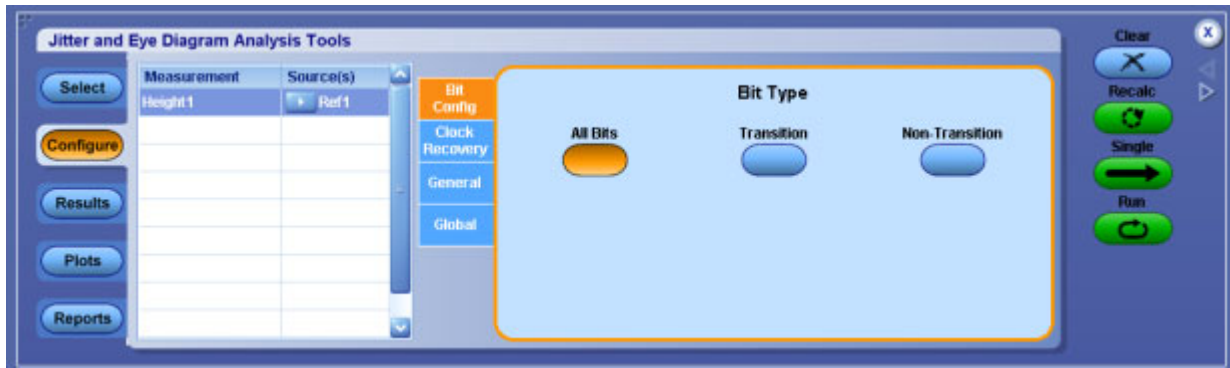


Table 54: Bit Config for eye height

Item	Description
<b>Bit Type</b>	
All Bits	Eye analysis includes both transition and non-transition bits.
Transition	Eye analysis only on transition bits.
Non-Transition	Eye analysis only on non-transition bits.

## Bit Config for Mask Hits Measurements

This configuration tab allows you to select the waveform bit type (All bits, Transition, Non-Transition) and the mask to be used for Mask Hits measurements.

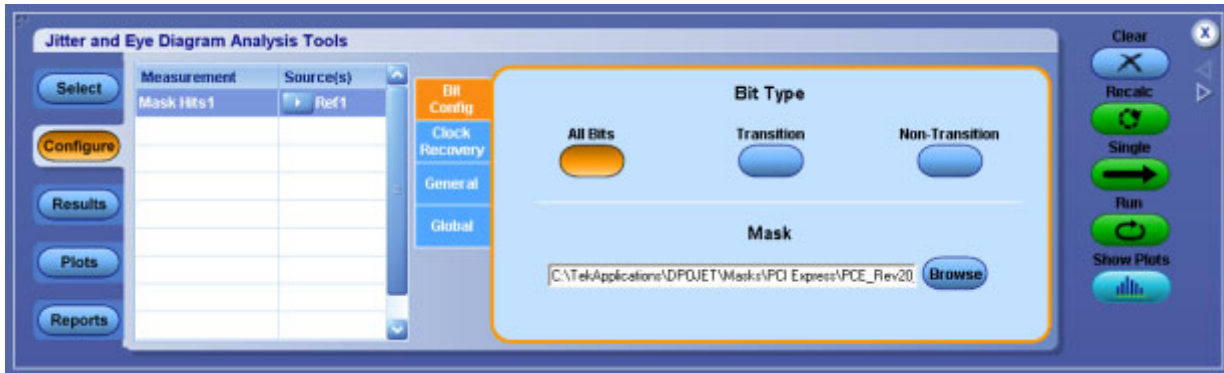


Table 55: Bit Config for mask hits

Item	Description
<b>Bit Type</b>	
All Bits	Eye analysis includes both transition and non-transition bits.
Transition	Eye analysis only on transition bits.
Non-Transition	Eye analysis only on non-transition bits.
<b>Mask</b>	
Browse	Allows selection of the mask file. (If none of the supplied mask files meets your need, you may create a custom mask file with a text editor by using one of the existing mask specification files as a template.)

## Bit Config for Amplitude Measurements

This configuration tab is present only for **High**, **Low** and **High-Low** measurements. You can select the waveform bit type (All Bits, Transition, Non-Transition) and method.

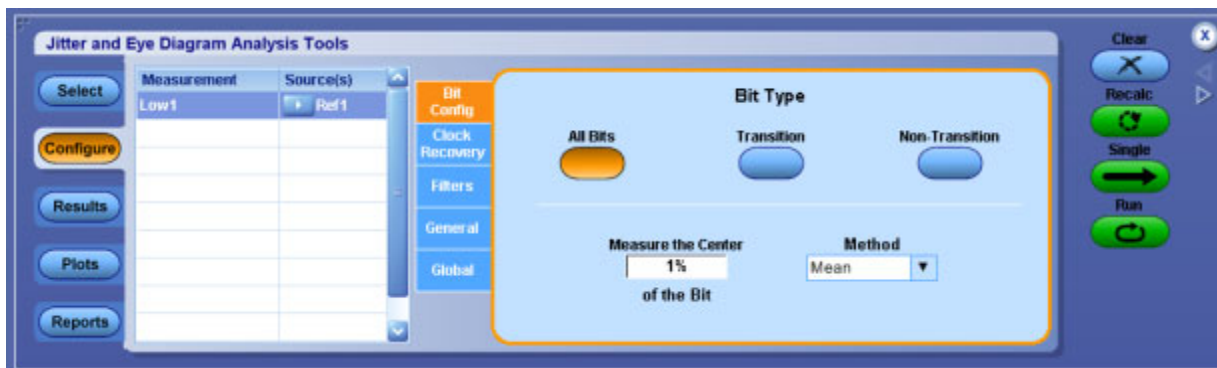


Table 56: Bit Config for amplitude measurements

Item	Description
<b>Bit Type</b>	
All Bits	Eye analysis includes both transition and non-transition bits.
Transition	Eye analysis only on transition bits.
Non-Transition	Eye analysis only on non-transition bits.
<b>Measure the Center X% of the Bit</b>	Determines what percentage (1 to 100) of a unit interval, centered in the middle of the bit, shall be included in each measurement. The waveform points selected by the percentage form a distribution (vertical histogram) from which a single value is extracted, based on the Method control.
<b>Method</b>	Determines whether the Mean value or the Median of the selected distribution is used for the measurement value for each unit interval.

## About RJ/DJ

This configuration tab allows you to select an appropriate decomposition method for jitter analysis. RJ/DJ decomposition analysis breaks the timing jitter into various categories and uses the results to predict the total jitter at a selected bit error rate (BER). The RJ/DJ tab is present for the RJ, DJ, PJ, DCD, DDJ, RJ- $\delta\delta$ , DJ- $\delta\delta$ , TJ@BER and Width@BER measurements.

The DPOJET application offers two methods of RJ/DJ analysis:

- A method based on spectral analysis that is appropriate for cyclically repeating data patterns.

- A method that works for arbitrary data sequences.

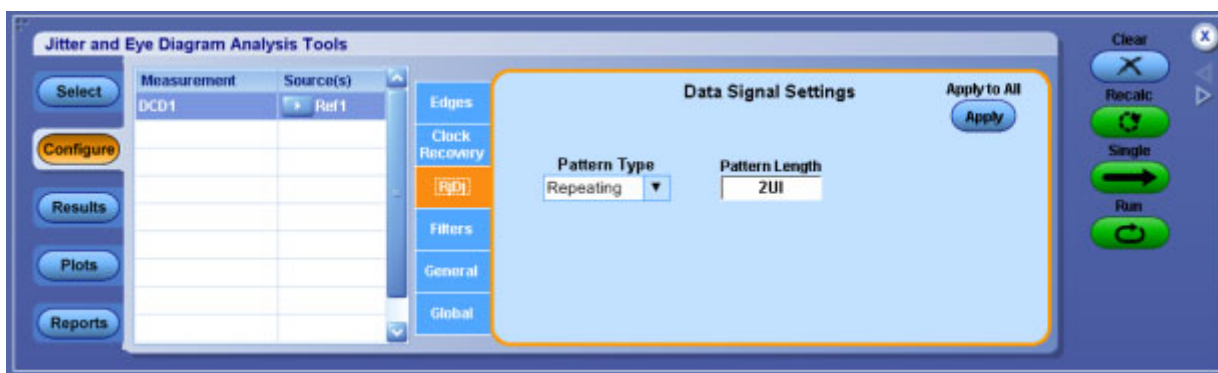
### Related Topics

- RJDJ Analysis of Arbitrary Pattern
- RJDJ Analysis of Repeating Pattern

## RJ/DJ Analysis of Repeating Pattern

This method of RJ/DJ analysis uses a Fourier transform of the time-interval error signal to identify and separate jitter components. It is described in the Fibre Channel - Methodologies for Jitter and Signal Quality Specification (MJSQ) and has wide industry acceptance.

This method requires that the data signal be composed of a pattern of N bits that are repeated over and over. The pattern length (N) must be known, although it is not necessary to know the specific bits that make up the pattern.



**Table 57: RJ/DJ analysis of repeating options**

Item	Description
<b>Data Signal Settings</b>	
Pattern Type	Selects between repeating or arbitrary pattern analysis.
Pattern Length	When the Pattern Type is set to Repeating, sets the pattern length of the repetitive pattern data; use for spectrum analysis RJ/DJ separation.
<b>Total Jitter Component</b>	
BER= 1E-? ‡	Sets the Bit Error Rate exponent, thereby setting the statistical level at which Total Jitter and Eye Opening are reported.
<b>Apply To All</b>	
Apply	Applies the current settings to all the measurements having RJDJ configuration tab.

‡ Only available for TJ@BER and Width@BER measurements.

## RJ/DJ Analysis of Arbitrary Pattern

When the data pattern is not repeating, or is unknown, a second method of RJ/DJ analysis may be used. (It may also be used if the pattern is repeating, and correlates well with the Spectral method in this case.) This method assumes that the effects of Inter Symbol Interference (ISI) only last for a few bits. For example, in a band-limited link where a string of ones follows a string of zeros, the signal may require three or four bit periods to fully settle to the “high” state.

In this method, an analysis window with a width of K bits is slid along the waveform. For each position of the window, the time interval error of the rightmost bit in the window is stored, along with the K-1 bit pattern that preceded it. After the window has been slid across all positions, it is possible to calculate the component of the jitter that is correlated with each observed K-1 bit pattern, by averaging together all the observed errors associated with that specific pattern.

In the configuration menu for the arbitrary-pattern method, the Window Length field allows you to select how many bits are included in the sliding window. The window should include enough bits to encompass the impulse response of the system under test, usually 5 to 10 bits. A good practical test is to check whether increasing the window length causes any appreciable change in the jitter results; if not, the window length is effectively capturing all the ISI effects. The disadvantage of increasing the window length is that it uses more memory and requires additional processing time.

The configuration menu also includes a field for selecting what population of each K-1 bit pattern must be accumulated before the TIE associated with that pattern is considered accurate. Using a larger population means that more observations are averaged together, so that the variance of the measurement is reduced. Specifying a larger population has the disadvantage of requiring a longer measurement period before results can be calculated and it may be necessary to sequence the instrument several times before enough statistics are accumulated to provide results.

The arbitrary pattern approach for measuring jitter may not be appropriate if there are very-long-duration memory effects in your data link. An example would be if there are impedance mismatch reflections that arrive long enough after the initial edge to fall outside the analysis window.

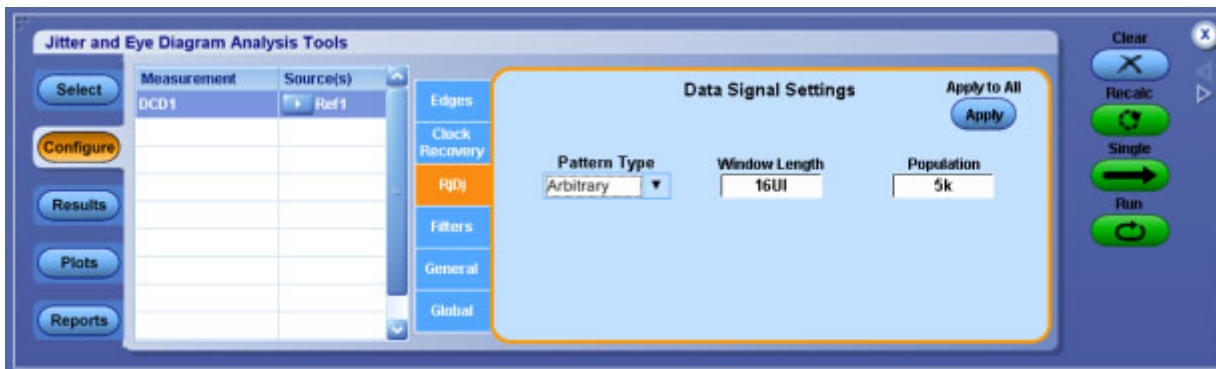


Table 58: RJ/DJ analysis of arbitrary options

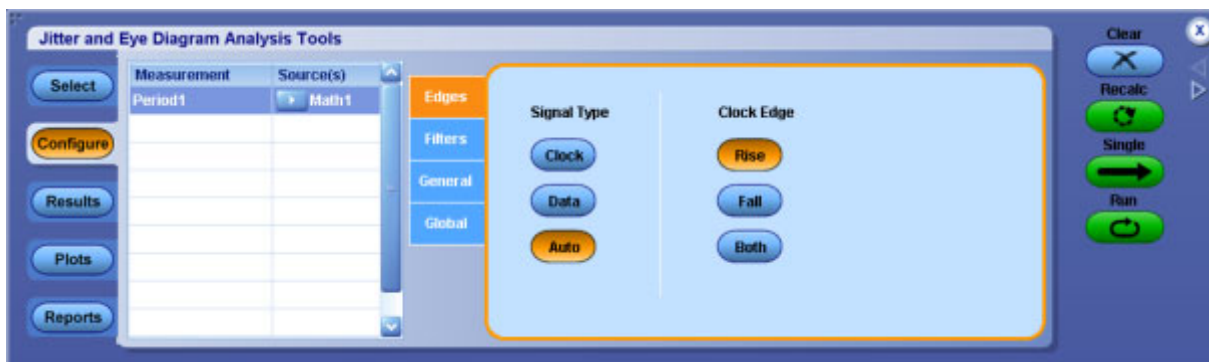
Item	Description
<b>Data Signal Settings</b>	
Pattern Type	Selects between repeating or arbitrary pattern analysis.
Window Length	When the Pattern Type is set to Arbitrary, sets the pattern window length in terms of Unit Interval (UI) used for arbitrary pattern RJ/DJ separation.
Population	When the Pattern Type is set to Arbitrary, sets the minimum population limit for each pattern to be qualified for arbitrary pattern RJ/DJ separation.
<b>Total Jitter Component †</b>	
BER= 1E-?	Set the Bit Error Rate exponent, thereby setting the statistical level at which Total Jitter and Eye Opening are reported.
<b>Apply to All</b>	
Apply	Applies the current RJ/DJ configuration settings to all the selected measurement(s) having RJ/DJ configuration tab.

† Available only for TJ@BER and Width@BER measurements.

## Configuring Edges

This configuration tab allows you to select which waveform edge or edges the application will use to take each measurement. Depending on the particular measurement, the tab will offer access to other options and constraints that help guide the analysis. The application is able to automatically detect whether a signal is clock or data, and will do so by default. This can be overridden by configuring the signal type as Clock or Data.

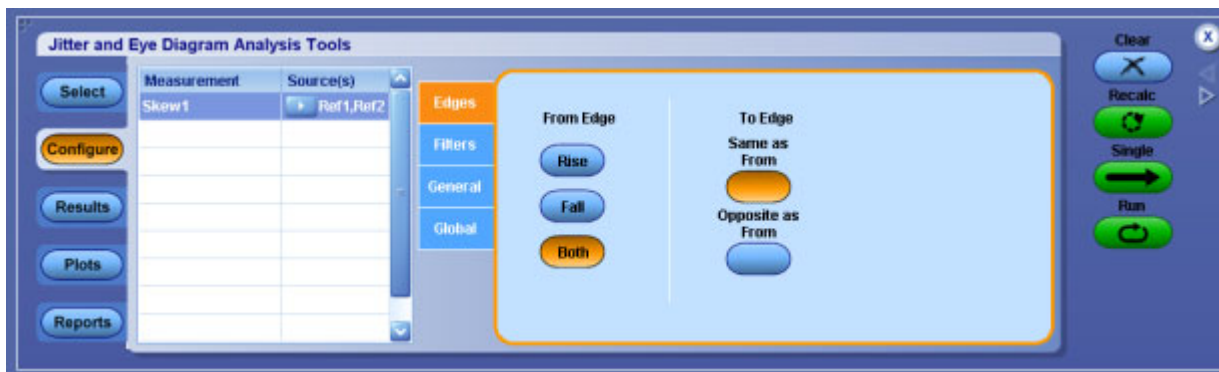
The following configuration options apply to most measurements. Please see the subsequent sections for Edge tabs corresponding to particular measurements.



Item	Description
<b>Signal Type</b>	
Clock	Forces the signal type to be interpreted as a Clock. Measurements will take place on the edges specified by the Clock Edge control.
Data	Forces the signal to be interpreted as a Data. Both rising and falling edges are used.
Auto	Allows the application to automatically detect whether the signal is clock or data. If the signal is a clock, the Clock Edge control will determine which edges are used; otherwise the Clock Edge control will have no effect.
<b>Clock Edge</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.

## Configuring Edges for Skew Measurements

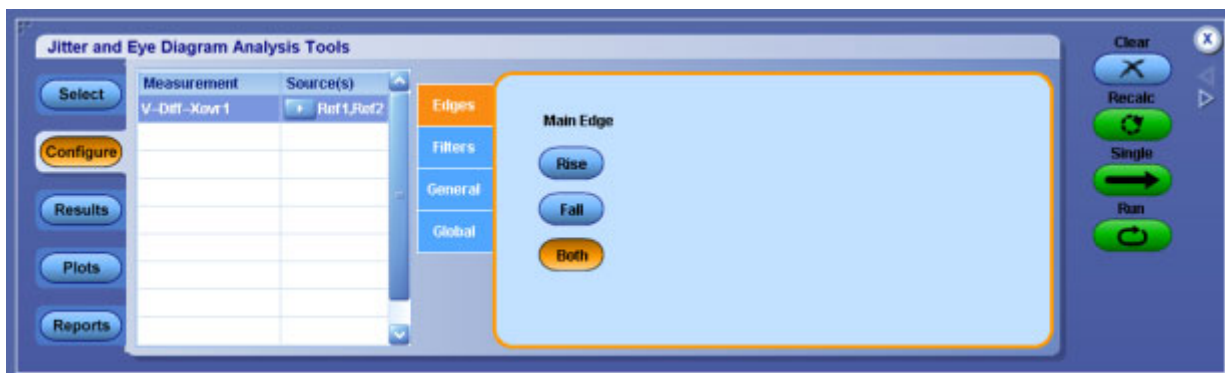
This configuration tab is displayed for Skew measurements.



Item	Description
<b>From Edge - Defines which edge of the first waveform is used to take measurements.</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.
<b>To Edge - Defines which edge on the second waveform is used to take measurements.</b>	
Same as From	Each measurement is defined by a pair of like edges (Rise to Rise or Fall to Fall).
Opposite as From	Each measurement is defined by a pair of opposing edges (Rise to Fall or Fall to Rise).

## Configuring Edges for Differential CrossOver Voltage Measurements

This configuration tab is displayed for Differential CrossOver Voltage measurements.



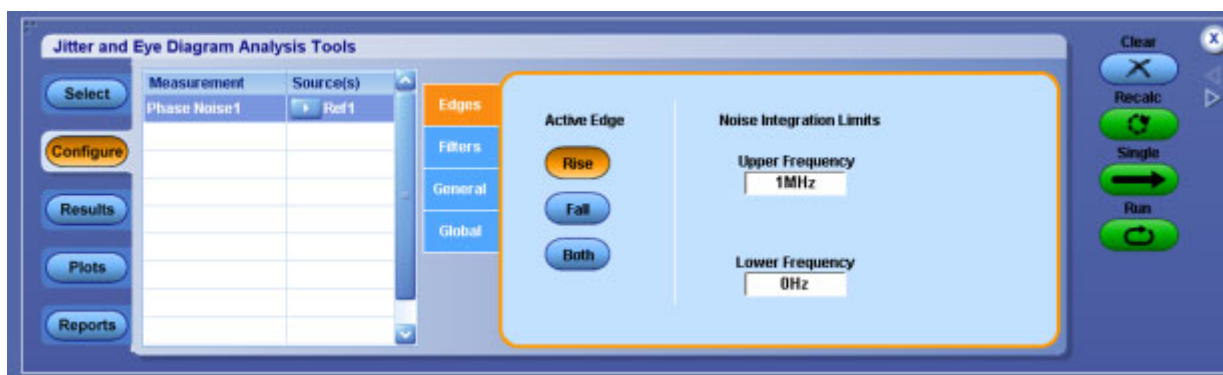
Item	Description
<b>Main Edge - Defines which edges on the Source1 waveform are used to take the measurement.</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.



## Configuring Edges for Phase Noise Measurements

This configuration tab is displayed for Phase Noise measurements. Phase noise measurements are undefined for data signals, so the signal is assumed to be a clock.

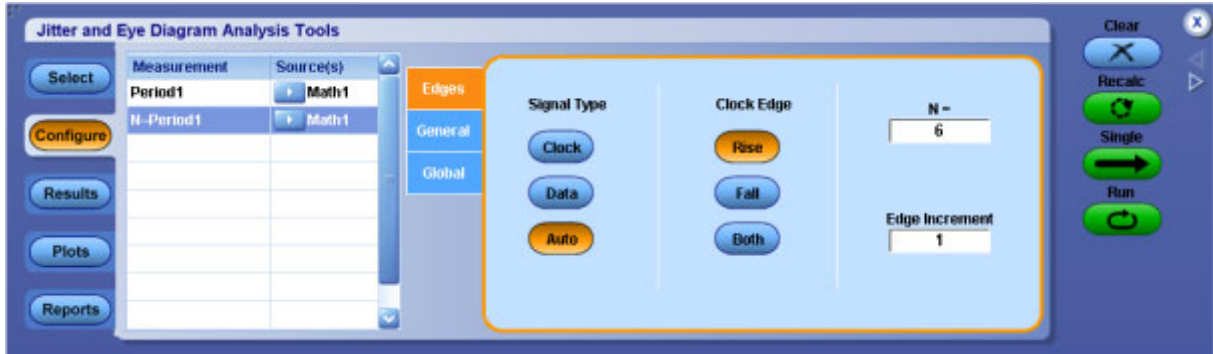
The Noise Integration Limits determine the portion of the phase noise spectrum that is integrated to produce a single measurement per waveform acquisition.



Item	Description
<b>Active Edge-Defines which edge of the source waveform is used to take measurements.</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.
<b>Noise Integration Limits</b>	
Upper Frequency	Sets the upper end of the noise integration frequency range.
Lower Frequency	Sets the lower end of the noise integration frequency range.

## Configuring Edges for N-Period Measurements

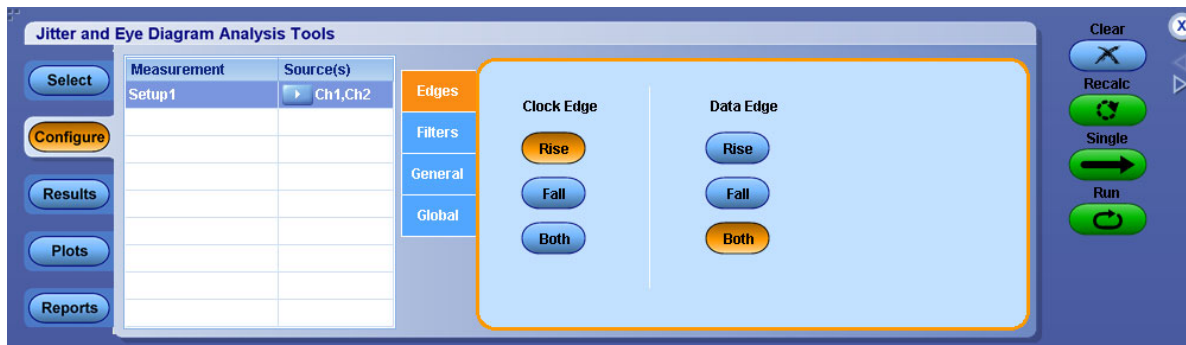
This configuration tab is displayed for N-Period measurements.



Item	Description
<b>Signal Type</b>	
Clock	Forces the signal to be interpreted as a Clock. Measurements will take place on the edges specified by the Clock Edge control.
Data	Forces the signal to be interpreted as a Data. Both rising and falling edges are used.
Auto	Allows the application to automatically detect whether the signal is clock or data. If the signal is a clock, the Clock Edge control will determine which edges are used; otherwise the Clock Edge control will have no effect.
<b>Clock Edge</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.
<b>N=</b>	Specifies number of cycles or unit interval in each N-period group.
<b>Edge Increment</b>	Specifies the temporal displacement in edges between consecutive measurements.

## Configuring Edges for Two Source Measurements

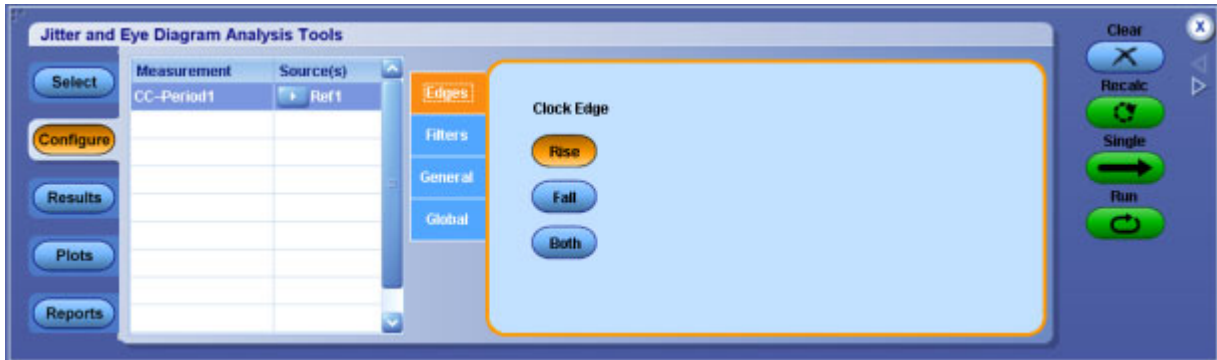
This configuration tab is displayed for two source measurements: Setup and Hold.



Item	Description
<b>Clock Edge</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.
<b>Data Edge</b>	
Rise	Only the rising edges of the signal are used.
Fall	Only the falling edges of the signal are used.
Both	Both the rising and falling edges of the signal are used.

## Configuring Edges for CC-Period/Duty Cycle Measurements

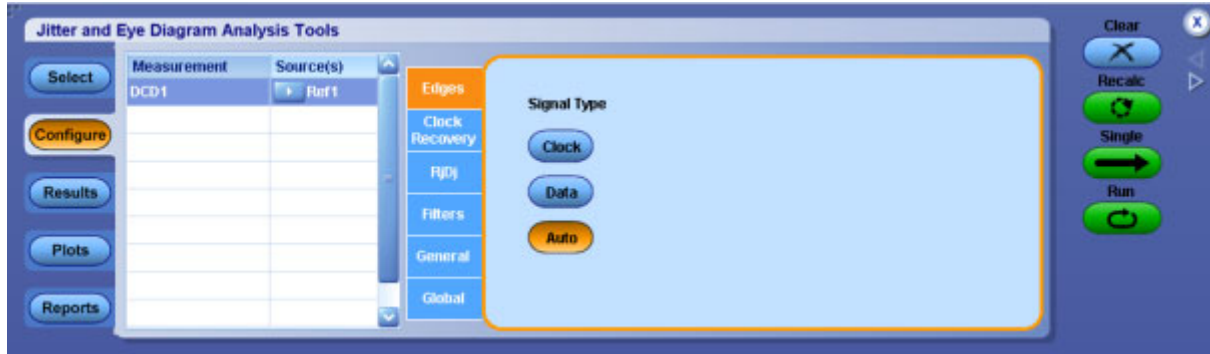
This configuration tab is displayed for the CC-Period, +Duty Cycle and -Duty Cycle measurements. These measurements are only defined for clock signals, and each measurement value is evaluated over one full clock cycle.



Item	Description
<b>Clock Edge</b>	
Rise	Measurements are only initiated on the Rising edges of the clock signal.
Fall	Measurements are only initiated on the Falling edges of the clock signal.
Both	Measurements are initiated on both the Rising and falling edges of the clock signal.

## Configuring Edges for DCD Measurement

This configuration tab is displayed for DCD measurement.



Item	Description
<b>Signal Type</b>	
Clock	Forces the signal type to Clock. Edges are selectable.
Data	Forces the signal type to Data. Both rising and falling edges are used.
Auto	Automatically detects whether the signal is clock or data.

## Sequencing

Use the [Control Panel](#) to start or stop the sequence of processes the application and oscilloscope use to acquire information from a waveform. The application then determines if the algorithm for the selected measurement can be applied to the waveform information. Sequencing is the steps to acquire waveform information, determine if the information is usable for the measurement, take the measurement, and display the results (and plots if selected).

When you click Recalc, Single or Run, the corresponding button is changed to Stop and the Progress indicator is displayed. For more details, refer to the [Control Panel](#).



The Progress Indicator displays the sequencer state. Select Stop, if you want to interrupt the sequence before its completion.

For more details on progress bar status messages, refer to [Progress Bar Status Messages](#).

## Viewing Statistical Results

There are two ways to view the statistical results of measurements:

- Summary
- Details

The application displays results for the measurements for all acquisitions or for the current acquisition. By default in the detail view, the limits will not be shown unless the limits are turned on.

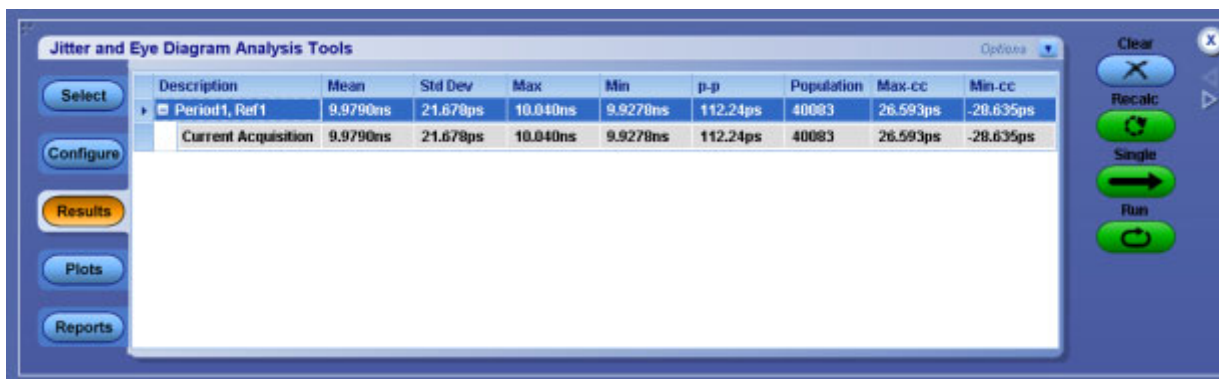







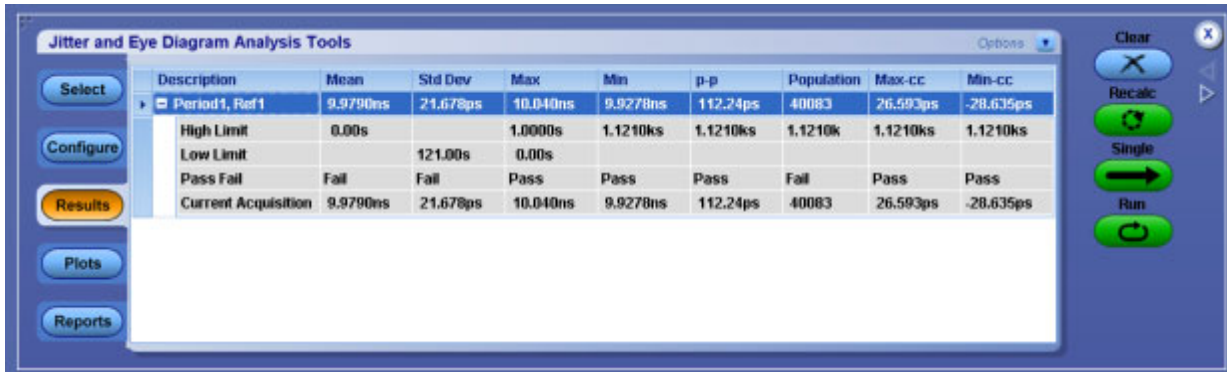


Table 59: Results menu options

Item	Description
	Displays an error message. You can click  to view the error log information in a text editor.
	Displays a warning. You can click  to view the error log information in a text editor.
Description	Lists the measurement name and the source.
Mean	Lists a statistical mean value for the measurement data.
Std Dev	Lists a statistical standard deviation value for the measurement data.
Max	Lists a statistical maximum value for the measurement data.
Min	Lists a statistical minimum value for the measurement data.
p-p	Lists a statistical peak-to-peak value for the measurement data.
Population	Lists the total number of measurement data points used for displaying the statistics.
Max-cc	Lists the maximum cycle-to-cycle differences per acquisition.
Min-cc	Lists the minimum cycle-to-cycle differences per acquisition.
	Click to view Save Current Stats, View Result Summary, View Result Details, Export to Ref Waveform, View Plot Summary, and Display Units-Absolute options.
Options	
Save Current Stats...	Saves the current statistics as log information.
View Results Summary	Displays the summary of the results for all acquisitions.
View Results Details	Displays the detailed results specifying values for High Limit, Low Limit, Pass/Fail, and current acquisition.
Export to Ref Waveform	Exports time trend data of the selected measurement to the reference memory.
Display Units- Absolute	Default display unit is Absolute.
	Click to view the result details.


**NOTE.** For Mask Hits measurement, only Mean, Max, Min and Population values are displayed in the results table. On clicking , Hits in Segment 1, Segment 2 and Segment 3 are displayed. For Mask Hits measurements, mean indicates the total number of hits for all acquisitions.

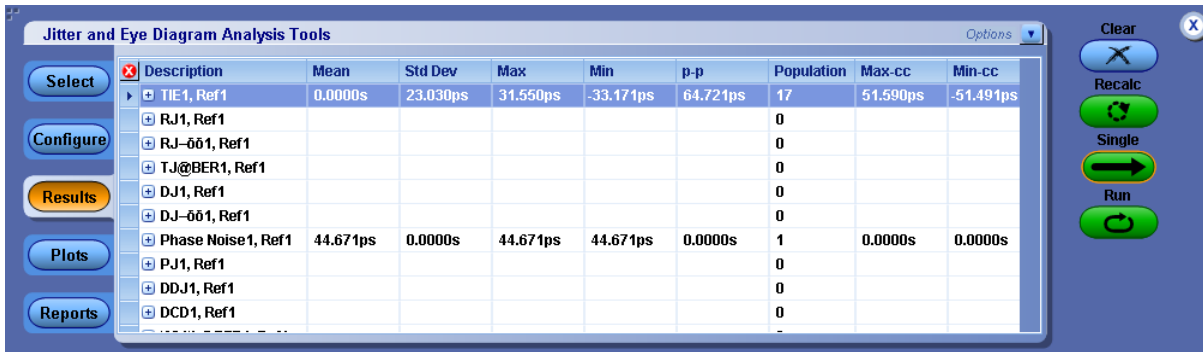
The results tab with limits turned on is as follows:




Description	Mean	Std Dev	Max	Min	p-p	Population	Max-cc	Min-cc
Period1, Ref1	9.9790ns	21.678ps	10.040ns	9.9278ns	112.24ps	40083	26.593ps	-28.635ps
High Limit	0.00s		1.0000s	1.1210ks	1.1210ks	1.1210k	1.1210ks	1.1210ks
Low Limit		121.00s	0.00s					
Pass Fail	Fail	Fail	Pass	Pass	Pass	Fail	Pass	Pass
Current Acquisition	9.9790ns	21.678ps	10.040ns	9.9278ns	112.24ps	40083	26.593ps	-28.635ps

### Results with Error/Warning Notification

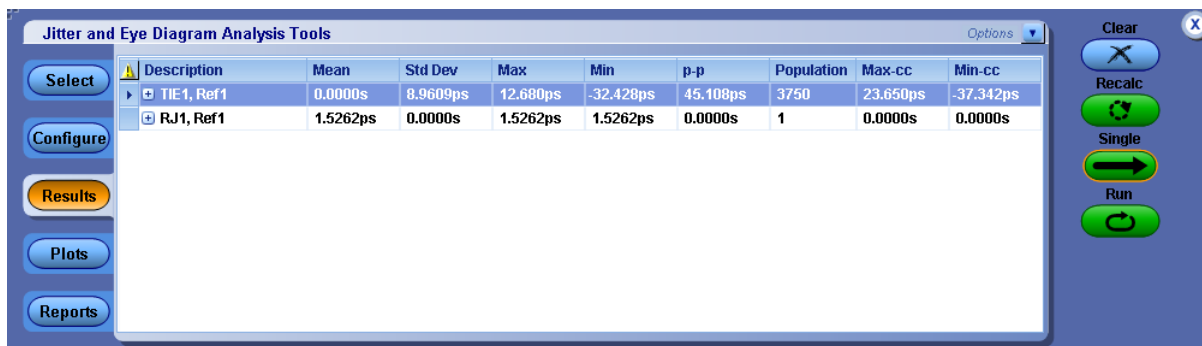
The results tab with error  icon is as shown. You can click **View Log** to view the error log information in a text editor.




Description	Mean	Std Dev	Max	Min	p-p	Population	Max-cc	Min-cc
TIE1, Ref1	0.0000s	23.030ps	31.550ps	-33.171ps	64.721ps	17	51.590ps	-51.491ps
RJ1, Ref1						0		
RJ-001, Ref1						0		
TJ@BER1, Ref1						0		
DJ1, Ref1						0		
DJ-001, Ref1						0		
Phase Noise1, Ref1	44.671ps	0.0000s	44.671ps	44.671ps	0.0000s	1	0.0000s	0.0000s
PJ1, Ref1						0		
DDJ1, Ref1						0		
DCD1, Ref1						0		

The results tab with warning  icon is as shown. You can click **View Log** to view the error log information in a text editor.





## Export Results to Ref Waveform

Using this option, you can export the time trend plot of a measurement to any of the available reference memory, Ref1-Ref4. Click  on the right corner of the results panel to select the “Export Results to Ref” option.

The Export Results to Ref waveform dialog box appears. It lists all the possible measurements that have time trend result data (that is measurements for which time trend plot is enabled in the plot panel).

From the list of measurements, results of any **one** measurement can be exported to any **one** of the reference memory (Ref1-Ref4) which is not used as source of any measurement.



Before exporting results to a reference memory, the application checks for the following:

- If any of the ref waveforms are already used as source for one of the measurement(s), then you cannot export the results on those ref destinations. The application prevents exporting by displaying an error message [2003](#).
- If all the reference waveforms (Ref1-Ref4) are already used as sources for various measurements, the “Export Results to Ref Waveform” is not displayed. Instead, an error message [2002](#) is displayed.
- If a ref destination is assigned to a measurement from the list which is not empty (that is, if the ref is already defined and holds any other recalled waveform), a warning prompts you from overwriting the existing definition of the selected destination ref.
- In case of any error (2002 or 2004) or warning (Overwriting the existing definition) and you select the response as “No”, the destination ref reverts to its previous value. For example, if the selected measurement is Period-Ref1, and the destination ref assigned to the measurement is Ref3, and if you try to change the destination from Ref3 to Ref1, an error message [2003](#) is displayed. Ref3 is retained as the destination ref.
- Time trend result export to the reference waveform for a measurement is independent of time trend plot. Time trend result can be exported to ref without selecting/defining plots in the plots panel.
- If “Export Results to Ref” is selected without any measurement selection, an error message [2005](#) is displayed.
- If none of the selected measurements have time trend data, an error message [2007](#) is displayed and “Export Results to Ref” dialog is not displayed.
- If the selected measurements have no results (results are cleared or measurements are not run to produce results), an error message [2006](#) is displayed and “Export Results to Ref” dialog box is not displayed.
- If the destination is none for all measurements, the results are not exported to ref on clicking **OK**. An information/warning [2008](#) is displayed.

## Results as Plots

The application can display the results as two-dimensional plots for easier analysis. Before or after you take measurements, you can set up the Select Plots and Plots Configure menus to define up to four plots. The last plot selected is displayed when the application completes [sequencing](#).

If you set up plots after sequencing, the application displays the plot based on the current measurement and result.

---

**NOTE.** *When taking measurements in the Run mode, you must stop the sequencing before you can use some plot features.*

---

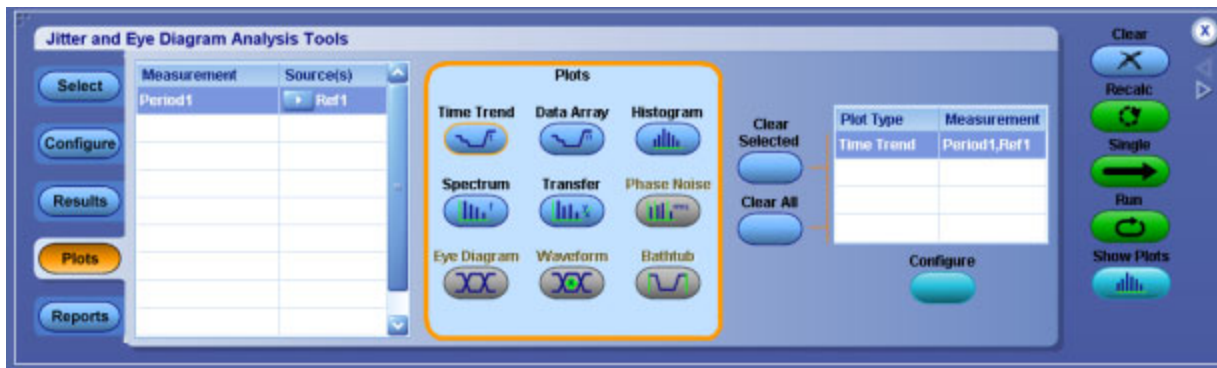


Table 60: Plot type definitions

Item	Description
Time Trend	Represents the measurement values versus the time location.
Data Array	Represents the measurement values versus the index number of the measurement array.
Histogram <sup>1</sup>	Represents measurements sorted by value as a distribution of measurement values versus the number of times the value occurred.
Spectrum	Represents the frequency content computed using the FFT of the Time Trend of the measurement data.
Transfer	Represents the magnitude ratio of spectrum of time trend data of two measurements from the following set: Clock Period, Clock Frequency, Clock TIE, Clock PLL TIE, Data Period, Data Frequency, Data TIE, Data PLL TIE.
Phase Noise <sup>2</sup>	Represents the phase noise of a clock signal and is plotted in the frequency domain for only Clock TIE measurements.
Eye Diagram <sup>3</sup>	Represents data for the eye diagram based on the recovered clock as the timing reference; used for mask testing.
Waveform <sup>4</sup>	Represents the acquired waveform. It is available for use with eye diagram mask tests to locate bit errors in the real-time waveform.
Bathtub <sup>5</sup>	Represents the Bit Error Rate versus the unit interval for measurements that include RJ/DJ analysis.

<sup>1</sup> Available for all measurements except Mask Hits.  
<sup>2</sup> Available only for Phase Noise measurement.  
<sup>3</sup> Available only for all Eye and TIE measurements.  
<sup>4</sup> Available only for Mask Hits measurement.  
<sup>5</sup> Available for TJ@BER and Width@BER measurements.

You can select the measurements from the displayed measurement list table on the left. The Plots for the selected measurements are displayed in Select Plots. The plots which are not applicable for the selected measurement are not available under Select Plots. You can select up to 4 plots.

## Plot Usage

This section provides a description of various plots such as Histogram, Time Trend, Data Array, Spectrum, Transfer, Phase Noise, Eye Diagram, Waveform, and Bathtub.

### Histogram Plot Usage

A Histogram plot displays the results such that the horizontal axis represents the measurement values and the vertical axis represents the number of times that each value occurred. Unlike most other plots, a histogram plot can accumulate measurements over multiple acquisitions, up to a total population size of 2.1 billion.

Histograms are particularly useful in analyzing jitter. A histogram of the Time Interval Error (TIE) represents the basis of jitter analysis using a histogram approach. In a histogram, Deterministic Jitter (DJ) is bounded so that the horizontal span of the plot will remain relatively constant. Random Jitter (RJ) is unbounded and amplitude (horizontal span) will continue to grow as more population is acquired. The TIE histogram provides a good way to quickly and informally assess jitter.

### Spectrum Plot Usage

A Spectrum plot is obtained from the Fourier Transform of measurement data from a Time Trend. This plot is useful in identifying periodic frequency components that contribute to timing errors, such as phase modulation.

When the signal has a repetitive data pattern, an analysis of the TIE Spectrum of the signal can be used to separate Random Jitter (RJ) from Deterministic Jitter (DJ) as well as to separate subcomponents such as Periodic Jitter (PJ), ISI and DCD. Spectral components (spikes) that do not correlate with the frequencies contained in the data pattern can be a clue that external deterministic noise sources are coupling into a system.

### Data Array Plot Usage

A Data Array plot shows measurement values versus measurement index, where the indexes are always equally spaced along the horizontal axis. In contrast, the measurement values on a Time Trend plot are not equally spaced along the horizontal time axis.

### Time Trend Plot Usage

A Time Trend plot is a waveform trace of a measurement versus time. Each measurement value is placed precisely at the time at which the measurement took place. Measurements that involve two timing points

are placed at the midpoint between those two time. For example, a Risetime measurement is placed halfway between the low threshold crossing and the high threshold crossing.

A Time Trend plot is useful, for example, in determining if the embedded clock in a serial bit stream is modulated outside the capabilities of your receiver to recover the clock. If the TIE time trend plot starts to take an unexpected periodic shape, then this could indicate that you have uncorrelated periodic jitter from crosstalk or from power supply coupling.

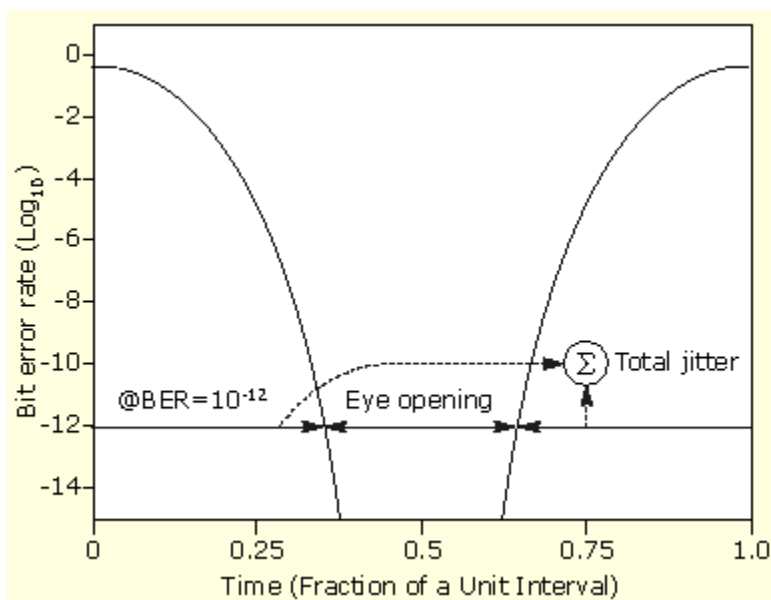
### Bathtub Plot Usage

A Bathtub curve is the industry standard way of viewing the statistical Jitter Eye Opening. A Bathtub curve represents eye opening as a function of the BER (Bit Error Ratio). Most serial standards call for Total Jitter to be measured at a BER of  $10^{-12}$ . The eye opening represented by the Bathtub Curve is what is left of the unit interval after the total jitter measurement is subtracted.

The Jitter Eye opening and the Total Jitter have the following relationship:

$$\text{Total Jitter} + \text{Jitter Eye Opening} = 1 \text{ Unit Interval}$$

The Bathtub Curve plot shows the eye opening and total jitter values as functions of the BER level. The plot is obtained from jitter analysis that performs RJ/DJ separation.



### Phase Noise Plot Usage

A Phase Noise plot shows a frequency domain view of the jitter noise on a waveform normalized in an industry-standard way. The vertical axis is logarithmic and uses the units of dBc/Hz, which means “decibels (relative to the carrier) per Hertz”. The horizontal axis is logarithmic with units.

### Transfer Function Plot Usage

A Transfer Function plot shows the magnitude ratio of the frequency spectrums of two measurements on logarithmic axes. This can be a useful way to depict the response of a system to stimuli at various frequencies, or to identify poles and zeros in a system characteristic equation. Suppose that  $x(t)$  is a jitter measurement at the input of a device, and  $y(t)$  is a corresponding jitter measurement at the output of the device. The Transfer Function plot can be used to show the following function, where  $X(f)$  is the Fourier Transform of  $x(t)$ :

$$H(f) = \frac{|Y(f)|}{|X(f)|}$$

The horizontal axis of the Transfer Function plot goes up to the Nyquist frequency of  $X$  or  $Y$ , whichever is lower. These plots work best if averaged across multiple acquisitions to reduce the effects of measurement noise.

### Waveform Plot Usage

The waveform plot is only applicable to the Mask Hits measurement. It depicts a copy of the source waveform, with all mask violations denoted in a highlight color. These are the same violations that appear on the Mask Hits eye diagram, but the waveform plot allows them to be seen in the context of a continuous-time waveform.

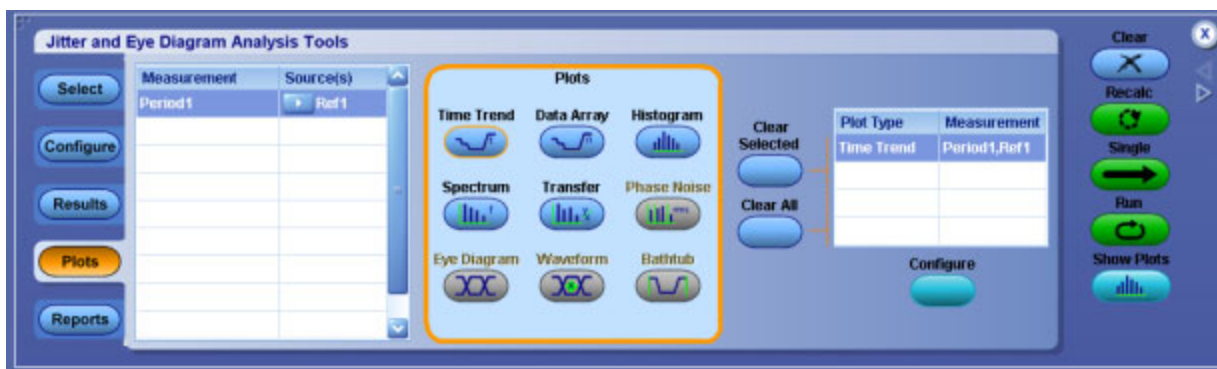
### Eye Diagram Plot Usage

An eye diagram is a plot of the voltage versus time for a serial bit stream, with the time axis “wrapped” so that all unit intervals are superimposed on top of each other in a time-aligned fashion. Because the resulting plot has many waveforms overlaid, color grading is used to separate areas with many coincident waveforms from areas that are only rarely crossed.

If there is an area free of waveforms in the center of the diagram, the eye is said to be “open”, and a comparator circuit repetitively sampling the waveform at this point in the unit interval could unambiguously separate the two logic states. For experienced signal integrity engineers, the eye diagram allows many common problems to be recognized instantly.

## Selecting Plots

Before or after you take measurements, you can set up plots for the selected measurements by following these steps:



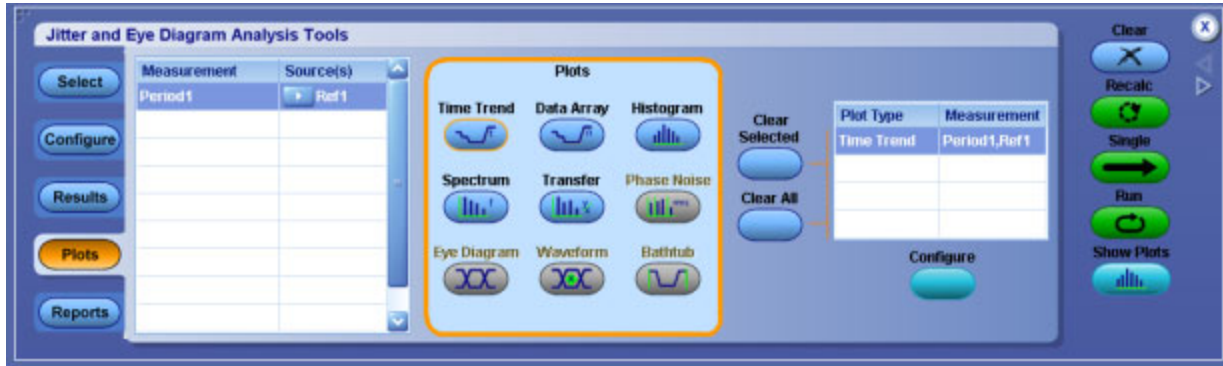
1. Click **Plots** in the [navigation panel](#) to view the Select Plot window. The currently active measurements and source(s) are displayed in the table on the left (measurement table).
2. Click any of the plot icons that are available for the selected measurement. The corresponding plot type and measurement are then added to a table on the right (plot table).
3. Add another plot for the current measurement, or select a different measurement and choose from its plot types. A maximum of four plots can be selected at any given time.

**Table 61: Plot selections**

Item	Description
Plots	Lists only the plots which are available for the selected measurement. Click a plot icon to add the plot type to the table on the right.
Clear Selected	Clears the selected plot from the plot table.
Clear All	Clears all plots from the plot table.
Configure	Allows you to adjust display options for the selected plot.

## About Configuring Plots

Most plot types (except Data Array and Waveform) have display options that can be adjusted for each instance of the selected plot.



The steps to configure a plot are:

1. Select a plot instance by clicking on a row from plot table on the right.
2. Click **Configure** to display a pop-up window with the available configuration options.
3. Adjust the configuration options and click **OK** to accept the changes and close the window.
4. Click **Show Plots** in the control panel to view the configured plot.

---

**NOTE.** The Show Plots icon appears in the [control panel](#) only when one or more plots are defined.

---

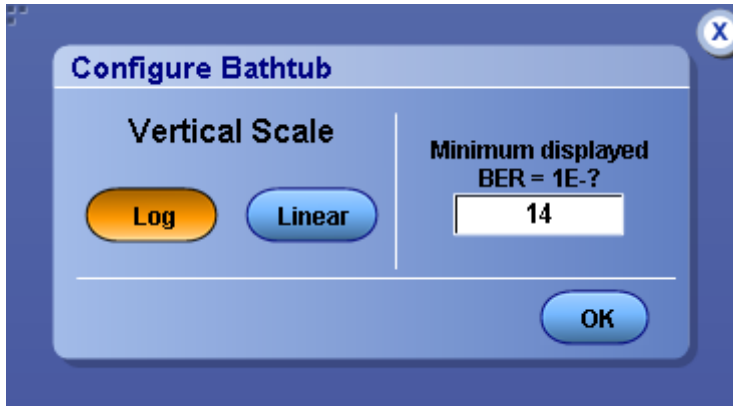
### Related Topics

- Configuring a Time Trend
- Configuring a Histogram Plot
- Configuring a Spectrum Plot
- Configuring a Transfer Plot
- Configuring a Phase Noise Plot
- Configuring an Eye Diagram for Mask Hits
- Configuring an Eye Diagram Plot for Eye Height
- Configuring a Bathtub Plot

## Configuring a Bathtub Plot

Select a Bathtub plot in the table on the right and click **Configure** to configure the plot.

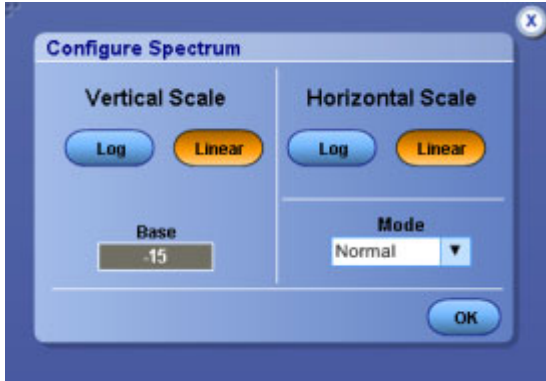




Item	Description
<b>Vertical Scale</b>	
Log	Selects logarithmic scaling for the vertical axis.
Linear	Selects linear scaling for the vertical axis.
<b>Minimum Displayed BER=1E?</b>	Sets the lower axis limit for logarithmic plots to this value (expressed as the negative of a base-10 exponent).
OK	Accepts the changes and closes the window.

## Configuring a Spectrum Plot

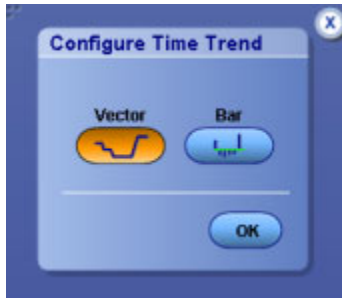
Select a Spectrum plot in the table on the right to and click **Configure** to configure the plot.



Item	Description
<b>Vertical Scale</b>	
Log	Selects logarithmic scaling for the vertical axis.
Linear	Selects linear scaling for the vertical axis.
Base	Sets the lower axis limit for logarithmic plots to this value (expressed as a base-10 exponent). Available only when the vertical scale is log.
<b>Horizontal Scale</b>	
Log	Selects logarithmic scaling for the horizontal axis.
Linear	Selects linear scaling for the horizontal axis.
<b>Mode</b>	Selects whether the plot shows only the most recent spectrum, the uniform average of all spectrums since the last time the results were cleared, or the peak of the envelope of all spectrums since the last time the results were cleared. <b>Normal</b> - Shows magnitude values from the most recent acquisition. <b>Average</b> - Averages the magnitude values at each frequency. <b>Peak Hold</b> - Keeps the maximum value at each frequency.
OK	Accepts the changes and closes the window.

## Configuring a Time Trend

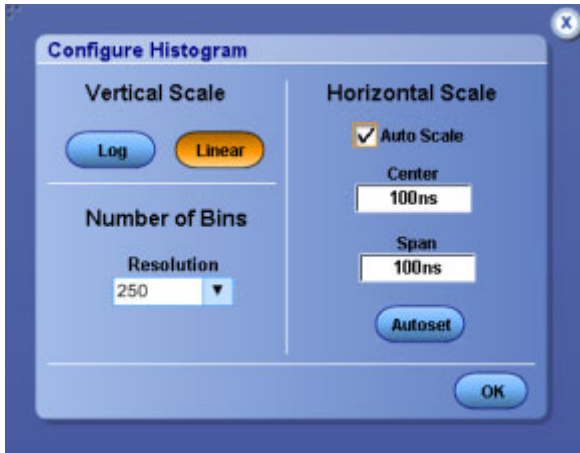
Select a Time Trend plot in the table on the right and click **Configure** to configure the plot.



Item	Description
Vector	Connects measurement points with straight lines to form a continuous waveform.
Bar	Places a vertical bar at the horizontal position of each measurement with a height (positive or negative) that represents the value of that measurement; a horizontal baseline represents the mean value of the Time Trend.
OK	Accepts the changes and closes the window.

## Configuring a Histogram Plot

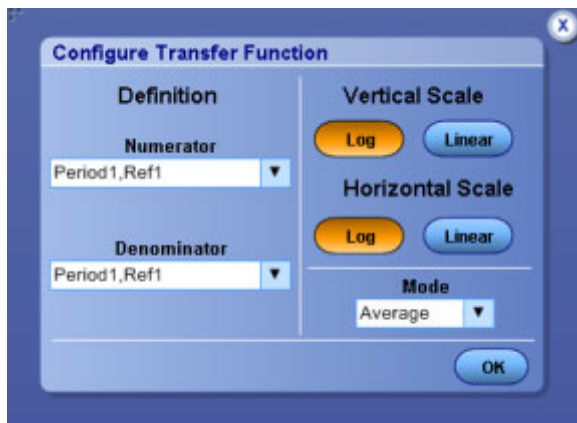
Select a Histogram plot in the table on the right and click **Configure** to configure the plot.



Item	Description
<b>Vertical Scale</b>	
Linear	Selects linear scaling for the vertical axis.
Log	Selects logarithmic scaling for the vertical axis.
<b>Number of Bins</b>	
Resolution	Defines resolution by the number of bins into which Span is divided: 25, 50, 100, 250, or 500.
<b>Horizontal Scale</b>	
Auto Scale	Causes the horizontal scale of the histogram to be adjusted automatically based on the accumulated data points. If subsequently acquired data falls outside the current horizontal scale, histogram bins are consolidated so that the number of bins is preserved and the horizontal scale allows all data to be plotted. When checked, disables the "Center" and "Span" numerical inputs.
Center	Manually sets the value for the horizontal center of the Histogram, for subsequent plot updates.
Span	Manually sets the value for the total horizontal range of the Histogram, for subsequent plot updates.
Autoset	Uses the results of the latest acquisition to determine the logical values for the Center and Span options (if the population of the measurement is three or more).
OK	Accepts the changes and closes the window.

## Configuring a Transfer Plot

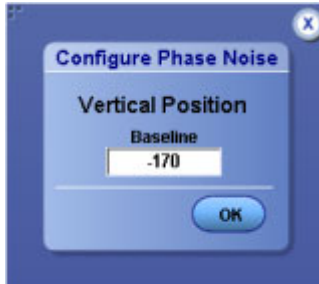
Select a Transfer Function plot in the table on the right and click **Configure** to configure the plot.



Item	Description
<b>Definition</b>	
Numerator	Measurement for which the magnitude spectrum is used as a reference.
Denominator	Measurement for which the magnitude spectrum is used to normalize the numerator.
<b>Vertical Scale</b>	
Linear	Selects linear scaling for the vertical axis.
Log	Selects logarithmic scaling for the vertical axis (default).
<b>Horizontal Scale</b>	
Linear	Selects linear scaling for the vertical axis.
Log	Selects logarithmic scaling for the horizontal axis (default).
<b>Mode</b>	
	Selects whether the plot shows only the most recent spectrum, or the uniform average of all spectrums since the last time the results were cleared (default).
	<b>Normal</b> - updates the plot with current values.
	<b>Average</b> - averages the magnitude values at each frequency.
OK	Accepts the changes and closes the window.

## Configuring a Phase Noise Plot

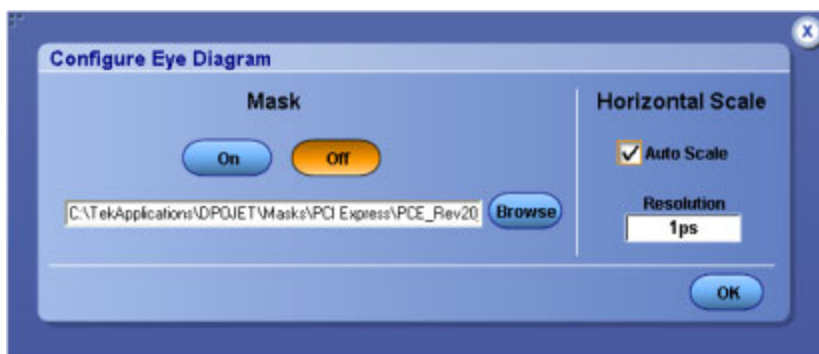
Select a Phase Noise plot in the table on the right and click **Configure** to configure the plot.



Item	Description
<b>Vertical Position</b>	
Baseline	Sets the lower axis limit for logarithmic plots to this value.
OK	Accepts the changes and closes the window.

## Configuring an Eye Diagram Plot for Eye Height

Select an Eye Diagram plot (for all eye measurements other than Mask Hits) in the table on the right and click **Configure** to configure the plot.



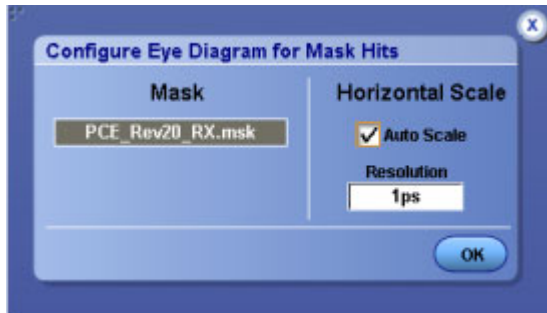
Item	Description
<b>Mask</b>	
On	Enables display and mask testing.
Off	Disables display and mask testing.
Browse	Select a mask file to import from the C:\TekApplications\DPOJET\Masks directory.
<b>Horizontal Scale</b>	
Auto Scale	When checked, causes the horizontal scale to be adjusted automatically.
Resolution	Manually sets the horizontal resolution, when Auto Scale is unchecked.
OK	Accepts the changes and closes the window.

### Related Topics

- Effect of Nominal Clock Offset on Eye Diagrams

## Configuring an Eye Diagram for Mask Hits

An eye diagram plot is activated whenever a mask hits measurement is selected. Click **Configure** in the plots panel to configure the plot.




Item	Description
Mask	Shows which mask has been selected (For the Mask Hits measurement, the mask selection is performed as part of measurement configuration rather than plot configuration).
<b>Horizontal Scale</b>	
Auto Scale	When checked, causes the horizontal scale to be adjusted automatically.
Resolution	Manually sets the horizontal resolution, when Auto Scale is unchecked.
OK	Accepts the changes and closes the window.

### Related Topics

- Effect of Nominal Clock Offset on Eye Diagrams



## About Viewing Plots

You can create and configure up to four plots. If you already have measurement results, creating a plot will cause it to be displayed immediately. If there are no current results, the plot will be created when you sequence the application and results have been calculated. The Show Plots icon appears in the control panel whenever at least one plot is defined. The Show Plots  icon appears in the control panel whenever at least one plot is defined. By default, all defined plots windows are grouped in a single window on the upper half of the display, but the window can be moved, resized, or dragged to a second monitor. The application includes tools to help you select which plots to view, to size and position the plot windows, to save plot information, to use the zoom function, and to use the cursors functions.

If your windows desktop is extended to a second monitor, you can drag the plots window to the second monitor.

---

**NOTE.** *When sequencing is complete, the plot window displays with the last plot selected. The plot window also updates whenever you reconfigure a plot.*

---

## Using a Second Monitor to View Plots

If your oscilloscope setup includes a second monitor that extends the Windows desktop, you can select and drag the title bar of the plot window to position it in the second monitor. This allows you to simultaneously display a waveform on the oscilloscope, measurement results, and the plot for easy viewing.

## Toolbar Functions in Plot Windows

The Plot Toolbar window includes the following functions:



**Table 62: Plot toolbar functions**

Icon	Functions
	Export Figure.
	Print Figure.
	Zoom and Pan.
	Vertical and Horizontal Cursor controls.
	Moving and Resizing Plots.
	Plot properties.
	Plot Summary Views.
	Full view of plots 1 to 4.

## Moving and Resizing plots

You can move and resize plot windows the same way you would move and resize any window.

You can change the plot size to the whole display of the oscilloscope, or to half the display. When viewing a plot in half the display, you can position the plot to the top or bottom. The tools also return the plot to the original size. To position a plot quickly on the oscilloscope, select one of the following tools in the plot window:

- enlarges the plot to fill the entire display.
- positions the plot to the top.
- positions the plot to the bottom.
- always keep the plot on top layer.

## Using Zoom in a Plot





Once you have created a plot, you can use the Zoom tools to examine the data at various scales.

---

**TIP.** *If you prefer to use the zoom functions in a plot window with your finger, you can activate the Touch Screen on the oscilloscope.*






---


**Table 63: Zoom functions in a plot**

Item	Description
	Zoom in (Horizontal and Vertical) – Expands part of the plot; the data appears in more detail.
	Zoom out – Contracts part of the plot; the data appears in less detail.
	Zoom in (Horizontal only) – Expands the horizontal axis only and retains the vertical axis.
	Resets the zoom to 100%.

### Changing the Scale of Data in a Plot (Zoom)

To change the scale of the data in a Plot Details window, select one of the following plot zoom tools:


-  zooms in to expand the scale.
-  zooms out to contract the scale.
-  zooms in to expand the horizontal axis only.
-  moves the plot anywhere within the scale.
-  zooms in to restore the entire waveform data.

When you select the  tool, you can use a select-drag-release action to expand part of the waveform (zoom in) by an arbitrary amount on both axes. After you select (touch with a finger or click with the mouse) and begin dragging, a bounding box shows what part of the waveform will be expanded upon release.

Select any part of the plot to expand the data by a factor of two (2X) equally on both axes. Double selecting expands the data to the maximum factor.

To contract an expanded part of the data (zoom out), select anywhere on the data. The view contracts to the values that existed before the most recent expansion of the data. Selecting multiple times will restore successively earlier views. To expand the scale of the horizontal axis only by a factor of two (2X), click a part of the waveform. The plot retains the scale of the vertical axis.

---

**TIP.** *Select  to see the entire available waveform.*





---

## Using Cursors in a Plot

Cursors allow you to view numerical values associated with a plot based on cursor locations. There are two types of cursors:




- Horizontal cursors
- Vertical cursors

**Table 64: Cursor functions in a plot**

Item	Description
	Displays the vertical coordinate where each cursor touches the plot and the difference ( $\Delta$ ) between the cursors.
	Displays the horizontal coordinate where each cursor touches the plot and the difference ( $\Delta$ ) between the cursors.
	Brings the cursors into the visible part of the plot.
	Displays the plot properties.

### Cursors in a Plot

You can use cursors to read the coordinate where each cursor (line) touches the plot and also view the difference ( $\Delta$ ) between the two cursors. The steps to use cursors in a plot details window are:

1. Select any of the following cursors:
  -  to use horizontal cursors.
  -  to use vertical cursors.
  -  to bring cursors into the visible plot.
2. Select and drag either cursor to move the cursor to the desired part of the plot. The cursor readout changes to reflect the cursor position.

---

**NOTE.** *You can drag cursors only when the Zoom functions are disabled.*

---




---


**TIP.** *If you prefer to move the cursors in the plot window with your finger, you can activate the touch screen on the oscilloscope.*

---

## Exporting Plot Files



You can export plot image in Plot Toolbar window. Click  to save the contents of the plot window in any of the format as a MATLAB figure format (.fig), .bmp, .jpg, .png, .emf, .tif, .mat and .csv.

The steps to export a plot file are:

1. Set up the plot window.
2. Select  to save the plot as a figure.
3. Select the directory and enter a file name.
4. Click **Save**. The application saves the file in C:\TekApplications\DPOJET\images.

## Printing Plots

The steps to print a plot are:

1. Verify that the printer is configured.
2. Set up the plot window with zoom, cursors, or grid functions.
3. Click  icon in the plot details/summary window. The Print Preview dialog is displayed.
4. Click  to set up the printing options and print a plot file.

---

**NOTE.** You can customize the print layout using the MATLAB page setup options. The DPOJET online help does not provide information on MATLAB page setup. For more information, refer to the MATLAB documentation.

---

## About Reports

You can use the Reports to configure and generate a compliance report to view later or to share with others. You can also access reports using **Analyze > Jitter and Eye Analysis > Reports**. You can select the option which you want to display in the report as shown in the following table:

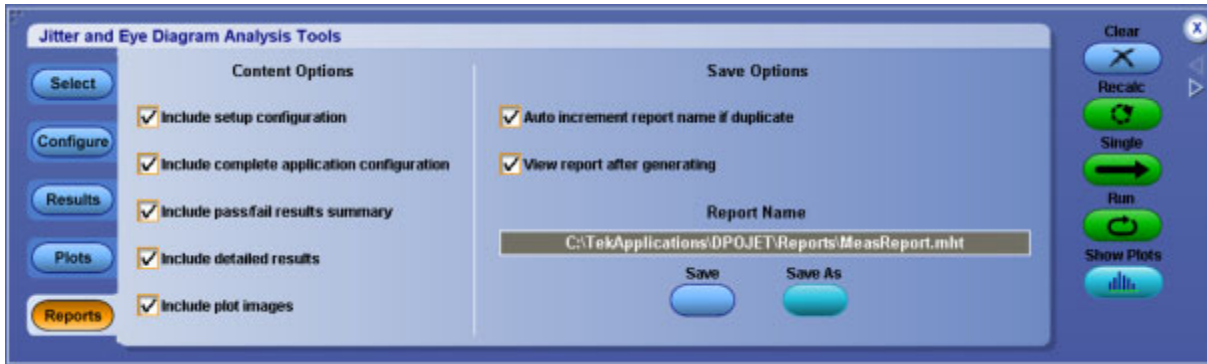


Table 65: Report generation options

Item	Description
<b>Content Options</b>	
Include setup configuration	Select/Clear the option to include/exclude the setup information like DPOJET version, oscilloscope version, and status in the generated report.
Include complete application configuration	Select/Clear the option to include/exclude the complete configuration details in the generated report.
Include summary pass/fail results	Select/Clear the option to include/exclude the pass/fail status in the generated report.
Included detailed results	Select/Clear the option to include/exclude the measurement result details in the generated report.
Include plot images	Select/Clear the option to include/exclude the plot images like measurement plots and oscilloscope waveform in the generated report.
<b>Save Options</b>	
Auto increment report name if duplicate	Select/Clear the option to autoincrement the report name if its already existed. The autogenerated report is of YYMMDD_HHMMSS_ savedfile.mht format.
View report after generating	Select this option to view the report after generation.
Report Name	Lists the directory path where the last generated report is stored.
Save	Saves the changes in the default report directory. Manipulates the report name based on "Auto increment report name if duplicate" option.
Save As	Displays the browser where you specify the directory to save the generated report. You can also edit the report name in the Save As browser. The generated report is saved in C:\TekApplications\DPOJET\Reports.

## Reports Format

The generated reports are in `.mht` format and includes the following configured set of information:

- **Setup Configuration** such as DPOJET version, oscilloscope version, and the Pass/Fail status.
- **Measurement Configuration** such as measurement name, source and other configuration parameters.
- **Source Reference Levels** displays the reference voltage levels for the high, mid, and low thresholds for the rising edge and for the falling edge of all sources, and the hysteresis.
- **Miscellaneous Settings** such as Gating, Qualify and Population status.
- **Pass/Fail Summary** indicating the Pass/Fail status for the selected measurements.
- **Measurement Results** with statistics.
- **Plot Images** includes both selected plots and oscilloscope waveforms.





## Introduction to the Tutorial

This tutorial teaches how to set up the application, take measurements, and view results as plots or statistics.

Before you begin the tutorial, perform the following tasks:

- Set up the oscilloscope.
- Start the application.
- Recall the tutorial waveform.

---

**NOTE.** *The screen captures shown in this section are from a DPO7254 oscilloscope.*

---

## Setting Up the Oscilloscope

The steps to set up the oscilloscope are:

1. Click **File > Recall Default Setup** in the oscilloscope menu bar to recall the default settings.
2. Press the individual CH1, CH2, CH3, and CH4 buttons as needed to add or remove active waveforms from the display.

## Starting the Application

Click **Analyze > Jitter and Eye Analysis > Select** to open the application.

## Waveform Files

The application provides the following tutorial waveforms:

- Rt-EyeTutorial.wfm
- ckminus\_50gs\_18g\_20m\_pat1.wfm
- ckplus\_50gs\_18g\_20m\_pat1.wfm
- dplus\_50gs\_18g\_20m\_pat1.wfm
- dminus\_50gs\_18g\_20m\_pat1.wfm

The waveform files are found at C:\TekApplications\DPOJET\Examples.

## Recalling a Waveform File


To recall a waveform file, follow these steps:

1. Click **File > Recall** in the oscilloscope menu bar to display the Recall dialog box.

---

**NOTE.** *If the application is in button mode, select the Recall button to recall the tutorial waveform.*

---

2. Click **Waveform** icon in the left of the Recall dialog box.
3. Select Ref1, Ref2, Ref3, or Ref4 as the Destination option.
4. Browse to select the waveform. Use the keypad to edit the waveform file name.
5. Click **Recall**. The oscilloscope recalls and activates the Reference Waveform control window.
6. Click **On** to display the waveform.
7. Click  to return to the application. Alternatively, DPOJET can also be accessed from **Analyze > Jitter and Eye Analysis > Select**.



In the Summary tutorial, the tutorial waveforms are recalled as Math waveforms using the following setup:

- dplus\_50gs\_18g\_20m\_pat1.wfm is recalled as **Ref1** and dminus\_50gs\_18g\_20m\_pat1.wfm as **Ref2**.

---

**NOTE.** *Using Math Setup ( Select Math > Math Setup in the menu bar to view the Math Setup dialog. For more details, refer to the “Math Equation Editor: Controls in your oscilloscope online help), set Math1=Ref1–Ref2 (Data signals).*

---

- ckplus\_50gs\_18g\_20m\_pat1.wfm is recalled as **Ref3** and ckminus\_50gs\_18g\_20m\_pat1.wfm as Ref4.

---

**NOTE.** *Using Math Setup, set Math2 =Ref3–Ref4 (Clock Signals).*

---

## Taking a Period Measurement

In this lesson, you will learn how to take a period measurement and view the results. You can also learn the following tasks:

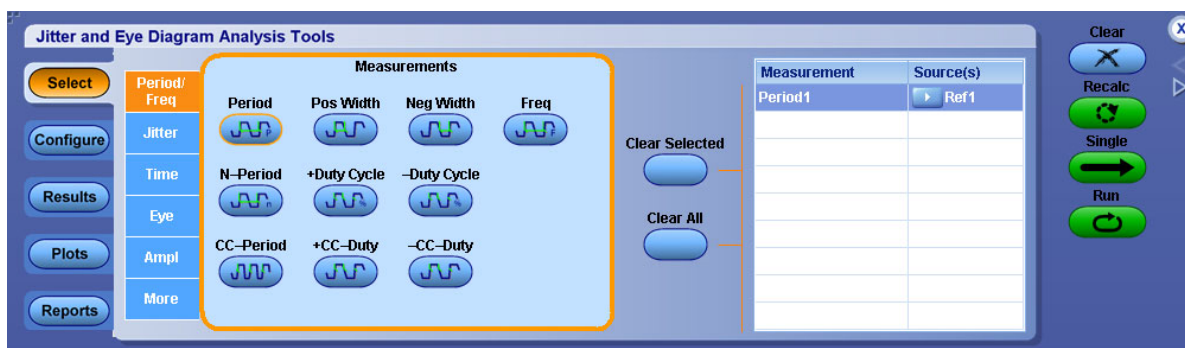
- Select a measurement and a source


- Configure measurement
- Take measurements
- View results as plots or statistics
- View reports
- Return to the application

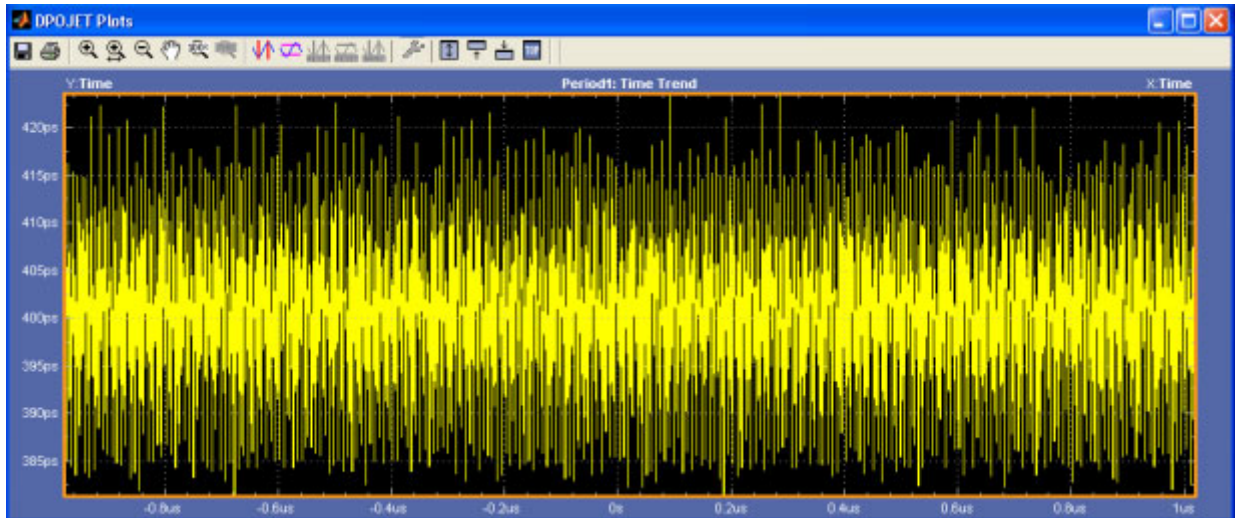
## Setting up a Period Measurement

Follow these steps to take a period measurement:

1. To set the application to default values, click **File > Recall Default Setup**. This is not necessary if you have just started the application.
2. To view the DPOJET application, select **Analyze > Jitter and Eye Analysis > Select**.
3. Go to **Select** in the left navigation panel. Click **Period** in the Measurements area. The application shows the measurement and source selection on the right of the display. The current measurement selection is displayed as Period1. The subsequent selections will be Period2, Period3 and so on. In this example, Rt-EyeTutorial.wfm is recalled as Ref1 and is selected as source for Period1. New measurements initially use the same source as the earlier measurement, or the most recently used source.



4. Click  or the row which lists the selected measurement to configure the source. Select Ref1 for Period1. For more details, refer to [Source Setup](#).
5. Click **Ref Levels Setup**. The Configure Reflevel menu appears. For more details, refer to [Ref Levels](#).
6. Click **Configure** in the left navigation panel of the main application window to view the configure tabs. For more details, refer to [About Configuring a Measurement](#).
7. Click Plots to view the available plots for the selected measurement . Select Time Trend for Period. For more details, refer to [Configuring Time Trend](#).
8. Click **Single** to run the application. When complete, the result statistics is shown in the results tab. The plots are displayed as shown:

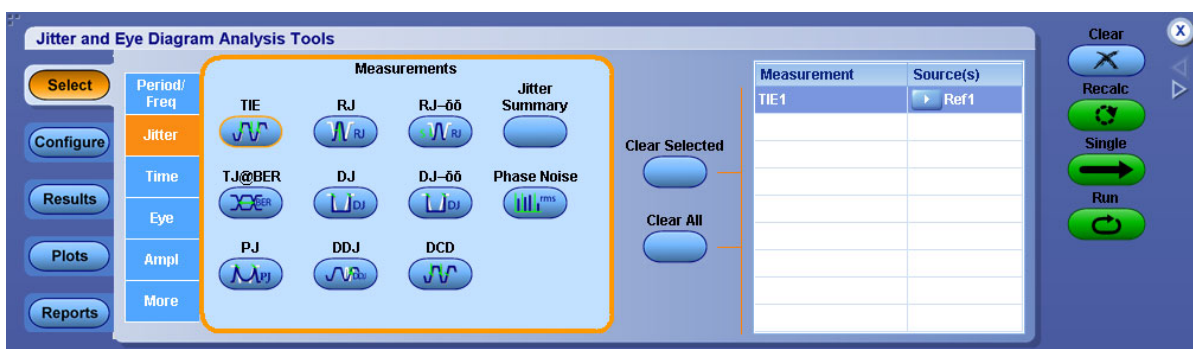



**NOTE.** You can log result [statistics](#), [measurement data points](#) to a .csv file and [worst case waveforms](#) to a .wfm file.

## Taking a TIE Measurement

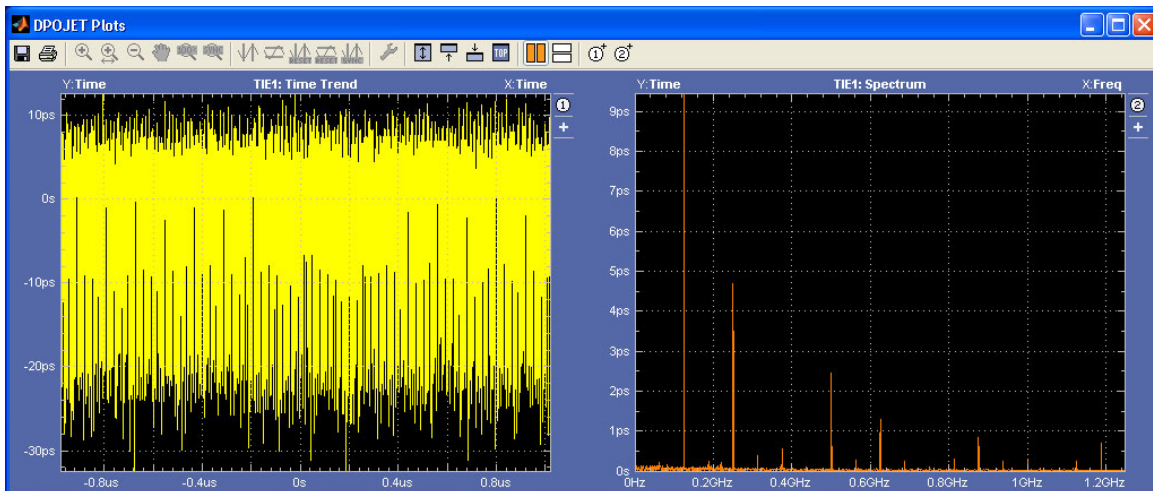
For jitter application, we use PLL TIE measurement. The steps to take a TIE measurement are:

1. To set the application to default values, click **File > Recall Default Setup**. This is not necessary if you have just started the application.
2. Go to **Select** in the left navigational panel. Click **Jitter** tab to select TIE in the Measurements area. The application shows the measurement and source selection on the right of the display. In this example, Rt-EyeTutorial.wfm is recalled as Ref1 and is selected as source for TIE1.



3. Click  or the row which lists the selected measurement to configure the source. Select Ref1 for TIE1. For more details, refer to [Source Setup](#).
4. Click **Ref Levels Setup** in the source configuration dialog. The Configure Reflevel menu appears. For more details, refer to [Ref Levels](#).

5. Click **Configure** in the left navigation panel to view the configure tabs. For more details, refer to [Configuring Measurements](#).
6. Click Plots to view the available plots for the selected measurement. Select Time Trend and Spectrum plots for TIE measurement. For more details, refer to [Configure Plots](#).
7. Click **Single** to run the application. When complete, the result statistics is shown in the results tab. The plots are displayed as follows:

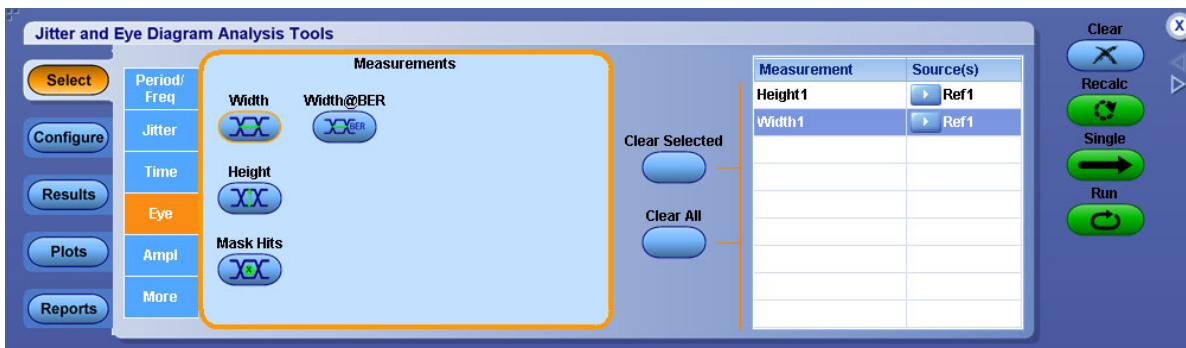


**NOTE.** You can log result [statistics](#), [measurement data points](#) to a .csv file and [worst case waveforms](#) to a .wfm file.

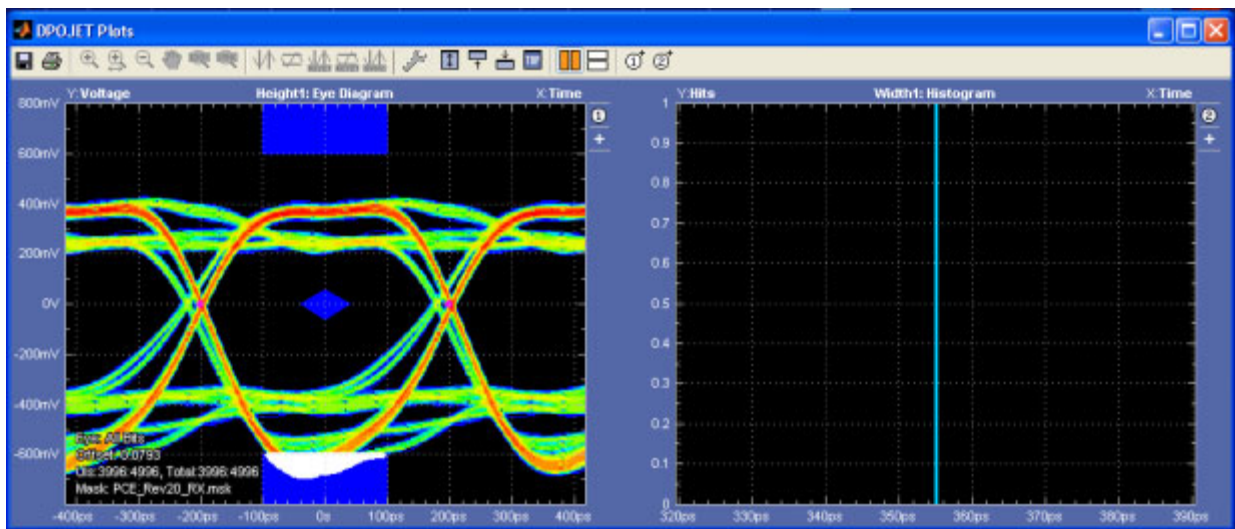
## Taking an Eye Height and Width Measurement

For signal integrity application, we use Eye Height and Width measurements.

1. Select **Analyze > Jitter and Eye Analysis > Select** to run the DPOJET application.
2. Go to Select in the left navigation panel. Click **Eye** tab to select Height and Width measurement. In this example, Rt-EyeTutorial.wfm is recalled as Ref1 and is selected as source for Height1 and Width1.



3. Select Ref1 as source for Height and Width measurements. For more details, refer to [Source Setup](#).
4. Click Plots to view the available plots for the selected measurement. Select Eye Diagram for Height measurement.
5. Select Eye diagram Plot type and click **Configure** to turn on the Mask in the Configure Eye Diagram for Eye Height dialog. For more details, refer to the [Configuring Eye Diagram Plot for Eye Height](#).
6. Select Histogram plot for Width measurement.
7. Click **Single** to run the application. When complete, the result statistics is shown in the results tab.
8. The Plot summary window is displayed as shown in the following figure:




---

**NOTE.** You can log result [statistics](#), [measurement data points](#) to a .csv file and [worst case waveforms](#) to a .wfm file.

---

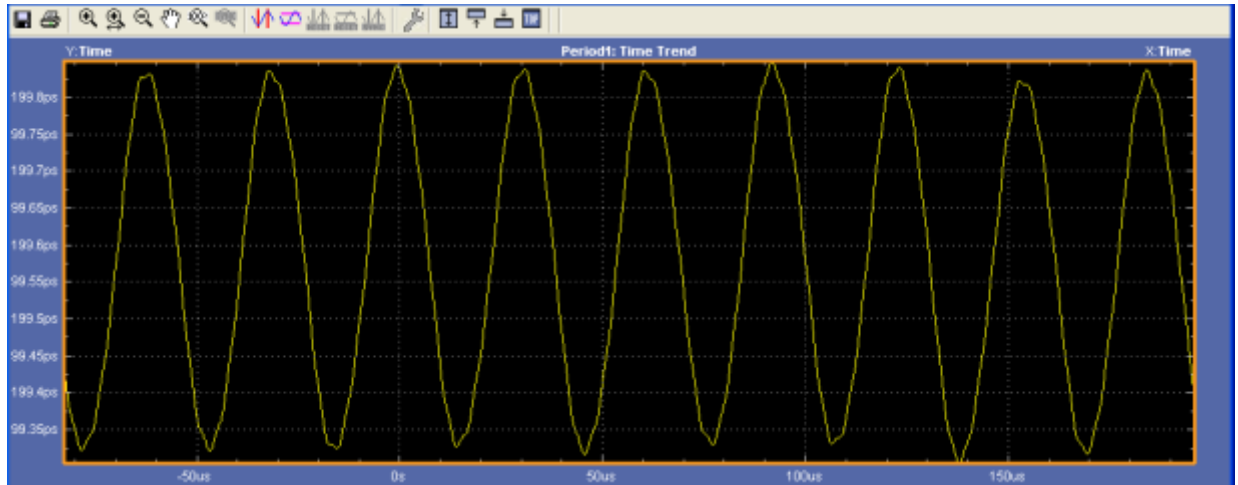
## Summary Tutorial

For a summary tutorial, we use the following example:

**Case 1:** Period measurement with Low pass filters to show SSC profile:

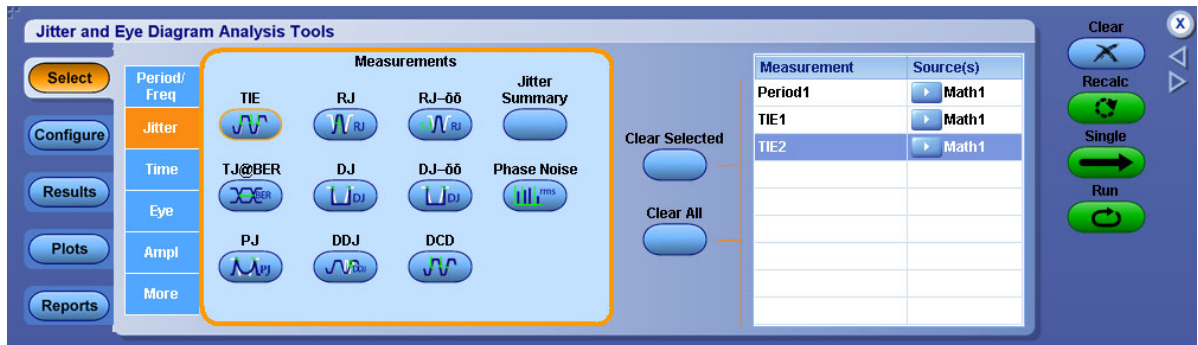
1. Select **Analyze > Jitter and Eye Analysis > Select** to run the DPOJET application. For more details on waveforms recalled on Math1, Refer [Recalling a Waveform File](#).
2. Select Period measurement on Math1.
3. Click **Configure**. In the Filters configuration tab, select 2<sup>nd</sup> order low pass filter and specify the cut-off frequency as 33kHz. ( $F_2 = F_{\text{baud}}/1667$ ).
4. Go to Plots. Select Time Trend for Period measurement.

- Click **Single** to run the application. When complete, the result statistics is shown in the results tab. The Time Trend plot is as shown.

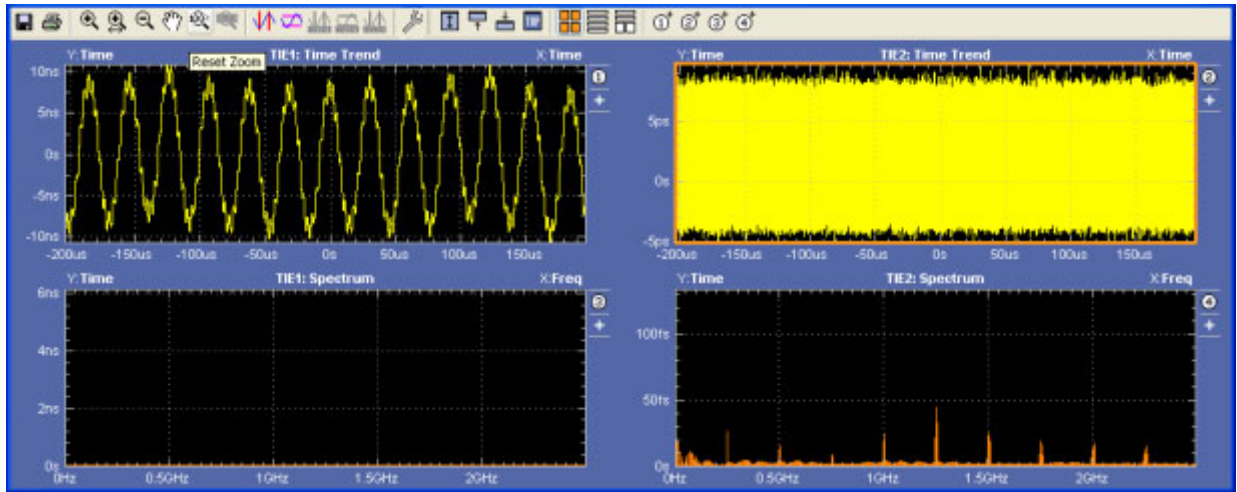


**Case 2:** A pair of TIE for showing jitter integration caused by SSC and the effect of a high pass filter on SSC spectrum plots:

- Click **Jitter** to select TIE measurement.
- Select [Math1](#) as the source for both TIE1 and TIE2.



- Click **Configure**. Do the following settings for TIE1 and TIE2 in the Filters configuration tab:
  - Select “No Filter” for TIE1.
  - Select 2<sup>nd</sup> order High Pass filter for TIE2. In this example, we have set F1 cut-off frequency as 1 GHz.
- Go to Plots. Select Time Trend for both TIE1 and TIE2.
- Select Spectrum plot for both TIE1 and TIE2.
- Click **Single** to run the application. When complete, the result statistics is shown in the results tab.
- A Plot Summary window shows Time Trend plots for TIE1, TIE2 and Spectrum plots for TIE1, TIE2.




---

**NOTE.** You can log results as [statistics](#), [measurement data points](#) to a .csv file and [worst case waveforms](#) to a .wfm file.

---

## Stopping the Tutorial

If you need more than one session to complete the tutorial lessons, you can stop the tutorial and return to it later.

To save the application setup, refer to [Saving a Setup File](#). To exit the DPOJET application, click



present at the right corner of the application.

## Returning to the Tutorial

To return to the tutorial setup, you can start the application and then recall the saved setup. To recall the application setup, refer to [Recalling a Saved Setup File](#).



## About Parameters

This section describes the DPOJET application parameters and includes the menu default settings. Refer to the user manual for your oscilloscope for operating details of other controls, such as front-panel buttons.

The parameter tables list the selections or range of values available for each option, the incremental unit of numeric values, and the default selection or value.

Refer to the  [GPIB](#) section for a complete list of the GPIB Command Syntax. The topics include a complete list of the GPIB commands along with the arguments, variables, and variable values that correspond to the DPOJET parameters.

## Measurement Select Parameters

The Measurement Select includes the following measurement categories:

- **Period/Freq** : Frequency, Period, CC-Period , N-Period, Pos Width, Neg Width, +Duty Cycle, -Duty Cycle, +CC-Duty, and -CC-Duty.
- **Jitter** : TIE, RJ, DJ, PJ, DDJ, DCD, RJ- $\delta\delta$ , DJ- $\delta\delta$ , TJ@BER, Jitter Summary, and Phase Noise.
- **Time** : Rise Time, Fall Time, High Time, Low Time, Setup, Hold, and Skew.
- **Eye** : Height, Width, Mask Hits, and Width@BER.
- **Ampl** : High, Low, Common Mode, High-Low, T/nT Ratio, and V-Diff -Xovr .
- **More**: DDR Setup-SE, DDR Setup-Diff, DDR Hold-SE, and DDR Hold-Diff

You can set the Source option as any of the following waveforms: Ch1, Ch2, Ch3, Ch4, Ref1, Ref2, Ref3, Ref4, Math1, Math2, Math3, or Math4.

**Table 66: Source parameters**

Option	Parameters	Default
Source1	Ch1-Ch4, Math1-Math4, Ref1-Ref4	Ch1
Source2	Ch1-Ch4, Math1-Math4, Ref1-Ref4	Ch2

## Autoset Parameters

The Configure Source Autoset includes the following command buttons:

- Vert Scale
- Horiz Res
- Vert & Horiz
- Undo

## Ref Level Menu Parameters

The Configure Ref Level menu parameters includes the following command buttons:

- Autoset
- Setup

**Table 67: Source autoset ref level parameters**

Option	Parameters	Default setting
Source	Ch1-Ch4, Ref1-Ref4, Math1-Math4	
Autoset	Set, Clear	Set
Rise High	-20 V to 20 V	1 V
Rise Mid	-20 V to 20 V	0 V
Rise Low	-20 V to 20 V	-1 V
Fall High	-20 V to 20 V	1 V
Fall Mid	-20 V to 20 V	0 V
Fall Low	-20 V to 20 V	-1 V
Hysteresis	0 to 10 V	30 mV

### Autoset Ref Levels Parameters

**Table 68: Autoset ref levels parameters**

Option	Parameters	Default setting
Base Top Method	<ul style="list-style-type: none"> <li>■ Min-Max</li> <li>■ Low-High Histogram (Full Waveform)</li> <li>■ Low- High Histogram (Center of Eye)</li> <li>■ Auto</li> </ul>	Auto
Rise High	1 to 99%	90%
Rise Mid	1 to 99%	50%
Rise Low	1 to 99%	10%
Fall High	1 to 99%	90%
Fall Mid	1 to 99%	50%
Fall Low	1 to 99%	10%
Hysteresis	0 to 50%	3%

## Preferences Parameters

The **Analyze > Jitter and Eye Analysis > Preferences** includes the following tabs:

- General
- Measurement
- Path Defaults

**Table 69: Preferences parameters**

Option	Parameters	Default setting
<b>General</b>		
Display Units	Seconds, Unit Intervals	Seconds
Default Image Type	PNG, JPG, BMP	PNG
Notifier Duration	2 to 20 s	5 s
<b>Measurement</b>		
Limit Rise/Fall measurements to transition bits only	Set, Clear	
Enable high-performance eye rendering	Set, Clear	Set
Dual Dirac Model	Fibre Channel, PCI/FB-DIMM	PCI/FB-DIMM
Waveform Interpolation Type	Linear, Sin(x)/x	Linear
<b>Path Defaults</b>		
Default image export directory	Browser	C:\TekApplications\DPOJET\Images
Default logging export directory	Browser	C:\TekApplications\DPOJET\Logs
Default report output directory	Browser	C:\TekApplications\DPOJET\Reports

## Deskew Parameters

The **Analyze > Jitter and Eye Analysis > Deskew** includes the following command buttons:

- Perform Deskew
- Summary

**Table 70: Deskew parameters**

Option	Parameters	Default setting
<b>Reference Channel</b>		
Source	Ch1, Ch2, Ch3, Ch4	Ch1
Mid	-20 V to 20 V	0 V
Hysteresis	0 to 10 V	30 mV
<b>Channel to be Deskewed</b>		
Source	Ch1, Ch2, Ch3, Ch4	Ch2
Mid	-20 V to 20 V	0 V
Hysteresis	0 to 10 V	30 mV
<b>Edges</b>	Rise, Fall, Both	Rise
<b>Deskew Range</b>		
Max Value	-24.9 ns to 25 ns	1 ns
Min Value	-25.0 ns to 24.9 ns	-1 ns

## Data Logging Parameters

The application includes the following Log menus:

- Statistics
- Measurement
- Worst Case

**Table 71: Logging parameters**

Option	Parameters	Default
<b>Statistics</b>		
Select Target Measurements	Set, Clear	Set
Log Statistics	Off, On	Off
File Name	Browser	C:\TekApplications\DPO-JET\Logs\Statistics
<b>Measurement</b>		
Select Target Measurements	Set, Clear	Set
Log Measurements	Off, On	Off
Folder	Browser	C:\TekApplications\DPO-JET\Logs\Measurements
<b>Worst Case</b>		
Select Target Measurements	Set, Clear	Set
Log Worst Case Waveforms	Off, On	Off
Folder	Browser	C:\TekApplications\DPO-JET\Logs\waveforms

## Control Panel Parameters

The Control Panel menu includes the following command buttons:

- Clear
- Recalc
- Single
- Run
- Show Plots

---

**NOTE.** *Show Plots appears in the control panel only when one or more plots are selected.*

---

## Bit Config Parameters

The Eye configure menu has the following parameters

Option	Parameters	Default setting
Bit Type	All Bits, Transition, Non-Transition	All Bits
Mask *	Browser	C:\TekApplications\DPO-JET\Masks
Measure the Center of the Bit †	1 to 100%	1%
Method †	Mean, Mode	Mean

\* The Mask selector is available only for Mask Hits measurement.

† Available only for High, Low and High-Low measurements.

## Edges Parameters

The Edges configure menu depends on the measurement selected.

### Edges-Two Source Parameters

Option	Parameters	Default setting
Clock Edge	Rise, Fall, Both	Rise
Data Edge	Rise, Fall, Both	Both

### Edges-Phase Noise Parameters

Option	Parameters	Default setting
Active Edge	Rise, Fall, Both	Rise
<b>Noise Integration Limits</b>		
Upper Frequency	0 to 1 T	1 MHz
Lower Frequency	0 to 1 T	0 Hz

### Edges-CrossOver Parameters

Option	Parameters	Default setting
Main Edge	Rise, Fall, Both	Both

**Edges-TIE Parameters**

Option	Parameters	Default setting
Signal Type	Clock, Data, Auto	Auto
Clock Edge	Rise, Fall, Both	Rise

**Edges-Skew Parameters**

Option	Parameters	Default setting
From Edge	Rise, Fall, Both	Both
To Edge	Same as From, Opposite as From	Same as From

**Edges-N-Period Parameters**

Option	Parameters	Default setting
Signal Type	Clock, Data, Auto	Auto
Clock Edge	Rise, Fall, Both	Rise
N=	1 to 1M	6
Edge Increment	1, 10 K	1

**Edges-DCD Parameters**

Option	Parameters	Default setting
Signal Type	Clock, Data, Auto	Auto

## Clock Recovery Parameters

The Clock recovery configure menu depends on the clock recovery method being selected.

**PLL Clock Recovery Method Parameters**

Option	Parameters	Default setting
<b>PLL Standard BW</b>		
PLL Model	Type I, Type II	Type I



Option	Parameters	Default setting
Standard: b/s	IBA2500 : 2.5G , PCI-E : 2.5G FC133 : 132.8M, FC266 :265.6M, FC531: 531.2M, FC1063: 1.063G , FC2125:2.125G, SerATAG1:1.5G, SerATAG2:3.0, SerATAG3:6.0G USB FS:12M, USB HS:480M 1394b S400b : 491.5M, 1394b S800b : 983.0M, 1394b S1600b : 1.966G GB Ethernet : 1.25G 100BaseT:125M OC1:51.8M, OC3:155M, OC12:622M, OC48:2.488G, FC4250:4.25G, FC8500:8.5G PCI_E_GEN2: 5.0G,IBA_GEN2 : 5.0G FBD1:3.2G, FBD2 : 4.0G, FBD3: 4.8G XAUI: 3.125G, XAUI_GEN2: 6.25G SAS15:1.5G, SAS3: 3.0G, SAS6: 6.0G RIO125 :1.25G, RIO250 :2.5G , RIO3125 :3.125G	PCI-E : 2.5G
Damping <sup>1</sup>	0.5 to 2	700 m
Loop BW	1 to 2.5 GHz	1.5 MHz
<b>PLL Custom BW</b>		
PLL Model	Type I, Type II	Type I
Loop BW	1 to 2.5 GHz	1.5 MHz

<sup>1</sup> Enable only for Type II PLL models.

### Constant Clock Recovery Method Parameters

Option	Parameters	Default setting
<b>Constant Clock-Mean</b>		
Auto Calc	First Acq, Every Acq	First Acq
<b>Constant Clock-Median</b>		
Auto Calc	First Acq, Every Acq	First Acq
<b>Constant Clock-Fixed</b>		
Clock Frequency	1 Hz to 25 GHz	2.5 GHz

**Explicit Clock Recovery Method Parameters**

Option	Parameters	Default setting
<b>Explicit Clock-Edge/Explicit Clock-PLL</b>		
Clock Source	Ch1-Ch4, Ref1-Ref4, Math1-Math4	Ch2
Clock Edge	Rise, Fall, Both	Both
Clock Multiplier	1 to 10 K	1

**Advanced Clock Recovery Configuration Parameters**

Option	Parameters	Default setting
<b>PLL Custom BW/PLL Standard BW/ Constant Clock-Mean/Constant Clock-Median</b>		
Nominal Data Rate	Off, On	Off
Bit Rate	1 b/s to 25 Gb/s	2.5 b/s
Known Data Pattern	On, Off	Off
Pattern Filename	Browse	C:\TekApplications\DPO-JET\Patterns
<b>Explicit Clock: Edge</b>		
Nominal Clock Offset Relative to Data	-1 to 1 s	0 s
<b>Explicit Clock:PLL</b>		
PLL Method	Type I,Type II	Type I
Damping	0.5 to 2	700 m
Loop B/W	1 to 2.5 GHz	1.5 MHz
Nominal Clock Offset Relative to Data	-1 to 1 s	0 s

## RJDJ Analysis Parameters

The RJDJ configure menu has the following parameters:

**Table 72: RJDJ analysis parameters**

Option	Parameters	Default setting
<b>Data Signal Settings</b>		
Pattern Type	Repeating, Arbitrary	Repeating
Pattern Length *	2 UI to 1M	2 UI
Window Length †	2 to 16 UI	5 UI
Population †	5 to 5000	100
<b>Total Jitter Component</b>		
BER = 1E-? ‡	2 to 18 in whole numbers	12

\* Only for Repeating Patterns.

† Only for Arbitrary Patterns.

‡ Only for TIE, TJ@BER and Width@BER measurements.

## Filters Parameters

The Filter configure menu has the following parameters:

**Table 73: Filters parameters**

Option	Parameters	Default setting
<b>High Pass (F1)</b>		
Filter Spec	No Filter, 1 <sup>st</sup> order, 2 <sup>nd</sup> order, 3 <sup>rd</sup> order	No Filter
Freq (F1)	1 Hz to 1000 GHz	1 KHz
<b>Low Pass (F2)</b>		
Filter Spec	No Filter, 1 <sup>st</sup> order, 2 <sup>nd</sup> order, 3 <sup>rd</sup> order	No Filter
Freq (F2)	1 Hz to 1000 GHz	1 KHz

### Advanced Filter Configure Parameters

The Advanced Filter Configuration includes the following parameters:

Option	Parameters	Default setting
Ramp Time	0/F to 10/F	2/F
Blanking Time	0/F to 10/F	4/F

## General Parameters

The General configure menu has the following parameters:

**Table 74: General parameters**

Option	Parameters	Default setting
Measurement Range Limits	Off, On	Off

Maximum and minimum values vary for different measurements. For more details, refer to [Measurement Values](#).

## Global Parameters

The Global configure menu has the following parameters:

**Table 75: Global parameters**

Option	Parameter	Default setting
<b>Gating</b>		
Gating	Off, Zoom, Cursors	Off
<b>Qualify</b>		
Qualify	Off, On	Off
<b>Qualify With Logic</b>		
Source	Ch1-Ch4, Ref1-Ref4, Math1-Math4, Search1-Search8	Ch1
Mid	-20 V to 20 V	0 V
Hysteresis	0 to 10 V	30 mV
Active	High, Low	High
<b>Population</b>		
Population	Off, On	Off
<b>Population Limit</b>		
Limits By	Population, Acquisitions	Acquisitions
Limit	1 to 2 <sup>31</sup>	1 K
Stop Condition	Each Measurement, Last Measurement	Each Measurement

## Histogram Plot Parameters

The Histogram plot has Autoset as the command button.

Option	Parameters	Default setting
Vertical Scale	Log, Linear	Linear
<b>Number of Bins</b>		
Resolution	25, 50, 100, 250, 500	250
<b>Horizontal Scale</b>		
Auto Scale	Set, Clear	Set
Center	-1.00E+12 to 1.00E+12	1.00E-07
Span	1.00E-12 to 1.00 E+12	4.00E-09

## Eye Diagram Plot Parameters

The Eye Diagram plot has the following parameters:

Option	Parameters	Default setting
Mask	On, Off	Off
	Browser	C:\TekApplications\DPO-JET\Masks
<b>Horizontal Scale</b>		
Auto Scale	Set, Clear	Set
Resolution	2.00E-13 to 2.00E-08	1.00E-12

## Spectrum Plot Parameters

The Spectrum plot has the following parameters:

Option	Parameters	Default setting
Vertical Scale	Log, Linear	Linear
Base	-20 to 15	-15
Horizontal Scale	Log, Linear	Linear
Mode	Normal, Average, Peak Hold	Normal

## Time Trend Plot Parameters

The Time Trend plot has the following parameters:

Option	Parameters	Default setting
Mode	Vector, Bar	Vector

## Phase Noise Plot Parameters

The Phase Noise plot has the following parameters:

Option	Parameters	Default setting
<b>Vertical Position</b>		
Baseline	-200 to 0	-170

## Bathtub Plot Parameters

The Bathtub plot has the following parameters:

Option	Parameters	Default setting
Vertical Scale	Log, Linear	Log
Minimum displayed BER= 1E-?	2 to 18 *	14

\* Applicable for Log and Linear scale only.

## Transfer Function Plot Parameters

The Transfer Function plot has the following parameters:

Option	Parameters	Default setting
Vertical Scale	Log, Linear	Log
Horizontal Scale	Log, Linear	Log
Mode	Normal, Average	Average

## Reports

The Reports menu has the following command buttons:

- Save
- Save As

Option	Parameters	Default setting
Include Setup configuration	Set, Clear	Set
Include complete application configuration	Set, Clear	Set
Include pass/fail results summary	Set, Clear	Set
Include detailed results	Set, Clear	Set
Include plot images	Set, Clear	Set
Auto increment report name if duplicate	Set, Clear	Set
View report after generating	Set, Clear	Set
Report Name	Browser	C:\TekApplications\DPO-JET\Reports





## Progress Bar Status Messages

Function/Measurement module	Status/Message	Description
Autoset-Source Autoset	VertAuto-Chx	Vertical autoset for Chx is going on.
Autoset-Source Autoset	HorizAuto-Chx	Horizontal autoset for Chx is going on.
Autoset-Source Autoset	Zooming Horiz	Zooming the horizontal scale after horizontal autoset.
Autoset-Ref Level Autoset	RefAuto-Chx	Reference level autoset for Chx is going on.
Autoset-Ref Level Autoset	RefAuto-Refx	Reference level autoset for Refx is going on.
Autoset-Ref Level Autoset	RefAuto-Mathx	Reference level autoset for Mathx is going on.
Sequencing	Sequencing	Refers to the measurement setup-edge extraction.
	Measurement Name	Running the measurement specified by name.
Plots	Plotting	Plotting is started.
	Bathtub	Creating Bathtub plot.
	Spectrum	Creating spectrum plot.
	Time Trend	Creating time trend plot.
	Histogram	Creating Histogram plot.
	Transfer Func	Creating Transfer Function plot.
	Eye Mask Hits	Creating Eye Diagram plot.
	Eye Height	Creating Eye Diagram plot.
	Data Array	Creating Data Array plot.
Phase Noise	Creating Phase noise plot.	
Edge Extraction	Finding Edges	Extracting Edges from signal waveform.
Clock Data Recovery	Recovery Clk	Clock and Data recovery.
Worst case logging	Saving WC Wfm	Logging the worst case waveform.
Trigger	Slow Trigger	Waiting for trigger/trigger not available.
<b>Measurements Name</b>	<b>Progress Bar Display</b>	
Amplitude High Low	Ampl High-Low	
Amplitude HighV	Amp High	
Amplitude LowV	Ampl Low	
CMV	Common Mode	
DCD	DCD	
DDJ	DDJ	
DiffXovrV	V-Diff-Xovr	
DJ	DJ	

Function/Measurement module	Status/Message	Description
DJδδ	DJ-δδ	
EdgeExtractor	Edge Extractor	
EyeHeight	Eye Height	
EyeMaskHits	Eye Mask Hits	
EyeWidth	Eye Width	
EyeWidthBER	Eye Width@BER	
FallTime	Fall Time	
Frequency	Freq	
HighTime	High Time	
Hold	Hold	
LowTime	Low Time	
NegativeDutyCycle	-Duty Cycle	
NegativeDutyCycleCycle	-CC-Duty	
NegativeWidth	Neg Width	
NPeriod	N-Period	
PerCycleCycle	CC-Period	
Period	Period	
PhaseNoise	Phase Noise	
PJ	PJ	
PositiveDutyCycle	+Duty Cycle	
PositiveDutyCycleCycle	+CC-Duty	
PositiveWidth	Pos Width	
RiseTime	Rise Time	
RJ	RJ	
RJδδ	RJ-δδ	
Setup	Setup	
Skew	Skew	
TIE	TIE	
TJ	TJ@BER	
TNTRatio	T/nT Ratio	

## Error Codes

Code	Description
W410	Number of edges are not sufficient for a measurement: Positive Width.
E1001	Vertical Autoset Failed: Signal on Source x has extreme offset.
E1002	Vertical Autoset Failed: Amplitude of Source x is too small.
E1003	Vertical Autoset Failed: Amplitude or DC offset of Source x is too high.

Code	Description
E1004	Vertical Autoset Failed: No signal on Source x.
E1005	Vertical Autoset Failed: Signal on Source x exceeds top of scale.
E1006	Vertical Autoset Failed: Signal on Source x exceeds bottom of scale.
E1007	Vertical Autoset Failed: Signal on Source x is clipped on top.
E1008	Vertical Autoset Failed: Signal on Source x is clipped on bottom.
E1009	Vertical Autoset Failed: Measurement error ( ISDB error code = 6 ) on Source x.
E1010	Vertical Autoset Failed: Measurement error ( ISDB error code = 7 ) on Source x.
W1011	A change to Source x vertical settings caused overload disconnect. Original settings are restored and Source x is reconnected. Ignore oscilloscope message.
E1012	Vertical Autoset Failed: None of the selected measurements use live sources (Ch1-Ch4). Horizontal autoset works for live sources only.
E1013	Vertical Autoset Failed: Invalid signal on Source x.
E1020	Horizontal Autoset Failed: None of the selected measurements use live sources (Ch1-Ch4). Horizontal autoset works for live sources only.
E1021	Horizontal Autoset Failed: On Source x, cannot determine resolution of rising/falling edges.
E1022	Horizontal Autoset Failed: Horizontal resolution is at the maximum.
E1035	Oscilloscope has gone into invalid state. Please restart the system.
E1040	Autoset Failed: None of the live sources (Ch1-Ch4) selected.
W1051	Ref Level Autoset: Waveform for the source x is clipped.
W1053	Ref Level Autoset: Source amplitude is extremely low.
E1054	Ref Level Autoset: Error in setting reference levels.
E1055	Ref Level Autoset Failed: No waveform to measure.
E1056	Ref Level Autoset: Unstable Histogram for waveform on source x.
E1057	Ref Level Autoset: No selected source.
E1058	Ref Level Autoset Failed: Invalid signal on source x.
E1059	Ref Level Autoset Error: Source x is not defined.
E2002	All the refs are used as sources by the measurements. Export to Ref is not possible.
E2003	Ref 'x' is already used as a measurement source.
E2004	Ref 'x' is already used as a destination for other measurement.
E2005	No measurement(s) are selected. Export to Ref is not possible.
E2006	No results available to export to ref.
E2007	There are no time trend results for the selected measurement(s).
E2008	No ref destination is selected. Results will not be exported to ref.
E3001	Could not open or create a log file. Please ensure that you have read/write permission to access log folders and files.
E3002	The specified path is invalid (for example: The specified path is not mapped to a drive).
E3003	The specified path, file name or both exceed the system defined length. For Example: On Windows-based platforms, the path name must be less than 248 characters and file names less than 260 characters.

Code	Description
E3004	The specified path directory is read-only or is not empty.
E3005	Please ensure that the file is currently not in use by other process and/or has not exceeded the file size limit.
E3006	Invalid filename: Check whether the file name contains a colon (:) in the middle of the string.
E3007	Select at least one measurement from the table before you save.
E3008	There are currently no results to save. Please run a measurement.
E3010	Access to file/directory denied. Please ensure that the file/directory has read/write permissions.
E3011	Mask Hits Measurements will not be selected as this feature is not available for Mask Hits measurement.
E3012	Folder does not exist.
E4000	Not enough data points. Unable to render plot(s).
E4001	Out of memory. Please remove a measurement and try again.
E4002	Not enough data points for spectrum computation.
E4003	Low Memory. The entire waveform was not processed and the measurement results are for part of the waveform.
E4004	Edge Extraction failure.
E4005	Qualifier: Horizontal parameters do not match across waveforms.
W4006	A maximum of 10 qualifier zones are supported. The entire waveform will not be processed and hence partial measurement results are available.

## Measurement Values

The following table lists the maximum and minimum values of all measurements:

Name	Measurement Range Limits (Max)			Measurement Range Limits (Min)		
	Default	Max	Min	Default	Max	Min
<b>Period/Freq measurements</b>						
Period	1 ms	1 ks	0 ns	0 ns	1 ks	0 ns
CC-Period	1 ns	1 s	1 fs	-1 ns	-1 fs	-1 s
Freq	10GHz	50GHz	1 MHz	10 KHz	50 GHz	1 MHz
N-Period	1 ms	1 ks	0 ns	0 ns	1 ks	0 ns
Pos Width/ Neg Width	10 ns	1 Ms	1 ps	1 ns	1 Ms	1 ps
+Duty Cycle/-Duty Cycle	90 %	100 %	0 %	10 %	100 %	0 %
+CC-Duty/ -CC-Duty	1 ns	1 ks	-1 ks	-1 ns	1 ks	-1 ks

	Measurement Range Limits (Max)			Measurement Range Limits (Min)		
<b>Jitter Measurements</b>						
TIE	1 ns	1 $\mu$ s	-1 $\mu$ s	-1 ns	1 $\mu$ s	-1 $\mu$ s
RJ	1 ns	1 $\mu$ s	0 ns	1 ns	1 $\mu$ s	0 ns
RJ- $\delta\delta$	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
TJ	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
DJ	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
DJ- $\delta\delta$	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
Phase Noise	1 ms	1 ms	0 s	0 s	1 ms	0 s
DCD	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
DDJ	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
PJ	1 ns	1 $\mu$ s	0 ns	0 ns	1 $\mu$ s	0 ns
<b>Time Measurements</b>						
Rise Time	200 ns	1 ks	0 ns	0 s	1 ks	0 ns
Setup	10 ns	1 s	-1 s	0 ns	1 s	-1 s
High Time	10 ns	1 Ms	1 ps	0 s	1 Ms	1 ps
Fall Time	200 ns	1 ks	0 ns	0 s	1 ks	0 ns
Hold	10 ns	1 s	-1 s	0 ns	1 s	-1 s
Low Time	10 ns	1 Ms	1 ps	0 s	1 Ms	1 ps
Skew	10 ns	1 s	-1 s	-10 ns	1 s	-1 s
<b>Eye Measurements</b>						
Height	500 mV	1 kV	0 mV	50 mV	1 kV	0 mV
Width	1 ns	1 s	0 ps	50 ps	1 s	0 ps
Mask Hits	500 Hits	1 MHit	0 Hits	0 Hits	1 MHit	0 Hits
Width@BER	0.9 UI	1.0 UI	0 UI	0.1 UI	1.0 UI	0 UI
<b>Amplitude Measurements</b>						
Common Mode	500 mV	10 V	-10 V	-500 mV	10 V	-10 V
High	500 mV	10 V	-10 V	-500 mV	10 V	-10 V
T/nt-Ratio	8 dB	12 dB	-12 dB	0 dB	12 dB	-12 dB
High-Low	500 mV	10 V	-10 V	-500 mV	10 V	-10 V
Low	500 mV	10 V	-10 V	-500 mV	10 V	-10 V
V-Diff-Xovr	500 mV	10 V	-10 V	-500 mV	10 V	-10 V
<b>More Measurements</b>						
DDR Setup-SE	10 ns	1 s	-1 s	0 ns	1 s	-1 s
DDR Setup-Diff	10 ns	1 s	-1 s	0 ns	1 s	-1 s

	Measurement Range Limits (Max)			Measurement Range Limits (Min)		
DDR Hold-SE	10 ns	1 s	-1 s	0 ns	1 s	-1 s
DDR Hold-Diff	10 ns	1 s	-1 s	0 ns	1 s	-1 s

## About Algorithms

The DPOJET application can take measurements from one or two waveforms. The number of waveforms used by the application depends on the type of measurement being taken.

### Oscilloscope Setup Guidelines

For all measurements, use the following guidelines to set up the oscilloscope:

1. The signal is any channel, reference, or math waveform.
2. The vertical scale for the waveform must be set so that the waveform does not exceed the vertical range of the oscilloscope.
3. The sample rate must be set to capture sufficient waveform detail and avoid aliasing.
4. Longer record lengths increase measurement accuracy but the oscilloscope takes longer to measure each waveform.

## Period

### If the Signal Type is Clock

The Period measurement calculates the duration of a cycle as defined by a start and a stop edge. Edges are defined by polarity, threshold, and hysteresis. The application calculates clock period measurement using the following equation:

$$P_n^{Clock} = T_{n+1} - T_n$$

Where:

$P^{Clock}$  is the clock period.

$T$  is the VRefMid crossing time for the selected polarity.

### If the Signal Type is Data

The Period measurement calculates the duration of a Unit Interval. The application calculates this measurement using the following equation:

$$P_n^{Data} = (T_n^{Data} - T_{n-1}^{Data}) / K_n$$

Where:

$P^{Data}$  is the data period.

$T^{Data}$  is the VRefMid crossing time in either direction.

$K_n = C_n - C_{n-1}$  is the estimated number of unit intervals between two successive edges.  $C_n$  is the calculated data bit index of  $T_n^{Data}$ .

Each measurement result  $P_n^{Data}$  is repeated  $K_n$  times in the measurement result vector, so that the measurement population is equal to the number of unit intervals in the qualified waveform, rather than the number of edge pairs.

## Positive and Negative Width

Amount of time the waveform remains above/below the mid reference voltage level.

The application calculates these measurements using the following equations:

$$W_n^+ = T_n^- - T_n^+$$

$$W_n^- = T_n^+ - T_n^-$$

Where:

$W^+$  is the positive pulse width.

$W^-$  is the negative pulse width.

$T^-$  is the VRefMid crossing on the falling edge.

$T^+$  is the VRefMid crossing on the rising edge.



## Frequency

Frequency measurement calculates the inverse of the data period for each cycle.

### If the Signal Type is Clock

The application calculates clock frequency measurement using the following equation:

$$F_n^{Clock} = 1 / P_n^{Clock}$$

Where:

$F^{Clock}$  is the clock frequency.

$P^{Clock}$  is the clock period measurement.

### If the Signal Type is Data

The application calculates data frequency measurement using the following equation:

$$F_n^{Data} = 1 / P_n^{Data}$$

Where:

$F^{Data}$  is the data frequency.

$P^{Data}$  is the data period measurement.

## N-Period

### If the Signal Type is Clock

The N-Period measurement calculates the elapsed time for N consecutive crossings of the mid reference voltage level in the direction specified.

The application calculates this measurement using the following equation:

$$NP_n^{Clock} = T_{n+N}^{Clock} - T_n^{Clock}$$

Where:

$NP^{Clock}$  is the accumulated period for N clock cycles.

$T^{Clock}$  is the VRefMid crossing time for the selected edge polarity.

### If the Signal Type is Data

The N-Period measurement calculates the elapsed time for N consecutive unit intervals.

The application calculates this measurement using the following equation:

$$NP_n^{Data} = T_{n+N}^{Data} - T_n^{Data}$$

Where:

$NP^{Data}$  is the duration for N unit intervals.

$T^{Data}$  is the VRefMid crossing time in either direction.

If  $T_{n+N}^{Data}$  does not exist for a given n, no measurement is recorded for that position.

## Positive and Negative Duty Cycle

The +Duty Cycle and –Duty Cycle measurements calculate the ratio of the positive (or negative) portion of the cycle relative to the period.

The application calculates these measurements using the following equations:

$$D_n^+ = W_n^+ / P_n^{Clock}$$

$$D_n^- = W_n^- / P_n^{Clock}$$

Where:

$D^+$  is the positive duty cycle.

$D^-$  is the negative duty cycle.

$W^+$  is the positive pulse width.

$W^-$  is the negative pulse width.

$P^{Clock}$  is the period.

### Related Topics

- Period
- Positive and Negative Width

## CC-Period

The CC–Period measurement calculates the difference in period measurements from one cycle to the next.

The application calculates CC–Period measurement using the following equation:

$$\Delta P_n = P_{n+1}^{Clock} - P_n^{Clock}$$

Where:

$\Delta P$  is the difference between adjacent periods.

$P^{Clock}$  is the clock period measurement.

## Positive and Negative CC Duty

The + CC-Duty and – CC-Duty measurements calculate the difference in positive (or negative) pulse widths from one cycle to the next.

The application calculates these measurements using the following equations:

$$\Delta W_n^+ = \Delta W_n^+ - \Delta W_{n-1}^+$$

$$\Delta W_n^- = \Delta W_n^- - \Delta W_{n-1}^-$$

Where:

$\Delta W^+$  is the difference between positive pulse widths of adjacent clock cycles.

$\Delta W^-$  is the difference between negative pulse widths of adjacent clock cycles.

$W^+$  is the positive pulse width measurement.

$W^-$  is the negative pulse width measurement.

## TIE

TIE (Time Interval Error) is the difference in time between an edge in the source waveform and the corresponding edge in a reference clock. The reference clock is usually determined by a clock recovery process performed on the source waveform. For Explicit-Clock clock recovery, the process is performed on an explicitly identified source.

### If the Signal Type is Clock

The application calculates Clock TIE measurement using the following equation:

$$TIE_n^{Clock} = T_n^{Clock} - T_n^{'Clock}$$

Where:

$TIE^{Clock}$  is the clock time interval error.

$T^{Clock}$  is the VRefMid crossing time for the specified clock edge.

$T^{'Clock}$  is the corresponding edge time for the specified reference clock.

### If the Signal Type is Data

The application calculates Data TIE measurement using the following equation:

$$TIE_k^{Data} = T_k^{Data} - T_k^{RefData}$$

Where:

$TIE^{Data}$  is the data time interval error.

$T^{Data}$  is the VRefMid crossing time in either direction.

$T^{RefData}$  is the corresponding edge time for the specified reference clock.

The subscript k is used to indicate that there is one measurement per Unit Interval, rather than one measurement per actual edge.

## RJ

Random Jitter (RJ) is the rms magnitude of all timing errors not exhibiting deterministic behavior. A single RJ value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation

## Dual Dirac Random Jitter

Dual Dirac Random Jitter (RJ- $\delta\delta$ ) is the rms magnitude of all timing errors not exhibiting deterministic behavior, calculated based on a simplifying assumption that the histogram of all deterministic jitter can modeled as a pair of equal-magnitude dirac functions (impulses). A single RJ- $\delta\delta$  value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation
- Jitter Estimation Using Dual-Dirac Models

## Jitter Summary

The Jitter Summary is not a single measurement. The Jitter Summary button on the graphical user interface simply creates one each of all the other jitter measurements, as a convenience. This convenience function is not supported via the programmable interface.

## TJ@BER

Total Jitter at a specified Bit Error Rate (BER). This extrapolated value predicts a peak-to-peak jitter that will only be exceeded with a probability equal to the BER. It is generally not equal to the total jitter actually observed in any given acquisition. A single TJ@BER value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation
- Estimation of TJBer and Eye WidthBer

## DJ

Deterministic Jitter (DJ) is the peak-to-peak amplitude for all timing errors that follow deterministic behavior. A single DJ value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation

## Dual Dirac Deterministic Jitter

Dual Dirac Deterministic Jitter ( $DJ-\delta\delta$ ) the peak-to-peak magnitude for all timing errors exhibiting deterministic behavior, calculated based on a simplifying assumption that the histogram of all deterministic jitter can modeled as a pair of equal magnitude dirac functions (impulses). A single  $DJ-\delta\delta$  value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation
- Jitter Estimation Using Dual-Dirac Models

## Phase Noise

The Phase Noise measurement performs a jitter measurement, converts the result into the frequency domain, and reports the rms jitter integrated between two specific frequencies selected by the user.

The phase noise measurement is defined only for clock signals. If the source waveform appears to be a data signal, a warning message will be produced but the measurement will proceed.

A Phase Noise measurement is required in order to enable the Phase Noise plot.

## PJ

Periodic Jitter (PJ) is the peak-to-peak amplitude for that portion of the deterministic jitter which is periodic, but for which the period is not correlated with any data pattern in the waveform. A single PJ value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation

## DDJ

Data-Dependent Jitter (DDJ) is the peak-to-peak amplitude for that portion of the deterministic jitter directly correlated with the data pattern in the waveform. A single DDJ value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation

## DCD

Duty Cycle Distortion (DCD) is the peak-to-peak amplitude for that portion of the deterministic jitter directly correlated with signal polarity, that is the difference between the mean positive edge displacement versus that on negative edges. A single DCD value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation



## Rise Time

The Rise Time measurement is the time difference between when the VRefHi reference level is crossed and the VRefLo reference level is crossed on the rising edge of the waveform. The Rise Time algorithm uses the VRef values as the reference voltage level. Each edge is defined by the slope, voltage reference level (threshold), and hysteresis.

The application calculates this measurement using the following equation:

$$T_n^{Rise} = T_n^{Hi+} - T_n^{Lo+}$$

Where:

$T^{Rise}$  is the Rise Time.

$T^{Hi+}$  is the VRefHi crossing on the rising edge.

$T^{Lo+}$  is the VRefLo crossing on the rising edge.

## Fall Time

The Fall Time measurement is the time difference between when the VRefLo reference level is crossed and the VRefHi reference level is crossed on the falling edge of the waveform. The Fall Time algorithm uses the VRef values as the reference voltage level. Each edge is defined by the slope, voltage reference level (threshold), and hysteresis.

The application calculates this measurement using the following equation:

$$T_n^{Fall} = T_n^{Lo-} - T_n^{Hi-}$$

Where:

$T^{Fall}$  is the Fall Time.

$T^{Lo-}$  is the VRefLo crossing on the falling edge.

$T^{Hi-}$  is the VRefHi crossing on the falling edge.

## Skew

The Skew measurement calculates the difference in time between the designated edge on a principle waveform to the designated edge on another waveform. The closest data edge to the clock edge that falls within the range limits is used.

The application calculates this measurement using the following equation:

$$T_n^{Skew} = T_n^{Main} - T_n^{2nd}$$

Where:

$T^{Skew}$  is the timing skew.

$T^{Main}$  is the Main input VRefMidMain crossing time in the specified direction.

$T^{2nd}$  is the 2nd input VRefMid2nd crossing time in the specified direction.

## High Time

The High Time Measurement is the amount of time that a waveform cycle is above the VRefHi voltage reference level.

The application calculates the measurement using the following equation:

$$T_n^{High} = T_n^{Hi-} - T_n^{Hi+}$$

Where:

$T^{High}$  is the high time.

$T^{Hi-}$  is the VRefHi crossing on the falling edge.

$T^{Hi+}$  is the VRefHi crossing on the rising edge.

## Low Time

The Low Time measurement is the amount of time that a waveform cycle is below the VRefLo voltage reference level.

The application calculates this measurement using the following equation:

$$T_n^{Low} = T_n^{Lo+} - T_n^{Lo-}$$

Where:

$T^{Low}$  is the low time.

$T^{Lo+}$  is the VRefLo crossing on the rising edge.

$T^{Lo-}$  is the VRefLo crossing on the falling edge.

## Setup

The Setup Time measurement is the elapsed time between the designated edge of a data waveform and when the clock waveform crosses its own voltage reference level. The closest data edge to the clock edge that falls within the range limits is used.

The application calculates this measurement using the following equation:

$$T_n^{Setup} = T_i^{Main} - T_n^{2nd}$$

Where:

$T^{Setup}$  is the setup time.

$T^{Main}$  is the Main input (clock) VRefMidMain crossing time in the specified direction.

$T^{2nd}$  is the 2nd input (data) VRefMid2nd crossing time in the specified direction.

## Hold

The Hold Time measurement is the elapsed time between when the clock waveform crosses its own voltage reference level and the designated edge of a data waveform. The closest data edge to the clock edge that falls within the range limits is used.

The application calculates this measurement using the following equation:

$$T_n^{Hold} = T_n^{2nd} - T_i^{Main}$$

Where:

$T^{Hold}$  is the hold time.

$T^{Main}$  is the Main input (clock) VRefMidMain crossing time in the specified direction.

$T^{2nd}$  is the 2nd input (data) VRefMid2nd crossing time in the specified direction.

## Eye Width

The Eye Width measurement is the measured minimum horizontal eye opening at the zero reference level.

The application calculates this measurement using the following equation:

$$T_{EYE-WIDTH} = UI_{AVG} - TIE_{pk-pk}$$

Where:

$UI_{AVG}$  is the average UI.

$TIE_{pk-pk}$  is the Peak-Peak TIE.

## Width@BER

Width@BER is the Eye Width at a specified Bit Error Rate (BER). This extrapolated value predicts a horizontal eye opening that will be violated with a probability equal to the BER. It is generally not equal to the eye width actually observed in any given acquisition. A single Width@BER value is determined for each acquisition, by means of RJ/DJ separation analysis.

### Related Topics

- Jitter Analysis Through RJDJ Separation
- Estimation of TJ@BER and Eye Width@BER

## Eye Height

The Eye Height measurement is the measured minimum vertical eye opening at the UI center as shown in the plot of the eye diagram. There are three types of Eye Height values.

The application calculates this measurement using the following equation:

$$V_{EYE-HEIGHT} = V_{EYE-HI-MIN} - V_{EYE-LO-MAX}$$

Where:

$V_{EYE-HI-MIN}$  is the minimum of the High voltage at mid UI.

$TIE_{EYE-LO-MAX}$  is the maximum of the Low voltage at mid UI.

### Eye Height-Transition

The application calculates this measurement using the following equation:

$$V_{EYE-HEIGHT-TRAN} = V_{EYE-HI-TRAN-MIN} - V_{EYE-LO-TRAN-MAX}$$

Where:

$V_{EYE-HI-TRAN-MIN}$  is the minimum of the High transition bit eye voltage at mid UI.

$TIE_{EYE-LO-TRAN-MAX}$  is the maximum of the Low transition bit eye voltage at mid UI.

### Eye Height-Non-Transition

The application calculates this measurement using the following equation:

$$V_{EYE-HEIGHT-NTRAN} = V_{EYE-HI-NTRAN-MIN} - V_{EYE-LO-NTRAN-MAX}$$

Where:

$V_{EYE-HI-NTRAN-MIN}$  is the minimum of the High non- transition bit eye voltage at mid UI.

$TIE_{EYE-LO-NTRAN-MAX}$  is the maximum of the Low non-transition bit eye voltage at mid UI.

## Mask Hits

The Mask Hits measurement reports the number of unit intervals in the acquisition for which mask hits occurred, for a user-specified mask. In the Results Summary view, the Mask Hits measurement reports the total number of unit intervals for which a mask hit occurred in at least one mask zone. In the Results Details view, the number of hits in each of three segments is reported. The population field shows the total number of unit intervals measured.

The Mask Hits measurement has several unique properties:

- Unlike other measurements, it requires a Mask hits plot. Adding a Mask Hits measurement will cause the corresponding plot to be created automatically. If you delete a Mask Hits plot, the application will remove the corresponding Mask Hits measurement after verifying the action with you.
- The Mask Hits measurement does not support the Worst-Case Waveforms logging feature.
- The Mask Hits measurement does not support Measurement Range Limits.

## High

The High Amplitude measurement calculates the mean or mode of a selected portion of each unit interval corresponding to a “1” bit.

The application calculates this measurement using the following equation:

$$V_{HI}(n) = OP[v_{PERCENT}(n)]$$

Where:

$V_{HI}$  is the high amplitude measurement result.

$OP[\bullet]$  is the selected Operation (either Mean or Mode).

$v_{PERCENT}$  is the set of voltage samples over the selected portion (percent) of the unit interval, ranging from 1% to 100%.

$n$  is the index of a high bit, a high transition bit, or a high non-transition bit.

## Low

The Low Amplitude measurement calculates the mean or mode of a selected portion of each unit interval corresponding to a “0” bit.

The application calculates this measurement using the following equation:

$$V_{LO}(n) = OP[v_{PERCENT}(n)]$$

Where:

$V_{LOW}$  is the low amplitude measurement result.

$OP[\bullet]$  is the selected Operation (either Mean or Mode).

$v_{PERCENT}$  is the set of voltage samples over the selected portion (percent) of the unit interval, ranging from 1% to 100%.

$n$  is the index of a low bit, a low transition bit, or a low non-transition bit.

## Common Mode

The Common Mode Voltage measurement (also called DC Common Mode) calculates the mean of the Common Mode voltage waveform.

The application calculates this measurement using the following equation:

$$V_{CM} = \text{Mean}(v_{CM}(i))$$

Where:

$V_{CM}$  is the common mode voltage measurement.

$$v_{CM} = \frac{(v_{Source\ 1} + v_{Source\ 2})}{2}$$

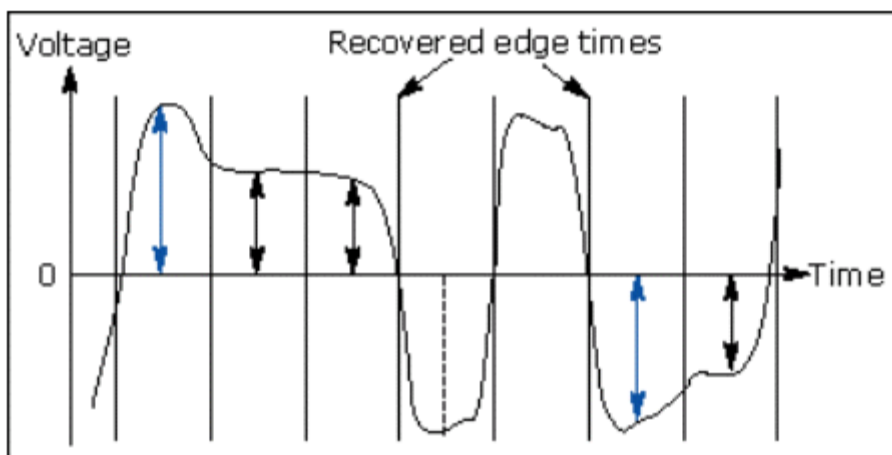
is the common mode voltage waveform.

$i$  is the sample index of common mode waveform values.

## T/nT Ratio

The T/nT Ratio measurement reports the amplitude ratio between transition and non-transition bits.

The measurement calculates the ratios of all non-transition eye voltages (2nd and subsequent eye voltages after one edge but before the next) to their nearest preceding transition eye voltage (1st eye voltage succeeding an edge). In the accompanying diagram, it is the ratio of the Black voltages to the Blue voltages. The results are given in dB.



The application calculates the T/nT Ratio using the following equations:



$$TnT(m) = dB \left( \frac{v_{EYE-HI-NTRAN}(m)}{v_{EYE-HI-TRAN}(n)} \right)$$

following a rising edge.

$$TnT(m) = dB \left( \frac{v_{EYE-LO-NTRAN}(m)}{v_{EYE-LO-TRAN}(n)} \right)$$

following a falling edge.

Where:

$v_{EYE-HI-TRAN}$  is the High voltage at the interpolated midpoint of the first unit interval following a positive transition.

$v_{EYE-LO-TRAN}$  is the Low voltage at the interpolated midpoint of the first unit interval following a negative transition.

$v_{EYE-HI-NTRAN}$  is the High voltage at the interpolated midpoint of all unit intervals except the first following a positive transition.

$v_{EYE-LO-NTRAN}$  is the Low voltage at the interpolated midpoint of all unit intervals except the first following a negative transition.

$m$  is the index for all non-transition UIs.

$n$  is the index for the nearest transition UI preceding the UI specified by  $m$ .

In a time trend plot of the measurement results, there is one measurement for each non-transition bit in the waveform (that is the black arrows in the diagram).

## High-Low

The High–Low measurement calculates the change in voltage level across a transition in the waveform.

The application calculates the High–Low using the following equation:

$$V_{HIGH-LOW}(n) = |V_{LEVEL}(i) - V_{LEVEL}(i + 1)|$$

Where:

$V_{HIGH-LOW}$  is the high-low amplitude measurement result.

$n$  is the index of a selected transition.

$i$  is the index of the UI (bit) location preceding the transition.

$i+1$  is the index of the UI (bit) location following the transition.

$V_{LEVEL} = OP[V_{PERCENT}(i)]$  is the state level of the unit interval (bit period).

$OP[\bullet]$  is the selected Operation (either Mean or Mode).

$V_{PERCENT}$  is the set of voltage samples over the selected portion (percent) of the unit interval, ranging from 1% to 100%.

---

**NOTE.** *If there are no waveform samples that fall within the identified percentage of the unit interval, the single nearest waveform sample preceding the center point of the unit interval will be used.*

---

## V-Diff-Xovr

The Differential Crossover Voltage measurement (V–Diff–Xovr) calculates the voltage level at the crossover voltage of a differential signal pair. If there is timing jitter on one of the pair of signal lines relative to the other, the crossover point will be modulated by the jitter. The measurement is calculated using the following equation:

$$V_n^{Crossover} = V_n^{Source1}(T_n^{Crossover})$$

Where:

$V^{Crossover}$  is the crossing voltage.

$V^{Source1}$  is the voltage of the first source waveform.

$T^{Crossover}$  is the crossover time, when the Source1 and Source2 waveforms are equal in voltage.

## DDR Setup and Hold Measurements

The following four measurements are modified versions of the basic Setup and Hold measurements found on the Time tab. In contrast to the basic measurements which always use the Mid voltage reference to determine edge times, these measurements use the High and Low references as required to conform to some DDR specifications. For all these measurements, the Strobe signal (DQS) is assigned to Source1 and the Data signal is assigned to Source2.

The measurements with names ending in “-Diff” are appropriate if you have a differential Data Strobe (DQS) signal. Either connect to DQS+ and DQS- with a differential probe, or acquire these signals with two single-ended probes and create a (pseudo-) differential signal using a Math expression (for example: “Math1 = Ch1 – Ch2”). In this case, the data (DQ) signal uses thresholds other than the mid threshold, but the DQS signal uses a mid threshold set to 0 V.

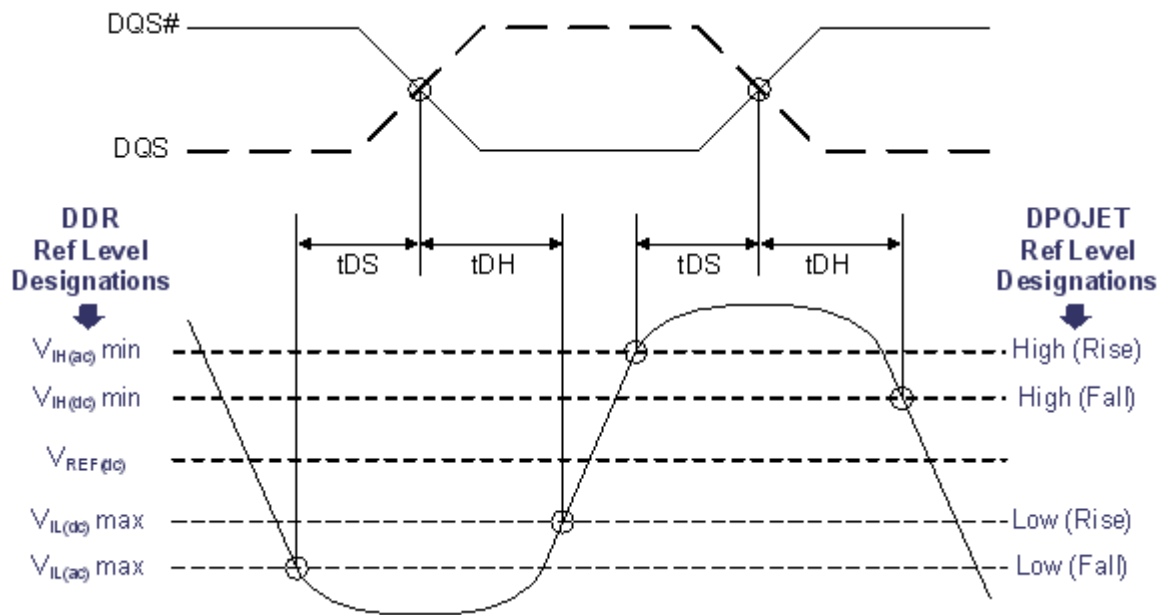
Check that the DPOJET reference levels for the data source are set to match the proper values of VIH(ac), VIH(dc), VIL(ac) and VIL(dc) for the DDR technology that you are measuring. Depending on which edges you choose to measure (Rising, Falling or Both), you may not need to set up all of these levels. For more details on reference level setup, refer to [DDR Setup/Hold Reference Levels: Differential DQS](#).

The measurements with names ending in “-SE” are appropriate if you have a single-ended data strobe (DQS) signal. This is allowed in DDR2 but not in DDR3. In this case, both the clock (DQS) and data (DQ) signals use thresholds other than the mid threshold.

Check that the DPOJET reference levels for the strobe and data sources are set to match the proper values of VIH(ac), VIH(dc), VIL(ac), and VIL(dc) for the DDR technology that you are measuring. Depending on which edges you choose to measure (Rising, Falling or Both), you may not need to set up all of these levels. For more details on the reference level setup, refer to [DDR Setup/Hold Reference Levels: Single-ended DQS](#).

### DDR Setup/Hold Reference Levels: Differential DQS

For systems with a differential DQS signal, the waveform reference points for the Setup (tDS) and Hold (tDH) measurements details are as shown:



For the Strobe channel (Source1), the mid reference level should be set to 0V and the High and Low references are not used. The reference levels for the Data channel (Source2) are mapped to the source configuration panel as follows:

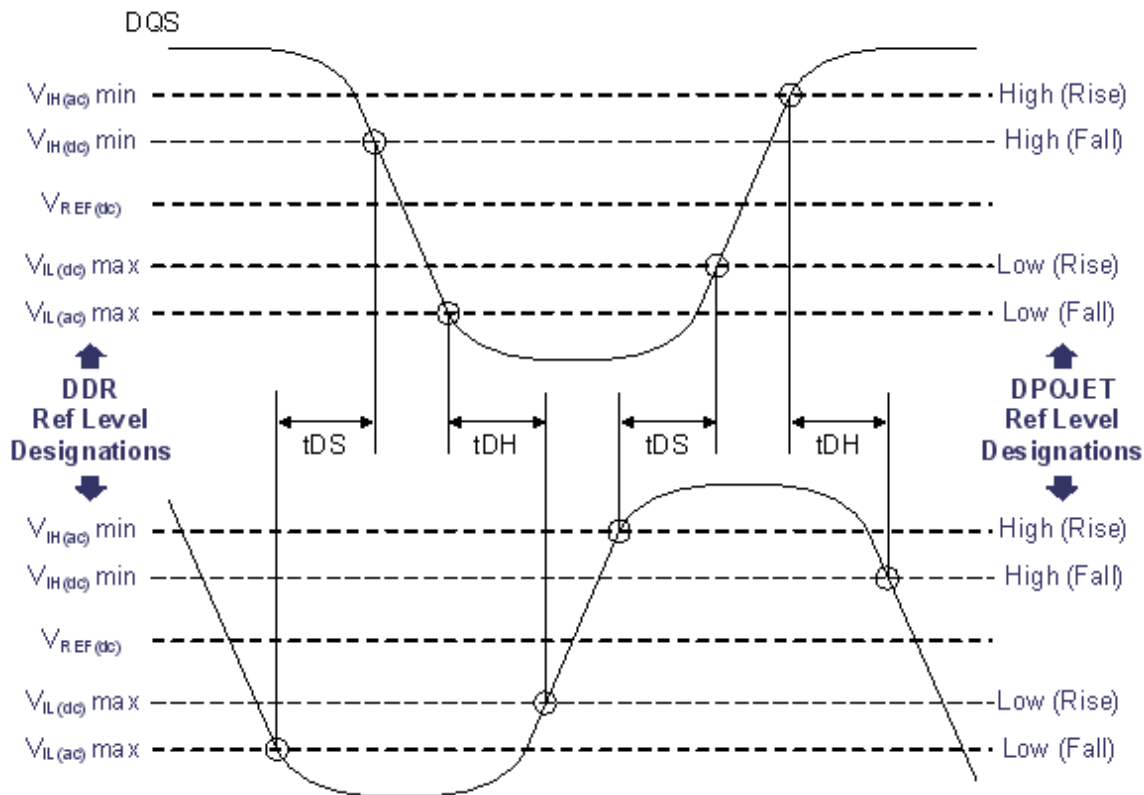
<b>Rise</b>	<b>Fall</b>	
<b>High</b>	<b>High</b>	
$V_{IH(ac)} \min$	$V_{IH(dc)} \min$	
<b>Mid</b>	<b>Mid</b>	<input checked="" type="checkbox"/> Mid = 0V
<b>Low</b>	<b>Low</b>	<b>Hysteresis</b>
$V_{IL(dc)} \max$	$V_{IL(ac)} \max$	

Typical values for the reference levels for some current technologies can be found here:

- [DDR2-400, DDR2-533 Reference Levels](#)
- [DDR2-667, DDR2800 Reference Levels](#)
- [DDR3-800 through DDR3-1600 Reference Levels](#)

### DDR Setup/Hold Reference Levels: Single-ended DQS

For systems with a single-ended DQS signal, the waveform reference points for the Setup ( $t_{DS}$ ) and Hold ( $t_{DH}$ ) measurements details are as shown:



For both the Strobe channel (Source1) and the Data channel (Source2), the reference levels are mapped to the source configuration panel as follows:

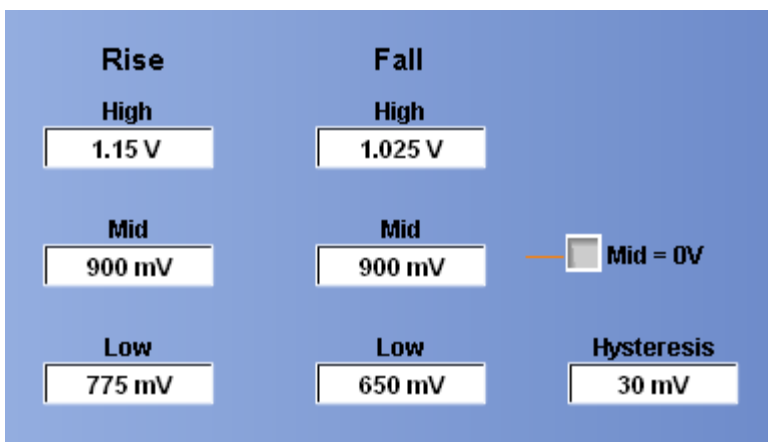
Rise	Fall	
High	High	
$V_{IH(ac) min}$	$V_{IH(dc) min}$	
Mid	Mid	<input type="checkbox"/> Mid = 0V
Low	Low	Hysteresis
$V_{IL(dc) max}$	$V_{IL(ac) max}$	

Typical values for the reference levels for some current technologies can be found here:

- [DDR2-400, DDR2-533 Reference Levels](#)
- [DDR2-667, DDR2800 Reference Levels](#)
- [DDR3-800 through DDR3-1600 Reference Levels](#)

### DDR2-400, DDR2-533 Reference Levels

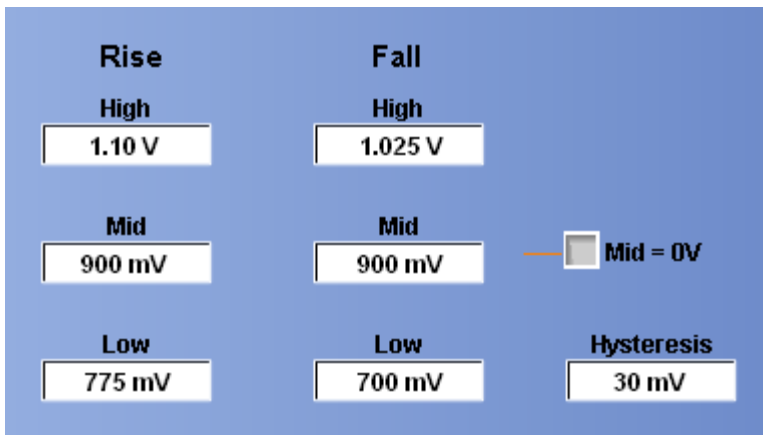
The following reference levels are typical for single-ended signals in DDR2-400 and DDR2-533 technologies.



The best levels depend on many variables, including the supply voltage, probe point and any spec amendments, and so use this information only for general guidance.

### DDR2-667, DDR2-800 Reference Levels

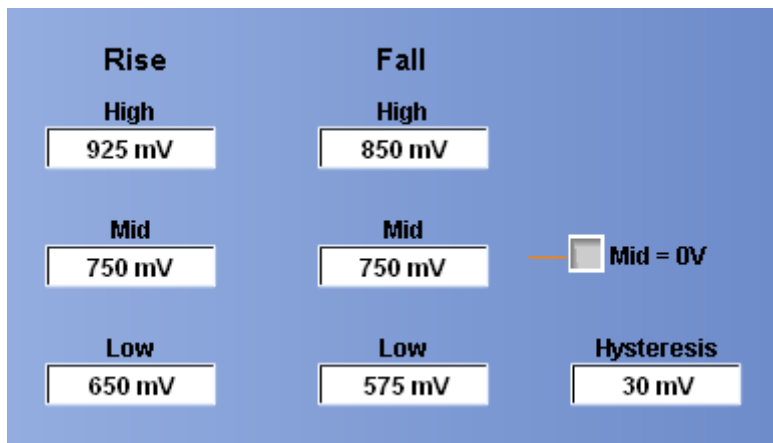
The following reference levels are typical for single-ended signals in DDR2-667 and DDR2-800 technologies.



The best levels depend on many variables, including the supply voltage, probe point and any spec amendments, and so use this information only for general guidance.

### DDR3-800 through DDR3-1600 Reference Levels

The following reference levels are typical for single-ended signals in DDR3-800 through DDR3-1600 technologies.



The best levels depend on many variables, including the supply voltage, probe point and any spec amendments, and so use this information only for general guidance.

## DDR Setup-SE

The DDR Setup-SE measures the elapsed time between the designated edge of a data waveform and when the single-ended strobe (DQS) waveform crosses its own voltage reference level. The closest data edge to the clock edge that falls within the range limits is used. The strobe is placed on Source1 and the Data is placed on Source2. This is the base Setup measurement, which does not include slew-rate derating. Slew-rate derating tables can be found in the applicable JEDEC specification.

This measurement is identical to the basic Setup measurement except that instead of using the Mid reference voltage for determining edge times, it uses the High and Low reference voltages for both the Data and Strobe (DQS). For more details on the reference voltage setup, refer to [DDR Setup/Hold Reference Levels: Single-ended DQS](#).

The application calculates this measurement using the following equation:

$$T_n^{Setup} = T_i^{Min} - T_n^{2nd}$$

Where:

$T_{Setup}$  is the setup time.

$T^{Main}$  is the Main input (strobe or DQS) crossing time of VRefHighFall (for falling strobe edges) or VRefLowRise (for rising strobe edges).

$T^{2nd}$  is the 2nd input (data or DQ) crossing time of VRefLowFall (for falling data edges) or VRefHighRise (for rising data edges).

## DDR Setup-Diff

The DDR Setup–Diff measures the elapsed time between the designated edge of a data waveform and when the differential strobe (DQS) waveform crosses its own voltage reference level. The closest data edge to the clock edge that falls within the range limits is used. The strobe is placed on Source1 and the Data is placed on Source2. This is the base Setup measurement, which does not include slew-rate derating. Slew-rate derating tables can be found in the applicable JEDEC specification.

This measurement is identical to the basic Setup measurement except that instead of using the Mid reference voltage for determining edge times, it uses the High and Low reference voltages for the Data. The Mid reference level is still used for the Strobe (DQS). For more details on the reference voltage setup, refer to [DDR Setup/Hold Reference Levels: Differential DQS](#).

The application calculates this measurement using the following equation:

$$T_n^{Setup} = T_i^{Main} - T_n^{2nd}$$

Where:

$T^{Setup}$  is the setup time.

$T^{Main}$  is the Main input (strobe or DQS) crossing time of VRefMid in the specified direction.

$T^{2nd}$  is the 2nd input (data or DQ) crossing time of VRefLowFall (for falling data edges) or VRefHighRise (for rising data edges).



## DDR Hold-SE

The DDR Hold-SE measures the elapsed time between the designated edge of the single-ended strobe (DQS) waveform and the designated edge of a data waveform. The closest data edge to the clock edge that falls within the range limits is used. The strobe is placed on Source1 and the Data is placed on Source2. This is the base Hold measurement, which does not include slew-rate derating. Slew-rate derating tables can be found in the applicable JEDEC specification.

This measurement is identical to the basic Hold measurement except that instead of using the Mid reference voltage for determining edge times, it uses the High and Low reference voltages for both the data and strobe (DQS). For more details on the reference voltage setup, refer to [DDR Setup/Hold Reference Levels: Single-ended DQS](#).

The application calculates this measurement using the following equation:

$$T_n^{Hold} = T_n^{2nd} - T_i^{Main}$$

Where:

$T^{Hold}$  is the hold time.

$T^{Main}$  is the Main input (strobe or DQS) crossing time of VRefLowFall (for falling strobe edges) or VRefHighRise (for rising strobe edges).

$T^{2nd}$  is the 2nd input (data or DQ) crossing time of VRefHighFall (for falling data edges) or VRefLowRise (for rising data edges).

## DDR Hold-Diff

The DDR Hold–Diff measures the elapsed time between the designated edge of the single-ended strobe (DQS) waveform and the designated edge of a data waveform. The closest data edge to the clock edge that falls within the range limits is used. The strobe is placed on Source1 and the Data is placed on Source2. This is the base Hold measurement, which does not include slew-rate derating. Slew-rate derating tables can be found in the applicable JEDEC specification.

This measurement is identical to the basic Hold measurement except that instead of using the Mid reference voltage for determining edge times, it uses the High and Low reference voltages for the data. The mid reference level is still used for the strobe (DQS). For more details on the reference voltage setup, refer to [DDR Setup/Hold Reference Levels: Differential DQS](#).

The application calculates this measurement using the following equation:

$$T_n^{Hold} = T_n^{2nd} - T_i^{Main}$$

Where:

$T^{Hold}$  is the hold time.

$T^{Main}$  is the Main input (strobe or DQS) crossing time of VRefMid in the specified direction.

$T^{2nd}$  is the 2nd input (data or DQ) crossing time of VRefHighFall (for falling data edges) or VRefLowRise (for rising data edges).

## Jitter Analysis Through RJ/DJ Separation

Many of the jitter measurements are based on the concept of RJ/DJ separation. The application begins with the measured jitter-versus-time (as represented by the TIE measurement array) and analytically determines the random and deterministic components of the jitter. The deterministic part is further separated into independent subcomponents with specific characteristics.

The random jitter (RJ) is assumed to be zero-mean Gaussian, and is assumed to have a flat spectrum when viewed in the frequency domain. The measured RJ is fitted to a Gaussian mathematical model, which is parameterized by its standard deviation. Using the mathematical model for RJ, statistically probable jitter extremes may be predicted for much greater populations than actually measured.

The deterministic jitter (DJ) is predictable and can be generated consistently given known circumstances. The various DJ measurements each report the peak-to-peak value of the corresponding DJ subcomponent.

Once all the jitter components have been identified and the random jitter has been converted to a mathematical model, the components can be reassembled such that performance may be extrapolated to extremely low bit error rates. The probabilistic Total Jitter (TJ@BER) and probabilistic Eye Width (Width@BER) are examples of such measurements. The reported values are predictions that correspond to a user-specified Bit Error Rate, rather than observed values.

Two approaches are supported for performing jitter separation. The first method is based on spectrum analysis. It is only possible when the data pattern is repetitive. A clock waveform is always repetitive.

Other repetitive testing data patterns are used, such as the K28.5 data pattern. Patterns may have rather long repetition lengths; for example, the CJTPAT pattern is 2640 bits. When using this method, you must specify the pattern length, and you will receive a warning if the pattern length appears to differ from that specified.

The second RJ/DJ separation method, known as arbitrary pattern analysis, may be used when the data pattern is not necessarily repetitive. This method works by correlating deterministic jitter observed over many repetitions with the bit pattern within a time-domain window surrounding each observation.

## RJ/DJ Separation via Spectrum Analysis

When the source waveform represents a repeating data pattern, Deterministic Jitter (DJ) has a frequency spectrum of impulses. The impulses due to the data pattern are equally spaced and occur at predictable frequencies related to the pattern length and bit rate. Specifically, the pattern-related jitter impulse must occur at multiples of  $f_0/N$ , where  $f_0$  is the data bit rate and  $N$  is the data pattern length. Other spectral impulses may occur due to periodic jitter not correlated with the data pattern.

To obtain measurements of DJ and RJ, all the components of the jitter spectrum that exceed the noise floor by a chosen margin are attributed to deterministic jitter. Those components that fall at the frequency increment corresponding to the pattern length are identified as data-dependent jitter, and those occurring at other frequencies are attributed to uncorrelated periodic jitter. The remaining spectral noise floor (appropriately normalized to account for the removed deterministic jitter) is integrated to predict the standard deviation of the underlying Gaussian random noise process.

Once the spectral components corresponding to each deterministic jitter type have been identified, each component is inverse-transformed back to the time domain. From these waveforms, the peak-to-peak jitter for each component is determined. For the random jitter, the RMS deviation is directly computable from the standard deviation of the Gaussian model.

## RJ/DJ Separation for Arbitrary Patterns

When the data pattern borne by the source waveform is not cyclically repeating, any periodic jitter still has a frequency spectrum consisting of impulses but this is not true of the data-dependent jitter.

In this case, analysis of the data-dependent jitter may proceed based on the assumption that any given bit is affected by a finite (and relatively small) number of preceding bits. By averaging all events for which a given bit is preceded by a particular bit sequence, the data-dependent jitter attributable to that bit sequence is obtained. This is because PJ and RJ are not correlated to a particular data sequence and thus are averaged out.

If each bit is assumed to be affected by  $N$  preceding bits, there are a total of  $2^N$  possible data sequences. The sequence length  $N$  is a configurable parameter. To get statistically sound average values for the data-dependent jitter, a minimum population of observations is required for each individual pattern that occurs at least once. This population limit is also configurable by the user.

By the above means, the data-dependent jitter is characterized. Once characterized, the data-dependent jitter, on a bit-by-bit basis, may be removed from the original jitter versus time record. The remaining jitter is composed of periodic and random jitter. This jitter is transformed into the frequency domain, and the spectral analysis approach is used to separate the impulsive periodic jitter from the broad noise floor of random jitter.

### Estimation of TJ@BER and Eye Width@BER

One of the outcomes of the RJ/DJ separation was a mathematical model for random jitter's probability density function (PDF) and measured values for the PDFs of the deterministic jitter components. Since all of these components are assumed to be statistically independent, the PDF of the total jitter can be calculated by convolution.

Integration of the PDF yields the cumulative distribution function (CDF), which can then be used to create the bit error rate curve (bathtub curve). Based on the bathtub curve, the eye opening (Width@BER) and eye closure (TJ@BER) can be estimated for a given bit error rate.

The application calculates the eye opening at the specified BER using the following equation:

*Eye opening =  $1 - TJ@BER$  when  $TJ@BER$  is less than one Unit Interval*

*Eye opening = 0 when  $TJ@BER$  exceeds one Unit Interval*

## Jitter Estimation Using Dual-Dirac Models

Jitter estimation based on RJ/DJ separation depends in part on the specific jitter components modeled. For the purposes of analyzing jitter and identifying root cause, it is very useful to identify components as specifically as possible. But for the purposes of determining compliance, it has been found that a simplified jitter model yields results that are more consistent across different measurement instruments and different vendors.

A simplified model that has found acceptance in several industry standards is known as the Dual-Dirac model. This is because the probability density function (PDF) of all the deterministic jitter is replaced with a PDF consisting of two Dirac functions such that the total jitter and eye opening at very low bit error rates is unchanged. The Random Jitter and Deterministic Jitter values derived from this model are identified as RJ- $\delta\delta$  and DJ- $\delta\delta$ , respectively.

Two slightly different Dual-Dirac models have been defined. Both models begin with a jitter versus BER (bathtub) curve, either created from a full jitter analysis based on RJ/DJ separation, or from direct measurement of error rate versus sample point offset. The two models differ in how the RJ- $\delta\delta$  and DJ- $\delta\delta$  values are extracted from the curve.

For the Fibre-Channel standard, values for RJ- $\delta\delta$  and DJ- $\delta\delta$  are chosen such that the Dual-Dirac bathtub curve exactly matches the measured curve at the BER =  $10^{-5}$  and BER= $10^{-9}$  points.

For the PCI-Express and FB-DIMM standards, the bathtub curve is re-plotted using a different y-axis. Instead of directly plotting against the log of the BER, the y-axis is converted to the Q-scale. The BER to Q-scale transformation was designed such that Gaussian distributions are converted to straight lines, with a slope that is directly related to the standard deviation of the Gaussian.

When using the Dual-Dirac jitter measurements, it is critical that you select the model that matches the applicable standard. This may be configured in the DPOJET preferences, which are found under **Analyze > Jitter and Eye Analysis > Preferences**, on the Measurement tab.

## Results

The application calculates statistics for all selected measurements. The application displays the following statistics in the Results menu:

- Mean
- Std Dev (Standard Deviation)
- Max (Maximum Value)
- Min (Minimum Value)
- p-p (Peak-to-Peak)
- Population
- Max-cc (Maximum positive cycle-to-cycle variation)

- Min-cc (Maximum negative cycle-to-cycle variation)

### Mean

The application calculates the mean value using the following equation:

$$\text{Mean}(X) = \bar{X} = \frac{1}{N} \sum_{n=1}^N X_n$$

### Standard Deviation

The application calculates the standard deviation using the following equation:

$$\text{StdDev}(X) = \sigma_X = \sqrt{\frac{1}{(N-1)} \sum_{n=1}^N (X_n - \bar{X})^2}$$

It may seem odd that the equation for the estimate of the Standard Deviation contains a 1/(N-1) scaling factor. If you knew the true mean of X and used it in place of the estimated mean  $\bar{X}$  then you would, in fact, scale by 1/N. But,  $\bar{X}$  is an estimate and is likely to be in error (or bias), causing the estimate of the Standard Deviation to be too small if scaled by 1/N. This is the reason for the scaling shown in the equation. (Refer to Chapter 9.2 in A. Papoulis, Probability, Random Variables, and Stochastic Processes, McGraw Hill, 1991.)

---

**NOTE.** RMS value can be calculated using the relation  $(\text{rms})^2 = (\text{mean value})^2 + (\text{stddev})^2$

---

### Maximum Value

The application calculates maximum value using the following equation:

$$\text{Max}(X) = \text{Most Positive Value of } X$$

### Minimum Value

The application calculates minimum value using the following equation:

$$\text{Min}(X) = \text{Most Negative Value of } X$$

### p-p

The application calculates peak-to-peak using the following equation:

$$p-p(X) = \text{Max}(X) - \text{Min}(X)$$

### Population

Population is the total number of events or observations over which the other statistics were calculated.

Population (X) = N

### Max-cc

The application calculates Max-cc using the following equation:

$$\text{Max-cc}(X) = \text{Max}(X_{CC})$$

Where:

$X_{CC}$  is the first difference of X.

$$X_{CC} = X_n - X_{n-1}$$

### Min-cc

The application calculates Min-cc using the following equation:

$$\text{Min-cc}(X) = \text{Min}(X_{CC})$$

Where:

$X_{CC}$  is the first difference of X.

$$X_{CC} = X_n - X_{n-1}$$





## About the GPIB Program

You can use remote GPIB commands to communicate with the DPOJET application. An example of a GPIB program that can execute the DPOJET application is included with the application in `C:\TekApplications\DPOJET\Examples`.

The example shows how a GPIB program executes the application to do the following tasks:

1. Start the application.
2. Recall a setup.
3. Take a measurement.
4. View measurement results and plots.
5. Exit the application.

---

**NOTE.** *Commands are not case and space sensitive. Your program will operate correctly even if you do not follow the capitalization and spacing precisely.*

---

## GPIB Reference Materials

To use GPIB commands with your oscilloscope, you can refer to the following materials:

- The GPIB Program Example in `C:\TekApplications\DPOJET\Examples` for guidelines to use while designing a GPIB program.
- The Parameters topics for range of values, minimum units and default values of parameters.
- The programmer information in the online help of your oscilloscope.

## Argument Types

The syntax shows the format that the instrument returns in response to a query. This is also the preferred format when sending the command to the instrument though any of the formats will be accepted. This documentation represents these arguments as follows:

**Table 76: Argument types**

Symbol	Meaning
<NR1>	Signed integer value.
<NR2>	Floating point value without an exponent.
<NR3>	Floating point value with an exponent.

## DPOJET: ADDMeas

This set-only parameter adds the specified measurement to the bottom of the current DPOJET list of measurements and will appear in the results summary page.

### Syntax

```
DPOJET:ADDmeas {PERIOD | CCPeriod | FREQUENCY | NPERIOD | PWIDTH | NWIDTH |
PDUTY | NDUTY | PCCDUTY | NCCDUTY | TIE | RJ | RJDirac | TJber | DJ | DJDirac
| PHASENoise | DCD | DDJ | PJ | RISEtime | SETUP | HIGHTime | FALLtime | HOLD
| LOWtime | SKEW | HEIGHT | WIDTH | MASKHits | WIDTHBer | COMMONmode | HIGH |
TNratio | HIGHLOW | LOW | VDIFFxovr| DDRSETUPSe | DDRSETUPdiff | DDRHOLDSe |
DDRHOLDDiff}
```

### Arguments

Same as syntax for measurement options.

### Outputs

NONE

## DPOJET: CLEARALLMeas

This set-only parameter clears the entire current list of defined measurements in DPOJET.

### Syntax

DPOJET: CLEARALLMeas

### Arguments

NONE

### Outputs

NONE

## DPOJET: STATE

Returns the current measurement state of DPOJET.

### Syntax

DPOJET: STATE { RUN | SINGLE | RECALC | CLEAR | STOP }

### Inputs

{ RUN | SINGLE | RECALC | CLEAR | STOP }

### Outputs

The current state of the DPOJET measurement sequencer, including any of the possible inputs.

## DPOJET:LASTError?

Returns the contents of the last pop-up warning dialog box. It returns an empty string should no error have occurred since startup, or since the last call to DPOJET:LASTError?.

### Syntax

DPOJET:LASTError?

### Inputs

STRING

## DPOJET:MEAS<x>

Returns the branch query for the application measurement slot with index <x>. This will always match the measurement defined at the associated index <x> displayed in the DPOJET screen, where index 1 is the first, or top of the measurement list.

Branch queries will only contain the measurement branches for those branches which have measurements defined. This is required because of the number of measurements that can be defined in DPOJET, is 99.

### Syntax

DPOJET:MEAS<x>

DPOJET:MEAS<x>?

## DPOJET:MEAS<x>:NAME?

Returns the measurement name for the measurement in slot x.

### Syntax

DPOJET:MEAS<x>:NAME?

### Outputs

String

## DPOJET:MEAS<x>:CUSTomname

This sets or queries the custom measurement name for the measurement in slot x.

### Syntax

DPOJET:MEAS<x>:CUSTomname

### Inputs

string

### Outputs

string

## DPOJET:MEAS<x>:MEASStart

Sets or queries the measurement start value.

### Syntax

DPOJET:MEAS<x>:MEASStart

### Inputs

<NR3>

### Outputs

<NR1>

## DPOJET:MEAS<x>:EDGEIncre

Sets or queries the measurement edge increment value.

### Syntax

```
DPOJET:MEAS<x>:EDGEIncre
```

### Inputs

<NR3>

### Outputs

<NR1>

## DPOJET:MEAS<x>:N

Sets or queries the measurement N value.

### Syntax

```
DPOJET:MEAS<x>:N
```

### Inputs

<NR3>

### Outputs

<NR1>

## DPOJET:MEAS<x>:SOUrce1

Sets or queries the Source1 value.

### Syntax

```
DPOJET:MEAS<x>:SOUrce1
```

### Inputs

```
{CH1 - CH4, MATH1 - MATH4, REF1 - REF4}
```

### Outputs

```
{CH1 - CH4, MATH1 - MATH4, REF1 - REF4}
```

## DPOJET:MEAS<x>:SOUrce2

Sets or queries the Source2 value. May return NONE for single-source measurement.

### Syntax

```
DPOJET:MEAS<x>:SOUrce2
```

### Inputs

```
{CH1 - CH4, MATH1 - MATH4, REF1 - REF4}
```

### Outputs

```
{CH1 - CH4, MATH1 - MATH4, REF1 - REF4}
```

## DPOJET:MEAS<x>:EDGE1

Sets or queries the Source1 edge type.

### Syntax

```
DPOJET:MEAS<x>:EDGE1
```

### Inputs

```
{RISe, FALL, BOTH}
```

### Outputs

```
{RISe, FALL, BOTH}
```

## DPOJET:MEAS<x>:EDGE2

Sets or queries the Source2 edge type.

### Syntax

```
DPOJET:MEAS<x>:EDGE2
```

### Inputs

```
{RISe, FALL, BOTH}
```

### Outputs

```
{RISe, FALL, BOTH}
```



## DPOJET:MEAS<x>:SIGNALType

Sets the signal type for various measurements.

### Syntax

```
DPOJET:MEAS<x>:SIGNALType
```

### Inputs

```
{CLOCK, DATA, or AUTO}
```

### Outputs

```
{CLOCK, DATA, or AUTO}
```

## DPOJET:MEAS<x>:TOEdge

Sets the TOEdge value for the measurement.

### Syntax

```
DPOJET:MEAS<x>:TOEdge
```

### Inputs

```
{SAMEas, OPPOSITEas}
```

### Outputs

```
{SAMEas, OPPOSITEas}
```

## DPOJET:MEAS<x>:FROMedge

Sets the FROMedge value for the measurement.

### Syntax

DPOJET:MEAS<x>:FROMedge

### Inputs

{RISe, FALL, BOTH}

### Outputs

{RISe, FALL, BOTH}

## DPOJET:MEAS<x>:FILTERs:RAMPTime

Sets or queries the current filter ramp time.

### Syntax

DPOJET:MEAS<x>:FILTERs:RAMPTime

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:FILTERs:BLANKingtime

Sets or queries the current filter blanking time.

### Syntax

DPOJET:MEAS<x>:FILTERs:BLANKingtime

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:FILTERs:HIGHPass:SPEC

Sets or queries the current high pass filter specification.

### Syntax

```
DPOJET:MEAS<x>:FILTERs:HIGHPass:SPEC {NONE, FIRST, SECOND, THIRD}
```

### Inputs

```
{NONE, FIRST, SECOND, THIRD}
```

### Outputs

```
{NONE, FIRST, SECOND, THIRD}
```

## DPOJET:MEAS<x>:FILTERs:HIGHPass:FREQ

Sets or queries the current high pass filter frequency.

### Syntax

```
DPOJET:MEAS<x>:FILTERs:HIGHPass:FREQ
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:FILTERs:LOWPass:SPEC

Sets or queries the current low pass filter specification.

### Syntax

```
DPOJET:MEAS<x>:FILTERs:LOWPass:SPEC {NONE, FIRST, SECOND, THIRD}
```

### Inputs

```
{NONE, FIRST, SECOND, THIRD}
```

### Outputs

```
{NONE, FIRST, SECOND, THIRD}
```

## DPOJET:MEAS<x>:FILTERs:LOWPass:FREQ

Sets or queries the current low pass filter frequency.

### Syntax

```
DPOJET:MEAS<x>:FILTERs:LOWPass:FREQ
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:RJDJ:BER

Sets or queries the current RJDJ BER value.

### Syntax

```
DPOJET:MEAS<x>:RJDJ:BER
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:RJDJ:TYPE

Sets or queries the current RJDJ measurement type.

### Syntax

```
DPOJET:MEAS<x>:ENVIRONMENT:RJDJ:TYPE {ARBITRARY, REPEATING}
```

### Inputs

{ARBITRARY, REPEATING}

### Outputs

{ARBITRARY, REPEATING}

## DPOJET:MEAS<x>:RJDJ:PATLen

Sets or queries the current RJDJ pattern length.

### Syntax

DPOJET:MEAS<x>:RJDJ:PATLen

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:RJDJ:WINDOwlength

Sets or queries the current RJDJ window length.

### Syntax

DPOJET:MEAS<x>:RJDJ:WINDOwlength

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:RJDJ:POPulation

Sets or queries the current RJDJ population.

### Syntax

```
DPOJET:MEAS<x>:RJDJ:POPulation
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:CLOCKRecovery:METHOD

Sets or queries the current Clock recovery method.

### Syntax

```
DPOJET:MEAS<x>:CLOCKRecovery:METHOD {STANDARD, CUSTOM, CONSTMEAN, CONSTFIXED, EXPEDGE, EXPPLL, CONSTMEDIAN }
```

### Inputs

{STANDARD, CUSTOM, CONSTMEAN, CONSTFIXED, EXPEDGE, EXPPLL, CONSTMEDIAN}

### Outputs

{STANDARD, CUSTOM, CONSTMEAN, CONSTFIXED, EXPEDGE, EXPPLL, CONSTMEDIAN}



## DPOJET:MEAS<x>:CLOCKRecovery:MODEl

Sets or queries the current clock recovery model.

### Syntax

```
DPOJET:MEAS<x>:CLOCKRecovery:MODEl {ONE | TWO}
```

### Inputs

{ONE, TWO}

### Outputs

{ONE, TWO}

## DPOJET:MEAS<x>:CLOCKRecovery:STANDARD

Sets or queries the current clock recovery standard, as specified in the user interface.

### Syntax

```
DPOJET:MEAS<x>:CLOCKRecovery:STANDARD
```

### Inputs

string

### Outputs

string

## DPOJET:MEAS<x>:CLOCKRecovery:DAMPing

Sets or queries the clock recovery damping value.

### Syntax

DPOJET:MEAS<x>:CLOCKRecovery:DAMPing

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:CLOCKRecovery:LOOPBandwidth

Sets or queries the clock recovery loop bandwidth.

### Syntax

DPOJET:MEAS<x>:CLOCKRecovery:LOOPBandwidth

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:CLOCKRecovery:DATARate

Turns on or off the usage of DATARate.

### Syntax

DPOJET:MEAS<x>:CLOCKRecovery:DATARate

### Inputs

1/0

### Outputs

1/0

## DPOJET:MEAS<x>:CLOCKRecovery:CLOCKBitrate

Sets or queries the clock bit rate. Used if DATARate is 1.

### Syntax

DPOJET:MEAS<x>:ENVIRONMENT:CLOCKRecovery:CLOCKBitrate

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:CLOCKRecovery:CLOCKFrequency

Sets or queries the clock frequency. Used with Constant Clock - Fixed clock recovery method.

### Syntax

```
DPOJET:MEAS<x>:ENVIRONMENT:CLOCKRecovery:CLOCKFrequency
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:CLOCKRecovery:PATtern

Turns on or off the usage of CLOCKPath to specific a known data pattern.

### Syntax

```
DPOJET:MEAS<x>:CLOCKRecovery:PATtern
```

### Inputs

1/0

### Outputs

1/0

## DPOJET:MEAS<x>:CLOCKRecovery:CLOCKPath

Sets or queries the current known clock pattern path.

### Syntax

```
DPOJET:MEAS<x>:ENVIRONMENT:CLOCKRecovery:CLOCKPath
```

### Inputs

string

### Outputs

string

## DPOJET:MEAS<x>:CLOCKRecovery:MEANAUTOCalculate

Sets or queries how often the clock is calculated, either FIRST, or on EVERY acquisition.

### Syntax

```
DPOJET:MEAS<x>:CLOCKRecovery:MEANAUTOCalculate
```

### Inputs

{FIRST, EVERY}

### Outputs

{FIRST, EVERY}

## DPOJET:MEAS<x>:CLOCKRecovery:NOMINALOFFset

Sets or queries the clock offset.

### Syntax

DPOJET:MEAS<x>:CLOCKRecovery:NOMINALOFFset

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:CLOCKRecovery:CLOCKMultiplier

Sets or queries the clock multiplier.

### Syntax

DPOJET:MEAS<x>:CLOCKRecovery:CLOCKMultiplier

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:BITType

Sets or queries the measurement bit type setting.

### Syntax

```
DPOJET:MEAS<x>:BITType
```

### Inputs

```
{ALLbits, NONTRANSition, TRANSition}
```

### Outputs

```
{ALLbits, NONTRANSition, TRANSition}
```

## DPOJET:MEAS<x>:BITPcnt

Sets or queries the percentage of the center of bit to measure.

### Syntax

```
DPOJET:MEAS<x>:BITPcnt
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:BITCfmethod

Sets or queries the measurement bit configure method.

### Inputs

{MEAN, MODE}

### Outputs

{MEAN, MODE}

## DPOJET:MEAS<x>:MASKfile

Sets or queries the current mask file name.

### Syntax

DPOJET:MEAS<x>:MASKfile

### Inputs

String

### Outputs

String



## DPOJET:MEAS<x>:MEASRange:STATE

Turns on or off the measurement range limits.

### Syntax

DPOJET:MEAS<x>:MEASRange:STATE

### Inputs

1/0

### Outputs

1/0

## DPOJET:MEAS<x>:MEASRange:MIN

Sets or queries the minimum measurement range limit value.

### Syntax

DPOJET:MEAS<x>:MEASRange:MIN

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:MEASRange:MAX

Sets or queries the maximum measurement range limit value.

### Syntax

```
DPOJET:MEAS<x>:MEASRange:MAX
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:PHASENoise:LOWLimit

Sets or queries the lower phase noise integration limit.

### Syntax

```
DPOJET:MEAS<x>:PHASENoise:LOWLimit
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:PHASENoise:HIGHLimit

Sets or queries the upper phase noise integration limit.

### Syntax

```
DPOJET:MEAS<x>:PHASENoise:HIGHLimit
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:LOGging:STATistics:SElect

Sets or queries the given measurement for inclusion in any statistic logging. Statistic logging is turned on or off as a whole, using the DPOJET:LOGging branch.

### Syntax

```
DPOJET:MEAS<x>:LOGging:STATistics:SElect
```

### Inputs

1/0

### Outputs

1/0

## DPOJET:MEAS<x>:LOGging:MEASurements:SElect

Sets or queries the given measurement for inclusion in any measurement logging. Statistic logging is turned on or off as a whole, using the DPOJET:LOGging branch.

### Syntax

```
DPOJET:MEAS<x>:LOGging:MEASurements:SElect
```

### Inputs

1/0

### Outputs

1/0

## DPOJET:MEAS<x>:LOGging:MEASurements:FILEname?

Queries current file name that will be used for the measurement, should measurement logging be turned on.

### Syntax

```
DPOJET:MEAS<x>:LOGging:MEASurements:FILEname?
```

### Outputs

string

## DPOJET:MEAS<x>:LOGging:WORSTcase:SElect

Sets or queries the given measurement for inclusion in any worst case logging. Statistic logging is turned on or off as a whole, using the DPOJET:LOGging branch.

### Syntax

```
DPOJET:MEAS<x>:LOGging:WORSTcase:SElect
```

### Inputs

1/0

### Outputs

1/0

## DPOJET:GATING

Sets or queries the gating state.

### Syntax

DPOJET:GATING

### Inputs

{OFF, ZOOM, CURSORS}

### Outputs

{OFF, ZOOM, CURSORS}

## DPOJET:QUALify:STATE

Turns on or off measurement qualification.

### Syntax

DPOJET:QUALify:STATE

### Inputs

1/0

### Outputs

1/0

## DPOJET:QUALify:SOURce

Sets the qualifier source.

### Syntax

DPOJET:QUALify:SOURce

### Inputs

{CH1 - CH4, MATH1 - MATH4, REF1 - REF4, SEARCH1 - SEARCH8}

### Outputs

{CH1 - CH4, MATH1 - MATH4, REF1 - REF4, SEARCH1 - SEARCH8}

## DPOJET:QUALify:ACTIVE

Sets the active state for the qualifier source, either HIGH or LOW.

### Syntax

```
DPOJET:QUALify:ACTIVE
```

### Inputs

```
{HIGH, LOW}
```

### Outputs

```
{HIGH, LOW}
```

## DPOJET:POPULATION:STATE

Turns on or off population limits.

### Syntax

```
DPOJET:POPULATION:STATE
```

### Inputs

```
1/0
```

### Outputs

```
1/0
```



## DPOJET:POPULATION:LIMITBY

Sets or queries the mechanism by limits, either acquisition or population.

### Syntax

```
DPOJET:POPULATION:LIMITBY
```

### Inputs

```
{ACQuisitions, POPUlation}
```

### Outputs

```
{ACQuisitions, POPUlation}
```

## DPOJET:POPULATION:LIMIT

Sets or queries the current limit value.

### Syntax

```
DPOJET:POPULATION:LIMIT
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR1>
```

## DPOJET:POPULATION:CONDition

Sets or queries the current population limit condition.

### Syntax

DPOJET:POPULATION:CONDition

### Inputs

{EACHmeas | LASTmeas}

### Outputs

{EACHmeas | LASTmeas}

## DPOJET:LIMITRise

Turns on or off the ability to limit Rise/Fall measurements to transition bits only.

### Syntax

DPOJET:LIMITRise

### Inputs

1/0

### Outputs

1/0

## DPOJET:DIRacmodel

Sets or queries the current dirac model.

### Syntax

```
DPOJET:DIRacmode]
```

### Inputs

```
{FIBREchannel, PCIExpress}
```

### Outputs

```
{FIBREchannel, PCIExpress}
```

## DPOJET:INTERp

Sets or queries the current interpolation model.

### Syntax

```
DPOJET:INTERp
```

### Inputs

```
{LINEar, SINX}
```

### Outputs

```
{LINEar, SINX}
```

## DPOJET:SOURCEAutoset

Performs a DPOJET horizontal, vertical, or autoset on both horizontal and vertical for any sources used in current measurements.

### Syntax

DPOJET:SOURCEAutoset

### Inputs

{HORIZONTAL | VERTICAL | BOTH}

## DPOJET:REFLevels:AUTOSet

Performs a DPOJET relevel autoset on any sources selected using DPOJET:REFLevels:CH<x>:AUTOSet.

### Syntax

DPOJET:REFLevels:AUTOSet

### Inputs

EXECute

---

**NOTE.** All pieces of the relevel branch have the ability to set ref levels for CH1-CH4, MATH1-MATH4, and REF1-Ref4. Only the CH<x> portion is shown in this OLH,, but it exists and matches exactly for MATH (DPOJET:REFLevels:MATH<x> and REF (DPOJET:REFLevels:REF<x>).

---

## DPOJET:REFLevels:CH<x>:AUTOSet

Sets or clears the relevel autoset state of the given source. When set to 1, the given source will have a ref level autoset done on it during the next acquisition.

### Syntax

```
DPOJET:REFLevels:CH<x>:AUTOSet
```

### Inputs

1/0

### Outputs

1/0

---

**NOTE.** The Ref Level Autoset state is shown only for Ch1-Ch4 sources. It is the same for MATH and Ref waveforms. For example: DPOJET:REFLevels: MATH<x>, DPOJET:REFLevels:REF<x>.

---

## DPOJET:REFLevels:CH<x>:BASETop

Sets the base-top method for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:BASETop {MINMax, FULLhistogram, EYEhistogram, AUTO}
```

### Inputs

{MINMax, FULLhistogram, EYEhistogram, AUTO}

### Outputs

{MINMax, FULLhistogram, EYEhistogram, AUTO}

## DPOJET:REFLevels:CH<x>:ABsolute

The ABSolute branch specifies the ref levels in the event a user chooses not to run a ref level autoset on a given source. In the event the user does run a ref level autoset, the percentage values below are used.

## DPOJET:REFLevels:CH<x>:ABsolute:RISEHigh

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABsolute:RISEHigh
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:ABsolute:RISEMid

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABsolute:RISEMid
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:ABsolute:RISELow

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABsolute:RISELow
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:ABsolute:FALLHigh

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABsolute:FALLHigh
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:ABsolute:FALLMid

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABsolute:FALLMid
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:ABsolute:FALLLow

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABsolute:FALLLow
```

### Inputs

<NR3>

### Outputs

<NR3>



## DPOJET:REFLevels:CH<x>:ABSolute:HYSTeresis

Sets the hysteresis value used for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:ABSolute:HYSTeresis
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent

Sets percent refllevel parameters work as the absolute parameters do, only setting the various percentage levels used by the autoset.

## DPOJET:REFLevels:CH<x>:PERcent:RISEHigh

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:RISEHigh
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent:RISEMid

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:RISEMid
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent:RISELow

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:RISELow
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent:FALLHigh

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:FALLHigh
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent:FALLMid

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:FALLMid
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent:FALLLow

Sets the ref level voltage relative to base top for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:FALLLow
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:REFLevels:CH<x>:PERcent:HYSteresis

Sets the hysteresis value used for autoset.

### Syntax

```
DPOJET:REFLevels:CH<x>:PERcent:HYSteresis
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULTS?

Returns the measurement branch for the currently selected measurement for measurement slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULTS?
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:POPulation?

Returns the population measurement value for the currently selected measurement for measurement slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:POPulation?
```

### Outputs

```
<NR1>
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:POPulation:STATus?

Returns the pass/fail status for the population measurement for the currently loaded limit file. (Set using DPOJET:LIMits:FILEName)

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:POPulation:STATus?
```

### Outputs

```
{PASS | FAIL}
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:MEAN?

Returns the mean measurement for the currently loaded limit file.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MEAN?
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:MEAN:STATUs?

Returns the pass/fail status for the mean measurement for the currently loaded limit file. (Set using DPOJET:LIMits:FILEName)

### Syntax

DPOJET:MEAS<x>:RESULts:CURRentacq:MEAN:STATUs?

### Outputs

{PASS | FAIL}

## DPOJET:MEAS<x>:RESULts:CURRentacq:STDDev?

Returns the standard deviation of the measurement value for the currently selected measurement for measurement slot <x>.

### Syntax

DPOJET:MEAS<x>:RESULts:CURRentacq:StdDev?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:CURRentacq:STDDev:STATUs?

Returns the pass/fail status for the standard deviation measurement for the currently loaded limit file. (Set using DPOJET:LIMits:FILEName)

### Syntax

DPOJET:MEAS<x>:RESULts:CURRentacq:STDDev:STATUs?

### Outputs

{PASS | FAIL}

## DPOJET:MEAS<x>:RESULts:CURRentacq:MAX?

Returns the maximum value of the measurement value for the currently selected measurement for measurement slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MAX?
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:MAX:STATUs?

Returns the pass/fail status for the max measurement for the currently loaded limit file. (Set using DPOJET:LIMits:FILEName)

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MAX:STATUs?
```

### Outputs

```
{PASS | FAIL}
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:MIN?

Returns the minimum value for the currently selected measurement for measurement slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MIN?
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:MIN:STATUs?

Returns the pass/fail status for the minimum measurement for the currently loaded limit file. (Set using DPOJET:LIMits:FILEName)

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MIN:STATUs?
```

### Outputs

```
{PASS | FAIL}
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:PK2PK?

Returns the peak-to-peak value for the currently selected measurement for measurement slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:PK2PK?
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:RESULts:CURRentacq:PK2PK:STATUs?

Returns the pass/fail status for the peak-to-peak measurement for the currently loaded limit file. (Set using DPOJET:LIMits:FILEName)

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:PK2PK:STATUs?
```

### Outputs

```
{PASS | FAIL}
```



## DPOJET:MEAS<x>:RESULts:CURRentacq:MAXCC?

Returns the maximum positive cycle-to-cycle delta of the selected measurement.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MAXCC?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:CURRentacq:MAXCC:STATUs?

Returns the pass/fail status for the max cycle-to-cycle measurement for the currently loaded limit file.  
(Set using DPOJET:LIMits:FILEName)

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MAXCC:STATUs?
```

### Outputs

{PASS | FAIL}

## DPOJET:MEAS<x>:RESULts:CURRentacq:MINCC?

Returns the maximum negative cycle-to-cycle delta of the selected measurement.

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MINCC?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:CURRentacq:MINCC:STATus?

Returns the pass/fail status for the min cycle-to-cycle measurement for the currently loaded limit file.  
(Set using DPOJET:LIMits:FILEName)

### Syntax

```
DPOJET:MEAS<x>:RESULts:CURRentacq:MINCC:STATus?
```

### Outputs

```
{PASS | FAIL}
```

## DPOJET:MEAS<x>:RESULts:ALLAcqs:POPULation?

Returns the mean measurement value for the currently selected measurement for measurement slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:POPULation?
```

### Outputs

```
<NR1>
```

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MEAN?

Returns the mean value for all accumulated measurement acquisitions for slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:MEAN?
```

### Outputs

```
<NR3>
```

## DPOJET:MEAS<x>:RESULts:ALLAcqs:STDev?

Returns the standard deviation for all accumulated measurement acquisitions for slot <x>.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:STDev?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MAX?

Returns the maximum value for all accumulated measurement acquisitions for slot <x>.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:MAX?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MIN?

Returns the minimum value for all accumulated measurement acquisitions for slot <x>.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:MIN?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:PK2PK?

Returns the peak-to-peak value for all accumulated measurement acquisitions for slot <x>.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:PK2PK?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MAXCC?

Returns the maximum positive cycle-to-cycle delta of the selected measurement.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:MAXCC
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MINCC?

Returns the maximum negative cycle-to-cycle delta of the selected measurement.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:MINCC?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:SEG<x>:MINHits?

Returns the minimum mask hits measurement for the given segment, either SEG1, SEG2 or SEG3.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:SEG<x>:MINHits?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:SEG<x>:MAXHits?

Returns the maximum mask hits measurement for the given segment, either SEG1, SEG2 or SEG3.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:SEG<x>:MAXHits?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:SEG<x>:Hits?

Returns the mask hits measurement for the given segment, either SEG1, SEG2 or SEG3.

### Syntax

```
DPOJET:MEAS<x>:RESULts:ALLAcqs:SEG<x>:Hits?
```

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MINHits?

Returns the minimum mask hits measurement for all segments.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:MINHits?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:MAXHits?

Returns the maximum mask hits measurement for all segments.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:MAXHits?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:HITS?

Returns the mask hits measurement for all segments.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:HITS?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULts:ALLAcqs:HITPopulation?

Returns the mask hit population.

### Syntax

DPOJET:MEAS<x>:RESULts:ALLAcqs:HITPopulation?

### Outputs

<NR3>

## DPOJET:MEAS<x>:RESULTS:STATUs?

Returns the status of the given measurement values in slot MEAS<x>. Valid for currently valid measurements, or the error status such as “Not enough edges”.

### Syntax

DPOJET:MEAS<x>:RESULTS:STATUs?

### Outputs

string

## DPOJET:ADDPlot

This set-only command creates a plot of the specified type on the specified DPOJET measurement. Up to four plots can be created.

### Syntax

```
DPOJET:ADDPlot
```

### Inputs

```
{TIMETrend | DATAarray | HISTOgram | SPECTrum | TRANSfer | PHASEnoise | EYE |  
WAVEform | BATHtub}, MEAS<x>}
```

### Example

```
DPOJET:ADDPlot HISTOgram, MEAS2
```

## DPOJET:CLEARALLPlots

This set-only parameter clears the entire current list of defined plots in DPOJET.

### Syntax

```
DPOJET:CLEARALLPlots
```

### Arguments

```
NONE
```

### Outputs

```
NONE
```



## DPOJET:PLOT<x>:TYPE?

Returns the current plot type for the selected plot.

### Syntax

DPOJET:PLOT<x>:TYPE?

### Outputs

{TIMEtrend | DATAarray | HISTOgram | SPECTrum | TRANSfer | PHASEnoise | EYE  
| WAVEform | BATHtub}

## DPOJET:PLOT<x>:SOURCE?

Returns the source measurement for the selected plot.

### Syntax

DPOJET:PLOT<x>:SOURCE?

### Outputs

{MEAS1 - MEAS99}

## DPOJET:PLOT<x>:TREND:TYPE

Sets or returns the trend type setting for Trend plots.

### Syntax

DPOJET:PLOT<x>:TREND:TYPE

### Inputs

{VECTOR | BAR}

### Outputs

{VECTOR | BAR}

## DPOJET:PLOT<x>:HISTOgram:AUTOset

Runs a histogram autoselection for the specified slot.

### Syntax

DPOJET:PLOT<x>:HISTOgram:AUTOset

### Inputs

{EXECute}

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:HISTOgram:VERTical:SCALE

Sets or returns the vertical scale setting for applicable plots, either Linear or Log.

### Syntax

```
DPOJET:PLOT<x>:HISTOgram:VERTical:SCALE
```

### Inputs

```
{LINEAR | LOG}
```

### Outputs

```
{LINEAR | LOG}
```

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:HISTOgram:HORizontal:AUTOscale

Sets or returns the horizontal auto scale settings.

### Syntax

```
DPOJET:PLOT<x>:HISTOgram:HORizontal:AUTOscale
```

### Inputs

```
1/0
```

### Outputs

```
1/0
```

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:HISTOgram:HORizontal:RESolution

Sets or returns the horizontal resolution used in Eye Diagram plots.

### Syntax

```
DPOJET:PLOT<x>:HISTOgram:HORizontal:RESolution
```

### Inputs

<NR3>

### Outputs

<NR3>

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:HISTOgram:NUMBins

Sets or queries the current histogram resolution.

### Syntax

```
DPOJET:PLOT<x>:HISTOgram:NUMBins
```

### Inputs

{TWENTYfive | FIFTY | HUNDred | TWOFifty | FIVEHundred}

### Outputs

{TWENTYfive | FIFTY | HUNDred | TWOFifty | FIVEHundred}

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:HISTOgram:HORizontal:CENter

Sets or returns the histogram center.

### Syntax

DPOJET:PLOT<x>:HISTOgram:HORizontal:CENter

### Inputs

<NR3>

### Outputs

<NR3>

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:HISTOgram:HORizontal:SPAN

Sets or returns the histogram span.

### Syntax

DPOJET:PLOT<x>:HISTOgram:HORizontal:SPAN

### Inputs

<NR3>

### Outputs

<NR3>

---

**NOTE.** *Undefined for non-histogram plots.*

---

## DPOJET:PLOT<x>:SPECTrum:VERTical:SCALE

Sets or returns the vertical scale setting for applicable plots, either Linear or Log.

### Syntax

```
DPOJET:PLOT<x>:SPECTrum:VERTical:SCALE
```

### Inputs

```
{LINEAR | LOG}
```

### Outputs

```
{LINEAR | LOG}
```

---

**NOTE.** *Undefined for non-spectrum plots.*

---

## DPOJET:PLOT<x>:SPECTrum:HORizontal:SCALE

Sets or returns the horizontal scale setting for applicable plots, either Linear or Log.

### Syntax

```
DPOJET:PLOT<x>:SPECTrum:HORizontal:SCALE
```

### Inputs

```
{LINEAR | LOG}
```

### Outputs

```
{LINEAR | LOG}
```

---

**NOTE.** *Undefined for non-spectrum plots.*

---

## DPOJET:PLOT<x>:SPECtrum:BASE

Sets or returns the spectrum base. Undefined for non-spectrum plots.

### Syntax

```
DPOJET:PLOT<x>:SPECtrum:BASE
```

### Inputs

<NR3>

### Outputs

<NR1>

## DPOJET:PLOT<x>:SPECtrum:MODE

Sets or returns the spectrum mode.

### Syntax

```
DPOJET:PLOT<x>:SPECtrum:MODE
```

### Inputs

{NORMa1 | AVErage | PEAKho1d}

### Outputs

{NORMa1 | AVErage | PEAKho1d}

## DPOJET:PLOT<x>:TRANSfer:VERTical:SCALE

Sets or returns the vertical scale setting for applicable plots, either Linear or Log. Undefined for non-transfer plots.

### Syntax

```
DPOJET:PLOT<x>:TRANSfer:VERTical:SCALE
```

### Inputs

```
{LINEAR | LOG}
```

### Outputs

```
{LINEAR | LOG}
```

## DPOJET:PLOT<x>:TRANSfer:HORIZontal:SCALE

Sets or returns the horizontal scale setting for applicable plots, either Linear or Log. Undefined for non-transfer plots.

### Inputs

```
{LINEAR | LOG}
```

### Outputs

```
{LINEAR | LOG}
```



## DPOJET:PLOT<x>:TRANSfer:MODE

Sets or returns the transfer plot mode.

### Syntax

DPOJET:PLOT<x>:TRANSfer:MODE

### Inputs

{NORMa1 | AVERage}

### Outputs

{NORMa1 | AVERage}

## DPOJET:PLOT<x>:TRANSfer:NUMerator

Sets or returns the transfer plot numerator.

### Syntax

DPOJET:PLOT<x>:TRANSfer:NUMerator

### Inputs

{MEAS1 - MEAS99}

### Outputs

{MEAS1 - MEAS99}

---

**NOTE.** *Undefined for non-transfer plots.*

---

## DPOJET:PLOT<x>:TRANSfer:DENominator

Sets or returns the transfer plot denominator.

### Syntax

DPOJET:PLOT<x>:TRANSfer:DENominator

### Inputs

{MEAS1 - MEAS99}

### Outputs

{MEAS1 - MEAS99}

---

**NOTE.** *Undefined for non-transfer plots.*

---

## DPOJET:PLOT<x>:PHASEnoise:BASEline

Sets or returns the phase noise baseline.

### Syntax

DPOJET:PLOT<x>:PHASEnoise:BASEline

### Inputs

<NR3>

### Outputs

<NR1>

---

**NOTE.** *Undefined for non-phase noise plots.*

---

## DPOJET:PLOT<x>:BATHtub:VERTical:SCALE

Sets or returns the vertical scale setting for applicable plots, either Linear or Log.

### Syntax

```
DPOJET:PLOT<x>:BATHtub:VERTical:SCALE
```

### Inputs

```
{LINEAR | LOG}
```

### Outputs

```
{LINEAR | LOG}
```

---

**NOTE.** *Undefined for non-bathtub plots.*

---

## DPOJET:PLOT<x>:BATHtub:BER

Sets or returns the bathtub BER value.

### Syntax

```
DPOJET:PLOT<x>:BATHtub:BER
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR1>
```

---

**NOTE.** *Undefined for non-bathtub plots.*

---

## DPOJET:PLOT<x>:EYE:HORizontal:RESolution

Sets or returns the Horizontal Eye resolution.

### Syntax

DPOJET:PLOT<x>:EYE:HORizontal:RESolution

### Inputs

<NR3>

### Outputs

<NR1>

---

**NOTE.** *Undefined for non-eye plots.*

---

## DPOJET:PLOT<x>:EYE:HORizontal:AUTOscale

Sets or returns the horizontal auto scale setting.

### Syntax

DPOJET:PLOT<x>:EYE:HORizontal:AUTOscale

### Inputs

1/0

### Outputs

1/0

---

**NOTE.** *Undefined for non-eye plots.*

---

## DPOJET:PLOT<x>:EYE:STATE

Sets or returns the eye state, either on or off.

### Syntax

DPOJET:PLOT<x>:EYE:STATE

### Inputs

1/0

### Outputs

1/0

---

**NOTE.** *Undefined for non-eye plots.*

---

## DPOJET:PLOT<x>:EYE:MASKfile

Sets or returns the mask file.

### Syntax

DPOJET:PLOT<x>:EYE:MASKfile

### Inputs

string

### Outputs

string

---

**NOTE.** *Undefined for non-eye plots.*

---

## DPOJET:REPORT

This set-only parameter executes a DPOJET report save operation for the currently defined report configuration.

### Syntax

DPOJET:REPORT

### Inputs

EXECute

## DPOJET:REPORT:SETupconfig

Turns on or off including setup configuration in reports.

### Syntax

DPOJET:REPORT:SETupconfig

### Inputs

1/0

### Outputs

1/0

## DPOJET:REPORT:APPLicationconfig

Turns on or off including complete application configuration in reports.

### Syntax

DPOJET:REPORT:APPLicationconfig

### Inputs

1/0

### Outputs

1/0

## DPOJET:REPORT:PASSFailresults

Turns on or off including pass/fail results in reports.

### Syntax

DPOJET:REPORT:PASSFailresults

### Inputs

1/0

### Outputs

1/0

## DPOJET:REPORT:DETAILEDresults

Turns on or off including detailed results in reports.

### Syntax

DPOJET:REPORT:DETAILEDresults

### Inputs

1/0

### Outputs

1/0

## DPOJET:REPORT:PLOTimages

Turns on or off including detailed plot images in reports.

### Syntax

DPOJET:REPORT:PLOTimages

### Inputs

1/0

### Outputs

1/0



## DPOJET:REPORT:AUTOincrement

Turns on or off auto increment of report file names.

### Syntax

DPOJET:REPORT:AUTOincrement

### Inputs

1/0

### Outputs

1/0

## DPOJET:REPORT:VIEWreport

Turns on or off viewing report after generation.

### Syntax

DPOJET:REPORT:VIEWreport

### Inputs

1/0

### Outputs

1/0

## DPOJET:REPORT:REPORTName

Sets the current report file name.

### Syntax

DPOJET:REPORT:REPORTName

### Inputs

String

### Outputs

String

## DPOJET:LOGging:SNAPshot

DPOJET export of the specified type, either for statistics or measurements.

### Syntax

```
DPOJET:LOGging:SNAPshot {STATistics | MEASurements}
```

### Inputs

```
{STATistics | MEASurements}
```

### Outputs

```
{STATistics | MEASurements}
```

## DPOJET:LOGging:STATistics:STATE

Turns on or off the future logging of statistics. Individual measurements included in the logging are selected using the DPOJET:MEAS<x>:LOGging node. This parameter turns on or off the entire set of included measurements.

### Syntax

```
DPOJET:LOGging:STATistics:STATE
```

### Inputs

```
1/0
```

### Outputs

```
1/0
```

## DPOJET:LOGging:STATistics:FILEName

Sets or returns the current file used for statistics logging.

### Syntax

DPOJET:LOGging:STATistics:FILEName

### Inputs

String

### Outputs

String

## DPOJET:LOGging:MEASurements:STATE

Turns on or off the future logging of measurements. Individual measurements included in the logging are selected using the DPOJET:MEAS<x>:LOGging node. This parameter turns on or off the entire set of included measurements.

### Syntax

DPOJET:LOGging:MEASurements:STATE

### Inputs

String

### Outputs

String

## DPOJET:LOGging:MEASurements:FOLDer

Sets or returns the current folder used for measurement logging.

### Syntax

DPOJET:LOGging:MEASurements:FOLDer

### Inputs

string

### Outputs

string

## DPOJET:LOGging:WORSTcase:STATE

Turns on or off the future logging of worst case waveforms. Individual measurements included in the logging are selected using the DPOJET:MEAS<x>:LOGging node. This parameter turns on or off the entire set of included measurements.

### Syntax

DPOJET:LOGging:WORSTcase:STATE

### Inputs

1/0

### Outputs

1/0

## DPOJET:LOGging:WORSTcase:FOLDer

Sets or returns the current folder used for worst case logging.

---

**NOTE.** *Waveform filenames generated while worst case logging is on will follow the syntax of “Measurement Name”-“Source”\_Min1.wfm and “Measurement Name”-“Source”\_Max1.wfm, For example: Period1-Ch1\_Max1.wfm, Period1-Ch1\_Min1.wfm, Rise Time1-Ch1\_Max1.wfm, Rise Time1-Ch1\_Min1.wfm*

---

### Syntax

DPOJET:LOGging:WORSTcase:FOLDer

### Inputs

String

### Outputs

String

## DPOJET:LIMits:STATE

Turns on or off the pass-fail limit system. Pass-fail status can be queried using the DPOJET:MEAS <x>:RESULTS node.

### Syntax

```
DPOJET:LIMits:STATE
```

### Inputs

1/0

### Outputs

1/0

## DPOJET:LIMits:FILENAME

Sets or returns the current limits filename.

### Syntax

```
DPOJET:LIMits:FILENAME
```

### Inputs

string

### Outputs

string

## DPOJET:DESKEW

Performs a DPOJET deskew operation with the settings specified in DPOJET:DESKEW.

### Syntax

DPOJET:DESKEW EXEcute

### Inputs

EXEcute

## DPOJET:DESKEW:REFChannel

Sets or queries the reference channel used for deskew operation.

### Syntax

DPOJET:DESKEW:REFChannel

### Inputs

{CH1-CH4}

### Outputs

{CH1-CH4}



## DPOJET:DESKEW:REFMidlevel

Sets or returns the reference channel midlevel value.

### Syntax

```
DPOJET:DESKEW:REFMidlevel
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:DESKEW:REFHysteresis

Sets or returns the reference channel hysteresis value.

### Syntax

```
DPOJET:DESKEW:REFHysteresis
```

### Inputs

<NR3>

### Outputs

<NR3>

## DPOJET:DESKEW:DESKEWchannel

Sets or queries the channel to be deskewed.

### Syntax

```
DPOJET:DESKEW:DESKEWchannel
```

### Inputs

```
{CH1-CH4}
```

### Outputs

```
{CH1-CH4}
```

## DPOJET:DESKEW:DESKEWMidlevel

Sets or returns the deskew channel midlevel value.

### Syntax

```
DPOJET:DESKEW:DESKEWMidlevel
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:DESKEW:DESKEWHysteresis

Sets or returns the deskew channel hysteresis value.

### Syntax

```
DPOJET:DESKEW:DESKEWHysteresis
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:DESKEW:MAXimum

Sets or returns the maximum deskew value possible.

### Syntax

```
DPOJET:DESKEW:MAXimum
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:DESKEW:MINimum

Sets or returns the minimum deskew value possible.

### Syntax

```
DPOJET:DESKEW:MINimum
```

### Inputs

```
<NR3>
```

### Outputs

```
<NR3>
```

## DPOJET:DESKEW:EDGE

Sets or returns the edge types used when calculating deskew.

### Syntax

```
DPOJET:DESKEW:EDGE
```

### Inputs

```
{RISE | FALL | BOTH}
```

### Outputs

```
{RISE | FALL | BOTH}
```

## DPOJET:VERsion?

Returns the current DPOJET version string.

### Syntax

DPOJET:VERsion?

### Outputs

String

## DPOJET:NUMMeas?

Returns the current number of defined measurements.

### Syntax

DPOJET:NUMMeas?

### Outputs

<NR1>

## DPOJET:HIGHPerfrendering

Sets or queries the current high-performance eye rendering setting.

### Syntax

DPOJET:HIGHPerfrendering

### Inputs

1/0

### Outputs

<NR1>

## DPOJET:UNITType

Sets or queries the current unit typesetting for DPOJET, either Unit Interval, or seconds.

### Syntax

DPOJET:UNITType

### Inputs

{UNITinterval, SECONDS}

### Outputs

{UNITinterval, SECONDS}

## DPOJET:SAVE

Set-only parameter saves the specified DPOJET measurement result, to the specified ref. For Example:  
DPOJET:SAVE MEAS4, REF2

### Syntax

DPOJET:SAVE

### Inputs

{MEAS1-MEAS99, REF1-REF4}

## DPOJET:EXPORT

This sets-only parameter saves the specified DPOJET plot, to the specified file path. The Format is determined through the filename extension, with a default of png should no extension be specified.

Supported extensions include jpeg, jpg, tif, tiff, bmp, emf, and png. For example: DPOJET:EXPORT PLOT1, "savedimage.tif".

### Syntax

DPOJET:EXPORT

### Inputs

{PLOT1-PLOT4, <file string>}





# Index

## Symbols and Numbers

- Duty Cycle, 20
- + CC–Duty, 20

## A

- About DPOJET
  - Help > About DPOJET, 11
- Active Edge, 115
- Advanced Explicit
  - Clock-Edge, 103
- Advanced Explicit
  - Clock-PLL, 105
- Advanced Filter Configuration, 89
- Advanced Filter Configure Parameters, 165
- Algorithms, 177
- All Bits, 107
- Application Directories
  - installation directory for DPOJET, 16
- Application Interface Menu
  - Controls, 13
- Apply to AI, 94
- Argument Types, 212
- Armed/Disarmed, 73
- Auto Calc Every Acq, 95
- Auto Calc First Acq, 95
- Autocalc Every Acq, 94
- Autocalc First Acq, 94
- Autoset, 73
- Autoset Parameters, 156
- Autoset Ref Levels, 76

## B

- Band Pass, 87
- Base Top Method, 76
- Bathtub, 125
- Bathtub Plot Parameters, 168
- Bit Config for Amplitude, 109
- Bit Config for Eye Height, 107
- Bit Config for Mask Hits, 108
- Bit Config Parameters, 161

- blanked, 89
- blanking duration, 90
- Blanking Time, 92
- Browse, 13

## C

- CC-Period, 181
- CC–Duty, 20
- Check Boxes, 13
- Clear, 67
- Clear Log, 56
- Clock Edge, 116
- Clock Multiplier, 102
- Clock Recovery, 92
- Clock Recovery Advanced Setup, 96
- clock recovery methods, 92
- Clock Recovery Parameters, 162
- Clock Source, 102
- CM V, 24
- comma separated value, 44
- Command button, 13
- Common Mode, 194
- compatibility, 8
- Compatibility, 8
- configure, 28
- Configure, 66
- Configure Autosets, 34
- Configure Measurement-Jitter Summary, 31
- Configure Measurement-Skew, 30
- Configuring Bathtub Plot, 130
- Configuring Edges, 112
- Configuring Edges for
  - CC-Period/Duty Cycle, 118
- Configuring Edges for DCD, 119
- Configuring Edges for Differential
  - CrossOver, 114
- Configuring Edges for
  - N-Period, 116
- Configuring Edges for Phase Noise, 115

- Configuring Edges for Skew, 113
- Configuring Edges for Two Source Measurements, 117
- Configuring Histogram Plot, 134
- Configuring Measurement, 30
- Configuring Phase Noise Plot, 136
- Configuring Plots, 129
- Configuring Population Limit, 85
- Configuring Qualify with Logic, 83
- Configuring Spectrum Plot, 132
- Configuring Time Trend, 133
- Configuring Transfer Plot, 135
- Connecting to a Device Under Test (DUT), 37
- Constant Clock - Fixed, 92
- Constant Clock - Mean, 92
- Constant Clock - Median, 95
- Content Options, 144
- Control Panel, 66
- Control Panel Parameters, 160
- Conventions, 3
- Cursors and Reset Cursors, 140
- Cursors in a Plot, 142
- Custom Measurement Name, 86
- Customer Feedback, 4

## D

- Damping, 99
- Data Array, 125
- Data Edge, 117
- Data Logging Parameters, 160
- Data Logging-Measurement, 46
- Data Logging-Statistics, 44
- Data Logging-Worst Case, 49
- DCD, 186
- DDJ, 21
- DDR Hold–Diff, 25
- DDR Hold–SE, 25
- DDR Setup–Diff, 25
- DDR Setup–SE, 25
- Description, 121

Deskew, 37  
Deskew Parameters, 159  
Deskew Summary, 39  
Details, 120  
DJ, 184  
DPOJET, 1  
Dual Dirac Deterministic  
    Jitter, 184  
Dual Dirac Model, 57  
Dual Dirac Random Jitter, 183  
DUT, 3  
Duty Cy-Cy, 20  
+Duty Cycle, 20

## E

E1001, 172  
E1002, 172  
E1003, 172  
E1004, 173  
E1005, 173  
E1006, 173  
E1007, 173  
E1008, 173  
E1009, 173  
E1010, 173  
E1012, 173  
E1013, 173  
E1020, 173  
E1021, 173  
E1022, 173  
E1035, 173  
E1040, 173  
E1054, 173  
E1055, 173  
E1056, 173  
E1057, 173  
E1058, 173  
E1059, 173  
E2002, 173  
E2003, 173  
E2004, 173  
E2005, 173  
E2006, 173  
E2007, 173  
E2008, 173  
E3001, 173  
E3002, 173  
E3003, 173

E3004, 174  
E3005, 174  
E3006, 174  
E3007, 174  
E3008, 174  
E3010, 174  
E3011, 174  
E3012, 174  
E4000, 174  
E4001, 174  
E4002, 174  
E4003, 174  
E4004, 174  
E4005, 174  
Edge Increment, 116  
Error Codes, 172  
Error log file, 16  
Explicit Clock Recovery, 101  
Explicit Clock-Edge, 102  
Explicit Clock-PLL, 104  
Export Data Snapshot-  
    Measurement, 41  
Export Data Snapshot-  
    Statistics, 40  
Export Figure, 140  
Export Measurement  
    Summary, 44  
Export Results to Ref, 123  
Exporting Plot Files, 143  
Eye Analysis, 7  
Eye Diagram, 125  
Eye Diagram for Mask Hits, 138  
Eye Diagram Plot for Eye  
    Height, 137  
Eye Diagram Plot  
    Parameters, 167  
Eye Height, 191  
Eye Summary, 35  
Eye Width, 190

## F

Fall Time, 187  
File Name Extensions, 16  
Filter Spec, 89  
Filters, 87  
Filters Parameters, 165  
Five-Time Free Trial, 1  
Flier Spec, 89

Freq (F1), 89  
Freq (F2), 89  
Frequency, 179  
From Edge, 114

## G

Gating, 81  
General, 86  
General Parameters, 166  
Global, 81  
Global Parameters, 166  
GPIB Program, 211  
GPIB Reference Materials, 211

## H

Height, 23  
High, 193  
High Pass, 89  
High Pass filter, 87  
High Time, 22  
High-Low, 196  
Histogram, 125  
Histogram Plot Parameters, 167  
Hold, 190  
Horizontal cursors, 142  
Horizontal Resolution, 69  
Horizontal Scale, 132  
Hysteresis, 53

## I

image export directory, 59  
Installing the Application, 11

## J

Jitter Analysis, 7  
Jitter Analysis Through RJ/DJ  
    Separation, 204  
Jitter Estimation Using  
    Dual-Dirac, 207  
Jitter Summary, 183

## K

Known Data Pattern, 97

**L**

Limit, 85  
 Limit By  
   Population  
     Acquisitions, 85  
 Limits, 60  
 Limits files, 16  
 Log Future Statistics, 45  
 Log Notifiers, 65  
 Log Worst Case Waveforms, 49  
 logging export directory, 59  
 Loop BW, 99  
 Low, 24  
 Low Pass, 89  
 Low Pass filter, 87  
 Low Time, 189  
 Lower Frequency, 115

**M**

Main Edge, 114  
 Mask, 108  
 Mask files, 16  
 Mask Hits, 192  
 Max, 121  
 Max or Min value, 86  
 Max-cc, 121  
 Mean, 121  
 Measure the Center, 109  
 Measurement Range, 86  
 Measurement Select  
   Parameters, 155  
 measurements, 20  
 Measurements-Amplitude, 24  
 Measurements-Eye, 23  
 Measurements-Jitter, 21  
 Measurements-Period/Freq, 20  
 Measurements-Time, 22  
 Menu Shortcuts  
   Alt+A+J, 17  
 Method, 109  
 Min, 121  
 Min-cc, 121  
 Moving and Resizing plots, 140  
 Moving and Resizing Plots, 140

**N**

N-Period, 180

Navigation Panel, 66  
 Neg Width, 20  
 Noise Integration Limits, 115  
 Nominal Clock Offset, 105  
 Nominal Data Rate, 97  
 Non-Transition, 107  
 Notifier Duration, 56  
 N-Period, 20  
 Number of Bins, 134

**O**

One Touch Jitter, 25  
 Opposite as From, 114  
 Oscilloscope model number, 4

**P**

p-p, 121  
 Pass or Fail status, 60  
 Path Defaults, 59  
 Pattern File Name, 97  
 Pattern Length, 111  
 Pattern Type, 112  
 Period, 20  
 Phase Noise, 22  
 Phase Noise Plot Parameters, 168  
 PJ, 21  
 PLL Clock Recovery Setup, 98  
 PLL Custom BW, 99  
 PLL Model, 99  
 PLL Standard BW, 98  
 Plot files, 16  
 Plot Summary Views, 140  
 Plot Usage, 126  
 Plots, 66  
 Population, 121  
 Pos Width, 20  
 Positive and Negative CC  
   Duty, 182  
 Positive and Negative Duty  
   Cycle, 181  
 Positive and Negative Width, 178  
 Preferences Parameters, 158  
 Preferences Setup, 55  
 Preferences-General, 55  
 Preferences-Measurement, 56  
 Print Figure, 140  
 Printing Plots, 143

Probes, 10  
 Product Description, 7  
 Progress Bar Status  
   Messages, 171  
 Progress indicator, 120

**Q**

Qualify  
   Horizontal Sample Rate, 82

**R**

ramp function, 89  
 Ramp Time, 92  
 ramped up, 89  
 Recalc, 67  
 recall, 18  
 Recalling a Default Setup, 19  
 Recalling a Saved Setup, 18  
 Ref Level Menu Parameters, 157  
 Ref Levels, 71  
 Ref Levels Setup, 75  
 reference levels, 71  
 Related Documentation, 2  
 report export directory, 59  
 Report files, 16  
 Reports, 143  
 Reports Format, 145  
 Requirements and Restrictions, 9  
 Results, 66  
 Results as Plots, 124  
 Returning to the Application, 18  
 Rise Time, 22  
 Rising Versus Falling  
   Thresholds, 72  
 RJ, 183  
 RJ/DJ, 109  
 RJ/DJ Analysis of Arbitrary  
   Pattern, 111  
 RJ/DJ Analysis of Repeating  
   Pattern, 110  
 RJ/DJ Separation for Arbitrary  
   Patterns, 206  
 RJ/DJ Separation via Spectrum  
   Analysis, 205  
 RJDJ Analysis Parameters, 165  
 Run, 67  
 run a measurement, 28

- S**
- Safety Summary, xi
  - Same as From, 114
  - Save Current Stats..., 121
  - Save Options, 144
  - Saving a Setup, 18
  - Select, 66
  - Select Measurement, 29
  - Select Plots, 34
  - Select Sources, 32
  - Selecting a Measurement, 63
  - Selecting Plots, 129
  - Sequencing, 120
  - Serial Data/Jitter Guide, 28
  - set up, 28
  - Setup, 22
  - Show Plots, 67
  - Signal Type, 116
  - Sine(x)/x, 58
  - Single, 67
  - single source, 68
  - Skew, 188
  - Source Autoset, 69
  - Sources Setup, 68
  - Spectrum, 125
  - Spectrum Plot Parameters, 167
  - SSC, 87
  - Standard: b/s, 99
  - Starting the Application, 13
  - Stat Pop, 54
  - Statistical Results, 120
  - Statistics log files, 16
  - Std Dev, 121
  - Steps to Deskew Probes and Channels, 37
- Stop Conditions**
- Each Measurement
  - Last Measurement, 85
- Summary, 120
- Summary-Measurement, 51
- Summary-Misc, 54
- Summary-Ref Levels, 52
- Sync Cursor, 140
- T**
- T/nT Ratio, 194
- T/nT-Ratio, 24
- Tab, 13
- Technical Support, 3
- text editor, 65
- TIE, 21
- Time Trend, 125
- Time Trend Plot Parameters, 168
- Timing Analysis, 7
- TJ, 21
- TJ@BER, 184
- TJ@BER and Eye
- Width@BER, 206
- To Edge, 114
- Toolbar Functions in Plot, 140
- Total Jitter Component, 111
- Transfer, 125
- Transfer Function Plot
- Parameters, 168
- Transition, 107
- Tutorial, 147
- two source, 68
- U**
- Upper Frequency, 115
- V**
- V-Diff-Xovr, 24
- Vert & Horiz, 70
- Vertical cursors, 142
- Vertical Scale, 132
- View Log File, 42
- View Results Details, 121
- View Results Summary, 121
- Viewing Plots, 139
- virtual keypad, 14
- W**
- W1011, 173
- W1051, 173
- W1053, 173
- Waveform, 125
- Waveform Files, 147
- Waveform Interpolation Type, 58
- Width, 23
- Width@BER, 23
- Window Length, 112
- Worst Case Logging, 49
- Z**
- Zoom and Reset Zoom, 140
- Zoom in a Plot, 141